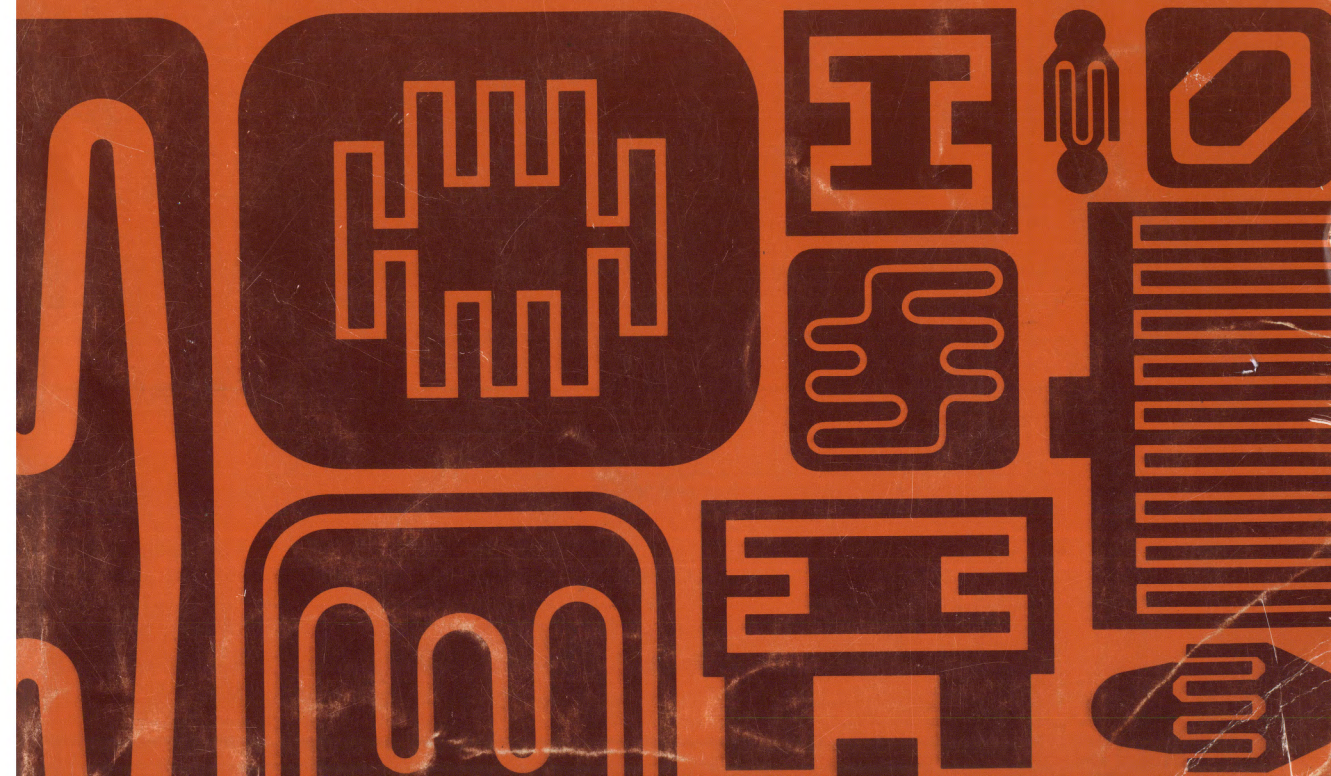


TRANSISTORS

SMALL SIGNAL
FIELD EFFECT
POWER

 **National**



Introduction

This is National Semiconductor's latest handbook on discrete semiconductor devices. You will notice that the company has added more than 350 transistor part numbers and three product families since publication of the last handbook in 1971. Many of these new products already have been widely acclaimed by users.

So, in addition to small signal and bipolar field effect transistors that have been the mainstay of our catalog, you will now find sections for multiple bipolar and multiple field effect transistors and the latest family — power transistors. More part numbers will be added as market needs expand.

To keep current on all new National transistors please contact your National sales representative or franchised distributor and ask to be placed on the customer mailing list.

How to Use This Catalog

Find the basic transistor type number in the Standard Parts Listing which begins on page v. This will reference a page number for the particular Specification sheet.

The Process Number for the device will be found in the extreme right-hand column of the Specification sheet. Process Characteristic sheets are arranged in numerical order and that section begins on page 77.

Refer to the Package Outlines beginning on page 216 for complete physical dimensions of all packages. Note that the numbers in parenthesis behind the case style numbers refer to NS internal package codes.

Process Characteristic sheets contain complete design/application data and limit information. Critical package parameters will be indicated in the "Notes" column of the Process Characteristic sheets.



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2N706	1	JANTXV2N2219A	13	JAN2N2904A	33
JAN2N706	1	2N2221	13	JANTX2N2904A	33
2N708	1	JAN2N2221	13	JANTXV2N2904A	33
2N718	12	JANTX2N2221	13	2N2905	33
2N722	33	JANTXV2N2221	14	JAN2N2905	33
2N744	1	2N2221A	14	JANTX2N2905	33
2N753	1	JAN2N2221A	14	JANTXV2N2905	34
2N760	9	JANTX2N2221A	14	2N2905A	34
2N760A	9	JANTXV2N2221A	14	JAN2N2905A	34
JAN2N760A	9	2N2222	14	JANTX2N2905A	34
2N834	1	JAN2N2222	14	JANTXV2N2905A	34
2N869	27	JANTX2N2222	14	2N2906	34
2N869A	27	JANTXV2N2222	14	JAN2N2906	34
2N915	12	2N2222A	14	JANTX2N2906	34
2N917	5	JAN2N2222A	14	JANTXV2N2906	34
JAN2N918	5	JANTX2N2222A	15	2N2906A	34
JANTX2N918	5	JANTXV2N2222A	15	JAN2N2906A	34
JANTXV2N918	5	2N2243	20	JANTX2N2906A	34
2N929	9	2N2243A	20	JANTXV2N2906A	34
JAN2N929	9	2N2270	20	2N2907	34
JANTX2N929	9	2N2369	1	JAN2N2907	35
JANTXV2N929	9	2N2369A	1	JANTX2N2907	35
2N929A	9	JAN2N2369A	1	JANTXV2N2907	35
2N930	9	JANTX2N2369A	1	2N2907A	35
JAN2N930	9	JANTXV2N2369A	1	JAN2N2907A	35
JANTX2N930	9	2N2453	24	JANTX2N2907A	35
JANTXV2N930	9	2N2453A	24	JANTXV2N2907A	35
2N930A	9	2N2483	10	2N2913	24
2N956	12	2N2484	10	2N2914	24
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2N995A	27	2N2511	10	2N2916	24
2N1132	33	2N2586	10	2N2916A	25
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2N1613	12	JAN2N2604	30	2N2918	25
2N1711	12	2N2605	31	2N2919	25
2N2017	20	JAN2N2605	31	2N2919A	25
2N2102	20	2N2608	54	2N2920	25
2N2192	20	2N2609	54	JAN2N2920	25
2N2192A	20	2N2639	24	JANTX2N2920	25
2N2193	20	2N2640	24	JANTXV2N2920	25
2N2193A	20	2N2641	24	2N2920A	25
2N2195	20	2N2642	24	2N2972	25
2N2195A	20	2N2643	24	2N2973	25
2N2218	12	2N2644	24	2N2974	25
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JANTXV2N2218	12	2N2722	24	2N2977	25
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2N3089A	48	2N3458	49	2N3722	2
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2N3108	21	2N3460	*48	2N3724	2
2N3109	21	2N3467	28	2N3724A	2
2N3110	21	2N3468	29	2N3725	2
2N3117	10	2N3478	5	2N3725A	3
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2N5139	38	2N5545	52	BC108	55
2N5140	30	2N5546	52	BC108A	55
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2N5307	23	2SC563	6	BC161-16	57
2N5308	23	2SC682	6	BC167A	57
2N5334	22	2SC683	6	BC167B	57
2N5335	22	2SC684	6	BC168A	57
2N5336	23	2SC717	6	BC168B	57
2N5337	23	40235	6	BC168C	57
2N5338	23	40236	6	BC169B	57
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BC179A	59	BC238C	62	BF257	65
BC179B	59	BC239	62	BF258	65
BC182K	59	BC239B	62	BF259	65
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BC207B	60	BC409	64	BSY54	67
BC208	61	BC409B	64	BSY95A	67
BC208A	61	BC409C	64	CS9010	7
BC208B	61	BC413	64	CS9011	7
BC208C	61	BC413B	64	CS9012	41
BC209	61	BC413C	64	CS9013	23
BC209B	61	BCY58	64	CS9016	7
BC209C	61	BCY58-7	64	CS9017	7
BC212K	61	BCY58-8	64	CS9018	7
BC212KA	61	BCY58-9	65	CS9019	7
BC212KB	61	BCY58-10	65	E100	50
BC213K	61	BCY59	65	E101	50
BC213KA	61	BCY59-7	65	E102	50
BC213KB	61	BCY59-8	65	E103	50
BC213KC	61	BCY59-9	65	E109	45

DEVICE	PAGE	DEVICE	PAGE	DEVICE	PAGE
EN697	17	FM1307	53	MPS2712	18
EN706	3	FM1308	53	MPS2713	4
EN708	3	FM1309	53	MPS2714	4
EN722	38	FM1310	53	MPS2716	18
EN744	3	FM1311	53	MPS2923	18
EN916	17	FM3954	53	MPS2924	18
EN918	7	FM3954A	53	MPS2925	18
EN930	11	FM3955	53	MPS2926	18
EN956	17	FM3955A	53	MPS3392	18
EN1132	38	FM3956	53	MPS3393	18
EN1711	17	FM3957	53	MPS3394	18
EN2219	17	FM3958	53	MPS3395	18
EN2222	18	KE3684	*50	MPS3396	18
EN2369A	4	KE3685	*51	MPS3397	18
EN2484	11	KE3686	*51	MPS3398	18
EN2905	38	KE3687	*51	MPS3563	7
EN2907	38	KE4091	45	MPS3638	39
EN3250	38	KE4092	45	MPS3638A	39
EN3502	38	KE4093	45	MPS3639	30
EN3504	38	KE4220	51	MPS3640	30
FM1100	52	KE4221	51	MPS3642	18
FM1101	52	KE4222	51	MPS3644	39
FM1102	52	KE4223	47	MPS3645	39
FM1103	52	KE4224	47	MPS3646	4
FM1104	52	KE4391	46	MPS3693	7
FM1105	52	KE4392	46	MPS3694	7
FM1106	52	KE4393	46	MPS3702	39
FM1107	52	KE4416	47	MPS3703	39
FM1108	52	KE4856	46	MPS3704	18
FM1109	52	KE4857	46	MPS3705	18
FM1110	52	KE4858	46	MPS3706	18
FM1111	52	KE4859	46	MPS3707	11
FM1100A	52	KE4860	46	MPS3708	11
FM1101A	52	KE4861	46	MPS3709	11
FM1102A	52	MPF102	47	MPS3710	11
FM1103A	52	MPF103	51	MPS3711	11
FM1104A	52	MPF104	51	MPS3721	18
FM1105A	52	MPF105	51	MPS3826	18
FM1106A	52	MPF106	47	MPS3827	18
FM1107A	52	MPF107	47	MPS4354	41
FM1108A	53	MPF108	47	MPS4355	41
FM1109A	53	MPF109	51	MPS4356	41
FM1110A	53	MPF110	51	MPS5172	18
FM1111A	53	MPF111	51	MPS6507	7
FM1200	53	MPF112	51	MPS6511	7
FM1201	53	MPSA05	23	MPS6512	18
FM1202	53	MPSA06	23	MPS6513	18
FM1203	53	MPSA09	11	MPS6514	18
FM1204	53	MPSA10	18	MPS6515	18
FM1205	53	MPSA12	23	MPS6516	39
FM1206	53	MPSA13	23	MPS6517	39
FM1207	53	MPSA14	23	MPS6518	39
FM1208	53	MPSA20	18	MPS6520	18
FM1209	53	MPSA42	68	MPS6521	18
FM1210	53	MPSA43	68	MPS6522	39
FM1211	53	MPSA55	41	MPS6530	19
FM1300	53	MPSA56	41	MPS6531	19
FM1301	53	MPSA70	32	MPS6532	19
FM1302	53	MPS706	4	MPS6533	39
FM1303	53	MPS834	4	MPS6534	39
FM1304	53	MPS918	7	MPS6535	39
FM1305	53	MPS2369	4	MPS6540	7
FM1306	53	MPS2711	18	MPS6542	7

*Also See Page 48

DEVICE	PAGE	DEVICE	PAGE	DEVICE	PAGE
MPS6543	7	NF4302	51	SE5023	8
MPS6544	7	NF4303	51	SE5024	8
MPS6546	7	NF4304	51	SE5035	8
MPS6560	23	NF4445	46	SE5050	8
MPS6561	23	NF4446	46	SE5051	8
MPS6562	41	NF4447	46	SE5052	8
MPS6563	41	NF4448	46	SE5055	8
MPS6564	19	NF5163	51	SE6001	19
MPS6565	19	NF5457	51	SE6002	19
MPS6566	19	NF5458	51	SE7056	68
MPS6567	7	NF5459	51	SP7056	68
MPS6568A	7	NF5485	47	ST3100	8
MPS6569	7	NF5486	47	ST5025	8
MPS6570	7	NF5555	46	ST5029	8
MPS6571	11	NF5638	46	ST5030	8
MPSH10	8	NF5639	46	ST5031	8
MPSH11	8	NF5640	46	ST5055	8
MPSH19	8	NF5653	46	TIS34	47
MPSH20	8	NF5654	46	TIS58	51
MPSH30	8	NS3762	30	TIS73	46
MPSH31	8	NS3763	30	TIS74	46
MPSH32	8	NS3903	19	TIS75	46
MPSH37	8	NS3904	19	TIS88	47
MPSL01	68	NS3905	39	U231	53
MPSL51	69	NS3906	39	U232	53
NF500	47	P1086E	54	U233	53
NF501	47	P1087E	54	U234	53
NF506	47	PF510	54	U235	53
NF510	46	SE1001	8	U1897E	46
NF520	51	SE1002	8	U1898E	46
NF521	51	SE2001	19	U1899E	46
NF530	51	SE3001	8	UC250	46
NF531	51	SE3002	8	UC251	46
NF580	46	SE4001	11	UC450	55
NF581	46	SE4002	11	UC451	* 55
NF582	46	SE4010	11	UC714	51
NF583	46	SE5020	8	UC734	47
NF584	46	SE5021	8	UC734E	47
NF585	46	SE5022	8		

*Also See Page 54



MIL-STD Qualifications

MIL-STD-19500 qualifications

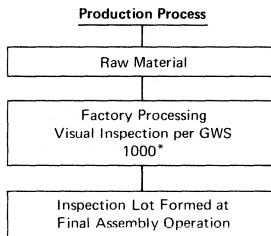
Type	Detail Spec.	Qualification			File or Approval No.	Date of Approval	Approving Agency	Part Included on MIL-STD-701
		JAN	TX	TXV				
2N706		X						
2N760A	218	X			19500-1069-68	3/4/69	DESC	X
2N918	301	X	X	X	19500-1162-67	2/21/68	DESC	X
2N929	253	X	X	X	6724	4/9/65	DESC	X
2N930	253	X	X	X	6725	4/9/65	DESC	X
2N2219	251	X	X	X	6935	10/6/67	DESC	X
2N2218A	251	X	X	X	6921	10/6/67	DESC	X
2N2219	251	X	X	X	6936	10/6/67	DESC	X
2N2219A	251	X	X	X	6922	10/6/67	DESC	X
2N2221	255	X	X	X	6937	10/9/67	DESC	X
2N2221A	255	X	X	X	6923	10/9/67	DESC	X
2N2222	255	X	X	X	6938	10/9/67	DESC	X
2N2222A	255	X	X	X	6924	10/9/67	DESC	X
2N2369A	317	X	X	X	19500-161-68	4/25/68	DESC	X
2N2604	354	X			7066	10/27/66	AMES	X
2N2605	354	X			7067	10/27/66	AMES	X
2N2904	290	X	X	X	6939	10/17/67	DESC	X
2N2904A	290	X	X	X	6940	10/17/67	DESC	X
2N2905	290	X	X	X	6941	10/17/67	DESC	X
2N2905A	290	X	X	X	6942	10/17/67	DESC	X
2N2906	291	X	X	X	6943	10/17/67	DESC	X
2N2906A	291	X	X	X	6944	10/17/67	DESC	X
2N2907	291	X	X	X	6945	10/17/67	DESC	X
2N2907A	291	X	X	X	2946	10/17/67	DESC	X
2N2900	355	X	X	X	7124	1/5/67	DESC	X
2N3019	391	X	X	X	19500-356-68	5/19/69	DESC	X
2N3250A	323A	X	X	X	19500-1204-69	6/19/70	DESC	X
2N3251A	323A	X	X	X	19500-1204-69	6/19/70	DESC	X
2N3810	366	X	X	X	19500-1065-68	5/28/69	DESC	X
2N3811	366	X	X	X	19500-1065-68	5/28/69	DESC	X

JAN TX, TXV, NX and NXV processing

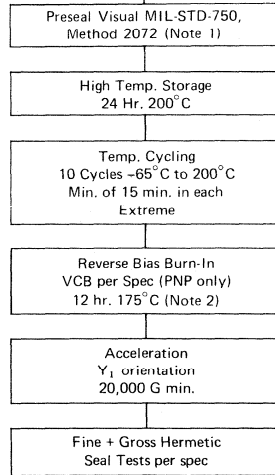
The 100% reliability pre-conditioning on JAN TX parts (vs. no pre-conditioning of JAN parts) has resulted in a significant improvement in field reported failure rates.

National Semiconductor also offers JAN TXV types (JAN TX with 100% preseal visual inspection per MIL-STD-750 Method 2072) per the above list.

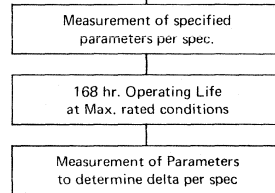
All hermetically sealed transistors in this catalog (where JAN TX or JAN TXV specifications do not exist) are available with TX and TXV type 100% processing as NX and NXV types respectively; e.g., NX2N4033 is 2N4033 processed per the flow plans on this page.



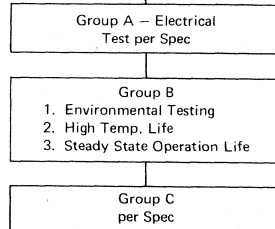
100% Process Conditioning



100% Burn-In (Note 3)



Inspection Test to Verify LTPD



*Patterned after Visual Criteria of MIL-STD-883.

Note 1: JAN TXV types only.

Note 2: Reverse Bias Burn-in restricted to PNP devices only on current JAN TX specs.

Note 3: JAN TX and JAN TXV types only.



JFET Application Guide

National Semiconductor manufactures a broad line of silicon Junction Field Effect Transistors (JFETs). National's JFETs provide excellent performance in many areas such as RF amplifiers, analog switching, low input current amplifiers, low noise high impedance amplifiers and outstand-

ing matched duals for operational amplifiers input applications.

The following chart is a guide to enable the user to determine what parameters are important in each application.

APPLICATIONS AND THEIR PARAMETERS LISTED IN APPROXIMATE ORDER OF IMPORTANCE

LOW FREQUENCY AMPLIFIER	LOW NOISE AMPLIFIER	HIGH FREQUENCY AMPLIFIER	DIFFERENTIAL AMPLIFIER	ANALOG SWITCHING	DIGITAL SWITCHING
Y_{fs}	e_n and i_n	$Re(Y_{fs})$	$ V_{GS1} - V_{GS2} $	$R_{DS(ON)}$	$R_{DS(ON)}$
I_{DSS}	NF	$Re(Y_{is})$	$\frac{\Delta V_{GS1} - V_{GS2} }{\Delta T}$	$I_{D(OFF)}$	$V_{GS(OFF)}$
$V_{GS(OFF)}$	Y_{fs}	NF	$ I_{G1} - I_{G2} $	C_{iss}	$t_{on} + t_{off}$
C_{iss}	I_{DSS}	C_{rss}	I_G	C_{rss}	C_{iss}
C_{rss}	$V_{GS(OFF)}$	$Re(Y_{os})$	Y_{fs}	$V_{GS(OFF)}$	C_{rss}
		I_{DSS}	Y_{fs1}/Y_{fs2}		
		$V_{GS(OFF)}$	$ Y_{os1} - Y_{os2} $		

For any particular JFET product type, $V_{GS(OFF)}$, $Y_{fs(o)}$ and I_{DSS} can be used to calculate circuit bias conditions and gain within reasonable accuracy. For instance, if $V_{GS(OFF)}$ and I_{DSS} are

known, $Y_{fs(o)}$ (Y_{fs} at zero gate source voltage) can be calculated. The actual devices will deviate slightly from the theoretical formulae listed below.

FORMULAE USED TO ENABLE CALCULATION OF PARAMETERS FROM DATA SHEET INFORMATION

$$I_D = I_{DSS} \left(1 - \frac{V_G}{V_{GS(OFF)}}\right)^2$$

- Variation of drain current with gate bias.

$$Y_{fs} = Y_{fs(o)} \left(1 - \frac{V_G}{V_{GS(OFF)}}\right)$$

- Variation of g_m with gate bias.

$$Y_{fs}^2 - \frac{Y_{fs}^2}{I_{DSS}} I_D$$

- Variation of g_m with drain current.

$$V_{GS(OFF)} = \frac{2 I_{DSS}}{Y_{fs(o)}}$$

- Pinch-off voltage in terms of I_{DSS} and g_{mo} .

$$V_{GS(OFF)} = 1.46 V_G @ I_D = 0.1 I_{DSS}$$

- Pinch-off voltage in terms of V_G at a drain current of $\frac{1}{10} I_{DSS}$.

$$I_D = V_{DS}^2 \frac{I_{DSS}}{V_{GS(OFF)}^2}$$

- Focus of point where the triode (VVR) region ends and linear region starts.

$$R_{DS} \cong \frac{K V_{GS(OFF)}^2}{I_{DSS} (V_{GS(OFF)} - V_G)}$$

- Variation of drain resistance in the triode region in terms of I_{DSS} and V_p with gate bias.

$$K = 0.5 - 0.9$$



Bipolar Transistor and FET Dice

DICE

Standard types from National's transistor families are available in unencapsulated die form for use in hybrid circuits.

FEATURES

- 100% probed and guaranteed to 10% LTPD for key 2N parameters.
 - a. BV_{CBO} , BV_{CEO} , BV_{EBO} and h_{FE} for bipolar transistors.
 - b. BV_{GSS} , I_{DSS} , I_{GSS}^* , R_{ON}^* , Y_{fs} , $V_{GS(off)}$ for FET's.
- Minimum 60% yield to all unprobed 2N parameters.
- 100% visual inspection guaranteed to 10% LTPD for criteria equivalent to MIL-STD-883 Method 2010.
- Gold backing on all types.
- Shipment in wafer carriers.
- Die geometries shown in process section of catalog. Base Pad is identified by adjacent metalized circle on all interdigitated geometries. (e.g. see Process 21)

STANDARD TYPES (see index for page listing specification)

BIPOLAR TRANSISTOR DICE		FETs	
2N915	2N3250A	2N3684	2N4340
2N918	2N3251	2N3685	2N4341
2N929	2N3251A	2N3686	2N4391
2N930	2N3467	2N3687	2N4392
2N2219, 2222	2N3468	2N3821	2N4393
2N2219A, 2222A	2N3564	2N3822	2N4416
2N2218, 2221	2N3565	2N3823	2N4416A
2N2218A, 2221A	2N3568	2N3824	2N4856
2N2369A	2N3569	2N3921	2N4857
2N2484	2N3638A	2N3954	2N4858
2N2605	2N3640	2N4091	2N4859
2N2880	2N3646	2N4092	2N4860
2N2890	2N3694	2N4093	2N4861
2N2891	2N3724	2N4117	2N5163
2N2894	2N3725	2N4118	2N5196
2N2894A	2N3903	2N4119	2N5432
2N2904, 2906	2N3904	2N4338	2N5433
2N2904A, 2906A	2N3905	2N4339	2N5434
2N2905, 2N2907	2N3906		
2N2905A, 2907A	2N4030		
2N3014	2N4033		
2N3019	2N4208		
2N3020	2N4209		
2N3250			

Information on alternative specifications and packaging methods available on request.

*FET NOTE:

Leakages (I_{GSS}) $\leq 100\text{PA}$ 10% AQL
 $R_{DS(ON)}$ $\leq 10\Omega$ 10% AQL



SATURATED SWITCHES

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Min	V _{EB0} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) Min	h _{FE} Min	h _{FE} Max	I _C (mA) @ &	V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C (mA) @	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C (mA) @	I _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N706	TO-18	25	15	3	500	15	20	10	10	1	0.6	0.9	10	6	200	10	10	75		9	21
JAN2N706	TO-18	25	15	5	100	15	20	120	10	1	0.5	0.7	10	6	200	700	10	75		9	21
2N708	TO-52	40	15	5	25	20	30	120	10	1	0.4	0.72	10	6	300	10	10				22
2N744	TO-18	20	12	5	1.0 μA	20	40	120	10	0.25	0.65	0.85	10	5	282	10	24				21
2N753	TO-18	25	15	5	400	20	40	120	10	1	0.6	0.9	10	5	200	10	10				21
2N834	TO-18	40	15	5	500	20	25	120	10	1	0.25	0.9	10	4	350	10	75				21
2N2369	TO-18	40	15	4.5	400	20	40	120	10	1	0.25	0.7	10	4	500	10	18			1	21
2N2369A	TO-18	40	15	4.5	400	20	40	120	10	0.35	0.2	0.7	10	4	500	10	18			1	21
JAN2N2369A	TO-18	40	15	4.5	30	20	40	120	30	0.35	0.2	0.7	10	4	500	10	18			1	21
JANTX2N2369A	TO-18	40	15	4.5	400	20	40	120	10	1	0.30	0.7	10	4	500	10	18			1	21
JANTXV2N2369A	TO-18	40	15	4.5	400	20	40	120	10	0.35	0.30	0.7	10	4	500	10	18			1	21
2N3009	TO-52	40	15	4	500	20	25	120	30	0.4	0.18	0.75	30	5	350	30	25			5	22
2N3011	TO-18	30	12	5	I _{CES}		12	120	10	0.35	0.2	0.72	10	4	400	20	20			5	21
2N3013	TO-52	40	15	4	300	20	25	120	30	0.4	0.18	0.75	30	5	350	30	25			5	22

Test Conditions:

- I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1.5 mA
- I_C = 300 mA, V_{CE} = 25V, I_{B1} = I_{B2} = 30 mA
- I_C = 500 mA, V_{CE} = 25V, I_{B1} = I_{B2} = 50 mA

- I_C = 500 mA, V_{CC} = 30V, I_{B1} = I_{B2} = 50 mA
- V_{CC} = 10V, I_C = 300 mA, I_{B1} = I_{B2} = 30 mA
- I_C = 10 mA, V_{CC} = 3V, I_{B1} = 3 mA, I_{B2} = 1.5 mA
- V_{CC} = 3V, I_C = 10 mA, I_{B1} = I_{B2} = 3.3 mA

- V_{CC} = 3V, I_C = 10 mA, I_{B1} = I_{B2} = 3.3 mA
- I_C = 10 mA, V_{CC} = 3V, I_{B1} = 3 mA, I_{B2} = 1.5 mA
- V_{CC} = 3V, I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA

- V_{CC} = 2V, I_C = 30 mA, I_{B1} = 3 mA, I_{B2} = 3 mA
- V_{CC} = 30V, I_C = 300 mA, I_{B1} = I_{B2} = 30 mA

- V_{CC} = 30V, I_C = 1A, I_{B1} = I_{B2} = 100 mA
- V_{CC} = 30V, I_C = 300 mA, I_{B1} = I_{B2} = 30 mA

$$(t = t_s + t_r)$$



NPN Transistors

SATURATED SWITCHES (Cont.)

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CBO} (mA) Max	V _{CB} (V) Max	h _{FE} Min	I _C @ (mA) Max	V _{CE} (V) & Min	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C @ (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3014	TO-52	40	20	5	300 I _{CES}	20	30 25 25	120 10 100	0.4 0.4 1	0.18 0.18 0.35	0.8 0.95 1.2	10 30 100	5	350	30	25		10	28
2N3015	TO-5 (Lo-Profile)	60	30	5	200 I _{CES}	30	30 10	120 300	10 10	1.0 1.0	1.2 1.6	150 500	8	250	50	60		2	25
2N3252	TO-5 (Lo-Profile)	60	30	5	500	40	30 30	90 150	1 1	0.3 0.5	0.7 1.0	150 500	12	200	10	70 [†]		4	25
2N3253	TO-5 (Lo-Profile)	75	40	5	500	60	25 25	75 750	5 5	0.6 1.2	0.7 1.8	100 1A	12	175	50	70 [†]		4	25
2N3444	TO-5 (Lo-Profile)	80	50	5	500	60	20 20	60 500	1 5	0.35 0.6	1.0 1.8	150 500	12	150	50	70 [†]		4	25
2N3605	TO-92(74)		14		500	18	30	10	1.0	0.25	0.85	10	6	300	10	45		9	21
2N3606	TO-92(74)		14		500	18	30	10	1.0	0.25	0.85	10	6	300	10	60		9	21
2N3607	TO-92(74)		14		500	18	30	10	1.0	0.25	0.85	10	6	300	10	70		9	21
2N3646	TO-106	40	15	5	500	20	30 25	120 100	0.4 0.5	0.2 0.28	0.75 1.2	30 100	5	350	30	28		5	22
2N3722	TO-5 (Lo-Profile)	80	60	6	500 I _{CES}	40	25 40	10 150	1 1	0.25 0.22	0.75 0.85	10 100	10	300	50	100		4	24
2N3723	TO-5 (Lo-Profile)	100	80	6	500 I _{CES}	50	25 15	150 300	1 2	0.25 0.44	0.75 1.1	10 300	9	300	50	130		4	24
2N3724	TO-5 (Lo-Profile)	50	30	6	1.7 μA	40	60 40	150 300	1 1	0.2 0.25	0.86 0.76	100 300	12	300	50	60		4	25
2N3724A	TO-5 (Lo-Profile)	50	30	6	500	40	60 30	150 1A	1 5	0.25 0.32	0.76 1.1	100 300	12	300	50	60		4	25
2N3725	TO-5 (Lo-Profile)	80	50	6	1.7 μA	60	30 35	800 500	5 1	0.65 0.75	1.5 1.4	800 1A	10	300	50	60		4	25

2N3725A	TO-5 (Lo-Profile)	80	50	6	500	60	30	150	10	1	0.25 0.26 0.4 0.52 0.8 0.9 0.9	0.76 0.86 1.1 1.2 1.3 1.4 1.4	10 100 300 500 800 1A 5 1.5A	10 300 1 2 5 10 1	300	50	60	4	25
2N4373A	TO-5 (Lo-Profile)	50	30	5							0.2 0.3 0.5 0.9	0.8 1.0 1.2 1.4	9	300	50	60	6	01	
2N4013	TO-18 (Solid)	50	30	6	1.7 μA	40	60	150	10	1	0.25 0.2 0.32 0.42 0.65 0.75	0.76 0.86 1.1 1.2 1.5 1.7	10 100 300 500 800 1A 5	12	300	50	60	4	25
2N4014	TO-18 (Solid)	80	50	6	1.7 μA	60	30	150	10	1	0.25 0.26 0.4 0.52 0.8 0.95	0.76 0.86 1.1 1.2 1.5 1.7	10 100 300 500 800 1A 5	10	300	50	60	4	25
2N4274	TO-106	30	12	4.5							0.2 0.5	0.72 1.6	4	400	10	12	7	21	
2N4275	TO-106	40	15	4.5							0.2 0.5	0.72 1.6	4	400	10	12	7	21	
2N5134	TO-106	20	10	3.5	400	15	20	150	10	1	0.25	0.7	4	250	10	18	7	21	
2N5224	TO-92(72)	25	12	5	500	15	40	400	10	1.0	0.35	0.90	4	250	10	60 [†]	8	21	
2N6375	TO-18 (Solid)	75	40	6	200	40	60	100	10	1	0.25 0.35 0.4 0.55	0.8 0.9 0.85 0.95	10 300 1 500	300	50	20-40 20-40 15-35	11 4 12	01	
2N6376	TO-5 (Lo-Profile)	75	40	6	200	40	30	90	1A	1	0.25 0.35 0.4 0.55	0.8 0.9 0.85 0.95	10 300 1 500	300	50	20-40 20-40 15-35	11 4 12	01	
EN706	TO-106	25	15	3	500	15	20	10	1	1	0.6	0.9	6	200	10	75	9	21	
EN708	TO-106	40	15	5	50	20	30	120	10	1	0.4	0.72	6	300	10	75	9	22	
EN744	TO-106	20	12	5	1.0 μA	20	20	120	0.5	1	0.25 0.35	0.65 1.5	10 20	290	10	24	8	21	

Test Conditions:

1. $I_C = 10 \text{ mA}$, $I_{B1} = 3 \text{ mA}$, $I_{B2} = 1.5 \text{ mA}$
 2. $V_{CC} = 30 \text{ V}$, $V_{CE} = 25 \text{ V}$, $I_{B1} = I_{B2} = 30 \text{ mA}$
 3. $I_C = 500 \text{ mA}$, $V_{CE} = 25 \text{ V}$, $I_{B1} = I_{B2} = 50 \text{ mA}$
 4. $I_C = 500 \text{ mA}$, $V_{CC} = 30 \text{ V}$, $I_{B1} = I_{B2} = 50 \text{ mA}$
 5. $V_{CC} = 10 \text{ V}$, $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$
 6. $I_C = 1 \text{ A}$, $V_{CC} = 30 \text{ V}$, $I_{B1} = I_{B2} = 100 \text{ mA}$
 7. $V_{CC} = 3 \text{ V}$, $I_C = 10 \text{ mA}$, $I_{B1} = I_{B2} = 3.3 \text{ mA}$
 8. $I_C = 10 \text{ mA}$, $V_{CC} = 3 \text{ V}$, $I_{B1} = 3 \text{ mA}$, $I_{B2} = 1.5 \text{ mA}$
 9. $V_{CC} = 3 \text{ V}$, $I_C = 10 \text{ mA}$, $I_{B1} = 3 \text{ mA}$, $I_{B2} = 1 \text{ mA}$
 10. $V_{CC} = 2 \text{ V}$, $I_C = 30 \text{ mA}$, $I_{B1} = 3 \text{ mA}$, $I_{B2} = 3 \text{ mA}$
 11. $V_{CC} = 30 \text{ V}$, $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$
 12. $V_{CC} = 30 \text{ V}$, $I_C = 1 \text{ A}$, $I_{B1} = I_{B2} = 100 \text{ mA}$
- († = $t_s + t_f$)



SATURATED SWITCHES (Cont.)

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) @ I _{CBO} Max	h _{FE} Min	I _C (mA) @ I _{CE} Max	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C (mA) @ V _{BE(sat)} Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) @ f _T Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
EN2369A	TO-106	40	15	4.5	400	20	40	10	0.2	0.7	0.85	4	500	10	18		8	21
MPS706	TO-92(72)	15	15	3	500	15	20	10	0.25	1.15	30	6	200	10	75		8	21
MPS834	TO-92(72)	40	5	5	500	20	25	10	0.6	0.9	10	4	350	10	30		9	21
MPS2369	TO-92(72)	40	15	4.5	400	20	40	10	0.25	0.7	0.85	4	500	10	18		8	21
MPS2713	TO-92(72)	18	15	5	500	18	30	2	0.3	1.3	50	5	350	30	28		5	22
MPS2714	TO-92(72)	40	15	5	500	18	30	120	0.2	0.75	0.95	5	350	30	28		5	22
MPS3646	TO-92(72)	40	15	5	500	18	30	120	0.28	1.2	100	5	350	30	28		5	22
							15	300	0.5	1.7	300							

Test Conditions:

- I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1.5 mA
- I_C = 300 mA, V_{CE} = 25V, I_{B1} = I_{B2} = 30 mA
- I_C = 500 mA, V_{CE} = 25V, I_{B1} = I_{B2} = 50 mA
- I_C = 500 mA, V_{CC} = 30V, I_{B1} = I_{B2} = 50 mA
- V_{CC} = 10V, I_C = 300 mA, I_{B1} = I_{B2} = 30 mA
- I_C = 1A, V_{CC} = 30V, I_{B1} = I_{B2} = 100 mA
- V_{CC} = 3V, I_C = 10 mA, I_{B1} = I_{B2} = 3.3 mA
- I_C = 10 mA, V_{CC} = 3V, I_{B1} = 3 mA, I_{B2} = 1.5 mA
- V_{CC} = 3V, I_C = 30V, I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA
- V_{CC} = 2V, I_C = 30 mA, I_{B1} = 3 mA, I_{B2} = 3 mA
- V_{CC} = 30V, I_C = 300 mA, I_{B1} = I_{B2} = 30 mA
- V_{CC} = 30V, I_C = 30V, I_{B1} = I_{B2} = 100 mA



RF-IF AMPS AND OSCILLATORS

NPN Transistors

Type No.	Case Style	V _{CEO} (V)		V _{EB0} (V)		I _{CBO} (nA)		h _{FE}		V _{CE(sat)} (V) & V _{BE(sat)} (V)		I _C (mA)		C _{cb} /C _{re} (pF)		f _T (MHz)		NF (dB) @ Max	Freq (MHz)	Process No.
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max			
2N917	TO-72	30	15	3	15	1	15	20	3	0.5	0.87	3	1.7¶	500	4	6	60	43		
JAN2N918	TO-72	30	15	3	15	10	15	20	10	0.4	1	10	1.7¶	600	4	6	60	43		
JANTX2N918	TO-72	30	15	3	15	10	15	20	3	0.4	1	10	1.7¶	600	4	6	60	43		
JANTXV2N918	TO-72	30	15	3	15	10	15	20	10	0.4	1	10	1.7¶	500	4	6	60	43		
2N3478	TO-72	30	15	2	15	1	15	25	150	2	8	2	1.0	750	1600	4.5	200	42		
2N3563	TO-106	30	12	2	15	20	15	20	200	8	10	8	1.7¶	600	1500	8	200	43		
2N3564	TO-106	30	15	4	15	20	15	20	500	15	10	15	3.5¶	400	1200	15	200	43		
2N3600	TO-72	30	15	3	15	10	15	20	150	3	1	3	1.0	850	1500	2	200	42		
2N3693	TO-106	45	45	4	15	50	30	40	160	10	10	10	6¶	200	10	10	450	27		
2N3694	TO-106	45	45	4	15	50	30	100	400	10	10	10	6¶	200	10	10	450	27		
2N3932	TO-72	30	20	2.5	10	15	40	40	150	2	8	2	0.55	750	1600	2	200	42		
2N3933	TO-72	40	30	2.5	10	15	60	200	2	8	2	2	0.55	750	1600	2	200	42		
2N4134	TO-72	30	30	3	30	3	50	25	200	4	10	4	5¶	350	800	4	60	44		
2N4135	TO-72	30	30	3	30	3	50	25	200	4	10	4	5¶	425	800	4	60	44		
2N4259	TO-72	40	30	2.5	10	15	60	250	2	8	2	2	0.55	750	1600	1.5	450	42		
2N4934	TO-72(28)	40	30	3	10	15	40	170	2	8	2	2	0.25§	700	1600	2	200	47		
2N4935	TO-72(28)	50	40	3	10	15	60	200	2	8	2	2	0.25§	700	1600	2	200	47		
2N4936	TO-72(28)	50	40	3	10	15	60	250	2	8	2	2	0.25§	700	1600	2	200	47		
2N5130	TO-106	30	12	1	15	10	15	15	250	8	10	8	1.7¶	450	8	8	450	43		
2N5132	TO-106	20	20	3	10	10	30	400	10	10	10	10	3.5¶	200	2000	5	200	27		
2N5179	TO-72	20	12	2.5	20	15	25	250	3	1	1	10	1.0	900	2000	5	200	42		
2N5180	TO-72	30	15	2	15	8	200	2	200	2	8	2	1.0	650	1700	2	200	42		
2N5181	TO-72(28)					20	1	27	1	6			0.32	400	1200	3	47	47		
2N5182	TO-72(28)					30	1	27	1	6			0.34	400	1200	3	47	47		
2N5222	TO-92(71)	20	15	2	100	10	20	1500	4	10	1.2	4	1.3	450	4	4	60	43		
2N5770	TO-92	30	15	3	10	15	20	3	1	10	1	10	1.7	900	8	6	60	43		
2SC313	TO-72	30	19	2	500	10	35	120	10	10	1	20	2¶	600			1 KHz	46		
2SC454	TO-92(74)	30	30	5	500	18	60	320	2	12	1.1	10	3.5¶				1 KHz	46		
2SC458	TO-92(74)	30	30	5	500	18	60	500	2	12	1.0	10	3.5¶				1 KHz	46		
2SC460	TO-92(74)	30	30	5	500	18	35	200	2	12	1.1	10	3.5¶				1 KHz	46		

¶ C_{cb} § Typical



RF-IF AMPS AND OSCILLATORS (Cont.)

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) Min	hFE Min	I _C (mA) Max	V _{CE(sat)} & V _{BE(sat)} (V) Max	I _C (mA) @ 0.75	C _{cb} /C _{re} (pF) Min	f _T (MHz) Min	I _C (mA) @	NF (dB) Max	Freq (MHz)	Process No.
25C461	TO-92(74)	30	30	5	500	18	35	200	1.1	10	3.5%					46
25C463	TO-72	35	35	4	100	10	30	150	1	2	0.6	400	2	4	200	44
25C464	TO-72	30	19	2	500	10	20	1	1	20	2.0%	600	10			42
25C466	TO-72	30	19	2	500	10	20	1	1	20	2.0%	600	10			42
25C535	TO-92(74)	30	20	4	500	10	35	200	1	1	1.2%	450	1	5.5	100	42
25C562	TO-72(28)	40	30	4	40	4	40	4	10	0.22	0.22					45
25C563	TO-72(28)	40	25	4	38	7	38	7	10	0.23	0.23					47
25C682	TO-72	20	20	3	100	10	20	200	2	10	0.6%	400	2			44
25C683	TO-72	20	20	3	100	10	20	200	2	10	0.6%	400	2	4	200	44
25C684	TO-92(74)	30	19	2	500	10	40	10	1	20	2.0%	900	10			42
25C717	TO-92(74)	30	19	2	500	10	40	1	1	20	2.0%	600	10			42
40235	TO-72	45	45	4.5	20	35	40	170	6	20	0.65			3.3%	216	42
40236	TO-72	45	45	4.5	20	35	40	275	6		0.65					42
40237	TO-72	45	45	4.5	20	35	27	275	6							42
40238	TO-72	45	45	4.5	20	35	40	170	6							42
40239	TO-72	45	45	4.5	20	35	27	100	6							42
40240	TO-72	45	45	4.5	20	35	27	275	6							42
40242	TO-72	45	45	4.5	20	1	40	170	6		0.65%			2.5%	100	42
40243	TO-72	45	45	4.5	20	1	40	170	6		0.65%					42
40244	TO-72	45	45	4.5	20	1	27	170	6		0.8%					42
40245	TO-72	45	45	4.5	20	1	70	275	6		0.65%					42
40246	TO-72	45	45	4.5	20	1	27	90	6		0.65%					42
40472	TO-72(28)	45	45	3	20	45	40	170	6		0.19%			3.3%	200	47
40473	TO-72(28)	45	45	3	20	45	40	275	6		0.19%					47
40474	TO-72(28)	45	45	3	20	45	27	275	6							47
40475	TO-72(28)	45	45	3	20	45	40	170	6		0.18%					47

40476	TO-72(28)	45	3	20	1	27	100	1	6				0.18§				47	
40477	TO-72(28)	45	3	20	1	27	275	1	6				0.18§				47	
40478	TO-72(28)	45	3	20	1	40	170	1	6				0.2§		2.5§	100	47	
40479	TO-72(28)	45	3	20	1	40	170	1	6				0.2§				47	
40480	TO-72(28)	45	3	20	1	27	275	1	6				0.2§				47	
40481	TO-72(28)	45	3	20	1	70	275	1	6				0.2§				47	
40482	TO-72(28)	45	3	20	1	27	90	1	6				0.2§			35	45	
BF167	TO-72(28)	40	3	20	1	27	4	10	10				0.15§				47	
BF173	TO-72(28)	40	25	4	38	7	10	10	10	0.65	0.74	1	0.95§			100	46	
BF194	TO-92	30	20	5	66	210	1	10									46	
BF195	TO-92	30	20	5	35	125	1	10		0.65	0.74	1	0.95§				46	
BF196	TO-92(71)	40	30	4	27	4	10	10	4	0.84	4						45	
BF197	TO-92(71)	40	25	4	38	7	10	10	7	0.9	7						47	
BF198	TO-92(71)	40	30	4	27	4	10	10	4	0.85	4						45	
BF199	TO-92(71)	40	25	4	38	7	10	10	7	0.925	7						47	
BF233	TO-92(71)	30	20	5	35	120	1	10					0.85§				49	
CS9010	TO-105	20	3	50	18	16	200	1	5	0.7	1	20					46	
CS9011	TO-106	18	3	50	18	29	280	1	5								27	
CS9016	TO-106	20	3	50	18	29	146	1	5	3	1	10					44	
CS9017	TO-106	18	3	50	18	40	198	1	5	2	0.9	10					27	
CS9018	TO-106	12	2	50	15	29	198	1	5	0.6	10						43	
CS9019	TO-72	20	3	50	18	16	280	1	5	3	1	10					44	
EN918	TO-106	30	15	3	50	15	20	3	1	0.4	1	10				60	43	
MPS918	TO-92	30	15	3	10	15	20	3	1	0.4	1	10				60	43	
MPS3563	TO-92	30	15	2	50	15	20	200	8	10							43	
MPS3693	TO-92	45	4	50	35	40	160	10	10								27	
MPS3694	TO-92	45	4	50	35	100	400	10	10								27	
MPS6507	TO-92	30	20	50	15	25	2	10									43	
	(V _{GES})																	
MPS6511	TO-92	30	20	50	15	25	2	10									43	
	(V _{GES})																	
MPS6540	TO-92(71)	30	30	4	100	25	25	2	10	0.5	0.95	10					49	
MPS6542	TO-92(71)	30	20	50	15	25	2	10									47	
	(V _{GES})																	
MPS6543	TO-92(71)	35	25	3	100	25	25	4	10	0.35	0.95	10					47	
MPS6544	TO-92(71)	60	45	4	500	35	20	30	10	0.5	30						49	
MPS6546	TO-92(71)	35	25	3	100	25	2	10	0.35	10							47	
MPS6557	TO-92(71)	40	5	500	35	25	10	5	0.5	0.8	10						49	
MPS6568A	TO-92(71)	20	20	3	50	10	20	200	4	3	0.96	10				200	44	
MPS6569	TO-92(71)	20	20	3	50	10	20	200	4	3	0.96	10				300	44	
MPS6570	TO-92(71)	20	20	3	50	10	20	200	4	3	0.96	10				300	44	

§ C_{ob} § Typical



RF-IF AMPS AND OSCILLATORS (Cont.)

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Min	V _{BE} (V) Min	V _{BO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) Max	h _{FE} Min	I _C @ (mA) Max	V _{CE} (V) & V _{BE(sat)} (V) Min	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max	I _C (mA) Max	C _{cb} /C _{re} (pF) Min Max	f _T (MHz) Min Max	I _C (mA) Max	NF (dB) Max	Freq @ (MHz) Max	Process No.	
MPSH10	TO-92(71)	30	25	3	3	100	25	60	4	10	0.5	4	0.7	650	4			42	
MPSH11	TO-92(71)	30	25	3	3	100	25	60	4	10	0.5	4	0.7	650	4			47	
MPSH19	TO-92(71)	30	25	3	3	100	15	46	4	10		4	0.65	300	4			47	
MPSH20	TO-92(71)	40	30	4	4	50	15	25	4	10		4	0.65	400	4			49	
MPSH30	TO-92(71)	20	20	3	3	50	10	20	4	5	3	10	0.65	300	4	6	45	44	
MPSH31	TO-92(71)	20	20	3	3	50	10	20	4	5	3	10	0.65	300	4	6	45	44	
MPSH32	TO-92(71)	40	30	4	4	50	10	27	4	5	3	10	0.22	300	4			45	
MPSH37	TO-92(71)		40	5	5	500	35	25	5	10	0.5	10	0.7	300	5			49	
SE1001	TO-106	45	45	4	4	500	30	40	160	10		10	3.5	200	10			26	
SE1002	TO-106	45	45	4	4	500	30	100	400	10		10	3.5	200	10			26	
SE3001	TO-106	30	12	2	2	500	15	20	8	10	0.6	10	1.7	600	8	4	60	43	
SE3002	TO-106	30	12	2	2	500	15	20	8	10	0.6	10	1.7	600	8	4	60	43	
SE5020	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	375	800	4	3.3	200
SE5021	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	375	800	4	4.0	200
SE5022	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	300	800	4		44
SE5023	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	300	800	4		44
SE5024	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	300	800	4		44
SE5035	TO-72(28)	40	30	4	4	50	30	40	180	5		10	.30	600	5			47	
SE5050	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	300	4	4	100	44
SE5051	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	300	4	3.0†	100	44
SE5052	TO-72	20	20	3	3	50	10	20	200	4	3.0	10	.25	.5	375	4	4.0	200	44
SE5055	TO-72(28)	20	20	3	3	50	20	20	220	2	2.0	10	.22	300	2	5.0	200	45	
ST3100	TO-92	30	30	3	3	200	30	30	225	5		10	0.85	500	5			47	
ST5025	TO-92	30	30	3	3	50	30	20	100	10	.6	20	.6	1.1	300	700	10	4.5	200
ST5029	TO-92	30	30	3	3	200	30	30	225	5		10	0.85	500	5	6	45	47	
ST5030	TO-92(71)	45	40	4.5	4.5	100	30	45	150	7	3.0	10	.25	.40	600	7		47	
ST5031	TO-92	40	30	4	4	100	30	30	180	5	1	10	0.4	500	5			47	
ST5055	TO-92(71)	20	20	3	3	50	20	220	2	10	2.0	10	.3	300	2	5.0	45	45	

† = Cob § = Typical



NPN Transistors

LOW LEVEL AMPS

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CB0} (mA) Max	V _{CB} (V) @ I _C & V _{CE}	h _{FE} (1kΩ)* Min Max	I _C (mA) @ V _{CE} & V _{BE(sat)}	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max	I _C (mA) @ V _{CE(sat)} & V _{BE(sat)} Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N760	TO-18	45	45	8	200	30	76	333*	1	0.6	1.1	10	8	50			07
2N760A	TO-18	60	60	8	100	30	76	333*	1	0.9	1.1	10	8	50			07
JAN2N760A	TO-18	75	60	8	10	30	76	333*	1	0.6	1.1	10	6	60	24	1	07
2N929	TO-18	45	45	4	10	45	40	120	0.01 μA	0.6	1.1	10	8	30	4	5	07
							60	350	0.5 μA								
JAN2N929	TO-18	60	45	6	10	45	40	120	0.01 μA	0.6	1.1	10	8	45	5	3	07
							60	350	0.5 μA								
JANTX2N929	TO-18	65	45	6	10	45	40	120	0.01 μA	0.6	1	10	8	45	5	3	07
							60	350	0.5 μA								
JANTXV2N929	TO-18	65	45	6	10	45	40	120	0.01 μA	0.6	1	10	8	45	5	3	07
							60	350	0.5 μA								
2N929A	TO-18	60	45	6	2	45	25	0.001	5	0.5	0.7	0.9	10	6	4	2	07
							40	120	0.01 μA								
							60	350	0.5 μA								
2N930	TO-18	45	45	5	10	45	100	300	0.01 μA	0.6	1	10	8	30	3	5	07
							150	600	0.5 μA								
JAN2N930	TO-18	60	45	6	10	45	100	300	0.01 μA	0.6	1	10	8	45	5	3	07
							150	600	0.5 μA								
JANTX2N930	TO-18	60	45	6	10	45	100	300	0.01 μA	0.6	1	10	8	45	5	3	07
							150	600	0.5 μA								
JANTXV2N930	TO-18	60	45	6	10	45	100	300	0.01 μA	0.6	1	10	8	45	5	3	07
							150	600	0.5 μA								
2N930A	TO-18	60	45	6	2	45	60	0.001	5	0.5	0.7	0.9	10	6	4	2	07
							100	300	0.01 μA								
							150	600	0.5 μA								
2N981	TO-18	80	80	8	1.0 μA	30	36	100*	1	3		10	5				07

Test Conditions:

- I_C = 1.0 mA, V_{CE} = 5V, R_G = 500Ω, f = 1 kHz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, f = 10 kHz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, f = 100 kHz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, f = 1 kHz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, BW = 15.7 kHz
- I_C = 5 μA, V_{CE} = 5V, R_G = 50 kΩ, f = 1 kHz
- I_C = 5 μA, V_{CE} = 5V, R_G = 50 kΩ, f = 10 kHz
- V_{CE} = 5V, I_C = 100 μA, R_G = 10 kΩ, W.B.
- V_{CE} = 5V, I_C = 30 μA, R_G = 10 kΩ, f = 1 kHz
- I_C = 20 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz
- I_C = 20 μA, V_{CE} = 5V, R_S = 22 kΩ, W.B.
- I_C = 100 μA, V_{CE} = 4.5V, R_G = 5 kΩ, W.B.



LOW LEVEL AMPS (Cont.)

NPN Transistors

Type No.	Case Style	V _{CE0} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) @ I _C	h _{FE} @ I _C (mA)	V _{CE(sat)} (V) Max & V _{BE(sat)} (V) Min	I _C (mA) @ V _{BE(sat)}	C _{ob} (pF) Max	f _T (MHz) @ I _C (mA)	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N2483	TO-18	60	60	6	10	45	40 75 175	0.35 0.5 0.7	1	6	60			4 2 5	07
2N2484	TO-18	60	60	6	10	45	100 500	0.35 0.5 0.7	1	6	60			3 4 4	07
2N2509	TO-18	125	80	7	5	100	25 250	1 0.9 0.5	5	6	45			2 3 5	07
2N2510	TO-18	100	65	7	5	80	40 75	1 0.9 0.5	5	6	45			4 4	07
2N2511	TO-18	80	50	7	5	60	150 80 120	1 0.9 0.5	5	6	45			4 4	07
2N2586	TO-18	60	45	6	2	45	240 80 120 360 150	0.5 0.7 0.9 10	7	7	45			3 4 2	07
2N3117	TO-18	60	60	6	10	45	250 300 400	0.35 0.7	1	8	60			6 7	07
2N3665	TO-106	30	25	6	50	25	150 600	1 10	4	4	40				07
2N3691	TO-106	35	20	4	50	15	40 160	1 10	10	3.5	200				23
2N3692	TO-106	35	20	4	50	15	100 400	1 10	10	3.5	200				23
2N3709	TO-92(74)		30		100	20	45 165	1 5	10						07
2N3877	TO-92(74)		70		4	500	20 250	2 4.5	10						07
2N3877A	TO-92(74)		85		4	500	20 250	2 4.5	10						07
2N3900A	TO-92(74)		18		5	100	18 250	2 4.5	10						07
2N4384	TO-18	40	30	5	10	30	60 100 120	0.01 0.01 5	8	8	30			13 5	07
2N4386	TO-18	40	30	5	10	30	150 400	0.2 0.65 0.8	10	8	30			5	07
2N4409	TO-92(72)		50		10	60	60 400	1 1	1.0	12	60				07
2N4410	TO-92(72)		80		10	100	60 400	1 1	1.0	12	60				07
2N4966	TO-106	50	40	6	25	25	40 200 50	0.4 0.4	1	6	40			4	07
2N4967	TO-106	50	40	6	25	25	100 600 120	0.01 0.01 5	1	6	40			4	07

2N4968	TO-106	30	25	6	50	25	40	200	0.01	5	0.4	6	40	1	6	4	07
2N5088	TO-92(72)	35	30		50	20	300	900	0.1	5	0.5	10			3	8	07
2N5089	TO-92(72)	35	30		50	15	400	120	0.1	5	0.5	10			3	8	07
2N5127	TO-106	20	12	3	50	10	15	300	2	10	0.3	3.5	150	2			07
2N5131	TO-106	20	15	3	50	10	30	500	10	10	1	6	100	10			27
2N5133	TO-106	20	18	3	50	15	60	1000	1	1	0.4	5	40	200			07
2N5209	TO-92(72)	50	50		50	35	100	300	0.1	5	0.7	10	30	0.5	3	10	07
2N5210	TO-92(72)	50	50		50	35	200	600	0.1	5	0.7	10	30	0.5	2	10	07
2N5232	TO-92(74)	50	50		30	50	250	500	2	5	0.125	4			3	11	
2N5232A	TO-92(74)	50	50		30	50	250	500	2	5	0.125	4			5	12	07
EN930	TO-106	45	45	5	50	45	100	300	0.01	5	1.0	8	30	0.5	3	5	07
EN2484	TO-106	60	60	6	50	45	30	600	0.001	5	0.35	6	60	0.5	3	5	07
MPSA09	TO-92(72)	50	50		100	25	100	600	0.1	5	0.9	10	30	0.5			07
MPS3707	TO-92(74)	30	30	6	100	20	100	400	0.1	5	1	10			5	12	07
MPS3708	TO-92(74)	30	30	6	100	20	45	660	1	5	1	10					07
MPS3709	TO-92(74)	30	30	6	100	20	45	165	1	5	1	10					07
MPS3710	TO-92(74)	30	30	6	100	20	90	330	1	5	1	10					07
MPS3711	TO-92(74)	30	30	6	100	20	180	660	1	5	1	10					07
MPS6571	TO-92(74)	25	20	3	50	20	250	1000	0.1	5	0.5	4.5	50	0.5			07
SE4001	TO-106	30	25	6	200	5.0	60	300	1	10	0.35	4	40	1			07
SE4002	TO-106	30	25	6	200	5.0	200	1000	1	10	0.35	4	60	1			07
SE4010	TO-106	30	25	6	200	5.0	200	1000	1	10	0.35	4	60	1			07

Test Conditions:

- $I_C = 1.0 \text{ mA}$, $V_{CB} = 5\text{V}$,
 $R_G = 500\Omega$, $f = 1 \text{ kHz}$
- $I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 10 \text{ k}\Omega$, $f = 10 \text{ kHz}$
- $I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 10 \text{ k}\Omega$, $f = 100 \text{ Hz}$
- $I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 10 \text{ k}\Omega$, $f = 1 \text{ kHz}$
- $I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 10 \text{ k}\Omega$, $BW = 15.7 \text{ kHz}$
- $I_C = 5 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 50 \text{ k}\Omega$, $f = 1 \text{ kHz}$
- $I_C = 5 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 50 \text{ k}\Omega$, $f = 10 \text{ kHz}$
- $V_{CE} = 5\text{V}$, $I_C = 100 \mu\text{A}$,
 $R_G = 10 \text{ k}\Omega$, W.B.
- $V_{CE} = 5\text{V}$, $I_C = 30 \mu\text{A}$,
 $R_G = 100 \text{ k}\Omega$, $f = 1 \text{ kHz}$
- $I_C = 20 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_S = 22 \text{ k}\Omega$, W.B.
- $I_C = 20 \mu\text{A}$, $V_{CE} = 4.5\text{V}$,
 $R_S = 10 \text{ k}\Omega$,
 $f = 1 \text{ kHz}$
- $I_C = 100 \mu\text{A}$,
 $V_{CE} = 5\text{V}$,
 $R_G = 5 \text{ k}\Omega$, W.B.
- $I_C = 100 \mu\text{A}$,
 $V_{CE} = 4.5\text{V}$,
 $R_G = 5 \text{ k}\Omega$, W.B.



GENERAL PURPOSE AMPS AND SWITCHES

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CBO} (mA) @ V _{CB} (V) Max	I _{FE} Min / Max	I _C @ V _{CE} & (mA) / (V)	V _{CE(sat)} (V) Max / V _{BE(sat)} (V) Min	I _C (mA) @ V _{BE(sat)} (V) Min / Max	C _{ob} (pF) Max	f _T (MHz) Min / Max	I _C (mA) @ f _T (MHz) Min / Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N697	TO-5	60	40	5	100	40	150	1.5	1.3	35	50	50				20
2N699	TO-39	120		5	2	40	150	5	1.3		50	50				12
2N718	TO-18	60	40	5	100	40	150	1.5	1.3	35	50	15				20
2N915	TO-18	70	50	5	10	50	10	1	0.9	3.5	250	10				27
2N956	TO-18	75		7	10	20	0.01	1.5	1.3	25	70	50				20
						75	10									
						100	300									
2N1420	TO-5	60		5	1.0 μA	100	150	1.5	1.3	35	50	50				20
2N1613	TO-5	75	50	7	10	20	0.1	1.5	1.3	25	60	50		12	5	20
						35	10									
						40	120									
2N1711	TO-5	75		7	100	20	0.01	1.5	1.3	25	70	50				20
						75	10									
						100	150									
2N2218	TO-5	60	30	5	10	35	0.1	0.4	1.3	8	250	20				20
						40	150	1.6	2.6							
						20	500									
JAN2N2218	TO-5	60	30	5	10	20	0.1	0.4	1.3	8	250	20	250		1	20
						25	1	1.6	2.6							
						35	10									
						40	150									
						20	500									
JANTX2N2218	TO-5	60	30	5	10	20	0.1	0.4	1.3	8	250	20	250		1	20
						35	10	1.6	2.6							
						20	500									
JANTX2N2218	TO-5	60	30	5	10	20	0.1	0.4	1.3	8	250	20	250		1	20
						35	10	1.6	2.6							
						20	500									
2N2218A	TO-5	75	40	6	10	20	0.1	0.3	1.2	8	250	20	285†		1	20
						35	10	1	2							
						20	150									
						25	500									
JAN2N2218A	TO-5	75	50	6	10	30	0.1	0.3	1.2	8	250	20	300		1	20
						35	1	1	2							
						40	10									
						20	150									
						20	500									
JANTX2N2218A	TO-5	75	50	6	10	30	0.1	0.3	1.2	8	250	20	300		1	20
						40	10	1	2							
						20	150									
						20	500									

JANTXV2N2218A	TO-5	75	50	6	10	60	30	0.1	10	0.3	0.6	1.2	150	8	250	20	300	1	20
							40	10	10	1		2	500						
2N2219	TO-5	60	30	5	10	50	35	0.1	10	0.4	1.3	150	8	250	20	20		1	20
							75	10	10	1.6	2.6	500							
JAN2N2219	TO-5	60	30	5	10	50	35	0.1	10	0.4	0.6	1.3	150	8	250	20	250	1	20
							50	1	10	1.6	2.6	500							
JANTX2N2219	TO-5	60	30	5	10	50	35	0.1	10	0.4	0.6	1.3	150	8	250	20	250	1	20
							75	10	10	1.6	2.6	500							
JANTXV2N2219	TO-5	60	30	5	10	50	35	0.1	10	0.4	0.6	1.3	150	8	250	20	250	1	20
							75	10	10	1.6	2.6	500							
2N2219A	TO-5	75	40	6	10	60	35	0.1	10	0.3	0.6	1.2	150	8	300	20	285 [†]	1	20
							75	10	10	1	2	500							
JAN2N2219A	TO-5	75	50	6	10	60	50	0.1	10	1	2	500	8	250	20	300	1	20	
							75	1	10	0.3	0.6	1.2	150						
JANTX2N2219A	TO-5	75	50	6	10	60	50	0.1	10	0.3	0.6	1.2	150	8	250	20	300	1	20
							100	10	10	1	2	500							
JANTXV2N2219A	TO-5	75	50	6	10	60	50	0.1	10	0.3	0.6	1.2	150	8	250	20	300	1	20
							100	10	10	1	2	500							
2N2221	TO-18	60	30	5	10	50	35	0.1	10	0.4	1.3	150	8	250	20	20			20
							40	120	10	1.6	2.6	500							
JAN2N2221	TO-18	60	30	5	10	50	25	0.1	10	0.4	0.6	1.3	150	8	250	20	250	1	20
							35	10	10	1.6	2.6	500							
JANTX2N2221	TO-18	60	30	5	10	50	35	0.1	10	0.4	0.6	1.3	150	8	250	20	250	1	20
							40	120	10	1.6	2.6	500							

Test Condition:

1. $I_C = 150 \mu A$, $V_{CC} = 30V$,
 $I_{B1} = I_{B2} = 15 \text{ mA}$

2. $I_C = 100 \mu A$, $V_{CE} = 5V$, $R_G = 1 \text{ k}\Omega$,
 $BW = 15.7 \text{ kHz}$

3. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 \text{ k}\Omega$, WB

4. $V_{CC} = 3V$
 $I_C = 10 \text{ mA}$
 $I_{B1} = I_{B2} = 1 \text{ mA}$

5. $I_C = 300 \mu A$, $V_{CE} = 10V$,
 $R_G = 510\Omega$, $f = 1 \text{ kHz}$

* $V_{BE(ON)}$
($t = t_s + t_f$)



GENERAL PURPOSE AMPS AND SWITCHES (Cont.)

NPN Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} (mA) Max	V _{CB} (V)	hFE Min	hFE Max	I _C (mA) Max	V _{CE} (V) & V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	V _{BE(sat)} (V) Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
JANTXV2N2221	TO-18	60	30	6	10	50	20	20	0.1	10	0.4	0.6	1.3	20	8	250	250	20	250		1	20
2N2221A	TO-18	75	40	6	10	60	35	40	10	10	1.6		2.6	500				20	285 [†]		1	20
JAN2N2221A	TO-18	75	50	6	10	60	30	35	0.1	10	0.3	0.6	1.2	20	8	250	250	20	300		1	20
JANTX2N2221A	TO-18	75	50	6	10	60	40	40	0.1	10	1	0.6	2	500	8	250	300	20	300		1	20
JANTXV2N2221A	TO-18	75	50	6	10	60	30	40	0.1	10	0.3	0.6	1.2	20	8	250	300	20	300		1	20
2N2222	TO-18	60	30	5	10	50	35	75	0.1	10	0.4	0.6	1.3	20	8	250	250	20				20
JAN2N2222	TO-18	60	30	5	10	50	50	100	0.1	10	1.6		2.6	500	8	250	250	20	250		1	20
JANTX2N2222	TO-18	60	30	5	10	50	35	75	0.1	10	0.4	0.6	1.3	20	8	250	250	20	250		1	20
JANTXV2N2222	TO-18	60	30	6	10	50	35	75	0.1	10	0.4	0.6	1.3	20	8	250	250	20	250		1	20
2N2222A	TO-18	75	40	6	10	60	35	100	0.1	10	1	0.6	2	500	8	300	300	20	285 [†]		1	20
JAN2N2222A	TO-18	75	50	6	10	60	50	100	0.1	10	0.3	0.6	1.2	20	8	250	300	20	300		1	20

JANTX2N2222A	TO-18	75	50	6	10	60	50	100	10	0.1	10	0.3	0.6	1.2	150	8	250	20	300	1	20
								100	10	10	10	1	2	500							
JANTXV2N2222A	TO-18	75	50	6	10	60	50	100	10	150	10	0.3	0.6	1.2	150	8	250	20	300	1	20
								30	10	500	10	1	2	500							
2N3299	TO-5	60	30	5			20	20	10	0.1	10	0.22	1.1	150	8	250	50	300	1	20	20
							35	40	150	10	10	0.6	1.5	500							
							40	120	500	10	10	0.45	1.3	300							
2N3300	TO-5	60	30	5			35	100	10	0.1	10	0.22	1.1	150	8	250	50	300	1	20	20
							75	100	10	150	10	0.6	1.5	500							
							100	300	500	10	10	0.45	1.3	300							
2N3301	TO-18	60	30	5			20	20	10	0.1	10	0.22	1.1	150	8	250	50	300	1	20	20
							35	100	10	10	10	0.6	1.5	500							
							40	120	500	10	10	0.45	1.3	300							
2N3302	TO-18	60	30	5			35	100	10	0.1	10	0.22	1.1	150	8	250	50	300	1	20	20
							75	100	10	10	10	0.6	1.5	500							
							100	300	500	10	10	0.45	1.3	300							
2N3566	TO-105	40	30	5	50	20	80	150	10	2	10	1	100	25	40	200	30	300	1	20	20
							15	500	10	10	10	0.22	150	8	250	50	300	1	20	20	20
2N3641	TO-105	60	30	5	50	50	40	120	10	150	10	0.22	150	8	250	50	300	1	20	20	20
							15	500	10	10	10	0.22	150	8	250	50	300	1	20	20	20
2N3642	TO-105	60	45	5	50	50	40	120	10	150	10	0.22	150	8	250	50	300	1	20	20	20
							15	500	10	10	10	0.22	150	8	250	50	300	1	20	20	20
2N3643	TO-105	60	30	5	50	50	100	300	10	150	10	0.22	150	8	250	50	300	1	20	20	20
							20	500	10	10	10	0.22	150	8	250	50	300	1	20	20	20
2N3704	TO-92(74)	50	30	5	100	20	100	300	2.0	50	2.0	0.6	100	12	100	50	300	1	13	13	13
							50	150	50	2.0	2.0	0.8	100	12	100	50	300	1	13	13	13
2N3705	TO-92(74)	50	30	5	100	20	50	150	2.0	50	2.0	0.8	100	12	100	50	300	1	13	13	13
							30	600	50	2	2	1	100	12	100	50	300	1	13	13	13
2N3706	TO-92(74)	40	20	5	100	20	30	600	2	50	2	1	100	12	100	50	300	1	13	13	13
							10	100	10	10	10	0.4	1.5	10	10	10	10	10	10	10	10
2N3793	TO-92(74)	40	20	5	500	15	10	120	10	100	10	0.4	1.5	10	10	10	10	10	10	10	10
							20	100	10	100	10	0.4	1.5	10	10	10	10	10	10	10	10
2N3794	TO-92(74)	40	20	5	500	15	35	100	10	100	10	0.4	1.5	10	10	10	100	600	10	13	13
							100	100	10	100	10	0.4	1.5	10	10	10	100	600	10	13	13
2N3858	TO-92(74)	30	30	4	500	18	60	120	2	4.5	4.5	4	90	2	4	90	2	27	27	27	27
							60	120	10	1	1	4	90	2	4	90	2	27	27	27	27
2N3858A	TO-92(74)	60	60	6	500	18	45	120	10	1	1	4	90	2	4	90	2	27	27	27	27
							60	120	10	1	1	4	90	2	4	90	2	27	27	27	27
2N3859	TO-92(74)	30	30	4	500	18	100	200	2	4.5	4.5	4	90	2	4	90	2	27	27	27	27
							75	100	10	1	1	4	90	2	4	90	2	27	27	27	27
2N3859A	TO-92(74)	60	60	6	500	18	100	200	10	1	1	4	90	2	4	90	2	27	27	27	27
							100	200	10	1	1	4	90	2	4	90	2	27	27	27	27
2N3860	TO-92(74)	30	30	4	500	18	150	300	2	4.5	4.5	4	90	2	4	90	2	27	27	27	27
							150	300	2	4.5	4.5	4	90	2	4	90	2	27	27	27	27

Test Condition:

1. $I_C = 150 \text{ mA}$, $V_{CC} = 30\text{V}$,
 $I_{B1} = I_{B2} = 15 \text{ mA}$

3. $I_C = 10 \text{ }\mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 10 \text{ k}\Omega$, WB

4. $V_{CC} = 3\text{V}$,
 $I_C = 10 \text{ mA}$,
 $I_{B1} = I_{B2} = 1 \text{ mA}$

5. $I_C = 300 \text{ }\mu\text{A}$, $V_{CE} = 10\text{V}$,
 $R_G = 510\Omega$, $f = 1 \text{ kHz}$

$^*V_{BE(ON)}$
($t = t_s + t_f$)



NPN Transistors

GENERAL PURPOSE AMPS AND SWITCHES (Cont.)

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CBO} (mA) Max	V _{CB} (V)	t _{rFE} Min	t _{rFE} Max	I _C @ (mA) & V _{CE}	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C @ (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3903	TO-92(72)	60	40	6	50 I _{CEX}	30	20	35	0.1 1	1	0.2 0.3	0.85 10 0.95 50	4	250	10	225†	6	2 4	23
2N3904	TO-92(72)	60	40	6	50 I _{CEX}	30	40	70	0.1 1	1	0.2 0.3	0.85 10 0.95 50	4	300	10	250†	5	2 4	23
2N3946	TO-18	60	40	6	10 I _{CEX}	40	30	45	0.1 1	1	0.2 0.3	0.9 10 1 50	4	250	10	375†	5	2 4	23
2N3947	TO-18	60	40	6	10 I _{CEX}	40	60	90	0.1 1	1	0.2 0.3	0.9 10 1 50	4	300	10	450†	5	2 4	23
2N4123	TO-92(72)	40	30	5	50	20	50	25	2 50	1	0.3	0.95 50	4	250	10		6	2	23
2N4124	TO-92(72)	30	25	5	50	20	120	60	2 50	1	0.3	0.95 50	4	300	10		5	2	23
2N4140	TO-106	60	30	5	50	40	20	25	0.1 10	10	0.4	1.3 150	8	250	20				20
2N4141	TO-106	60	30	5	50	40	35	75	0.1 10	10	0.4	1.3 150	8	250	20				20
2N4227	TO-106	60	30	5	50	40	25	50	0.1 10	10	0.4	1.3 150	8	250	20				20
2N4400	TO-92(72)	60	40	6			20	40	1 10	1	0.4 0.75	0.95 150 1.2 500		200	20	255†		1	13
2N4401	TO-92(72)	60	40	6			20	80	0.1 10	1	0.4 0.75	0.95 150 1.2 500		250	20	255†		1	13

2N4951	TO-92(74)	60	30	5	50	40	20	1	10	0.3	1.3	150	8	250	20	400	1	13
2N4952	TO-92(74)	60	30	5	50	40	60	10	10	0.3	1.3	150	8	250	20	400	1	13
2N4953	TO-92(74)	60	30	5	50	40	75	10	10	0.3	1.3	150	8	250	20	400	1	13
2N4954	TO-92(74)	40	30	5	50	40	200	10	10	0.3	1.3	150	8	250	20	400	1	13
2N4969	TO-106	50	30	5	50	30	40	10	10	0.4	0.6	1.2	150	8	200	20	20	20
2N4970	TO-106	50	30	5	50	30	70	10	10	0.4	0.6	1.2	150	8	200	20	20	20
2N5128	TO-105	15	12	3	50	10	20	10	10	0.25	1.1	150	10	200	800	50	20	20
2N5129	TO-106	15	12	3	50	10	20	10	10	0.25	1.1	150	10	200	800	50	20	20
2N5135	TO-105	30	25	4	300	15	35	50	10	1	1	100	25	40	300	30	20	20
2N5136	TO-105	30	20	3	100	20	20	400	1	0.25	1.1	150	35	40	400	50	20	20
2N5137	TO-106	30	20	3	100	20	20	400	1	0.25	1.1	150	35	40	400	50	20	20
2N5219	TO-92(72)	20	15	3	100	10	35	500	2	0.4	1.0	10	4	150	10	10	27	27
2N5220	TO-92(72)	15	15	3	100	10	25	10	10	0.5	1.1	150	10	100	20	20	13	13
2N5223	TO-92(72)	25	20	3	100	10	50	800	2	0.7	1.2	10	4	150	10	10	27	27
2N5225	TO-92(72)	25	25	4	300	15	25	10	10	0.8	1.0	100	20	50	20	20	13	13
EN697	TO-105	60	30	5	1000	30	40	120	150	1.5	1.3	150	35	50	30	30	20	20
EN916	TO-106	45	25	5	50	30	50	200	1	0.5	0.9	10	6	300	10	10	27	27
EN956	TO-106	75	40	7	50	60	20	0.01	10	1.5	1.3	150	25	70	30	30	5	20
EN1711	TO-106	75	40	7	50	60	40	100	10	1.5	1.3	150	25	70	30	30	5	20
EN2219	TO-105	60	30	5	50	50	35	10	10	0.4	1.3	150	8.0	250	20	20	20	20
							75	10	10	1.6	2.6	500						
							100	300	500									
							30											

Test Condition:

1. $I_C = 150 \mu A$, $V_{CC} = 30V$, $I_{B1} = I_{B2} = 15 mA$
2. $I_C = 100 \mu A$, $V_{CE} = 5V$, $R_G = 1 k\Omega$, $BW = 15.7 kHz$
3. $I_C = 10 \mu A$, $V_{CE} = 5V$, $R_C = 10 k\Omega$, WB
4. $V_{CC} = 3V$, $I_C = 10 mA$, $I_{B1} = I_{B2} = 1 mA$
5. $I_C = 300 \mu A$, $V_{CE} = 10V$, $R_G = 510\Omega$, $f = 1 kHz$

* $V_{BE(ON)}$
($t = t_s + t_f$)



GENERAL PURPOSE AMPS AND SWITCHES (Cont.)

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Max	V _{EBO} (V) Min	I _{CEO} (mA) @ (V)	V _{CB} (V)	I _{FE} Min	I _{FE} Max	I _C @ (mA)	V _{CE} & (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	V _{BE(sat)} (V) Max	I _C (mA)	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
EN2222	TO-106	60	30	5	50	50	35	100	0.1	10	0.4	1.3	1.6	150	8	250					20
MPSA10	TO-92(72)		40	4	100	30	75	300	10	10											27
MPSA20	TO-92(72)		40	4	100	30	100	300	150	10											27
MPS2711	TO-92(72)	18	18	5	500	18	30	90	2	4.5				10	4	50					23
MPS2712	TO-92(72)	18	18	5	500	18	75	225	2	4.5	0.25				4	125					23
MPS2716	TO-92(72)		25	5	500	18	75	225	2	4.5					3.5						23
MPS2923	TO-92(72)		25	5	500	25	90	180	2	10					12						23
MPS2924	TO-92(72)		25	5	500	25	150	300	2	10					12						23
MPS2925	TO-92(72)		25	5	500	25	235	470	2	10					12						23
MPS2926	TO-92(72)	18	18	5	500	18	35	470	2	10					3.5						23
MPS3392	TO-92(72)	25	25	5	100	18	150	300	2	4.5					3.5						07
MPS3393	TO-92(72)	25	25	5	100	18	90	180	2	4.5					3.5						23
MPS3394	TO-92(72)	25	25	5	100	18	55	110	2	4.5					3.5						23
MPS3395	TO-92(72)	25	25	5	100	18	150	500	2	4.5					3.5						23
MPS3396	TO-92(72)	25	25	5	100	18	90	500	2	4.5					3.5						23
MPS3397	TO-92(72)	25	25	5	100	18	55	500	2	4.5					3.5						23
MPS3398	TO-92(72)	25	25	5	100	18	55	800	2	4.5					3.5						23
MPS3642	TO-92(72)	60	45	5	50	50	40	120	150	10	0.22			150	8	250					20
MPS3704	TO-92(72)	50	30	5	100	20	100	300	50	2	0.6			100	12	100					13
MPS3705	TO-92(72)	50	30	5	100	20	150	50	2	2	0.8			100	12	100					13
MPS3706	TO-92(72)	40	20	5	100	20	30	600	50	2	1			100	12	100					13
MPS3721	TO-92(72)	25	25	5	500	18	60	660	2	10					3.5						23
MPS3826	TO-92(72)	60	45	4	100	30	40	160	10	10					3.5						23
MPS3827	TO-92(72)	60	45	4	100	30	100	400	10	10					3.5						23
MPS5172	TO-92(72)	25	25	5	100	25	100	500	10	10	0.25			10	10						27
MPS6512	TO-92(72)	40	30	4	50	30	50	100	2	10	0.5			50	3.5						27
MPS6513	TO-92(72)	40	30	4	50	30	90	180	2	10	0.5			50	3.5						27
MPS6514	TO-92(72)	40	25	4	50	30	150	300	2	10	0.5			50	3.5						27
MPS6515	TO-92(72)	40	25	4	50	30	250	500	2	10	0.5			50	3.5						27
MPS6520	TO-92(72)	40	25	4	50	30	100	300	2	10	0.5			50	3.5				3	1	27
MPS6521	TO-92(72)	40	25	4	50	30	150	600	2	10	0.5			50	3.5				3	1	27

MPS6530	TO-92(72)	60	40	5	50	40	30	10	1	0.5	1	100	5				13
MPS6531	TO-92(72)	60	40	5	50	40	25	100	10	0.3	1	100	5				13
MPS6532	TO-92(72)	50	30	5	100	30	30	100	1	0.5	1.2	100	5				13
MPS6564	TO-92(72)	60	45	4	500	40	25	10	5	0.5	10	4	4				27
MPS6565	TO-92(72)	60	45	4	100	30	100	160	10	0.4	10	3.5	200	10			27
MPS6566	TO-92(72)	60	45	4	100	30	100	400	10	0.4	10	3.5	200	10			27
NS3903	TO-18	60	40	6	50	30	20	0.1	1	0.2	0.65	0.85	10	4	250	10	23
					(I_{CEX})		35	1	1	0.3	0.95	50	4		225†	6	4
							50	10	1								2
NS3904	TO-18	60	40	6	50	30	70	0.1	1	0.2	0.65	0.85	10	4	300	10	23
					(I_{CEX})		100	10	1	0.3	0.95	50	4		250†	5	4
							60	50	1								2
							30	100	1								
SE2001	TO-106	35	20	4	500	15	40	160	10	0.7	0.9	10	6	200	10		27
SE6001	TO-105	40	30	5	500	20	50	200	10	1	0.9*	100	25	40	30		20
SE6002	TO-105	40	30	5	500	20	50	600	10	1	0.9*	100	25	40	30		20

Test Condition:

1. $I_C = 150 \text{ mA}$, $V_{CC} = 30\text{V}$, $R_G = 1 \text{ k}\Omega$, $BW = 15.7 \text{ kHz}$

2. $I_C = 10 \text{ }\mu\text{A}$, $V_{CE} = 5\text{V}$, $R_G = 1 \text{ k}\Omega$, $WB = 10 \text{ kHz}$, WB

3. $V_{CC} = 3\text{V}$, $I_C = 10 \text{ mA}$, $I_B = I_{B2} = 1 \text{ mA}$

4. $V_{CE} = 3\text{V}$, $I_C = 10 \text{ mA}$, $R_G = 510\Omega$, $f = 1 \text{ kHz}$

5. $I_C = 300 \text{ }\mu\text{A}$, $V_{CE} = 10\text{V}$, $V_{BE(ON)}$ ($t = t_R + t_f$)



POWER

NPN Transistors

Type No.	Case Style	$V_{CEX}(I_{SUS})$ (V) Min	$V_{CE0}(I_{SUS})$ (V) Min	V_{EBO} (V) Min	I_{CEX} (mA) @ VCE Max	I_{CEX} (mA) @ VCE Min	h_{FE} Min	I_C @ Max (A)	V_{CE} (V)	$V_{CE}(sat)$ (V) Max	$V_{BE}(sat)$ (V) Min	I_C @ Max (A)	f_T (MHz) Min	I_C @ Max (A)	Process No.
2N3054	TO-66	90	55	7	1.0	90	25	0.5	4	1	1.7	0.5	8	2	1A
2N3055	TO-3	90	60	7	5.0	100	5	3	4	6	1.8	3	8	1.0	1B
2N3442	TO-3	160	140	7	5.0	140	20	10	4	8	1.7	10	2	1.0	1C
2N3771	TO-3	50	40	5	2	50	15	15	4	2	2.7	15	2	1.0	1D
2N3772	TO-3	80	60	7	2.0	100	5	30	4	4	2.2	10	2	1.0	1D
2N3773	TO-3	160	140	7	5.0	140	5	20	4	4	2.2	20	2	1.0	1E
2N4347	TO-3	140	120	7	2.0	125	15	8	4	4	2.2	16	2	1.0	1C
2N4348	TO-3	140	120	7	2.0	120	15	16	4	2	3	5	2	1.0	1E
2N6253	TO-3	55	45	5	2.0	55	10	5	4	2	3	10	2	1.0	1B
							20	3	4	4	1.7	3	8	1.0	1B



MEDIUM POWER AMPS

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CBO} (nA) @ V _{CB} (V) Max	V _{CB} (V)	hFE Min	hFE Max	I _C (mA) @ V _{CE} (V) & V _{CE(sat)} (V) & V _{BE(sat)} (V) Min	I _C (mA) @ V _{BE(sat)} (V) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N2017	TO-39	60	60	8	10 μA	30	35	200	10	200	200	10	10				12
2N2102	TO-39	120	65	7	2	60	10	20	0.01	150	10	60	50				12
2N2192	TO-39	60	40	5	10	30	35	120	10	150	20	50	50				12
2N2192A	TO-39	60	40	5	10	30	75	300	10	150	20	50	50				12
2N2193	TO-39	80	50	8	10	60	15	120	0.1	150	20	50	50				12
2N2193A	TO-39	80	50	8	10	60	15	120	0.1	150	20	50	50				12
2N2195	TO-39	45	25	5	100	30	15	150	10	150	20	50	50				12
2N2195A	TO-39	45	25	5	100	30	20	150	10	150	20	50	50				12
2N2243	TO-39	120	80	7	10	60	15	120	0.1	150	15	50	50				12
2N2243A	TO-39	120	80	7	10	60	15	120	0.1	150	15	50	50				12
2N2270	TO-39	60	45	7	50	60	30	200	1	150	15	100	50				12
2N2657	TO-39	80	60	8	100	60	40	120	1A	150	150	20	200	1500		1	34
2N2658	TO-39	100	80	8	100	60	40	120	1A	150	150	20	200	1500		1	34
2N2890	TO-39	100	80	5	30	60	20	90	1A	150	70	30	200	1500		1	34
2N2891	TO-39	100	80	5	30	60	25	90	2A	150	1500	30	200	1500		1	34
2N3019	TO-39	140	80	7	10	90	35	150	1A	150	70	30	200	1500		1	34
							40	2A	2A	150	1500	100	50				12
							50	300	0.1	150	12	100	50				12
							15	1A	10	500	0.5						12
							90	10	10	10							12

JAN2N3019	TO-39	140	80	7	10	90	15	1A	10	0.2	1.1	150	12	100	400	50	12
							50	200	0.1	0.5		500					
JANTX2N3019	TO-39	140	80	7	10	90	90	100	10	0.20	1.1	150	12	100	400	50	12
							50	200	0.1	0.50		500					
JANTXV2N3019	TO-39	140	80	7	10	90	50	200	0.1	0.2	1.1	150	12	100	400	50	12
							90	100	10	0.5		500					
2N3020	TO-39	140	80	7	10	90	30	100	0.1	0.2	1.1	150	12	100	50		12
							40	120	10	0.5		500					
2N3053	TO-39	60	40	5	7	60	25	150	2.5	1.4	1.7	150	15	100	50		12
							50	250	10								
2N3107	TO-39	100	60	7	7	60	100	300	1	1	2	1A	20	350	50		12
							35	0.1	10	0.25	1.1	150					
2N3108	TO-39	100	60	7	10	60	20	100	0.1	0.25	1.1	150	20	60	50		12
							40	120	10	1	2	1A					
2N3109	TO-39	80	40	7	10	60	35	0.1	10	0.25	1.1	150	25	70	50		12
							100	150	1	1	2	1A					
2N3110	TO-39	80	40	7	10	60	20	100	0.1	0.25	1.1	150	25	60	50		12
							40	150	10	1	2	1A					
2N3567	TO-105	80	40	5	50	40	40	120	150	0.25		150	20	60	200	50	14
							40	30	1								
2N3568	TO-105	80	60	5	50	40	40	120	150	0.25		150	20	60	200	50	14
							40	30	1								
2N3569	TO-105	80	40	5	50	40	100	300	150	0.25		150	20	60	200	50	14
							100	30	1								
2N3665	TO-39	120	80	10	50	60	30	100	10	0.5	1.2	150	12	60	50		12
							40	120	10	1.2	1.8	500					
2N3666	TO-39	120	80	10	50	60	100	300	150	0.5	1.2	150	12	60	50		12
							50	500	10	1.2	1.8	500					
2N3700	TO-18	140	80	7	10	90	50	100	0.1	0.2	1.1	150	12	100	200	50	12
							90	100	10	0.5		500					
2N3742	TO-39	300	300	7	200	200	15	100	3	1	1	10	6	30	10		48
							20	200	10	5	1.2	30					

Test Conditions:

- $V_{CC} = 20V, I_C = 1A$
 $I_{B1} = I_{B2} = 100 mA$
- $V_{CE} = 10V, I_C = 100 \mu A,$
 $R_G = 1 k\Omega, f = 1 kHz$
- $I_C = 2A, V_{CC} = 40V$
 $I_{B1} = I_{B2} = 200 mA$



NPN Transistors

MEDIUM POWER AMPS (Cont.)

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) @ (V) Max	V _{CB} (V) @ (V)	h _{FE} @ I _C (mA) & V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C (mA) @ I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) @ I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3743	TO-39	300	300	5	300	200	20 25 25 25 25 20 30 15	5 8	1 1.2	10 10 30	15	30	10				48
2N3945	TO-39	70	50	8			10 10 10 10 10 10 10	0.5 1.8	1.2 1.8	50	12	60	50				12
2N4237	TO-39		40		100μA	50	30 30 30 15	0.3 0.6	1.5 1	100 250	100	1	100				14
2N4238	TO-39		60		100μA	80	30 30 15	0.3 0.6	1.5 1	100 500 250	100	1	100				14
2N4924	TO-39	100	100	5	100	50	25 35 40	0.25 0.4	0.95	10 50	10	100 500	20				12
2N4926	TO-39	200	200	7	100	100	10 15 20 20			10 300 10	6 C _{cb}	30 300	10				48
2N4927	TO-39	250	250	7	100	150	10 15 20 20			10 300 10	6 C _{cb}	30 300	10				48
2N4930	TO-39	200	200	4	1 μA	150	20 20 20			10 200 20	20 C _{cb}	20 200	20				48
2N4931	TO-39	250	250	4	1 μA	150	20 20 20			10 200 20	20 C _{cb}	10 100	20				48
2N4943	TO-39	120	80	7	10	60	60 100 100	0.25	0.95	150	12	150 1000	50				12
2N5148	TO-39		80				5 15 30 20	5 0.85 0.46	3 1.5 1.2 1.5	200 3A 2A 1A 2A	70 C _{cb}	50	200				34
2N5150	TO-39		80				15 30 70 50	5 0.85 0.46	3 1.5 1.2 1.5	200 3A 2A 1A 2A	70 C _{cb}	60	200				34
2N5334	TO-39		60		5 μA	60	30 15	0.7	1.5	2A 2A	75	40	100	1050		1	34
2N5335	TO-39		80		5 μA	80	30 15	0.7	1.5	2A 2A	75	40	100	1050		1	34

2N5336	TO-39	80	10 μ A	30	500	2	0.7	1.2	2A	30	500	2200	3	34
				120	2A	2	1.2	1.8	5A					
2N5337	TO-39	80	10 μ A	20	5A	2	0.7	1.2	2A	30	500	2200	3	34
				240	2A	2	1.2	1.8	5A					
2N5338	TO-39	100	10 μ A	30	500	2	0.7	1.2	2A	30	500	2200	3	34
				120	2A	2	1.2	1.8	5A					
2N5339	TO-39	100	10 μ A	60	500	2	0.7	1.2	2A	30	500	2200	3	34
				240	2A	2	1.2	1.8	5A					
CS9013	TO-105	25		64	202	50	1.0		250					09
MPSA05	TO-92 (72)	60	100	50	10	1	0.25		100		100			14
MPSA06	TO-92 (72)	80	100	50	10	1	0.25		100		100			12
MPS6560	TO-92 (72)	25	100	35	10	1	0.50		500		500			14
				50	100	1								
MPS6561	TO-92 (72)	20	100	35	10	1	0.50		350		350			14
				50	200	350								

Test Conditions:

- $V_{CC} = 20V, I_C = 1A$
 $I_{B1} = I_{B2} = 100 mA$
- $V_{CE} = 10V, I_C = 100 \mu A,$
 $R_G = 1 k\Omega, f = 1 kHz$
- $I_C = 2A, V_{CC} = 40V$
 $I_{B1} = I_{B2} = 200 mA$



DARLINGTON AMPS

NPN Transistors

Type No.	Case Style	V_{CB0} (V) Min	V_{CE0} (V) Min	V_{EB0} (V) Min	I_{CB0} (mA) @ Max	V_{CB} (V)	I_{FE} @ Max Min	I_C & V_{CE} (mA) (V)	$V_{CE(sat)}$ (V) @ Max	$V_{BE(sat)}$ @ Min Max	I_C @ (mA) Max	C_{ob} (pF) Max	f_T (MHz) Min Max	t_{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N5305	TO-92 (74)				100	25	2,000	2	1.4		200	10	60				05
2N5306	TO-92 (74)				100	25	7,000	2	1.4		200	10	60				05
2N5307	TO-92 (74)				100	40	2,000	2	1.4		200	10	60				05
2N5308	TO-92 (74)				100	40	7,000	2	1.4		200	10	60				05
MPSA12	TO-92 (72)	20 (V _{CEs})			100 (I _{CEs})	15	20,000	2	1.0		10						05
MPSA13	TO-92 (72)	30 (V _{CEs})			100	30	5,000	10	1.5		100		125				05
MPSA14	TO-92 (72)	30 (V _{CEs})			100	30	10,000	10	1.5		100		125				05
					100	30	20,000	10	1.5		100		125				05



DUAL DIFFERENTIAL AMPS

NPN Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} (mA) Max	V _{CB} (V)	h _{FE} Min	h _{FE} Max	I _C @ (mA)	h _{FE1} h _{FE2} (%) Max	V _{BE1} -V _{BE2} (mV) Max	ΔV _{BE1} -V _{BE2} ΔT (μV/°C) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	NF (dB) Max	Test Condition	Process No.
2N2453	TO-78	60	30	7	5	50	80	600	0.01	10	3	10	8	60	7	1	07
2N2453A	TO-78	80	50	7	5	60	150	600	0.01	10	5	5	4	60	4	1	07
2N2639	TO-78	45	45	5	10	45	150	300	0.01	10	5	10	8	80	4	2	07
2N2640	TO-78	45	45	5	10	45	65	300	0.1	20	10	20	8	80	4	2	07
2N2641	TO-78	45	45	5	10	45	55	300	0.01	10	5	10	8	80	4	2	07
2N2642	TO-78	45	45	5	10	45	65	300	0.1	10	5	10	8	80	4	2	07
2N2643	TO-78	45	45	5	10	45	100	300	0.01	20	10	20	8	80	4	2	07
2N2644	TO-78	45	45	5	10	45	110	300	0.1	20	10	20	8	80	4	2	07
2N2722	TO-78	45	45	5	1	30	130	250	0.001	10	5	10	6	100	4	2	07
2N2903	TO-78	60	30	7	10	50	110	625	0.01	20	10	20	8	60	7	1	07
2N2903A	TO-78	60	30	7	10	50	125	625	0.01	10	5	10	8	60	7	1	07
2N2913	TO-78	45	45	6	10	45	60	240	0.01	10	5	10	6	60	4	2	07
2N2914	TO-78	45	45	6	10	45	100	600	0.1	10	5	10	6	60	4	3	07
2N2915	TO-78	45	45	6	10	45	150	600	0.01	10	5	10	6	60	3	2	07
2N2915A	TO-78	45	45	6	10	45	225	240	0.1	10	5	5	6	60	3	3	07
2N2916	TO-78	45	45	6	10	45	300	600	0.01	10	5	5	6	60	4	2	07
							150	600	0.1	10	5	10	6	60	4	3	07
							225	600	0.1	10	5	10	6	60	4	3	07
							300	600	1	10	5	10	6	60	4	3	07

2N2916A	TO-78	45	45	6	10	45	150 225 300	600 0.1 1	10 1.5 2	5	6	60 160	3 3	2 3	07
2N2917	TO-78	45	45	6	10	45	60 100 150	240 0.01 1	*15 20	20	6	60	4 4	2 3	07
2N2918	TO-78	45	45	6	10	45	150 225 300	600 0.1 1	20	20	6	60	3 3	3 2	07
2N2919	TO-78	60	60	6	2	45	60 100 150	240 0.01 1	10 10	10	6	60	4 4	3 2	07
2N2919A	TO-78	60	60	6	2	45	60 100 150	240 0.1 1	10 1.5 2	5	6	60 160	4 4	3 2	07
2N2920	TO-78	60	60	6	2	45	150 225 300	600 0.01 1	10 10	10	6	60	3 3	3 2	07
JAN2N2920	TO-78	70	60	6	2	45	150 225 300	600 0.01 1	— — —	— — —	6	60 400	3 3 5	3 2 4	07
JANTX2N2920	TO-78	70	60	6	2	45	175 225 300	600 0.01 1	— — —	— — —	5	60 400	3 3 5	3 2 4	07
JANTXV2N2920	TO-78	70	60	6	2	45	175 225 300	600 0.1 1	10 10	10	5	60 400	3 3 5	3 2 4	07
2N2920A	TO-78	60	60	6	2	45	150 225 300	600 0.01 1	10 1.5 2	5	6	60 160	3 3	5 2	07
2N2972	TO-71	45	45	6	10	45	60 100 150	240 0.01 1	10	10	6	60	4 4	3 2	07
2N2973	TO-71	45	45	6	10	45	150 225 300	600 0.01 1	10	10	6	60	3 3	3 2	07
2N2974	TO-71	45	45	6	10	45	60 100 150	240 0.1 1	10	10	6	60	4 4	3 2	07
2N2975	TO-71	45	45	6	10	45	150 225 300	600 0.01 1	10	10	6	60	3 3	3 2	07
2N2976	TO-71	45	45	6	10	45	60 100 150	240 0.01 1	10 20	20	6	60	4 4	3 2	07
2N2977	TO-71	45	45	6	10	45	150 225 300	600 0.01 1	10 20	20	6	60	3 3	3 2	07

Test Conditions:

1. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 1 kHz$

2. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $BW = 15.7 kHz$

3. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 1 kHz$
 $BW = 200 Hz$

4. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 100 Hz$

5. $I_C = 100 \mu A$, $V_{CE} = 5V$.

$R_G = 10 k\Omega$, $BW = 15.7 kHz$

*This parameter measured at frequency = 1 kHz.
 $T_A = -55^\circ C$ to $+125^\circ C$.



DUAL DIFFERENTIAL AMPS (Cont.)

NPN Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) @ I _C	h _{FE} Min	h _{FE} Max	I _C (mA) @ I _C	h _{FE1} h _{FE2} (%) Max	V _{BE1} -V _{BE2} (mV) Max	ΔV _{BE1} -V _{BE2} (ΔT (μV/°C) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	NF (dB) Max	Test Condition	Process No.
2N2978	TO-71	60	60	6	2	45	60 100 150	240	0.01 0.1 1	10	5 3 3	10	6	60 4	4	3 2	07
2N2979	TO-71	60	60	6	2	45	150 225 300	600	0.01 0.1 1	10	5 3 5	10	6	60 3 3	3 3	3 2	07
2N3587	TO-78	60	45	5	10	40	50 80	500	0.1 1	f20	20	20	8	80 200	10	3	07
2N3680	TO-78	60	50	6	10	45	150 225 300	600	0.01 0.1 1	10	3	5	6	60 180	3	2	07
2N3907	TO-78	60	45	6	10	45	60 70 120	300 500	0.01 0.1	10	2 1	5	6	60 240	4	3	07
2N3908	TO-78	60	60	6	2	45	100 125 200	500 800	0.01 0.1	10	2 1 2.5	5	6	60 240	3	3	07
ND5700	TO-78	45	45	6	0.2	50	200 200 200	1500 2000 2000	0.01 1 5	5	0.5	2	3		3	5	570
ND5701	TO-78	45	45	6	0.2	50	200 200 200	1500 2000 2000	0.01 1 5	10	1	5	3		3	5	570
ND5702	TO-78	45	45	6	0.2	50	200 200 200	1500 2000 2000	0.01 1 5	10	2	10	3		3	5	570

Test Conditions:

- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, BW = 15.7 kHz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 10 μA, V_{CE} = 5V, R_G = 10 kΩ, f = 100 Hz
- I_C = 100 μA, V_{CE} = 5V, R_G = 10 kΩ, BW = 15.7 kHz

*This parameter measured at frequency = 1 kHz.
†T_A = -55°C to +125°C.



SATURATED SWITCHES

PNP Transistors

Type No.	Case Style	V _{CE0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} (mA) Max	V _{CB} (V)	I _{FE} Min	I _{FE} Max	I _C @ (mA)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	V _{BE(sat)} (V) Max	I _C (mA)	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _{CEI} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N869	TO-52	25	5	5	10	15	20	10	10	0.15	1	1	10		100	10	13			64
2N869A	TO-52	25	5	5	10	15	40	120	30	0.15	0.78	0.98	10	6	400	10	80		8	64
2N895	TO-52	20	4	4	50	15	25	140	20	0.2	0.95	1.7	100	10	100	10				64
2N895A	TO-52	20	4	4	5	15	25	140	20	0.2	0.95	1.7	100	6	100	10	90		2	64
2N2894	TO-52	12	4	4	80	6	40	150	30	0.15	0.78	0.98	10	6	400	30	90		2	64
2N2894A	TO-52	12	4.5	4.5	50	10	20	100	10	0.13	0.78	0.92	10	4.5	800	30	25		3	64
2N3012	TO-52	12	4	4	80	6	30	120	30	0.15	0.78	0.98	10	6	400	30	75		2	64
2N3209	TO-52	20	4	4	80	10	30	120	30	0.15	0.78	0.98	10	5	400	30	90		2	64
2N3244	TO-5 (Lo-Profile)	40	5	5	50	30	60	150	150	0.3	0.75	1.5	500	25	175	50	195		9	70
2N3245	TO-5 (Lo-Profile)	50	5	5	50	50	35	90	150	0.35	0.75	1.5	500	25	150	50	165		9	70
2N3248	TO-52	15	5	5	50	10	50	150	0.1	0.12	0.6	0.9	10	8	250	20	100		1	64
2N3249	TO-52	15	5	5	50	10	100	300	0.1	0.125	0.6	0.9	10	8	250	20	100		1	64

Test Conditions:

- I_C = 100 mA, I_{B1} = I_{B2} = 10 mA
- I_C = 30 mA, I_{B1} = I_{B2} = 1.5 mA
- I_C = 30 mA, I_{B1} = I_{B2} = 3 mA
- I_C = 100 μA, V_{CE} = 5V, R_G = 1 kΩ, f = 100 Hz
- I_C = 10 mA, I_{B1} = I_{B2} = 0.5 mA
- I_C = 80 mA, I_{B1} = I_{B2} = 5 mA
- I_C = 10 mA, I_{B1} = I_{B2} = 1 mA
- I_C = 30 mA, I_{B1} = I_{B2} = 1.5 mA
- I_C = 500 mA, I_{B1} = I_{B2} = 50 mA
- I_C = 1-A, I_{B1} = I_{B2} = 100 mA



SATURATED SWITCHES (Cont.)

PNP Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Min	V _{EB0} (V) Min	I _{CBO} (μA) @ V _{CB} (V) Max	h _{FE} Min	h _{FE} Max	I _C @ (mA) & V _{CE} (V)	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max	I _C (mA) @ V _{BE(sat)} (V) Min	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) @ I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3250	TO-18	50	40	5		40	150	0.1 1	0.25 0.5	0.6 1.2	6	250	10	225	6	7 4	69
2N3250A	TO-18	60	60	5		40	150	0.1 1	0.25 0.5	0.6 1.2	6	250	10	225	6	7 4	69
JAN2N3250A	TO-18	60	60	5		40	150	0.1 1	0.25 0.5	0.6 1.2	6	250	10	225	6	7 4	69
JANTXV2N3250A	TO-18	60	60	5		40	150	0.1 1	0.25 0.5	0.6 1.2	6	250	10	225	6	7 4	69
2N3251	TO-18	50	40	5		80	300	0.1 1	0.25 0.5	0.6 1.2	6	300	10	250	6	7 4	69
2N3251A	TO-18	60	60	5		80	300	0.1 1	0.25 0.5	0.6 1.2	6	300	10	250	6	7 4	69
JAN2N3251A	TO-18	60	60	5		80	300	0.1 1	0.25 0.5	0.6 1.2	6	300	10	250	6	7 4	69
JANTX2N3251A	TO-18	60	60	5		80	300	0.1 1	0.25 0.5	0.6 1.2	6	300	10	250	6	7 4	69
JANTXV2N3251A	TO-18	60	60	5		80	300	0.1 1	0.25 0.5	0.6 1.2	6	300	10	250	6	7 4	69
2N3304	TO-52	6	6	4		30	120	0.3 50	0.15 0.16	0.7 0.8	3.5	500	10	60		5	65
2N3451	TO-52	6	6	4.0	10	30	120	0.3 50	0.16 0.15	0.8 1.5	5.5	500	10	25		6	65
2N3467	TO-5 (Lo-Profile)	40	40	5	100	40	120	150 500 1A	0.25 0.3 1	0.75 1.5 0.8	10/5 50/5	175	50	90		5 9	70

2N3468	TO-5 (Lo-Profile)	50	50	5	100	30	25	150	1	150	25	150	50	90	9	70
2N3545	TO-52	20	20	5	10	10	30	75	150 500 1A	1 5	0.35 1.2 1.6	0.8 1.6 1A	1 1A	150 500	8	64
2N3546	TO-52	15	12	4.5	10	10	30	30	100	1	0.15 0.25 0.5	0.7 0.8 1.1	0.9 1.3 1.6	10 10	6	64
2N3576	TO-52	20	15	5	10	15	40	120	100	0.5	0.15 0.5	0.75 1.1	0.95 1.0	10 10	7	64
2N3639	TO-106	6	6	4	10	3	10	120	10	0.3	0.16 0.5 0.25	10/5 50 10/1.5	10 50 100	60 10	5	65
2N3640	TO-106	12	12	4	10	6	30	120	10	0.3	0.2 0.6	0.8 1.5	10/1 50	35 10	6	65
2N4208	TO-52	12	12	4.5	10	6	30	30	50	1	0.13 0.15 0.5	0.8 0.95 1.5	1 10	20 10	7	65
2N4209	TO-52	15	15	4.5	10	8	40	120	10	0.3	0.15 0.18 0.6	0.8 0.95 1.5	1 10 50	20 10	7	65
2N4258	TO-106	12	12	4.5	10	6	30	120	10	0.3	0.5 0.15	1.5 0.95	50 10	20 10	7	65
2N4313	TO-106	12	12	4.5	50	10	18	15	1	0.5	0.13 0.19 0.45	0.92 1.15 1.5	10 30 100	25 30	3	64
2N4423	TO-106	12	12	4	80	6	30	150	100	0.3	0.15 0.2 0.5	10 30 100	30 100	50 100	3	64
2N5022	TO-5 (Lo-Profile)	50	50	5	100	30	15	100	100	1	0.2 0.4 0.8	1 1.4 1.75	100 500 1A	50 90	9	70
2N5023	TO-5 (Lo-Profile)	30	30	5	100	20	40	100	500	1	0.17 0.35 0.7	1 1.4 1.75	100 500 1A	50 90	9	70
2N5055	TO-106	12	12	4.5	50	10	12	30	100	0.5	0.13 0.19 0.45	0.92 1.15 1.5	10 30 100	25 30	3	64
2N5056	TO-52	15	15	4.5	50	10	12	100	100	1	0.13 0.19 0.45	0.72 0.8 0.95	10 30 100	35 30	3	64
2N5057	TO-52	15	15	4.5	50	10	20	100	100	1	0.13 0.19 0.45	0.72 0.8 0.95	10 30 100	35 30	3	64

Test Conditions:

1. $I_C = 100 \text{ mA}$, $I_{B1} = I_{B2} = 10 \text{ mA}$
2. $I_C = 30 \text{ mA}$, $I_{B1} = I_{B2} = 1.5 \text{ mA}$
3. $I_C = 30 \text{ mA}$, $I_{B1} = I_{B2} = 3 \text{ mA}$
4. $I_C = 100 \mu\text{A}$, $V_{CE} = 5\text{V}$,
 $R_G = 1 \text{ k}\Omega$, $f = 100 \text{ Hz}$
5. $I_C = 10 \text{ mA}$, $I_{B1} = I_{B2} = 0.5 \text{ mA}$
6. $I_C = 50 \text{ mA}$, $I_{B1} = I_{B2} = 5 \text{ mA}$
7. $I_C = 10 \text{ mA}$, $I_{B1} = I_{B2} = 1 \text{ mA}$
8. $I_C = 30 \text{ mA}$, $I_{B1} = I_{B2} = 3 \text{ mA}$
9. $I_C = 500 \text{ mA}$, $I_{B1} = I_{B2} = 50 \text{ mA}$
10. $I_C = 1\text{-A}$, $I_{B1} = I_{B2} = 100 \text{ mA}$



SATURATED SWITCHES (Cont.)

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CB0} (nA) @ V _{CB} Max	I _C @ V _{CE} & V _{CE} (mA) & (V)	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max & Min	I _C (mA) @ V _{BE(sat)} Max	C _{ob} (pF) Max	f _T (MHz) @ I _C Min Max	I _C (mA) @ I _C Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N5140	TO-106	5	5	4	50 ICES	50 1 0.5 10 1	0.75 0.2	50 1.2 10	5	400	10	20		7	65
2N5141	TO-106	6	6	6	100 ICES	15 1 2 25 10 2 30 30 2 100 5	0.2 0.8 0.25 0.6	10 1.1 10 1.25 30 2.0 100	7	300	20	150		3	64
2N5910	TO-106	20	20	4.5	10	30	0.5	50	3	700	10	20		7	65
MPS3639	TO-92(70)	6	6	4	100 ICES	30 120 10 0.3 50 1	0.16 0.8 0.15 0.5	10 0.95 10 1.5 50	3.5	500 300	10 10	25 60		6 5	65
MPS3640	TO-92(70)	12	12	4	100 ICES	30 120 10 0.3 50 1	0.2 0.8 0.15 0.6	10 10 1.5 50	3.5	500	10	35 75		6 5	65
NS3762	TO-5 (Lo-Profile)	40	40	5	100 ICEX	35 40 35 30 120 1A 1.5A 5	0.15 0.22 0.5 0.9	10 0.8 10 1.50 1.2 500 1A 1.4	18	180	50	115		10	70
NS3763	TO-5 (Lo-Profile)	60	60	5	100 ICEX	35 40 35 20 1A 1.5A 5	0.15 0.22 0.5 0.9	10 0.8 10 1.50 1.2 500 1A 1.4	18	180	50	115		10	70

Test Conditions:

- I_C = 100 mA, I_{B1} = I_{B2} = 10 mA
- I_C = 30 mA, I_{B1} = I_{B2} = 1.5 mA
- I_C = 30 mA, I_{B1} = I_{B2} = 3 mA
- I_C = 100 μA, V_{CE} = 5V, R_G = 1 kΩ, f = 100 Hz
- I_C = 10 mA, I_{B1} = I_{B2} = 0.5 mA
- I_C = 50 mA, I_{B1} = I_{B2} = 5 mA
- I_C = 10 mA, I_{B1} = I_{B2} = 1 mA
- I_C = 30 mA, I_{B1} = I_{B2} = 1.5 mA
- I_C = 500 mA, I_{B1} = I_{B2} = 50 mA
- I_C = 1-A, I_{B1} = I_{B2} = 100 mA



LOW LEVEL AMPS

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CB0} (nA) @ V _{CB} Max	h _{FE} @ I _C & V _{CE} (mA) & (V)	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max & Min	I _C (mA) @ V _{BE(sat)} Max	C _{ob} (pF) Max	f _T (MHz) @ I _C Min Max	I _C (mA) @ I _C Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N2604	TO-46	60	45	6	10 45	40 120 0.01 5 60 350 10 5	0.5 0.7 0.9 10	6	6	30	0.5		4	1	62
JAN2N2604	TO-46	80	60	6	10 50	40 120 0.01 5 60 350 10 5	0.5 0.7 0.9 10	6	6	30	0.5		3	1	62

2N2605	TO-46	60	45	6	10	45	100	300	0.01	5	0.5	0.7	0.9	10	6	30	0.5	3	1	62
JAN2N2605	TO-46	70	60	6	10	50	100	300	0.010	5	0.5	0.7	0.9	10	6	30	300	3	1	62
2N3547	TO-18	60	60	6	25	45	60	500	1	5	1	1	10	8	45	150	1	5	1	62
2N3548	TO-18	60	45	6	10	45	100	300	0.01	5	1	1	10	8	60	150	1	4	1	62
2N3549	TO-18	60	60	6	10	45	100	500	0.010	5	1	1	10	8	60	150	1	4	1	62
2N3550	TO-18	60	45	8	1.0	45	125	200	0.001	5	0.5	0.7	0.9	5	8	60	150	4	1	62
2N3799	TO-18	60	60	5	10	50	75	300	0.001	5	0.2	0.7	0.01	4	30	0.5	1.5	9	10	62
2N3962	TO-18	60	60	6	10	50	100	300	0.010	5	0.25	0.8	1	6	40	160	0.5	1.5	11	62
2N3963	TO-18	80	80	6	10	70	100	300	0.010	5	0.25	0.9	10	6	40	160	0.5	3	2	62
2N3964	TO-18	45	45	6	10	40	250	500	0.010	5	0.25	0.9	10	6	40	160	0.5	2	2	62
2N3965	TO-18	60	60	6	10	50	250	500	0.010	5	0.25	0.9	10	6	40	160	0.5	2	2	62
2N4248	TO-106	40	40	5	10	40	50	300	0.1	5	0.25	10	10	6	40	160	0.5	2	2	62
2N4249	TO-106	60	60	5	10	40	100	300	0.1	5	0.25	10	10	6	40	160	0.5	2	2	62

Test Conditions:

1. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $BW = 15.7 kHz$
2. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $BW = 15.7 kHz$
3. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $BW = 1.5 kHz$
 $f = 10 kHz$
4. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $f = 1 kHz$, $BW = 150 Hz$,
 $R_G = 10 k\Omega$
5. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $f = 100 Hz$, $BW = 15 Hz$,
 $R_G = 10 k\Omega$
6. $I_C = 250 \mu A$, $V_{CE} = 5V$,
 $R_G = 1 k\Omega$, $f = 1 kHz$,
 $BW = 150 Hz$
7. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 1 kHz$
 $BW = 200$
8. $I_C = 100 \mu A$, $V_{CE} = 5V$,
 $R_S = 3K$, $f = 1 kHz$
9. $V_{CE} = 10V$, $I_C = 100 \mu A$, $R_G = 3 k\Omega$
 $f = 1 kHz$, $BW = 200 Hz$
10. $V_{CE} = 10V$, $I_C = 100 \mu A$, $R_G = 3 k\Omega$
 $f = 10 kHz$, $BW = 2 kHz$
11. $V_{CE} = 10V$, $I_C = 100 \mu A$, $R_G = 3 k\Omega$
 $f = 100 Hz$, $BW = 20 Hz$
12. $V_{CE} = 10V$, $I_C = 100 \mu A$, $R_G = 3 k\Omega$
 $BW = 15.7 Hz$



LOW LEVEL AMPS (Cont.)

PNP Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V)	hFE Min Max	I _C (mA) & V _{CE} (V)	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N4250	TO-106	40	40	5	10	40	250 700	0.1 5	0.25	10	6				2 4 6	2	62
2N4250A	TO-106	60	60	5	10	50	250 700	0.1 5	0.25	10	6				2 4 6	2	62
2N4964	TO-106	50	40	5	25	20	30 120	0.01 5	0.4	10	8	60	1		6 7	6	62
2N4965	TO-106	50	40	5	25	20	80 400	0.01 5	0.4	10	8	60	1		6 7	6	62
2N5086	TO-92(72)	50	50	50	50	35	150 500	0.1 5	0.3	10	4	40	0.5		3 8	3 2	62
2N5087	TO-92(72)	50	50	50	50	35	150 500	0.1 5	0.3	10	4	40	0.5		2 8	2	62
2N5227	TO-92(72)	30	30	3	100	10	30 700	0.1 10	0.4	1 10	5	100	10				62
MPSA70	TO-92(72)	40	40	4	100	30	40 400	5 10	0.25	10	4	125	5				62

Test Conditions:

- I_C = 10 μA, V_{CE} = 5V,
R_G = 10 kΩ, BW = 15.7 kHz
R_G = 10 kΩ
- I_C = 20 μA, V_{CE} = 5V,
R_G = 10 kΩ, BW = 15.7 kHz
R_G = 10 kΩ
- I_C = 20 μA, V_{CE} = 5V,
R_G = 10 kΩ, BW = 1.5 kHz
f = 10 kHz
- I_C = 20 μA, V_{CE} = 5V,
f = 1 kHz, BW = 150 Hz,
R_G = 10 kΩ
- I_C = 100 μA, V_{CE} = 5V,
R_S = 3k, f = 1 kHz
R_G = 200
- I_C = 10 μA, V_{CE} = 5V,
R_G = 10 kΩ, f = 1 kHz
BW = 200
- V_{CE} = 10V, I_C = 100 μA, R_G = 3 kΩ
f = 10 kHz, BW = 2 kHz
- V_{CE} = 10V, I_C = 100 μA, R_G = 3 kΩ
f = 100 Hz, BW = 20 Hz
- V_{CE} = 10V, I_C = 100 μA, R_G = 3 kΩ
f = 1 kHz, BW = 200 Hz
BW = 150 Hz
- V_{CE} = 10V, I_C = 100 μA, R_G = 3 kΩ
BW = 15.7 Hz



GENERAL PURPOSE AMPS AND SWITCHES

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V)	h _{FE} Min Max	I _C @ (mA)	V _{CE} (V) &	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min Max	I _C @ (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N122	TO-18	50	35	5	1.0 μA	30	30 90	150 5	10 10	1.5	1.3	150 50	45	60	50				63
2N1132	TO-5	50	35	5	1.0 μA	30	25 100	1 5	5 10	1.5	1.3	150 50	45	60	50				63
2N2904	TO-5	60	40	5	20	50	25* 40 120	0.1 150 500	10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50				63
JAN2N2904	TO-5	60	40	5	20	50	20 25 35 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	175		1	63
JANTX2N2904	TO-5	60	40	5	20	50	20 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	175		1	63
JANTXV2N2904	TO-5	60	40	5	20	50	20 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	175		1	63
2N2904A	TO-5	60	60	5	10	50	40 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50				63
JAN2N2904A	TO-5	60	60	5	10	50	40 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	175		1	63
JANTX2N2904A	TO-5	60	60	5	10	50	40 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	175		1	63
JANTXV2N2904A	TO-5	60	60	5	10	50	40 40 120	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	175		1	63
2N2905	TO-5	60	40	5	20	50	35 100 300	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50				63
JAN2N2905	TO-5	60	40	5	20	50	30 30 500	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200		1	63
JANTX2N2905	TO-5	60	40	5	20	50	30 30 500	0.1 150 500	10 10 10 10 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200		1	63

Test Conditions:

- I_C = 150 mA, V_{CC} = 30V, I_{B1} = I_{B2} = 15 mA



GENERAL PURPOSE AMPS AND SWITCHES (Cont.)

PNP Transistors

Type No.	Case Style	V _{CE0} (V) Min	V _{CE0} (V) Min	V _{CE0} (V) Min	I _{CBO} (nA) Max	V _{CB} (V)	hFE Min	hFE Max	I _C @ (mA) & V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C @ (mA) Max	C _{cb} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
JANTXV2N2905	TO-5	60	40	5	20	50	50	300	0.1	10	1.3	150	8	200	200	50	200		1	63
2N2905A	TO-5	60	60	5	10	50	75	300	0.1	10	2.6	500	8	200	200	50				63
JAN2N2905A	TO-5	60	60	5	10	50	75	300	0.1	10	1.3	150	8	200	200	50	200		1	63
JANTX2N2905A	TO-5	60	60	5	10	50	75	300	0.1	10	1.3	150	8	200	200	50	200		1	63
JANTXV2N2905A	TO-5	60	60	5	10	50	75	300	0.1	10	1.3	150	8	200	200	50	200		1	63
2N2906	TO-18	60	40	5	20	50	20	120	0.1	10	1.3	150	8	200	200	50				63
JAN2N2906	TO-18	60	40	5	20	50	25	100	0.1	10	2.6	500	8	200	175	50	175		1	63
JANTX2N2906	TO-18	60	40	5	20	50	20	120	0.1	10	1.3	150	8	200	200	50	175		1	63
JANTXV2N2906	TO-18	60	40	5	20	50	20	140	0.1	10	2.6	500	8	200	200	50	175		1	63
2N2906A	TO-18	60	60	5	20	50	40	120	0.1	10	1.3	150	8	200	200	50				63
JAN2N2906A	TO-18	60	60	5	10	50	40	120	0.1	10	1.3	150	8	200	200	50	175		1	63
JANTX2N2906A	TO-18	60	60	5	10	50	40	120	0.1	10	1.3	150	8	200	200	50	175		1	63
JANTXV2N2906A	TO-18	60	60	5	10	50	40	120	0.1	10	2.6	500	8	200	200	50	175		1	63
2N2907	TO-18	60	40	5	20	50	35	300	0.1	10	1.3	150	8	200	200	50				63

JAN2N2907	TO-18	60	40	5	20	50	35 50 75 100 30	0.1 1 10 10 10 300 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
JANTX2N2907	TO-18	60	40	5	20	50	35 50 75 100 30	0.1 1 10 10 10 300 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
JANTXV2N2907	TO-18	60	40	5	20	50	100 300 30	0.1 10 10 10 10 300 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
2N2907A	TO-18	60	60	5	20	50	75 100 300 50	1.0 10 10 10 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
JAN2N2907A	TO-18	60	60	5	10	50	75 100 100 100 50	0.1 1 10 10 10 300 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
JANTX2N2907A	TO-18	60	60	5	10	50	75 100 300 50	1 10 10 10 300 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
JANTXV2N2907A	TO-18	60	60	5	10	50	100 300 50	1 10 10 10 300 500 10	0.4 1.6	1.3 2.6	150 500	8	200	50	200	1	63
2N3072	TO-5	60	60	4	4	30	30 15	130 300 2	0.25 1.0	1.2 2.0	50 300	10	130	50	100	10	63
2N3073	TO-18	60	60	4	4	30	30 15	130 300 2	0.25 1.0	1.2 2.0	50 300	10	130	50	100	10	63
2N3120	TO-5	45	45	4	4	30	30 15	130 300 2	0.25 1.0	1.2 2.0	50 500	10	130	50	100	10	63
2N3121	TO-18	45	45	4	4	30	30 15	130 300 2	0.25 1.0	1.2 2.0	50 500	10	130	50	100	10	63
2N3133	TO-5	50	35	4	50	30	10 25 40	150 1 150 10	0.6	1.5	150	10	200	50	200	10	63
2N3134	TO-5	50	35	4	50	30	25 50 100	150 1 150 10	0.6	1.5	150	10	200	50	200	10	63
2N3135	TO-18	50	35	4	50	30	25 50 100	150 1 150 10	0.6	1.5	150	10	200	50	200	10	63
2N3136	TO-18	50	35	4	50	30	25 50 100	150 1 150 10	0.6	1.5	150	10	200	50	200	10	63

Test Conditions:

- $I_C = 150 \text{ mA}$, $V_{CC} = 30\text{V}$, $I_{B1} = I_{B2} = 15 \text{ mA}$
- $I_C = 100 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_G = 1 \text{ k}\Omega$, $BW = 15.7 \text{ kHz}$
- $I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_G = 10 \text{ k}\Omega$, WB
- $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$, $V_{CC} = 10\text{V}$
- $I_C = 30 \mu\text{A}$, $V_{CE} = 15\text{V}$, $R_S = 10 \text{ k}\Omega$, $f = 1 \text{ kHz}$
- $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$, $V_{CC} = 30\text{V}$
- $I_C = 50 \text{ mA}$, $V_{CC} = 10\text{V}$, $I_{B1} = I_{B2} = 5 \text{ mA}$
- $I_C = 150 \text{ mA}$, $I_{B1} = I_{B2} = 15 \text{ mA}$, $V_{CC} = 10\text{V}$
- $I_C = 10 \text{ mA}$, $I_{B1} = I_{B2} = 1 \text{ mA}$, $V_{CC} = 15\text{V}$
- $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$, $V_{CC} = 15\text{V}$



GENERAL PURPOSE AMPS AND SWITCHES (Cont.)

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CB0} (mA) Max	V _{CB} (V) @ I _C	h _{FE} Min	I _C (mA) @ I _{CE} Max	V _{CE(sat)} (V) & V _{CE} (V)	V _{BE(sat)} (V) Min	I _C (mA) @ V _{BE(sat)} Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3502	TO-5	45	45	5	10 ICES	30	80 120 135	0.01 0.1 1	10 10 10	0.25 0.4 1.0	1.0 1.3 2.0	50	200	50	100	4	7 5	63
2N3503	TO-5	60	60	5	10 ICES	50	80 120 135	0.01 0.1 1	10 10 10	0.25 0.4 1.0	1.0 1.3 2.0	50	200	50	100	4	7 5	63
2N3504	TO-18	45	45	5	10 ICES	30	80 120 135	0.01 0.1 1	10 10 10	0.25 0.4 1.0	1.0 1.3 2.0	50	200	50	100	4	7 5	63
2N3505	TO-18	60	60	5	10 ICES	50	80 120 135	0.01 0.1 1	10 10 10	0.25 0.4 1.0	1.0 1.3 2.0	50	200	50	100	4	7 5	63
2N3638	TO-105	25	25	4	35	15	80 100 100	1 50 10	2 10 10	1.0 0.25 0.15	2.0 1.1 1.1	50	100	50	170	4	4	63
2N3638A	TO-105	25	25	4	35	15	80 100 100	1 50 10	2 10 10	1.0 0.25 0.15	2.0 1.1 1.1	50	150	50	170	4	4	63
2N3644	TO-105	45	45	5	35	30	40 80 100	0.1 1 10	10 10 10	1.0	2.0	300	200	20	100	7	7	63
2N3645	TO-105	60	60	5	35	50	40 80 100	0.1 1 10	10 10 10	1.0 0.25	2.0 1.0	300 50	200	20	100	7	7	63
2N3905	TO-92(72)	40	40	5			30 40 50	0.1 1 10	1 1 1	0.25 0.4	0.65 0.95	10 50	200	10		5	2	66



GENERAL PURPOSE AMPS AND SWITCHES (Cont.)

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CB0} (mA) Max	V _{CB} (V) @ I _C	h _{FE} @ I _C (mA) Min Max	V _{CE(sat)} (V) & V _{BE(sat)} (V) Min Max	I _C (mA) @ V _{CE(sat)} Min Max	C _{ob} (pF) Max	f _T (MHz) @ I _C (mA) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N4972	TO-106	50	40	5	25	30	70 50 100 300	0.4	1.3	8	200	50			63
2N5138	TO-106	30	30	5	50	20	50 800 0.1	0.3	1.0	7	30	5			66
2N5139	TO-106	20	20	5	50	15	30 40 10 10	0.5	0.7	5	300	10			66
2N5142	TO-105	20	20	4	50	12	30 15 300	2	0.8	10	100	50		4	63
2N5143	TO-106	20	20	4	50	12	30 15 300	2	0.8	10	100	50		4	63
2N5221	TO-92(72)	15	15	3	100	10	25 30 600	0.5	1.1	15	100	20			63
2N5226	TO-92(72)	25	25	4	300	15	25 30 600	0.8	1	20	50	20			63
2N5356	TO-92(74)	25	25	4	100	25	250 500	0.25	50						63
EN722	TO-106	50	35	5	1000	30	25 30 90	1.5	1.3	45	60	50			63
EN1132	TO-105	50	35	5	1000	30	25 30 90	1.5	1.3	45	60	50			63
EN2905	TO-105	60	40	5	50	50	35 100 300	0.4	1.3	8	150	50		6	63
EN2907	TO-106	60	40	5	50	50	35 100 300	0.4	1.3	8	150	50		6	63
EN2250	TO-106	50	40	5	50	40	40 45 150	0.25	0.9	6	250	10		8	66
EN3502	TO-105	45	45	5	10	30	120 135 140 115 300	0.25	1.3	8	150	50		7 5	63
EN3504	TO-106	45	45	5	10	30	120 135 140 115 300	0.25	1.3	4	150	50		7 5	63

MPS3638	TO-92 (72)	25	25	4		20 30 20	10 50 300	10 1 2	0.25	1.1	50	20	100	50	170	4	63
MPS3638A	TO-92 (72)	25	25	4		80 100 100 20	1 10 10 300	10 10 10 2	0.25 1	1.1 0.8	50 300	10	150	50	170	4	63
MPS3644	TO-92 (72)	45	45	5	35 ICES	40 80 100 100 20	0.1 1 10 150 300	10 10 10 2	0.25 0.4 1	1 1.3 0.8	50 150 300	8	200	20	100	7	63
MPS3645	TO-92 (72)	60	60	5	35 ICES	40 80 100 100 20 115	0.1 1 10 150 300 50	10 1 10 10 2 1	0.25 0.4 1	1 1.3 0.8	50 150 300	8	200	20	100	7	63
MPS3702	TO-92(72)	40	25	5	100	60	300	5	0.25		50	12	100	50			63
MPS3703	TO-92(72)	50	30	5	100	30	150	5	0.25		50	12	100	50			63
MPS6516	TO-92(72)	40	40	4	50	50	100	2	0.5		50	4					66
MPS6517	TO-92(72)	40	40	4	50	90	180	2	0.5		50	4					66
MPS6518	TO-92(72)	40	40	4	500	30	300	2	0.5		50	4					66
MPS6522	TO-92(72)	25	25	4	50	200	400	2	0.5		50	4				3	66
MPS6533	TO-92(72)	40	40	4	50	30	100	1	0.5	1	100	6					63
MPS6534	TO-92(72)	40	40	4	50	25	500	10	0.3	1	100	6					63
MPS6535	TO-92(72)	30	30	4	100	30	100	1	0.5	1.2	100	6					63
NS3905	TO-18	40	40	5	50 (ICES)	30 40 50 30 15	0.1 1 1 1 1	1 1 1 1	0.25 0.4	0.65 0.95	10 50	4.5	200	10	260	8 2	66
NS3906	TO-18	40	40	5	50 (ICES)	60 80 100 60	0.1 1 1 1	1 1 1 1	0.25 0.4	0.65 0.95	10 50	4.5	250	10	300	8 2	66

Test Conditions:

- $I_C = 150 \mu\text{A}$, $V_{CE} = 30\text{V}$, $I_{B1} = I_{B2} = 15 \text{ mA}$
- $I_C = 100 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_G = 1 \text{ k}\Omega$, $BW = 15.7 \text{ kHz}$
- $I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_G = 10 \text{ k}\Omega$, WB
- $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$, $V_{CC} = 10\text{V}$
- $I_C = 30 \mu\text{A}$, $V_{CE} = 15\text{V}$, $R_S = 10 \text{ k}\Omega$, $f = 1 \text{ kHz}$
- $I_C = 150 \text{ mA}$, $I_{B1} = I_{B2} = 15 \text{ mA}$, $V_{CC} = 30\text{V}$
- $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$, $V_{CC} = 5\text{V}$
- $I_C = 10 \text{ mA}$, $I_{B1} = I_{B2} = 1 \text{ mA}$, $V_{CC} = 15\text{V}$
- $I_C = 50 \text{ mA}$, $V_{CC} = 10\text{V}$, $I_{B1} = I_{B2} = 5 \text{ mA}$
- $I_C = 300 \text{ mA}$, $I_{B1} = I_{B2} = 30 \text{ mA}$, $V_{CC} = 15\text{V}$



MEDIUM POWER AMPS

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) @ I _C	h _{FE} Min Max	I _C (mA) & V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min Max	I _C (mA) @ V _{CE(sat)}	C _{ob} (pF) Max	f _T (MHz) Min Max	f _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N4030	TO-39	60	60	5	50	50	30 40 15	0.10 100 1A	0.15 0.5 1.0	0.9 1.1 1.2	150 500 1000	20	100 400	400*		2	67
2N4031	TO-39	80	80	5	50	60	30 40 10	0.1 100 1A	0.15 0.5 1.1	0.9 1.1	150 500	20	100 400	400*		2	67
2N4032	TO-39	60	60	5	50	50	75 100 300	0.1 100 5	0.15 0.5 1.1	0.9 1.1 1.2	150 500 1000	20	150 500	400*		2	67
2N4033	TO-39	80	80	5	50	60	75 100 300	0.1 100 1A	0.15 0.5 1.1	0.9 1.1	150 500	20	150 500	400*		2	67
2N4036	TO-39	90	65	7	100	90	20 20 40 20	200 150 10 500	0.65	1.4	150		60	700		3	67
2N4037	TO-39	60	40	7	250	60	15 50 250	1 150 10	1.4			30	60	50			67
2N4234	TO-39	40	40	7	100 μA	40	10 30 40	1A 250 1	0.6	1.5 1*	1A 250	100	3	100			67
2N4235	TO-39	60	60	7	100 μA	60	20 10 30	500 1A 250	0.6	1.5 1*	1A 250	100	3	100			67
2N4236	TO-39	80	80	7	100 μA	80	10 30 20	1A 250 500	0.6	1.5 1*	1A 250	100	3	100			67
2N4314	TO-39	90	65		250	60	50 15	150 10	1.4	1.5*	150	30	60 200	50			67
2N4354	TO-105	60	60	5	50	50	25 40 50	0.1 1 10	0.15	0.9	150	30	100 500		3	1	67
2N4355	TO-105	60	60	5	50	50	60 100 75	0.1 10 100	0.15	0.9	150	30	100 500		3	1	67

2N4356	TO-105	80	80	5	50	59	25	0.1	10	0.15	0.9	150	30	100	500	50	3	1	67																																		
CS9012	TO-105	25	60	3	100	60	50	10	1	1.0	250	100	30	50	100	50	3	2	60																																		
																				MPSA55	TO-92(72)	60	4	100	50	50	100	1	0.25	100	100	50	100	67																			
																				MPSA56	TO-92(72)	80	4	100	80	50	100	1	0.25	100	100	50	50	100	67																		
																				MPSA354	TO-92(72)	60	5	50	50	25	0.1	10	0.15	150	150	30	100	500	50	400	2	67															
MPS4355	TO-92(72)	60	60	5	50	50	60	1	10	0.15	0.9	150	30	100	500	50	3	2	67																																		
																				MPS4356	TO-92(72)	80	5	50	50	25	0.1	10	0.15	1.1	500	30	100	500	50	3	2	67															
																																							MPS6562	TO-92(72)	80	5	100	20	35	10	1	0.5	500	30	60	10	67

Test Conditions:

1. $I_C = 100 \mu A$, $V_{CE} = 10V$,
 $R_G = 1 k\Omega$, $BW = 1 Hz$
 $f = 1.0 KHz$
2. $V_{CC} = 30V$, $I_C = 500 mA$,
 $I_{B1} = I_{B2} = 50 mA$,
3. $I_C = 150 mA$, $V_{CC} = 30V$
 $I_{B1} = I_{B2} = 15 mA$

(*ts + tf)



DUAL DIFFERENTIAL AMPS

PNP Transistors

Type No.	Case Style	V _{CE0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} (nA) Max	V _{CB} (V)	h _{FE} Min	h _{FE} Max	I _C (mA) @	hFE1 hFE2 (%) Max	V _{BE1} -V _{BE2} (mV) Max	ΔV _{BE1} -V _{BE2} ΔT (μV/°C) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	NF (dB) Max	Test Condition	Process No.	
2N3347	TO-78	60	45	6	10	45	40	300	0.01	10	5	10	6	60	240	4	1	62
2N3348	TO-78	60	45	6	10	45	40	300	0.01	20	10	20	6	60	240	4	1	62
2N3349	TO-78	60	45	6	10	45	40	300	0.01	40	20	40	6	60	240	4	1	62
2N3350	TO-78	60	45	6	10	45	100	300	0.01	10	5	10	6	60	240	4	1	62
2N3351	TO-78	60	45	6	10	45	100	300	0.01	20	10	20	6	60	240	4	1	62
2N3352	TO-78	60	45	6	10	45	100	300	0.01	40	20	40	6	60	240	4	1	62
2N3806	TO-78	60	60	5	10	50	100	450	0.1				4	100	500	7	2	62
							150	450	0.1							3	3	
							150	450	1							4	4	
2N3807	TO-78	60	60	5	10	50	225	900	0.1				4	100	500	4	2	62
							300	900	1							3	3	
							300	900	1							4	4	
2N3808	TO-78	60	60	5	10	50	100	450	0.1	20	8	20	4	100	500	7	6	62
							150	450	0.1		8					3	3	
							150	450	1		8					4	4	
2N3809	TO-78	60	60	5	10	50	225	900	0.1	20	8	20	4	100	500	4	6	62
							300	900	1		8					3	3	
							300	900	1		8					4	4	
2N3810	TO-78	60	60	5	10	50	100	450	0.1	10	5	10	4	100	500	7	6	62
							150	450	1		5					3	3	
							150	450	1		5					4	4	
JAN2N3810	TO-78	60	60	5	10	50	100	450	0.1	10	5	10	5	100	500	7	6	62
							150	450	0.1		5					3	3	
							150	450	0.5		5					4	4	
							150	450	1		5					5	5	
							125	450	10		5					3.5	3.5	
JANTX2N3810	TO-78	60	60	5	10	50	100	450	0.1	10	5	10	5	100	500	7	6	62
							150	450	0.1		5					3	3	
							150	450	0.5		5					4	4	
							150	450	1		5					5	5	
							125	450	10		5					3.5	3.5	
JANTX2N3810	TO-78	60	60	5	10	50	100	450	0.1	10	5	10	5	100	500	7	6	62
							150	450	0.1		5					3	3	
							150	450	0.5		5					4	4	
							150	450	1		5					5	5	
							125	450	10		5					3.5	3.5	

2N3810A	TO-78	60	60	60	5	10	50	100 150 150	0.01 0.1 450 1	5	5 1.5 5	5	4	100 500	7 3 2.5 4 3.5 5	2 3 4 5	62
2N3811	TO-78	60	60	60	5	10	50	225 300 300	0.01 0.1 900 1	10	5 3 5	4	4	100 500	4 2 3 1.5 4 2.5	2 3 4 5	62
JAN2N3811	TO-78	60	60	60	5	10	50	75 225 300 900 0.5 300 900 1 250	0.001 0.01 0.1 0.5 1 10 1	10	5 3	5	5	100 500	4 1.5 1.5 4 2.5	6 3 4 5	62
JANTX2N3811	TO-78	60	60	60	5	10	50	75 225 300 900 0.1 300 900 0.5 300 900 1 250	0.001 0.01 0.1 0.5 1 10 1	10	5 3	5	5	100 500	4 1.5 1.5 4 2.5	6 3 4 5	62
JANTXV2N3811	TO-78	60	60	60	5	10	50	75 225 300 900 0.1 300 900 0.5 300 900 1 250	0.001 0.01 0.1 0.5 1 10 1	10	5 3	5	5	100 500	4 1.5 1.5 4 2.5	6 3 4 5	62
2N3811A	TO-78	60	60	60	5	10	50	225 300 900 1	0.01 0.1 900 1	5	5 1.5 5	5	4	100 500	4 1.5 1.5 4 2.5	2 3 4 5	62
2N4015	TO-78	60	60	60	5	10	50	80 120 135 120	0.01 0.1 350 50	10 10 10	5 5	20 20	8	200 600	4	8	62
2N4016	TO-78	60	60	60	5	10	50	80 120 135 120	0.01 0.1 350 50	10 10 10	2 2	10 10	8	200 600	4	9	62
2N4017	TO-78	80	80	80	6	10	70	100 100 90	0.01 0.1 50	10	2	2	6	40 160	3 10 10	10 11	62
2N4018	TO-78	60	60	60	6	10	50	100 100 90	0.01 0.1 50	10	2	2	6	40 160	3 10 10	10 11	62
2N4019	TO-78	45	45	45	6	10	30	250 250 180	0.01 0.1 50	10	0.1 0.1 50	6	6	50 160	2 4	10 11	62

Test Conditions:

1. $I_E = 10 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $BW = 15.7 kHz$
2. $I_C = 100 \mu A$, $V_{CE} = 5V$,
 $R_G = 3 k\Omega$, $f = 100 Hz$,
 $BW = 20 Hz$
3. $I_C = 100 \mu A$, $V_{CE} = 10V$,
 $R_G = 3 k\Omega$, $f = 1 kHz$,
 $BW = 200 Hz$
4. $I_C = 100 \mu A$, $V_{CE} = 10V$,
 $R_G = 3 k\Omega$, $f = 10 kHz$,
 $BW = 2 kHz$
5. $I_C = 100 \mu A$, $V_{CE} = 10V$,
 $R_G = 3 k\Omega$, $BW = 15.7 kHz$
6. $I_C = 100 \mu A$, $V_{CE} = 10V$,
 $R_G = 3 k\Omega$, $f = 100 Hz$,
 $BW = 20 Hz$
7. $I_C = 30 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 2 kHz$,
 $BW = 200 Hz$
8. $I_C = 30 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 1 kHz$,
 $BW = 200 Hz$
9. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 1 kHz$,
 $BW = 150 Hz$
10. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 100 Hz$,
 $BW = 15 Hz$
11. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $R_G = 10 k\Omega$, $f = 100 Hz$,
 $BW = 15 Hz$



DUAL DIFFERENTIAL AMPS (Cont.)

PNP Transistors

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EB0} (V) Min	I _{CB0} (nA) Max	V _{CB} (V) Max	h _{FE} Min	I _C (mA) @ Max	h _{FE1} (%) Max	h _{FE2} (%) Max	V _{BE1} -V _{BE2} (mV) Max	ΔV _{BE1} -V _{BE2} (μV/°C) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	NF (dB) Max	Test Condition	Process No.
2N4020	TO-78	45	45	6	10	30	250 250 250	500 550 600	20	20	5 10	20	6	50	160	4 2	10 11	62
2N4021	TO-78	60	60	6	10	50	100 100 100	350 400 500	20	20	5 10	20	6	40	160	10 3	10 11	62
2N4023	TO-78	45	45	6	10	30	250 250 250	500 550 600	10	10	3 5	10	6	50	160	4 2	11 10	62
2N4024	TO-78	60	60	6	10	50	100 100 100	350 400 500	10	10	3 5	10	6	40	160	10 3	11 10	62

Test Conditions:

- I_E = 10 μA, V_{CE} = 5V,
R_G = 10 kΩ, BW = 15.7 kHz
- I_C = 100 μA, V_{CE} = 5V,
R_G = 3 kΩ, f = 100 Hz,
BW = 20 Hz
- I_C = 100 μA, V_{CE} = 10V,
R_G = 3 kΩ, f = 1 kHz,
BW = 200 Hz
- I_C = 100 μA, V_{CE} = 10V,
R_G = 3 kΩ, f = 10 kHz,
BW = 2 kHz
- I_C = 100 μA, V_{CE} = 10V,
R_G = 3 kΩ, BW = 15.7 kHz
- I_C = 100 μA, V_{CE} = 10V,
R_G = 3 kΩ, f = 100 Hz,
BW = 20 Hz
- I_C = 30 μA, V_{CE} = 5V,
R_G = 10 kΩ, f = 2 kHz,
BW = 200 Hz
- I_C = 30 μA, V_{CE} = 5V,
R_G = 10 kΩ, f = 1 kHz,
BW = 200 Hz
- I_C = 20 μA, V_{CE} = 5V,
R_G = 10 kΩ, f = 1 kHz,
BW = 150 Hz
- I_C = 20 μA, V_{CE} = 5V,
R_G = 10 kΩ, f = 100 Hz,
BW = 15 Hz
- I_C = 20 μA, V_{CE} = 5V,
R_G = 10 kΩ, f = 100 Hz,
BW = 15 Hz



SWITCHES

N-Channel FETs

Type No.	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G Min	I _{GSS} *I _{DGO} (nA) @ V _{DG} Max	I _{D(off)} V _{GS} (nA) @ (V) Max	V _D V _{DS} (V) @ (V) Min Max	I _D (nA)	I _{DSS} (mA) @ V _{DS} Min Max	r _{dd(on)} (Ω) @ I _D Max (mA)	C _{iss} (pF) @ V _{DS} (V)	V _{GS} (V)	C _{rss} (pF) @ V _{DS} (V)	V _{GS} (V)	t _{on} (ns) Max	t _{off} (ns) Max	Process No.				
2N3824	TO-72	50	0.1	30	0.1	15	-8	8	15	.1	6	15	0	3	0	-8	55		
2N3966	TO-72	30	1	0.1	20	1	10	-7	4	6	10	10	10	2	20	0	50		
2N3970	TO-18	40	1	0.25*	20	0.25	20	-12	4	10	20	1	25	20	0	6	0	50	
2N3971	TO-18	40	1	0.25*	20	0.25	20	12	2	5	20	1	60	1	25	0	51		
2N3972	TO-18	40	1	0.25*	20	0.25	20	-12	0.5	3	20	1	25	20	0	6	0	51	
2N4091	TO-18	40	1	0.2*	20	0.2	20	-12	5	10	20	1	30	20	0	5	0	51	
2N4092	TO-18	40	1	0.2*	20	0.2	20	-8	2	7	20	1	16	20	0	5	0	51	
2N4093	TO-18	40	1	0.2*	20	0.2	20	-6	1	5	20	1	16	20	0	5	0	51	
2N4391	TO-18	40	1	0.1	20	0.1	20	-12	4	10	20	1	50	20	0	3.5	0	51	
2N4392	TO-18	40	1	0.1	20	0.1	20	-7	2	5	20	1	14	20	0	3.5	0	51	
2N4393	TO-18	40	1	0.1	20	0.1	20	-5	0.5	3	20	1	14	20	0	3.5	0	51	
2N4856	TO-18	40	1	0.25	20	0.25	15	-10	4	10	15	5	18	0	8	0	51		
2N4856A	TO-18	40	1	0.25	20	0.25	15	-10	4	10	15	5	18	0	8	0	51		
2N4857	TO-18	40	1	0.25	20	0.25	15	-10	2	6	15	5	18	0	8	0	51		
2N4857A	TO-18	40	1	0.25	20	0.25	15	-10	2	6	15	5	18	0	8	0	51		
2N4858	TO-18	40	1	0.25	20	0.25	15	-10	0.8	4	15	5	18	0	8	0	51		
2N4858A	TO-18	40	1	0.25	20	0.25	15	-10	0.8	4	15	5	18	0	8	0	51		
2N4859	TO-18	30	1	0.25	15	0.25	15	-10	4	10	15	5	18	0	8	0	51		
2N4859A	TO-18	30	1	0.25	15	0.25	15	-10	4	10	15	5	18	0	8	0	51		
2N4860	TO-18	30	1	0.25	15	0.25	15	-10	2	6	15	5	18	0	8	0	51		
2N4860A	TO-18	30	1	0.25	15	0.25	15	-10	2	6	15	5	18	0	8	0	51		
2N4861	TO-18	30	1	0.25	15	0.25	15	-10	0.8	4	15	5	18	0	8	0	51		
2N4861A	TO-18	30	1	0.25	15	0.25	15	-10	0.8	4	15	5	18	0	8	0	51		
2N5432	TO-52	25	1	0.2	15	0.2	5	-10	4	10	5	3	150	5	10	30	0	58	
2N5433	TO-52	25	1	0.2	15	0.2	5	-10	3	9	5	3	100	7	10	30	0	58	
2N5434	TO-52	25	1	0.2	15	0.2	5	-10	1	4	5	3	10	10	30	0	58		
2N5555	TO-92	25	10	1	15	10	12	-10	15	15	0	1.2	0	5	15	0	50		
2N5638	TO-92	30	10	1	15	1	15	-12	50	20	0	12	4	0	0	-12	51		
2N5639	TO-92	30	10	1	15	1	15	-8	25	20	0	12	4	0	0	-8	51		
2N5640	TO-92	30	10	1	15	1	15	-6	5	20	100	1	10	0	0	-6	51		
2N5653	TO-92	30	10	1	15	1	15	-12	40	20	50	1	10	0	0	-12	51		
2N5654	TO-92	25	10	1	15	10	15	-8	15	20	100	1	10	0	0	-8	51		
E109	TO-106	25	1	3	15	3	5	-10	2	6	5	10	0	15	0	-10	58		
KE4091	TO-106	40	1	1*	20	1	20	-12	5	10	20	1	30	20	0	5	20	0	51
KE4092	TO-106	40	1	1*	20	1	20	-8	2	7	20	1	16	20	0	5	20	0	51
KE4093	TO-106	40	1	1*	20	1	20	-6	1	5	20	1	16	20	0	5	20	0	51



SWITCHES (Cont.)

N-Channel FETs

Type No.	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G Min	I _{GSS} *I _{DGO} (nA) @ V _{DG} Max (V)	I _{D(off)} @ V _{DG} (nA) (V)	V _p (V) @ V _{DG} Min Max	I _D (nA)	I _{DSS} (mA) @ V _{DG} Min Max	r _{ds(on)} (Ω) @ I _D Max (mA)	C _{iss} (pF) @ V _{DG} Max (V)	V _{GS} (V)	C _{oss} (pF) @ V _{DG} Max (V)	V _{GS} (V)	t _{on} (ns) Max	t _{off} (ns) Max	Process No.
KE4391	TO-106	40	1	20	4	1	50	30	14	20	0	-12	20	35	51
KE4392	TO-106	40	1	20	2	1	25	60	14	20	0	-7	40	80	51
KE4393	TO-106	40	1	20	0.5	3	5	100	14	20	0	-5	55	130	51
KE4856	TO-106	40	1	20	4	10	50	25	18	0	-10	8	9	25	51
KE4857	TO-106	40	1	15	2	6	20	40	18	0	-10	0	10	50	51
KE4858	TO-106	40	1	15	0.8	4	8	60	18	0	-10	0	10	100	51
KE4859	TO-106	30	1	15	4	10	50	25	18	0	-10	0	9	25	51
KE4860	TO-106	30	1	15	2	6	20	40	18	0	-10	0	10	50	51
KE4861	TO-106	30	1	15	0.8	4	8	60	18	0	-10	0	10	100	51
NF510	TO-18	30	1	10	0.5	10	5	100	18	0	-10	0	20	100	51
NF580	TO-52	25	1	15	4	12	5	5	25	0	-15	13	5	25	58
NF581	TO-52	25	1	15	4	10	5	6	10	25	0	-15	5	25	58
NF582	TO-52	25	1	15	2	6	5	10	25	0	-15	13	5	25	58
NF583	TO-52	25	1	15	0.5	4	3	20	20	0	-15	13	5	25	58
NF584	TO-52	15	1	50	10	5	3	10	25	0	-15	13	10	25	58
NF585	TO-52	15	1	50	6	5	3	20	20	0	-15	13	5	25	58
NF4445	TO-52	25	1	3*	2	10	5	5	50	0	-10	25	0	10	58
NF4446	TO-52	25	1	3*	2	10	5	10	50	0	-10	25	0	10	58
NF4447	TO-52	20	1	3*	2	10	5	6	50	0	-10	25	0	10	58
NF4448	TO-52	20	1	3*	2	10	5	12	50	0	-10	25	0	10	58
NF5555	TO-72	25	10	1	12	-10	15	150	5	15	0	-10	10	25	50
NF5638	TO-18	30	10	1	15	-12	50	30	10	0	-12	4	0	12	51
NF5639	TO-18	30	10	1	15	-8	25	60	10	0	-12	4	0	12	51
NF5640	TO-18	30	10	1	15	-6	5	100	10	0	-12	4	0	12	51
NF5653	TO-18	30	10	1	15	-12	40	50	10	0	-12	3.5	0	15	51
NF5654	TO-18	30	10	1	15	-8	15	100	10	0	-12	3.5	0	15	51
TI573	TO-106	30	1	2	15	-10	4	25	18	0	-10	8	14	30	51
TI574	TO-106	30	1	2	15	-10	2	40	18	0	-10	8	9	25	51
TI575	TO-106	30	1	2	15	-10	2	60	18	0	-10	8	10	50	51
U1897E	TO-106	40	1	0.2*	5	10	20	30	16	20	0	5	20	40	51
U1898E	TO-106	40	1	0.2*	2	7	20	50	16	20	0	5	35	60	51
U1899E	TO-106	40	1	0.2*	1	5	20	80	16	20	0	5	60	80	51
UC250	TO-18	30	1	1	5	10	20	30	25	20	0	7	10	0	51
UC251	TO-18	30	1	1	1	6	20	75	25	20	0	7	10	0	51



RF AMPS

N-Channel FETs

Type No.	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G (μ A)	I _{GSS} *ID _{GO} (nA) @ V _{DG} (V)	V _p @ V _{DG} (V)	I _D (nA)	I _{DSS} @ V _{DG} (mA)	R _e Y _{f_s} (m Ω) @ Freq (MHz)	R _e (Y _{g_s}) (μ Whol) @ f (MHz)	C _{iss} (pF) @ V _{DG} (V)	V _{GS} (V)	C _{iss} (pF) @ V _{DG} (V)	V _{GS} (V)	(dB) @ R _G = 1k Freq (MHz)	Process No.
		Min Max	Min Max	Min Max	Min Max	Min Max	Min	Max	Max	Max	Max	Max	Max	
2N3819	TO-106	25 1	2 15	8 15 2	2 20 15	2 20 15	1.6	100	8 15 0	4 15 0	4 15 0	0	50	
2N3823	TO-72	30 1	0.5 20	8 15 5	4 20 15	4 20 15	3.2	200	6 15 0	2 15 0	2 15 0	0	50	
2N4223	TO-72	30 10	0.25 20	0.1 8 15 .25	3 18 15	3 18 15	2.7	200	6 15 0	2 15 0	2 15 0	0	50	
2N4224	TO-72	30 10	0.5 20	0.1 8 15 .5	2 20 15	2 20 15	1.7	200	6 15 0	2 15 0	2 15 0	0	50	
2N4416	TO-72	30 1	0.1 20	6 15 1	5 15 15	4 400	4	400	100 400	4 15 0	0.8 15 0	4	400	
2N4416A	TO-72	30 1	0.1 20	2.5 6 15 1	5 15 15	4 400	4	400	100 400	4 15 0	0.8 15 0	4	400	
2N5078	TO-72	30 1	0.25 20	0.5 8 15 1000	4 25 15	4 200	4	200	150 200	6 15 0	2 15 0	3	200	
2N5245	TO-106	30 1	1 20	1 6 15 10	5 15 15	4 400	4	400	100 400	4.5 15 0	1 15 0	4	400	
2N5246	TO-106	30 1	1 20	0.5 4 15 10	1.5 7 15 2.5	400	100	400	100 400	4.5 15 0	1 15 0	0	50	
2N5247	TO-106	30 1	1 20	1.5 8 15 10	8 24 15	4 400	150	400	100 400	4.5 15 0	1 15 0	0	50	
2N5248	TO-92	30 1	5 20	1 8 15 10	4 20 15	3 200	200	200	200 400	6 15 0	2 15 0	0	50	
2N5484	TO-92	25 1	1 20	0.3 3 15 10	1 5 15 2.5	100	75	100	5 15 0	1 15 0	1 15 0	3	100	
2N5485	TO-92	25 1	1 20	1 4 15 10	4 10 15	3 400	100	400	5 15 0	1 15 0	1 15 0	4	400	
2N5486	TO-92	25 1	1 20	2 6 15 10	8 20 15	3 5	400	400	5 15 0	1 15 0	1 15 0	4	400	
2N5668	TO-92	25 10	2 15	0.2 4 15 10	1 5 15 1	100	50	100	50 100	7 15 0	3 15 0	2.5	100	
2N5669	TO-92	25 10	2 15	1 6 15 10	4 8 15 1.6	100	100	100	7 15 0	3 15 0	3 15 0	2.5	100	
2N5670	TO-92	25 10	2 15	2 8 15 10	8 20 15 2.5	100	150	100	7 15 0	3 15 0	3 15 0	2.5	100	
BF256A	TO-106	30 1	5 20	0.5 7.5 15 1000	3 7 15 4.5	1	4.5	1	1.2 15 0	0.7 20 -1	0.7 20 -1	7.0	800	
BF256B	TO-106	30 1	5 20	0.5 7.5 15 1000	6 13 15 4.5	1	4.5	1	1.2 15 0	0.7 20 -1	0.7 20 -1	7.0	800	
BF256C	TO-106	30 1	5 20	0.5 7.5 15 1000	11 18 15 4.5	1	4.5	1	1.2 15 0	0.7 20 -1	0.7 20 -1	7.0	800	
KE4223	TO-106	30 1	1 20	0.1 8 15 1	3 18 15 2.7	200	200	200	6 15 0	2 15 0	2 15 0	5	200	
KE4224	TO-106	30 1	1 20	0.1 8 15 .5	2 20 15 1.7	200	200	200	6 15 0	2 15 0	2 15 0	4	400	
KE4416	TO-106	30 1	1 20	6 15 1	5 15 15 4	400	100	400	4 15 0	0.8 15 0	0.8 15 0	4	400	
MPF102	TO-92	25 1	2 15	8 15 2	2 20 15 1.6	100	100	100	7 15 0	3 15 0	3 15 0	4	400	
MPF106	TO-92	25 1	1 20	0.5 4 15 .5	4 10 15 2.5	0.001	0.001	0.001	5 15 0	2 15 0	2 15 0	4	400	
MPF107	TO-92	25 1	1 20	2 6 15 5	8 20 15 4	0.001	0.001	0.001	5 15 0	2 15 0	2 15 0	4	400	
MPF108	TO-92	25 10	1 15	0.5 8 15 10 μ	1.5 24 15 1.6	100	200	100	6.5 15 0	2.5 15 0	2.5 15 0	3	100	
NF500	TO-72	25 10	10 20	8 15 10	1 30 15								50	
NF501	TO-72	15 10	50 10	8 10 1000	1 30 10								50	
NF506	TO-72	25 1	1 20	0.5 5 15 5000	4 15 15 2.5	0.001	0.001	0.001	4 15 0	1 15 0	1 15 0	2	100	
NF5485	TO-72	25 1	1 20	1 4 15 10	4 10 15 3	400	100	400	5 15 -10	1 15 -10	1 15 -10	4	400	
NF5486	TO-72	25 1	1 20	2 6 15 10	8 20 15 3.5	400	100	400	5 15 0	1 15 0	1 15 0	4	400	
TI534	TO-106	30 1	5 20	1 8 15 10	4 20 15 3	200	200	200	6 15 0	2 15 0	2 15 0	4	50	
TI588	TO-106	30 1	1 20	1 6 15 10	5 15 15 4	400	100	400	4.5 15 0	1 15 0	1 15 0	4	50	
UC734	TO-72	30 1	5 20	1 8 15 10	4 20 15 3	200	200	200	4 15 0	0.8 15 0	0.8 15 0	4	50	
UC734E	TO-106	30 1	5 20	1 8 15 10	4 20 15 3	200	200	200	4.5 15 0	1 15 0	1 15 0	4	50	



N-Channel FETs

LOW NOISE AMPS

Transistor Type	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G Min (μA)	IGSS *IDGO (nA) @ V _{DG} Max (V)	V _p (V) @ V _{Ds} Min Max	I _D (nA)	I _{DSS} (mA) @ V _{Ds} Min Max	G _{fs} (mMho) @ V _{Ds} Min Max	G _{oss} (μMho) @ V _{Ds} Max	C _{iss} (pF) @ V _{Ds} Max	V _{Gs} (V)	C _{rss} (pF) @ V _{Ds} Max	V _{Gs} (V)	f_{in} ($\frac{NV}{\sqrt{Hz}}$) @ f Max (Hz)	Process No.						
2N3089	TO-18	15	1	1	5	15	100	0.5	2	10	6	15	0	2	15	0	125 avg 10-15 k	52		
2N3089A	TO-18	15	1	1	5	15	100	0.5	2	10	6	15	0	2	15	0	45 avg 10-15 k	52		
2N3459	TO-18	50*	0.25	30	3.4	20	1000	0.8	4	20	18	0	-6	5	30	0	155	20	52	
2N3460	TO-18	50*	0.25	30	1.8	20	1000	0.2	1	20	18	0	-4	5	30	0	155	20	52	
2N4338	TO-18	50	0.1	30	0.3	1	15	0.2	0.6	15	7	15	0	3	15	0	70	1000	52	
2N4339	TO-18	50	0.1	30	0.6	1.8	15	0.5	1.5	15	7	15	0	3	15	0	70	1000	52	
2N4340	TO-18	50	0.1	30	1	3	15	1.2	3.6	15	7	15	0	3	15	0	70	1000	52	
2N4341	TO-18	50	0.1	30	2	6	15	3	9	15	7	15	0	3	15	0	70	1000	52	
2N4867	TO-72	40	0.25	30	0.7	2	20	1000	0.4	1.2	20	25	20	0	5	20	0	20	10	57
2N4867A	TO-72	40	0.25	30	0.7	2	20	1000	0.4	1.2	20	25	20	0	5	20	0	10	10	57
2N4868	TO-72	40	0.25	30	1	3	20	1000	1	3	20	25	20	0	5	20	0	20	10	57
2N4868A	TO-72	40	0.25	30	1	3	20	1000	1	3	20	25	20	0	5	20	0	10	10	57
2N4869	TO-72	40	0.25	30	1.8	5	20	1000	2.5	7.5	20	25	20	0	5	20	0	20	10	57
2N4869A	TO-72	40	0.25	30	1.8	5	20	1000	2.5	7.5	20	25	20	0	5	20	0	20	10	57
KE3684	TO-106	50	1	35	2	5	20	1	2.5	7.5	20	4	20	0	1.2	20	0	150	20	52
KE3685	TO-106	50	1	30	1	3.5	20	1	3	20	4	20	0	1.2	20	0	150	20	52	
KE3686	TO-106	50	1	30	0.6	2	20	1	0.4	1.2	20	4	20	0	1.2	20	0	150	20	52
KE3687	TO-106	50	1	30	0.3	1.2	20	1	0.1	0.5	20	4	20	0	1.2	20	0	150	20	52



N-Channel FETs

ULTRA-LOW INPUT CURRENT AMPS

Transistor Type	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G Min (μA)	IGSS *IDGO (pA) @ V _{DG} Max (V)	V _p (V) @ V _{Ds} Min Max	I _D (nA)	I _{DSS} (μA) @ V _{Ds} Min Max	G _{fs} (μMho) @ V _{Ds} Min Max	G _{oss} (μMho) @ V _{Ds} Max	C _{iss} (pF) @ V _{Ds} Max	V _{Gs} (V)	C _{rss} (pF) @ V _{Ds} Max	V _{Gs} (V)	f_{in} ($\frac{NV}{\sqrt{Hz}}$) @ f Max (Hz)	Process No.								
2N4117	TO-72	40	1	10	20	0.6	1.8	10	1	30	90	10	3	10	3	10	0	1.5	10	0	53	
2N4117A	TO-72	40	1	1	20	0.6	1.8	10	1	30	90	10	3	10	3	10	0	1.5	10	0	53	
2N4118	TO-72	40	1	10	20	1	3	10	1	80	240	10	5	10	3	10	0	1.5	10	0	53	
2N4118A	TO-72	40	1	1	20	1	3	10	1	80	240	10	5	10	3	10	0	1.5	10	0	53	
2N4119	TO-72	40	1	10	20	2	6	10	1	200	600	10	10	3	10	3	10	0	1.5	10	0	53
2N4119A	TO-72	40	1	1	20	2	6	10	1	200	600	10	10	3	10	3	10	0	1.5	10	0	53



GENERAL PURPOSE AMPS

N-Channel FETs

Transistor Type	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G (μA)	I _{GSS} *I _{DGO} (nA) @ V _{DG} (V)	V _P @ V _{DS} (V)	I _D (nA)	I _{DSS} (mA) @ V _{DS} (V)	G _{fs} (mMhol) @ V _{DS} (V)	G _{oss} (μMhol) @ V _{DS} (V)	C _{iss} (pF) @ V _{DS} (V)	V _{GS} (V)	C _{rss} (pF) @ V _{DS} (V)	V _{GS} (V)	$\frac{e_n}{\sqrt{Hz}}$ @ Freq (NV/√Hz) @ Freq (Hz)	Process No.													
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max														
2N3069	TO-18	*50	1	30	9.5	30	1	2.5	30	15	0	-12	1.5	30	0	125	1000	52									
2N3070	TO-18	*50	1	30	4.5	30	1000	0.75	2.5	30	30	15	0	-8	1.5	30	0	125	1000	52							
2N3071	TO-18	*50	1	30	2.2	30	1000	0.75	2.5	30	30	15	0	-8	1.5	30	0	125	1000	52							
2N3365	TO-18	*40	1	5	11.5	20	1000	0.4	2	30	50	30	15	8	0	2.5	30	0	125	1000	52						
2N3367	TO-18	*40	1	5	2.2	20	1000	0.05	0.25	30	10	30	15	8	0	2.5	30	0	125	1000	52						
2N3368	TO-18	*40	1	5	11.5	20	1000	2	12	30	80	30	20	8	0	3	30	0	125	1000	53						
2N3369	TO-18	*40	1	5	6.5	20	1000	0.5	2.5	30	30	30	20	8	0	3	30	0	125	1000	52						
2N3436	TO-18	*50	1	5	3.2	20	1000	0.1	0.6	30	15	30	20	8	0	3	30	0	125	1000	52						
2N3437	TO-18	*50	1	5	9.8	20	1000	3	15	20	35	30	18	0	-10	6	30	0	125	1000	55						
2N3438	TO-18	*50	1	5	3.2	20	1000	0.2	1	20	20	30	18	0	-6	6	30	0	125	1000	55						
2N3452	TO-72	*50	1	0.1	9.8	20	1000	0.8	4	30	5	30	18	0	-4	6	30	0	125	1000	55						
2N3453	TO-72	*50	1	0.1	4.8	20	1000	0.2	1	30	6	0	-12	1.5	30	0	100	1000	53								
2N3454	TO-72	*50	1	0.1	2.3	20	1000	0.05	0.25	30	5	30	6	0	-8	1.5	30	0	100	1000	53						
2N3455	TO-72	*50	1	0.4	9.8	20	1000	0.8	4	30	5	30	5	0	-12	1.5	30	0	100	1000	53						
2N3456	TO-72	*50	1	0.4	4.8	20	1000	0.2	1	30	3	30	6	0	-4	1.5	30	0	100	1000	53						
2N3457	TO-72	*50	1	0.4	2.3	20	1000	0.05	0.25	30	3	30	5	0	-4	1.5	30	0	100	1000	53						
2N3458	TO-18	*50	1	0.25	7.8	20	1000	3	15	20	35	30	18	0	-10	5	30	0	100	1000	55						
2N3459	TO-18	*50	1	0.25	3.4	20	1000	0.8	4	20	20	30	18	0	-6	5	30	0	100	1000	55						
2N3460	TO-18	*50	1	0.25	1.8	20	1000	0.2	1	20	5	30	18	0	-4	5	30	0	100	1000	52						
2N3684	TO-72	50	1	0.1	3.5	20	1	2.5	7.5	20	2	3	20	4	20	0	1.2	20	0	150	1000	52					
2N3686	TO-72	50	1	0.1	0.6	2	20	1	0.4	1.2	20	1	2	20	4	20	0	1.2	20	0	150	1000	52				
2N3687	TO-72	50	1	0.1	0.3	1.2	20	1	0.1	0.5	20	5	20	4	20	0	1.2	20	0	150	1000	52					
2N3821	TO-72	50	1	0.1	4	15	.5	0.5	2.5	15	10	15	6	15	0	3	15	0	200	10	55						
2N3822	TO-72	50	1	0.1	6	15	.5	2	10	15	3	6.5	15	20	15	6	15	0	200	10	55						
2N3967	TO-72	30	1	0.1	2	5	20	1	2.5	10	20	2.5	2.5	20	35	20*	5	20	†	84	100	50					
2N3967A	TO-72	30	1	0.1	2	5	20	1	2.5	10	20	2.5	2.5	20	35	20*	5	20	†	84	100	50					
2N3968	TO-72	30	1	0.1	3	20	1	1	5	20	2	2	20	15	20**	5	20	†	84	100	50						
2N3968A	TO-72	30	1	0.1	3	20	1	1	5	20	2	2	20	15	20**	5	20	†	84	100	50						
2N3969	TO-72	30	1	0.1	1.7	20	1	0.4	2	20	5	20††	5	20††	5	20††	5	20	†	84	100	50					
2N3969A	TO-72	30	1	0.1	1.7	20	1	0.4	2	20	5	20††	5	20††	5	20††	5	20	†	84	100	50					
2N4139	TO-18	50	1	1	2	8	20	1	8	11	20	3.5	7	20	35	20	18	20	0	5	20	0	100	1000	55		
2N4220	TO-72	30	10	0.1	4	15	1	0.5	3	15	1	4	15	10	15	6	15	0	2	15	0	2	15	0	100	1000	52

*I_D = 1 mA I_{1D} = 500μA †I_D = 250μA ††I_D = 200μA †††I_D = 100μA



N-Channel FETs

GENERAL PURPOSE AMPS (Cont.)

Transistor Type	Case Style	BV _{GSD} (V) @ I _G	I _{GSS} *I _{DGO} (nA) @ V _{DG}	V _p (V) @ V _{DS}	I _{DSS} (mA) @ V _{DS}	G _f (mMho) @ V _{DS}	G _{oss} (μMho) V _{DS}	C _{iss} (pF) @ V _{DS}	C _{iss} V _{GS} (pF) @ V _{DS}	\bar{e}_n (nV/√Hz) @ Freq Max	Process No.											
		Min Max	Max	Min Max	Min Max	Min Max	Max	Max	Max													
2N4220A	TO-72	30	10	4	0.5	3	15	1	4	15	10	15	6	15	0	2	15	0	115	100	52	
2N4221	TO-72	30	10	6	15	1	2	6	15	15	20	15	6	15	0	2	15	0	115	100	55	
2N4221A	TO-72	30	10	6	15	1	2	6	15	15	20	15	6	15	0	2	15	0	115	100	55	
2N4222	TO-72	30	10	8	15	1	5	15	15	15	25	6	15	0	2	15	0	115	100	55		
2N4222A	TO-72	30	10	8	15	1	5	15	15	15	25	6	15	0	2	15	0	115	100	55		
2N4222A	TO-72	30	10	8	15	1	5	15	15	15	25	6	15	0	2	15	0	115	100	55		
2N4302	TO-106	30	1	1	10	4	20	10	0.5	5	20	1	1	20	0	3	20	0	100	1000	52	
2N4303	TO-106	30	1	1	10	4	10	20	4	10	20	2	2	20	0	3	20	0	100	1000	52	
2N4304	TO-106	30	1	1	10	20	10	0.5	15	20	1	1	20	0	3	20	0	125	1000	52		
2N4338	TO-18	50	1	0.1	30	0.2	0.6	15	0.6	1.8	15	5	15	7	15	0	3	15	0	68	1000	52
2N4339	TO-18	50	1	0.1	30	0.6	1.8	15	0.5	1.5	15	15	15	7	15	0	3	15	0	68	1000	52
2N4340	TO-18	50	1	0.1	30	1	3	15	100	1.2	3.6	15	1.3	3	15	0	3	15	0	68	1000	52
2N4341	TO-18	50	1	0.1	30	2	6	15	100	3	9	15	2	4	15	0	3	15	0	68	1000	52
2N5103	TO-72	25	10	0.1	15	0.5	4	15	1	8	15	2	8	15	0	1	15	0	100	10	50	
2N5104	TO-72	25	1	0.1	15	0.5	4	15	1	2	6	15	3.5	7.5	15	0	1	15	0	50	10	50
2N5163	TO-106	25	1	10	15	0.4	8	15	1000	1	40	15	2	9	15	0	3	15	0	50	1000	50
2N5358	TO-72	40	1	0.1	20	0.5	3	15	100	0.5	1	15	1	3	15	0	2	15	0	115	100	52
2N5359	TO-72	40	1	0.1	20	0.8	4	15	100	0.6	1.6	15	1.2	3.6	15	0	2	15	0	115	100	52
2N5360	TO-72	40	1	0.1	20	0.8	4	15	100	0.5	2.5	15	1.4	4.2	15	0	2	15	0	115	100	52
2N5361	TO-72	40	1	0.1	20	1	6	15	100	2.5	5	15	1.5	4.5	15	0	2	15	0	115	100	55
2N5362	TO-72	40	1	0.1	20	2	7	15	100	4	8	15	2	5.5	15	0	2	15	0	115	100	55
2N5363	TO-72	40	1	0.1	20	2.5	8	15	100	7	14	15	2.5	6	15	0	2	15	0	115	100	55
2N5364	TO-72	40	1	0.1	20	2.5	8	15	100	9	18	15	2.7	6.5	15	0	2	15	0	115	100	55
2N5457	TO-92	25	1	1	15	0.5	6	15	10	1	5	15	2	5	15	0	3	15	0	115	100	55
2N5458	TO-92	25	1	1	15	1	7	15	10	2	9	15	1.5	5.5	15	0	3	15	0	115	100	55
2N5459	TO-92	25	1	1	15	2	8	15	10	4	16	15	2	6	15	0	3	15	0	115	100	55
2N5556	TO-72	30	1	0.1	15	0.2	4	15	1	0.5	2.5	15	1.5	6.5	15	0	3	15	0	35	10	50
2N5557	TO-72	30	1	0.1	15	0.2	4	15	1	0.5	2.5	15	1.5	6.5	15	0	3	15	0	35	10	50
2N5558	TO-72	30	1	0.1	15	0.8	5	15	1	2	5	15	1.5	6.5	15	0	3	15	0	35	10	50
2N5716	TO-92	40	10	1	20	0.2	3	15	1	0.05	0.25	15	0.2	1	15	0	1.5	15	0	52(172)		52
2N5717	TO-92	40	10	1	20	0.5	5	15	1	0.2	1	15	0.4	1.6	15	0	1.5	15	0	52		52
2N5718	TO-92	40	10	1	20	1	8	15	1	0.8	4	15	0.5	2	15	0	1.5	15	0	52		52
E 100	TO-106	30	1	0.5	20	0.3	10	20	10	0.2	20	20	0.5	0.5	20	0	3	20	0	52		52
E101	TO-106	30	1	0.5	20	0.3	1.5	20	10	0.2	1	20	0.5	0.5	20	0	3	20	0	52		52
E102	TO-106	30	1	0.5	20	0.8	4	20	10	0.9	4.5	20	1	1	20	0	3	20	0	52		52
E103	TO-106	30	1	0.5	20	2	10	20	10	4	20	20	1.5	1.5	20	0	3	20	0	52		52
KE3884	TO-106	50	1	1	30	2	5	20	1	2.5	7.5	20	2	3	20	0	1.2	20	0	150	20	52

KE3685	TO-106	50	1	30	1	3.5	20	1	1	3	20	1.5	2.5	20	25	20	4	20	0	1.2	20	0	150	20	52
KE3686	TO-106	50	1	30	0.6	2	20	1	0.4	1.2	20	1	2	20	10	20	4	20	0	1.2	20	0	150	20	52
KE3687	TO-106	50	1	30	0.3	1.2	20	1	0.1	0.5	20	0.5	1.5	20	5	20	4	20	0	1.2	20	0	150	20	52
KE4220	TO-106	30	10	15	4	15	1	15	0.5	3	15	1	4	15	10	15	6	15	0	2	15	0			55
KE4221	TO-106	30	10	15	6	15	1	15	2	6	15	2	5	15	20	15	6	15	0	2	15	0			55
KE4222	TO-106	30	10	15	8	15	1	15	5	15	15	2.5	6	15	40	15	6	15	0	2	15	0			55
MPF103	TO-92	25	1	15	6	15	1	15	1	5	15	1	5	15	50	15	7	15	0	3	15	0			55
MPF104	TO-92	25	1	15	7	15	1	15	2	9	15	1.5	5.5	15	50	15	7	15	0	3	15	0			55
MPF105	TO-92	25	1	15	8	15	1	15	4	16	15	2	6	15	50	15	7	15	0	3	15	0			55
MPF109	TO-92	25	10	15	0.2	8	15	10	0.5	24	15	0.8	6	15	75	15	7	15	0	3	15	0	115	1000	55
MPF110	TO-92	20	10	100	0.5	10	10	1000	0.5	20	10	0.5	7.5	10	200	10									50
MPF111	TO-92	20	10	100	0.5	10	10	1000	0.5	20	10	0.5	0.5	10	200	10									50
MPF112	TO-92	25	10	100	0.5	10	10	1000	1	25	10	1	7.5	10											55
NF520	TO-72	30	10	15	8	15	10	10	1	10	15	0.5	0.5	15	20	50	6	20	0	3	20	0	100	1000	52
NF521	TO-72	30	10	15	8	15	10	0.1	2	15	0.4	0.4	15	15	4	0	4	0	-15	1.2	0	-15	65	1000	52
NF530	TO-18	30	10	15	8	15	10	1	10	15	0.5	0.5	15	15	4	0	4	0	-15	1.2	0	-15	65	1000	52
NF531	TO-18	30	10	15	8	15	10	0.1	2	15	0.4	0.4	15	15	4	0	4	0	-15	1.2	0	-15	65	1000	52
NF4302	TO-18	30	1	10	4	20	10	0.5	5	20	1	1	20	1	20	50	6	20	0	3	20	0	100	1000	52
NF4303	TO-18	30	1	10	6	20	10	4	10	20	1	2	20	2	20	50	6	20	0	3	20	0	100	1000	52
NF4304	TO-18	30	1	10	10	10	20	10	0.5	15	20	1	1	20	50	20	6	20	0	3	20	0	125	1000	52
NF5163	TO-72	25	1	10	0.4	8	15	1000	1	40	15	2	9	15	200	15	12	15	0	3	15	0	50	1000	50
NF5457	TO-18	25	1	15	0.5	6	15	10	1	5	15	1	5	15	50	15	7	15	0	3	15	0			55
NF5458	TO-18	25	1	15	1	7	15	10	2	9	15	1.5	5.5	15	50	15	7	15	0	3	15	0			55
NF5459	TO-18	25	1	15	2	8	15	10	4	16	15	2	6	15	50	15	7	15	0	3	15	0			55
TI558	TO-92	25	1	4	15	0.5	5	15	20	2.5	8	15	1.3	4	15	6	15	2 mA	3	15	2 mA	3	15	2 mA	50
UC714	TO-18	30	1	1	20	8	20	1	2	20	20	2	6.5	20			8	20	0	4	20	0	100	100	52



MONOLITHIC DUALS

N-Channel FETs

Type No.	Case Style	*BV _{DGS} (V) Min	I _{GSS} *I _{DGO} (pA) @ V _{GS} Max (V)	V _p (V) Min Max	I _{DSS} (mA) Min Max	G _{fs} (mMho) Min Max	G _{oss} (μMho) Max	C _{iss} (pF) Max	C _{rss} (pF) Max	Oper. V _{DG} (V)	I _D (μA)	I _G (pA) Max	V _{GS} (V) Min Max	V _{OS} (mV) Max	DRIET (μA/V ² /C) Max	I _{G1} -I _{G2} @ 125°C (mA) Max	G _{oss} (μMho) Max	G _{fs} (mMho) Min	Process No.
2N3921	TO-71	*50	1000 30	3	1 10	1.5 7.5	35	18	6	10 700	250	250		5	10		20	1.5	83
2N3922	TO-71	*50	1000 30	3	1 10	1.5 7.5	35	18	6	10 700	250	250		5	25		20	1.5	83
2N3954	TO-71	50	100 30	1 4.5	0.5 5	1 3	35	4	1.5	20 200	50	50	0.5 4	5	10	10			83
2N3954A	TO-71	50	100 30	1 4.5	0.5 5	1 3	35	4	1.5	20 200	50	50	0.5 4	5	5	10			83
2N3955	TO-71	50	100 30	1 4.5	0.5 5	1 3	35	4	1.5	20 200	50	50	0.5 4	10	25	10			83



MONOLITHIC DUALS (Cont.)

N-Channel FETs

Type No.	Case Style	*BV _{DGO} BV/GSS (V) Min	I _{GSS} *IDGO (pA) @ V _{GS} Max	V _p (V) Min Max	I _{DSS} (mA) Min Max	G _{fs} (mMho) Min Max	G _{oss} (μMho) Max	C _{iss} (pF) Max	C _{rss} (pF) Max	Oper. Cond. V _{DG} (V)	I _D (μA) Max	I _G (pA) Max	V _{GS} (V) Min Max	V _{OS} (mV) (μV/°C) Max	DRIFT (μV/°C) Max	I _{G1-I_{G2}} @ 125°C (nA) Max	G _{oss} (μMho) Max	G _{fs} (mMho) Min	Process No.	
2N3955A	TO-71	50	100	3	0.5	1	3	4	1.5	20	200	50	0.5	5	15	10			83	
2N3956	TO-71	50	100	1	0.5	1	3	4	1.2	20	200	50	0.5	15	50	10			83	
2N3957	TO-71	50	100	1	0.5	1	3	4	1.2	20	200	50	0.5	20	75	10			83	
2N3958	TO-71	50	100	1	0.5	1	3	4	1.2	20	200	50	0.5	25	100	10			83	
2N4084	TO-71	*50	1000	3	1	1.5	7.5	18	6	10	700	250		15	10		20	1.5	83	
2N4085	TO-71	*50	1000	3	1	1.5	7.5	18	6	10	700	250		15	25		20	1.5	83	
2N5045	TO-71	50	250	0.5	0.5	1.5	6	8	4	15	200			5	10	10			83	
2N5046	TO-71	50	250	0.5	0.5	1.5	6	8	4	15	200			10	20	10			83	
2N5047	TO-71	50	250	0.5	0.5	1.5	6	8	4	15	200			15	50	10			83	
2N5196	TO-71	50	25	0.7	0.7	1	4	6	2	20	200	15	0.2	3.8	5	5	4	0.7	83	
2N5197	TO-71	50	25	0.7	0.7	1	4	6	2	20	200	15	0.2	3.8	5	5	4	0.7	83	
2N5198	TO-71	50	25	0.7	0.7	1	4	6	2	20	200	15	0.2	3.8	10	5	4	0.7	83	
2N5199	TO-71	50	25	0.7	0.7	1	4	6	2	20	200	15	0.2	3.8	15	40	5	4	0.7	83
2N5545	TO-71	50	100	0.5	0.5	1.5	6	25	6	15	200	50		5	10	5			83	
2N5546	TO-71	50	100	0.5	0.5	1.5	6	25	6	15	200	50		10	20	5			83	
2N5547	TO-71	50	100	0.5	0.5	1.5	6	25	6	15	200	50		15	40	5			83	
FM1100	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		2	5	10			59	
FM1101	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		5	5	10			59	
FM1102	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		10	5	10			59	
FM1103	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		10	20	10			59	
FM1104	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		25	50	10			59	
FM1105	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		2	5	10			59	
FM1106	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		5	5	10			59	
FM1107	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		10	5	10			59	
FM1108	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		10	20	10			59	
FM1109	TO-99	35	100	0.5	0.1	1.2	0.5	5	0.6	15	100	50		25	50	10			59	
FM1110	TO-99	25	1000	0.5	0.1	1.2	0.5	5	0.6	15	100	500		50	100	50			59	
FM1111	TO-99	25	1000	0.5	0.1	1.2	0.5	5	0.6	15	100	500		50	100	50			59	
FM1100A	TO-78	*35		0.5	0.3	0.1	0.5	1	5	0.6	15	100	1*	2	5	0.04			82	
FM1101A	TO-78	*35		0.5	0.3	0.1	0.5	1	5	0.6	15	100	1*	5	5	0.04			82	
FM1102A	TO-78	*35		0.5	0.3	0.1	0.5	1	5	0.6	15	100	1*	10	5	0.04			82	
FM1103A	TO-78	*35		0.5	0.3	0.1	0.5	1	5	0.6	15	100	1*	10	20	0.04			82	
FM1104A	TO-78	*35		0.5	0.3	0.1	0.5	1	5	0.6	15	100	1*	25	50	0.04			82	
FM1105A	TO-78	*35		1	6	1	10	5	0.6	15	100	1*	2	5	0.04				82	
FM1106A	TO-78	*35		1	6	1	10	5	0.6	15	100	1*	5	5	0.04				82	
FM1107A	TO-78	*35		1	6	1	10	5	0.6	15	100	1*	10	10	0.04				82	



SWITCHES

P-Channel FETs

Transistor Type	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G (μA)		I _{DGO} (nA) @ V _{DG} (V)		I _{D(off)} (nA) @ V _{DS} (V) V _{GS} (V)		V _p (V) @ V _{DS} (V) I _D (μA)		I _{DSS} (mA) @ V _{DS} (V)		r _{ds} (Ω) @ I _D (mA)		C _{iss} (pF) @ V _{DS} (V) V _{GS} (V)		C _{rss} (pF) V _{DS} (V) V _{GS} (V)		t _{on} (ns) Max		t _{off} (ns) Max		Process No.			
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max						
2N3382	TO-72	30	1	15	30	2	-5	6	1	5	-5	1	3	30	10	300						88			
2N3384	TO-72	30	1	15	30	2	-5	6	4	5	-5	1	15	30	10	180						88			
2N3386	TO-72	30	1	15	30	2.5	-5	10	4	9.5	-5	1	15	50	10	150						88			
2N3993	TO-72	25	1	1.2*	15	1.2	-10	10	4	9.5	-10	1	10	10	10	150	16	-10	0	4.5	0	10	88		
2N3993A	TO-72	25	1	1.2*	15	1.2	-10	10	4	9.5	-10	1	10	10	10	150	12	-10	0	3	0	10	88		
2N3994	TO-72	25	1	1.2*	15	1.2	-10	6	1	5.5	-10	1	2	2	10	300	16	-10	0	4.5	0	10	88		
2N3994A	TO-72	25	1	1.2*	15	1.2	-10	6	1	5.5	-10	1	2	2	10	300	12	-10	0	3	0	10	88		
2N5018	TO-18	30	1	2	15	10	-15	12	10	-15	1	10	10	20	75	45	-15	0	10	0	12	35	88		
2N5019	TO-18	30	1	2	15	10	-15	7	5	5	-15	1	5	5	20	150	45	-15	0	10	0	7	90	125	
2N5114	TO-18	30	1	0.5	20	0.5	-15	12	5	10	-15	.001	30	90	18	75	1	25	-15	0	7	0	12	16	21
2N5115	TO-18	30	1	0.5	20	0.5	-15	7	3	6	-15	.001	15	60	15	100	1	25	-15	0	7	0	7	30	38
2N5116	TO-18	30	1	0.5	20	0.5	-15	5	1	4	-15	.001	5	25	15	150	1	25	-15	0	7	0	5	42	60
P1086E	TO-106	30	1	2	20	10	-15	10	2	20	-15	.01	10	10	15	75	1	45	-15	0	10	15	0	35	50
P1087E	TO-106	30	1	2	20	10	-15	5	5	5	-15	.01	5	5	15	150	1	45	-15	0	10	15	0	40	75
PF510	TO-18	30	1	10	15	0.5	10	-15	.01	5	5	10	200	0.5	10	200	0.5	15	-10	0	4	0	12	88	
UC451	TO-18	25	1	0.25	20	6	-20	.001	6	-20	.001	3.75	37.5	20	150	25	-20	0	7	10				88	



AMPLIFIERS

P-Channel FETs

Transistor Type	Case Style	BV _{GSS} *BV _{GDO} (V) @ I _G (μA)		I _{DGO} (nA) @ V _{DG} (V)		V _p (V) @ V _{DS} (V) I _D (μA)		I _{DSS} (mA) @ V _{DS} (V)		G _{fs} (mMho) @ V _{DS} (V)		G _{oss} (μMho) @ V _{DS} (V)		C _{iss} (pF) @ V _{DS} (V) V _{GS} (V)		C _{rss} (pF) V _{DS} (V) V _{GS} (V)		f _{th} (NV/√Hz) @ Freq (Hz) Max		Process No.			
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max						
2N2608	TO-18	30	1	10	30	1	4	-5	0.9	4.5	5	1	1	5	17	-5	1	125	1000	89			
2N2609	TO-18	30	1	30	30	1	4	-5	2	10	5	2.5	2.5	5	30	-5	1	125	1000	88			
2N3329	TO-72	20	10	10	10	5	-15	10	1	3	10	1	2	10/1mA	20	10	-10	1	125	1000	89		
2N3330	TO-72	20	10	10	10	6	-15	10	2	6	10	1.5	3	10/2mA	40	10	-10	1	125	1000	89		
2N3331	TO-72	20	10	10	10	8	-15	10	5	15	10	2	4	10/5mA	100	10	-10	1	155	1000	89		
2N3332	TO-72	20	10	10	10	6	-15	10	1	6	10	1	2.2	10/1mA	20	10	-10	1	65	1000	89		
2N3520	TO-106	20	10	20	10	8	-10	10	0.3	15	10	0.8	5	10	200	10	32	-10	0	16	-10	0	89
2N4342	TO-106	25	10	10	15	5.5	-10	1	4	12	10	2	6	10	75	10	20	-10	0	5	-10	0	89
2N4343	TO-106	25	10	10	15	10	-10	1	10	30	10	4	8	10	100	10	20	-10	0	5	-10	0	88



Pro-Electron Series

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{CEO} (V) Min	VEBO (V) Min	ICBO (nA) Max	V _{CB} (V)	h _{FE} (h _{FE}) [*] Min Max	IC (mA)	V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min Max	IC (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition See Note	Process No.		
2N4360	TO-106	20	10	10	15	0.7	10	1	3	30	10	2	8	10	100	10	20	-10	0	190	100	89
2N4381	TO-18	25	1	1	15	1	5	1	3	12	15	2	6	15	75	15	20	-15	0	20	1000	89
2N4382	TO-18	25	1	1	15	2.5	9	1	10	30	15	4	8	15	100	15	20	-15	0	20	1000	88
2N5020	TO-18	25	1	1	15	0.3	1.5	1	0.3	1.2	15	1	3.5	15	20	15	25	-15	0	30	1000	89
2N5021	TO-18	25	1	1	15	0.5	2.5	1	1	3.5	15	1.5	5	15	20	15	25	-15	0	30	1000	89
2N5033	TO-106	20	10	10	15	0.3	2.5	1	0.3	3.5	10	1	5	10	20	10	25	-10	0	100	1000	89
2N5460	TO-92	40	10	5	20	0.75	6	1	1	5	15	1	4	15	50	15	7	-15	0	115	100	89
2N5461	TO-92	40	10	5	20	1	7.5	1	2	9	15	1.5	5	15	50	15	7	-15	0	115	100	89
2N5462	TO-92	40	10	5	20	1.8	9	1	4	16	15	2	6	15	50	15	7	-15	0	115	100	89
UC450	TO-18	25	1	0.25	20	5	10	.001	25	75	20	10	10	20	25	25	-20	0	7	0	10	88
UC451	TO-18	25	1	0.25	20	1	6	.001	37.5	37.5	20	6	6	20	25	25	-20	0	7	0	10	88

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{CE0} (V) Min	VEBO (V) Min	ICBO (nA) Max	V _{CB} (V)	h _{FE} (h _{FE}) [*] Min Max	IC (mA)	V _{CE} (V)	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min Max	IC (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition See Note	Process No.	
BC107	TO-18	50	50	45	6	15	50	125	900*	2	5	0.2	0.6	4.5	150	10			10	1	04
BC107A	TO-18	50	50	45	6	15	50	125	260*	2	5	0.55	0.7*	4.5	150	10			10	1	04
BC107B	TO-18	50	50	45	6	15	50	240	500*	2	5	0.55	0.7*	4.5	150	10			10	1	04
BC108	TO-18	30	30	20	5	15	30	125	900*	2	5	0.2	0.6	4.5	150	10			10	1	04
BC108A	TO-18	30	30	20	5	15	30	125	260*	2	5	0.55	0.7*	4.5	150	10			10	1	04
BC108B	TO-18	30	30	20	5	15	30	240	500*	2	5	0.55	0.7*	4.5	150	10			10	1	04
BC108C	TO-18	30	30	20	5	15	30	450	900*	2	5	0.55	0.7*	4.5	150	10			10	1	04
BC109	TO-18	30	30	20	5	15	30	240	900*	2	5	0.55	0.7*	4.5	150	10			10	1	04

Test Conditions:

1. I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 1 kHz, BW = 200 Hz
2. I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 20 Hz to 15 kHz
3. I_C = 30 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
4. I_C = 20 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 150 Hz
5. I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 20 Hz to 15 kHz
6. I_C = 100 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 10 Hz to 10 kHz
7. I_C = 50 μA, V_{CE} = 5V, R_S = 10 kΩ, BW = 10 Hz to 15 kHz
8. I_C = 50 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
9. I_C = 200 μA, V_{CE} = 2V, R_S = 2 kΩ, f = 1 kHz, BW = 200 Hz
10. I_C = 10 μA, V_{CE} = 5V, R_S = 10 kΩ, WB
11. I_C = 150 mA, V_{CE} = 10V, I_B = I_{B2} = 15 mA
12. I_C = 150 mA, I_{B1} = I_{B2} = ±7.5 mA
13. I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA
14. I_C = 100 mA, I_{B1} = 40 mA, I_{B2} = 20 mA
15. V_{CC} = 10V, I_C = 100 mA, I_{B1} = I_{B2} = 1 mA
16. I_C = 150 mA, V_{CE} = 6V, I_{B1} = I_{B2} = 15 mA
17. I_C = 10 mA, I_{B1} = 1 mA, I_{B2} = -1 mA
18. I_C = 300 mA, I_{B1} = I_{B2} = 30 mA, V_{CC} = 25V
19. V_{CC} = 20V, I_C = 100 mA, I_{B1} = I_{B2} = 5 mA



Pro-Electron Series

Type No.	Case Style	V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EB0} (V) Min	I _{CB0} (mA) Max	V _{CB} (V) @ I _{CB0}	h _{FE} (1KRZ)* Min	h _{FE} (1KRZ)* Max	I _C (mA) @ h _{FE}	V _{CE(sat)} (V) Max & V _{BE(om)*} (V) Min	V _{BE(sat)} (V) Max	I _C (mA) @ V _{BE(om)*} Min	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C (mA) @ f _T Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
BC109B	TO-18	30	20	5	15	30	240	500*	2	0.2	0.6	10	4.5	150	10			4	1	04
BC109C	TO-18	30	20	5	15	30	450	900*	2	0.2	0.6	10	4.5	150	10			4	2	04
BC113	TO-106	30	25	6	200	5	200	1000	1	0.35	0.7*	1	4							07
BC114	TO-106	30	25	6	200	5	200	1000	1	0.35	0.7*	1	4							07
BC115	TO-106	40	30	5	100	20	50	400	10	1		100	25	60	0.05			3	3	20
BC116	TO-105	60	40	5	100	20	20	20	0.1	0.4		150	8	200	30					63
BC118	TO-106	45	45	4	500	30	40	160	10	1.6	1	500								23
BC125B	TO-105	60	30	6	50	40	45	10	1	0.25	1.3	150	8	200	10					20
BC126	TO-105	35	5	5	50	20	30	120	150	0.25	1.3	50								63
BC126A	TO-105	40	40	5	50	10	30	10	10	0.5	1.3	150								63
BC132	TO-106	30	25	6	50	5	60	300	1	0.35	1*	50		40	1					04
BC136	TO-105	60	5	5	50	30	30	30	10	1.5	1.2	500	25							20
BC137	TO-105	40	40	4	50	30	25	50	4	2	1.3	500	10							63
BC140	TO-39	80	40	7	100	60	40	250	100	1	1.8*	1A	25	50	50	50	850		19	14
BC140-6	TO-39	80	40	7	100	60	40	100	100	1	1.8*	1A	25	50	50	50	850		19	14
BC140-10	TO-39	80	40	7	100	60	63	160	100	1	1.8*	1A	25	50	50	50	850		19	14
BC140-16	TO-39	80	40	7	100	60	100	250	100	1	1.8*	1A	25	50	50	50	850		19	14
BC141	TO-39	100	60	7	100	60	40	250	100	1	1.8*	1A	25	50	50	50	850		19	14
BC141-6	TO-39	100	60	7	100	60	40	100	100	1	1.8*	1A	25	50	50	50	850		19	14
BC141-10	TO-39	100	60	7	100	60	63	160	100	1	1.8*	1A	25	50	50	50	850		19	14
BC143	TO-5	60	60	5	50	40	20	200	2	1.5	1.5	500		60	50	50	850		19	63

BC153	TO-106	40	40	5	20	40	50	0.1	5	0.25	10				3	4	62
BC154	TO-106	40	40	5	10	40	160	0.1	5	0.25	10				2.5	4	62
BC160	TO-39	40	40	5	100	40	40	250	1	1	1.7*	1A	30	50	650	19	67
BC160-6	TO-39	40	40	5	100	40	40	100	1	1	1.7*	1A	30	50	650	19	67
BC160-10	TO-39	40	40	5	100	40	63	160	1	1	1.7*	1A	30	50	650	19	67
BC160-16	TO-39	40	40	5	100	40	100	250	1	1	1.7*	1A	30	50	650	19	67
BC161	TO-39	60	60	5	100	60	40	250	1	1	1.7*	1A	30	50	650	19	67
BC161-6	TO-39	60	60	5	100	60	40	100	1	1	1.7*	1A	30	50	650	19	67
BC161-10	TO-39	60	60	5	100	60	63	160	1	1	1.7*	1A	30	50	650	19	67
BC161-16	TO-39	60	60	5	100	60	100	250	1	1	1.7*	1A	30	50	650	19	67
BC167A	TO-92 (74)	45	45	6	15	50	125	260*	2	0.2	10	4.5	150	10	10	1	04
BC167B	TO-92 (74)	45	45	6	15	50	240	500*	2	0.2	10	4.5	150	10	10	1	04
BC168A	TO-92 (74)	20	20	5	15	30	125	260*	2	0.2	10	4.5	150	10	10	1	04
BC168B	TO-92 (74)	20	20	5	15	30	240	500*	2	0.2	10	4.5	150	10	10	1	04
BC168C	TO-92 (74)	20	20	5	15	30	450	900*	2	0.2	10	4.5	150	10	10	1	04
BC169B	TO-92 (74)	20	20	5	15	30	240	500*	2	0.2	10	4.5	150	10	4	1	04
BC169C	TO-92 (74)	20	20	5	15	30	450	900*	2	0.2	10	4.5	150	10	4	1	04
BC170A	TO-106	20	20	5	100	15	35	100	1	0.25	0.7	1			4	2	04
BC170B	TO-106	20	20	5	100	15	80	250	1	0.25	0.7	1			4	2	04
BC170C	TO-106	20	20	5	100	15	200	600	1	0.25	0.7	1			4	2	04
BC171	TO-106	45	45	5	15	45	125	500*	2	0.25	0.55	0.7*	150	10	6	1	04
BC171A	TO-106	45	45	5	15	45	40	260*	2	0.25	0.55	0.7*	150	10	6	1	04

Test Conditions: 1. $I_C = 200 \mu A$, $V_{CE} = 5V$, $R_S = 2 k\Omega$, $f = 1 kHz$, $BW = 200 Hz$
2. $I_C = 200 \mu A$, $V_{CE} = 5V$, $R_S = 2 k\Omega$, $f = 20 Hz$ to $15 kHz$
3. $I_C = 30 \mu A$, $V_{CE} = 5V$, $R_S = 10 k\Omega$, $f = 1 kHz$, $BW = 200 Hz$
4. $I_C = 20 \mu A$, $V_{CE} = 5V$, $R_S = 10 k\Omega$, $BW = 10 Hz$ to $15 kHz$
5. $I_C = 200 \mu A$, $V_{CE} = 5V$, $R_S = 2 k\Omega$, $f = 20 Hz$ to $15 kHz$
6. $I_C = 100 \mu A$, $V_{CE} = 5V$, $R_S = 10 k\Omega$, $f = 10 Hz$ to $10 kHz$
7. $I_C = 50 \mu A$, $V_{CE} = 5V$, $R_S = 10 k\Omega$, $BW = 10 Hz$ to $15 kHz$
8. $I_C = 50 \mu A$, $V_{CE} = 5V$, $R_S = 10 k\Omega$, $f = 1 kHz$, $BW = 200 Hz$
9. $I_C = 200 \mu A$, $V_{CE} = 2V$, $R_S = 2 k\Omega$, $f = 1 kHz$, $BW = 200 Hz$
10. $I_C = 10 \mu A$, $V_{CE} = 5V$, $R_S = 10 k\Omega$, $BW = 10 Hz$ to $15 kHz$
11. $I_C = 150 \mu A$, $V_{CE} = 10V$, $I_{B1} = 15 mA$
12. $I_C = 150 \mu A$, $V_{CE} = 10V$, $I_{B1} = 10 mA$, $I_{B2} = 20 mA$
13. $I_C = 10 mA$, $I_{B1} = 3 mA$, $I_{B2} = 1 mA$
14. $I_C = 100 mA$, $I_{B1} = 40 mA$, $I_{B2} = 20 mA$
15. $V_{CC} = 10V$, $I_C = 100 mA$, $I_{B1} = I_{B2} = 17.5 mA$
16. $I_C = 150 mA$, $V_{CE} = 6V$, $I_{B1} = I_{B2} = 15 mA$
17. $I_C = 10 mA$, $I_{B1} = 1 mA$, $I_{B2} = -1 mA$
18. $I_C = 300 mA$, $I_{B1} = I_{B2} = 30 mA$, $V_{CC} = 25V$
19. $V_{CC} = 20V$, $I_C = 100 mA$, $I_{B1} = I_{B2} = 5 mA$



Pro-Electron Series

Type No.	Case Style	V _{CEO} (V) Min	V _{CBO} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V)	f _{hFE} (MHz)* Min Max	I _C (mA) @ Min Max	V _{CE} (V) & V _{CE} (V)	V _{CE(sat)} (V) I _{max}	V _{BE(sat)} (V) & V _{BE(on)*} (V) Min Max	I _C (mA) @ Min Max	C _{ob} (pF) Max	f _T (MHz) @ I _C (mA) Min Max	t _{off} (ns) Max	NF (dB) (dB) Max	Test Condition	Process No.
BC171B	TO-106	45		5	5	15	45	40 240 500*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		6	1	04
BC172	TO-106	20		5	5	15	20	125 900*	2 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		6	1	04
BC172A	TO-106	20		5	5	15	20	40 125 260*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		6	1	04
BC172B	TO-106	20		5	5	15	20	40 240 500*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		6	1	04
BC172C	TO-106	20		5	5	15	20	100 450 900*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		6	1	04
BC173	TO-106	20		5	5	15	20	40 240 900*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		4	2	04
BC173A	TO-106	20		5	5	15	20	40 125 260*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		4 4 1	2	04
BC173B	TO-106	20		5	5	15	20	40 240 500*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		4	2	04
BC173C	TO-106	20		5	5	15	20	100 450 900*	0.01 2	5 5	0.25 0.6	0.55 0.7*	10 100		150		4	2	04
BC177	TO-18	45 BV _{CEO} 50	50	5	5	100	20 I _{CES}	75 260*	2 2	5 5	(V _{CEK}) 0.6	0.6 0.75* 2	10 10	6	150		10	1	71
BC177A	TO-18	45 BV _{CEO} 50	50	5	5	100	20 I _{CES}	125 260*	2 2	5 5	(V _{CEK}) 0.6	0.6 0.75* 2	10 10	6	150		10	1	71
BC177A-VI	TO-18	45 BV _{CEO} 50	50	5	5	100	20 I _{CES}	75 150*	2 2	5 5	(V _{CEK}) 0.6	0.6 0.75* 2	10 10	6	150		10	1	71
BC178	TO-18	25 BV _{CEO} 30	30	5	5	100	20 I _{CES}	75 500*	2 2	5 5	(V _{CEK}) 0.6	0.6 0.75* 2	10 10	6	150		10	1	71
BC178A	TO-18	25 BV _{CEO} 30	30	5	5	100	20 I _{CES}	75 500*	2 2	5 5	(V _{CEK}) 0.6	0.6 0.75* 2	10 10	6	150		10	1	71
BC178B	TO-18	25 BV _{CEO} 30	30	5	5	100	20 I _{CES}	75 500*	2 2	5 5	(V _{CEK}) 0.6	0.6 0.75* 2	10 10	6	150		10	1	71

BC179	TO-18	25	20 BV _{CE} S 25	5	100	ICES	20	(V _{CEK}) 0.6	0.6	0.75* 2	6	4	1	71
BC179A	TO-18	25	20 BV _{CE} S 30	5	100	ICES	20	(V _{CEK}) 0.6	0.6	0.75* 2	6	4	1	71
BC179B	TO-18	25	20	5	100	ICES	20	(V _{CEK}) 0.6	0.6	0.75* 2	6	4	1	71
BC182K	TO-106	60	50	5	15	50	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC182KA	TO-106	60	50	5	15	50	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC182KB	TO-106	60	50	5	15	50	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC182L	TO-92 (74)	60	50	5	15	50	40 100 80 125 500*	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC182LA	TO-92 (74)	60	50	5	15	50	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC182LB	TO-92 (74)	60	50	5	15	50	40 100 80 240 500*	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183K	TO-106	45	30	5	15	30	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183KA	TO-106	45	30	5	15	30	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183KB	TO-106	45	30	5	15	30	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183KC	TO-106	45	30	5	15	30	40 100 80	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183L	TO-92 (74)	45	30	5	15	30	40 80 125 900*	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183LA	TO-92 (74)	45	30	5	15	30	40 80 125 260*	0.25 0.6	1.2 0.7*	10 2	5	10	1	04
BC183LB	TO-92 (74)	45	30	5	15	30	40 80 240 500*	0.25 0.6	1.2 0.7*	10 2	5	10	1	04

Test Conditions:

1. I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 1 kHz, BW = 200 Hz
2. I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 20 Hz to 15 kHz
3. I_C = 30 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 10 Hz to 10 kHz, BW = 200 Hz
4. I_C = 20 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 150 Hz
5. I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 20 Hz to 15 kHz
6. I_C = 100 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 10 Hz to 10 kHz, BW = 200 Hz
7. I_C = 50 μA, V_{CE} = 5V, R_S = 10 kΩ, BW = 10 Hz to 15 kHz
8. I_C = 50 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
9. I_C = 200 μA, V_{CE} = 2V, R_S = 2 kΩ, f = 1 kHz, BW = 200 Hz
10. I_C = 10 μA, V_{CE} = 5V, R_S = 10 kΩ, WB
11. I_C = 150 μA, V_{CE} = 10V, I_{B1} = I_{B2} = 15 mA
12. I_C = 150 mA, I_{B1} = I_{B2} = 27.5 mA
13. I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA
14. I_C = 100 mA, I_{B1} = 40 mA, I_{B2} = 20 mA
15. V_{CC} = 10V, I_C = 100 mA, I_{B1} = I_{B2} = 10 mA
16. I_C = 150 mA, V_{CE} = 6V, I_{B1} = I_{B2} = 15 mA
17. I_C = 10 mA, I_{B1} = 1 mA, I_{B2} = -1 mA
18. I_C = 300 mA, I_{B1} = I_{B2} = 30 mA, V_{CC} = 25V
19. V_{CC} = 20V, I_C = 100 mA, I_{B1} = I_{B2} = 5 mA



Pro-Electron Series

Type No.	Case Style	V _{CE0} (V) Min	V _{CE0} (V) Max	V _{BE0} (V) Min	I _{CBO} (nA) @ V _{CB} (V) Max	h _{FE} (1kHz)* Min	I _C & V _{CE} (V) @ (mA) Max	V _{CE(sat)} (V) Max	V _{BE(sat)} & V _{BE(ont)} (V) @ I _C (mA)		C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
									Min	Max							
BC183LC	TO-92 (74)	30	15	5	30	40	0.01	0.25	0.55	1.2	5	150	10		10	1	04
BC184K	TO-106	30	15	5	30	80	100	0.6	0.55	0.7*	5	150	10		4	2	04
BC184KB	TO-106	30	15	5	30	100	0.01	0.25	0.55	1.2	5	150	10		4	2	04
BC184KC	TO-106	30	15	5	30	250	2	0.6	0.55	0.7*	5	150	10		4	2	04
BC184L	TO-92 (74)	30	15	5	30	130	100	0.6	0.55	0.7*	5	150	10		4	2	04
BC184LB	TO-92 (74)	30	15	5	30	250	2	0.6	0.55	0.7*	5	150	10		4	2	04
BC184LC	TO-92 (74)	30	15	5	30	130	100	0.6	0.55	0.7*	5	150	10		4	2	04
BC204	TO-106	45	50	5	45	240	900*	0.3	0.55	0.75*	2	150	10		10	1	71
BC204A	TO-106	45	50	5	45	110	220	0.3	0.55	0.75*	2	150	10		10	1	71
BC204B	TO-106	45	50	5	45	200	450	0.3	0.55	0.75*	2	150	10		10	1	62
BC204VI	TO-106	45	50	5	45	50	120	0.3	0.55	0.75*	2	150	10		10	1	71
BC205	TO-106	20	50	5	20	110	450	0.3	0.55	0.75*	2	150	10		10	1	71
BC205A	TO-106	20	50	5	20	110	220	0.3	0.55	0.75*	2	150	10		10	1	71
BC205B	TO-106	25	50	5	20	200	450	0.3	0.55	0.75*	2	150	10		10	1	62
BC206	TO-106	25	50	5	20	200	2	0.3	0.55	0.75*	2	150	10		4	1	62
BC206B	TO-106	25	50	5	20	200	450	0.3	0.55	0.75*	2	150	10		4	1	62
BC207	TO-106	45	15	5	40	110	450	0.25	0.55	0.75*	2	150	10		10	1	04
BC207A	TO-106	45	15	5	40	110	220	0.6	0.55	0.75*	2	150	10		10	1	04
BC207B	TO-106	45	15	5	40	200	450	0.25	0.55	0.75*	2	150	10		10	1	04

BC208	TO-106	25	20	5	15	20	110	800	2	5	0.25 0.6	10 100	6	10	1	04
BC208A	TO-106	25	20	5	15	20	110	220	2	5	0.25 0.6	100	6	10	1	04
BC208B	TO-106	25	20	5	15	20	200 40	450	2 0.10	5	0.25 0.6	10 100	6	10	1	04
BC208C	TO-106	25	20	5	15	20	420 100	800	2 0.10	5	0.25 0.6	100	6	10	1	04
BC209	TO-106	25	20	5	15	20	200 70	800	2 0.10	5	0.25 0.6	10 100	6	4	2	04
BC209B	TO-106	25	20	5	15	20	200 40	450	2 0.10	5	0.25 0.6	100	6	4	2	04
BC209C	TO-106	25	20	5	15	20	420 100	800	2 0.10	5	0.25 0.6	100	6	4	2	04
BC212K	TO-106	60	50	5	15	30	40 60	300	0.01 2	5	0.6 0.6	0.6 1.1	10 100	10	1	63
BC212KA	TO-106	60	50	5	15	30	40 60 100	300	0.01 2 2	5	0.25 0.6	0.6 1.1	10 100	10	1	63
BC212KB	TO-106	60	50	5	15	30	40 60 200	300	0.01 2 400*	5	0.25 0.6	0.6 1.1	10 100	10	1	63
BC213K	TO-106	45	30	5	15	30	40 80	400	0.01 2	5	0.25 0.6	10 100	10	10	1	63
BC213KA	TO-106	45	30	5	15	30	40 80 100	300*	0.01 2 2	5	0.25 0.6	10 100	10	10	1	63
BC213KB	TO-106	45	30	5	15	30	40 80 200	400*	0.01 2 2	5	0.25 0.6	10 100	10	10	1	63
BC213KC	TO-106	45	30	5	15	30	40 80 350	600*	0.01 2 2	5	0.25 0.6	10 100	10	10	1	63
BC213L	TO-92 (74)	45	30	5	15	30	40 80	400	0.01 2	5	0.25 0.6	10 100	10	10	1	63
BC213LA	TO-92 (74)	45	30	5	15	30	40 100	300*	0.01 2	5	0.25 0.6	10 100	10	10	1	63
BC213LB	TO-92 (74)	45	30	5	15	30	40 200	400*	0.01 2	5	0.25 0.6	10 100	10	10	1	63
BC213LC	TO-92 (74)	45	30	5	15	30	350 600*	2	2	5	0.25 0.6	10 100	10	10	1	63

Test Conditions: 1. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$ 4. $I_C = 20 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 150 Hz$ 7. $I_C = 50 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, BW = 10 Hz$ to 15 kHz 10. $I_C = 10 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, WB$

2. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 20 Hz$ to 15 kHz 8. $I_C = 50 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 200 Hz$ 11. $I_C = 150 mA, I_{B1} = 10V, I_{B2} = 15 mA$

3. $I_C = 30 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 200 Hz$ 6. $I_C = 100 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 10 Hz$ to 10 kHz 9. $I_C = 200 \mu A, V_{CE} = 2V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$ 12. $I_C = 150 mA, I_{B1} = I_{B2} = 7.5 mA$

13. $I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA$ 16. $I_C = 150 mA, V_{CE} = 6V, I_{B1} = I_{B2} = 15 mA$

14. $I_C = 100 mA, I_{B1} = 40 mA, I_{B2} = 20 mA$ 17. $I_C = 10 mA, I_{B1} = 1 mA, I_{B2} = -1 mA$

15. $V_{CC} = 10V, I_C = 100 mA, I_{B1} = I_{B2} = 10 mA$ 18. $I_C = 300 mA, I_{B1} = I_{B2} = 30 mA, V_{CC} = 25V$

19. $V_{CC} = 25V, I_C = 100 mA, I_{B1} = I_{B2} = 5 mA$



Pro-Electron Series

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CEO} (mA) Max	V _{CB} @ (V)	h _{FE} (1kHz)* Min	h _{FE} (1kHz)* Max	I _C @ (mA)	V _{CE} & (V)	V _{CE(sat)} (V) I _{max}	V _{BE(sat)} V _{BE(on)*} (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
BC214K	TO-106	45	30	5	15	30	100	400	0.01	5	0.25	0.6	0.72*	10	200	10			2	2	63
BC214KA	TO-106	45	30	5	15	30	120	400	100	5	0.6	1.1	100	10	200	10			2	2	63
BC214KB	TO-106	45	30	5	15	30	100	300*	100	5	0.25	0.6	1.1	10	200	10			2	2	63
BC214KC	TO-106	45	30	5	15	30	120	400*	100	5	0.25	0.6	1.1	10	200	10			2	2	63
BC214L	TO-92 (74)	45	30	5	15	30	100	600*	0.01	5	0.25	0.6	1.1	10	200	10			2	2	63
BC214LB	TO-92 (74)	45	30	5	15	30	120	400	0.01	5	0.25	0.6	1.1	10	200	10			2	2	63
BC214LC	TO-92 (74)	45	30	5	15	30	200	400*	2	5	0.25	0.6	1.1	10	200	10			2	2	63
BC237	TO-106	50	45	6	50	20	350	600*	2	5	0.25	0.6	1.1	10	200	10			2	2	63
BC237A	TO-106	50	45	6	50	20	125	500*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC237B	TO-106	50	45	6	50	20	125	260*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC238	TO-106	30	20	5	50	20	240	500*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC238A	TO-106	30	20	5	50	20	125	900*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC238B	TO-106	30	20	5	50	20	125	260*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC238C	TO-106	30	20	5	50	20	240	500*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC239	TO-106	30	20	5	50	20	450	900*	2	5	0.25	0.6	0.77*	10	4.5	10		10	1	1	04
BC239B	TO-106	30	20	5	50	20	240	900*	2	5	0.25	0.7*	2	4.5	10	4.5		4	1	2	04
BC239C	TO-106	30	20	5	50	20	240	500*	2	5	0.25	0.7*	2	4.5	10	4.5		4	1	2	04
BC251A	TO-106		45	5	50	45	450	900*	2	5	0.25	0.7*	2	4.5	10	4.5		4	1	2	27
							125	260*	2	5	0.25	0.9	10						6	1	71

BC251B	TO-106	45	50	45	240	500*	2	5	0.25 0.6	0.9	10	1	71
BC251CA	TO-106	45	50	45	450	900*	2	5	0.25	0.9	10	6	62
BC252A	TO-106	20	50	20	125	260*	2	5	0.25 0.6	0.9	10	6	71
BC252B	TO-106	20	50	20	240	500*	2	5	0.25 0.6	0.9	10	6	71
BC252CA	TO-106	20	50	20	450	900*	2	5	0.25	0.9	10	6	62
BC253A	TO-106	20	50	20	40	260*	0.01	5	0.25 0.6	0.9	10	2.5	71
BC253B	TO-106	20	50	20	40	260*	0.01	5	0.25 0.6	0.9	10	2.5	71
BC253CA	TO-106	20	50	20	100	500*	0.01	5	0.25	0.9	10	2.5	62
BC261A	TO-18	45	50	45	125	260*	2	5	0.25 0.6	0.9	10	6	71
BC261B	TO-18	45	50	45	240	500*	2	5	0.25 0.6	0.9	10	6	71
BC262A	TO-18	20	50	20	125	260*	2	5	0.25 0.6	0.9	10	6	71
BC262B	TO-18	20	50	20	240	500*	2	5	0.25 0.6	0.9	10	6	71
BC263A	TO-18	20	50	20	40	260*	0.01	5	0.25 0.6	0.9	10	2.5	71
BC263B	TO-18	20	50	20	40	260*	0.01	5	0.25 0.6	0.9	10	2.5	71
BC307	TO-106	45	50	45	75	50*	2	5	0.6 (V _{CEK})	0.6	0.75* 2	10	71
BC307A	TO-106	45	50	45	100	160*	2	5	0.6 (V _{CEK})	0.6	0.75* 2	10	71
BC307B	TO-106	45	50	45	100	20	240	500*	2	0.6 (V _{CEK})	0.6	0.75* 2	71
BC307VI	TO-106	45	50	45	75	150*	2	5	0.6 (V _{CEK})	0.6	0.75* 2	10	71
BC308	TO-106	30	25	50	125	500*	2	5	0.6 (V _{CEK})	0.6	0.75* 2	10	71
BC308A	TO-106	30	25	50	125	260*	2	5	0.6 (V _{CEK})	0.6	0.75* 2	10	71
BC308B	TO-106	30	25	50	240	500*	2	5	0.6 (V _{CEK})	0.6	0.75* 2	10	71
BC407	TO-106	50	45	50	125	500*	2	5	0.25 0.6	0.65	0.7* 2	10	04
BC407A	TO-106	50	45	50	125	260*	2	5	0.25 0.6	0.55	0.7* 2	10	04

Test Conditions:

1. $I_C = 200 \mu A$, $V_{CE} = 5V$,
 $R_S = 2 k\Omega$, $f = 1 kHz$,
 $BW = 200 Hz$

2. $I_C = 200 \mu A$, $V_{CE} = 5V$,
 $R_S = 2 k\Omega$, $f = 20 Hz$ to
15 kHz

3. $I_C = 30 \mu A$, $V_{CE} = 5V$,
 $R_S = 10 k\Omega$, $f = 1 kHz$,
 $BW = 200 Hz$

4. $I_C = 20 \mu A$, $V_{CE} = 5V$,
 $R_S = 10 k\Omega$, $f = 1 kHz$,
 $BW = 150 Hz$

5. $I_C = 200 \mu A$, $V_{CE} = 5V$,
 $R_S = 2 k\Omega$, $f = 20 Hz$ to
15 kHz

6. $I_C = 100 \mu A$, $V_{CE} = 5V$,
 $R_S = 2 k\Omega$, $f = 10 Hz$ to
10 kHz

7. $I_C = 50 \mu A$, $V_{CE} = 5V$,
 $R_S = 10 k\Omega$, $BW = 10 Hz$ to
15 kHz

8. $I_C = 50 \mu A$, $V_{CE} = 5V$,
 $R_S = 10 k\Omega$, $f = 1 kHz$,
 $BW = 200 Hz$

9. $I_C = 200 \mu A$, $V_{CE} = 2V$,
 $R_S = 2 k\Omega$, $f = 10 Hz$ to
10 kHz

10. $I_C = 10 \mu A$, $V_{CE} = 5V$,
 $R_S = 10 k\Omega$, BW

11. $I_C = 150 \mu A$, $V_{CE} = 10V$,
 $I_{B1} = I_{B2} = 15 mA$

12. $I_C = 150 \mu A$, $I_{B1} = I_{B2} = 17.5 mA$

13. $I_C = 10 mA$, $I_{B1} = 3 mA$,
 $I_{B2} = 1 mA$

14. $I_C = 100 mA$, $I_{B1} = 40 mA$,
 $I_{B2} = 20 mA$

15. $V_{CC} = 10V$, $I_C = 100 mA$,
 $I_{B1} = I_{B2} = 10 mA$

16. $I_C = 150 mA$, $V_{CE} = 6V$,
 $I_{B1} = I_{B2} = 15 mA$

17. $I_C = 10 mA$, $I_{B1} = 1 mA$,
 $I_{B2} = -1 mA$

18. $I_C = 300 mA$, $I_{B1} = I_{B2} = 30 mA$, $V_{CC} = 25V$

19. $V_{CC} = 20V$, $I_C = 100 mA$,
 $I_{B1} = I_{B2} = 5 mA$



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Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{BE0} (V) Min	I _{CBO} (mA) Max	V _{CB} (V)	h _{FE} (h _{FE}) Min	h _{FE} (h _{FE}) Max	I _C (mA)	V _{CE} (V)	V _{CE(sat)} (V) & V _{CE} (V)	V _{BE(sat)} (V) Min	V _{BE(oh)} (V) Max	I _C (mA) Min	I _C (mA) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
BC407B	TO-106	50	45	6	50	20	240	500*	2	5	0.25 0.6	0.77*	0.77*	10	100				10	1	04
BC408	TO-106	30	20	5	50	20	125	900*	2	5	0.25 0.6	0.55	0.7*	2	100				10	1	04
BC408A	TO-106	30	20	5	50	20	125	260*	2	5	0.25 0.6	0.55	0.7*	2	100				10	1	04
BC408B	TO-106	30	20	5	50	20	240	500*	2	5	0.25 0.6	0.55	0.7*	2	100				10	1	04
BC408C	TO-106	30	20	5	50	20	450	900*	2	5	0.25 0.6	0.55	0.7*	2	100				10	1	04
BC409	TO-106	30	20	5	50	20	240	900*	2	5	0.25 0.6	0.55	0.7*	2	100				4	1	04
BC409B	TO-106	30	20	5	50	20	240	500*	2	5	0.25 0.6	0.55	0.7*	2	100				4	2	04
BC409C	TO-106	30	20	5	50	20	450	900*	2	5	0.25 0.6	0.55	0.7*	2	100				4	1	04
BC413	TO-106	45	30	5	15	30	200	800	2	5	0.25 0.6	0.55	0.7*	2	100				3	2	04
BC413B	TO-106	45	30	5	15	30	200	450	2	5	0.25 0.6	0.55	0.7*	2	100				3	2	04
BC413C	TO-106	45	30	5	15	30	420	800	2	5	0.25 0.6	0.55	0.7*	2	100				3	2	04
BCY58	TO-18	32	32	7	10	32	120	630	2	5	0.35 0.7	0.6	0.85	10	800	125	10	800		17	04
BCY58-7	TO-18	32	32	7	10	32	40	1000	10	1	0.35 0.7	0.75	1.2	100	800				6	15	04
BCY58-8	TO-18	32	32	7	10	32	120	220	2	5	0.35 0.7	0.6	0.85	10	800	125	10	800		17	04
							40	100	1	1	0.35 0.7	0.75	1.2	100	800				6	15	04
							20	310	0.01	5	0.35	0.6	0.85	10	800	125	10	800		17	04
							180	400	2	5	0.7	0.75	1.2	100	800				6	15	04
							45	100	100	1		0.55	0.7*	2					6	1	04

BCY589	TO-18	32	32	7	10	I_{CES}	40 250 160 630 60	0.01 2 5 100 1	5 5 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY58-10	TO-18	32	32	7	10	I_{CES}	100 380 240 1000 60	0.01 2 5 10 100	5 5 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY59	TO-18	45	45	7	10	I_{CES}	120 80 40 1000 40	2 10 100 1 1	5 1 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY59-7	TO-18	45	45	7	10	I_{CES}	120 80 40 1000 40	2 10 100 1 1	5 1 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY59-8	TO-18	45	45	7	10	I_{CES}	20 180 120 400 45	0.01 2 5 10 100	5 5 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY59-9	TO-18	45	45	7	10	I_{CES}	40 250 160 630 60	0.01 2 5 10 100	5 5 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY59-10	TO-18	45	45	7	10	I_{CES}	100 380 240 1000 60	0.01 2 5 10 100	5 5 1 1 1	0.35 0.7 0.35 0.7	0.6 0.75 0.55 0.7*	10 100 2	6	125	10	800 800	17 15 1	04
BCY70	TO-18	50	40	5	10	50	40 45 50 15	0.1 1 10 50	1 1 1 1	0.25 0.5	0.6 1.2 50	10 50	6	250	10	420	6 6 17	71
BCY71	TO-18	45	45	5	500 50	45 40	40 80 90 100 100 400*	0.01 0.1 0.1 1 1 1	1 1 1 1 1 10	0.25 0.5	0.6 0.9 1.2 50	10 50	6	200 166	20 0.1	2	6 6 17	71
BCY71A	TO-18	45	45	5	50	40	40 80 90 100 100 400*	0.01 0.1 1 10 1	1 1 1 1 1	0.25 0.5	0.6 0.9 1.2 50	10 50	6	300 15	10 1	2	6 6 17	71
BCY72	TO-18	25	25	5	50 500	20 25	40 100 400*	1 10 1	1 1 1	0.25 0.5	1.2 50	10 50	6	200	10	420	6 6 17	71
BF153	TO-106	30	12	2	100	15	20	3	6	0.5	10	(CRE) 1.2	300	3	GT 40dB Min			43
BF160	TO106	30	12	2	500	15	20	3	10	0.5	10	1.7	400	10				43

Test Conditions: 1. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$
2. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$
3. $I_C = 30 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 200 Hz$
4. $I_C = 20 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 150 Hz$
5. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 20 Hz to 15 kHz$
6. $I_C = 100 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 10 Hz to 10 kHz$
7. $I_C = 50 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, BW = 10 Hz to 15 kHz$
8. $I_C = 50 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 200 Hz$
9. $I_C = 300 \mu A, V_{CE} = 2V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$
10. $I_C = 10 mA, V_{CE} = 5V, R_S = 10 k\Omega, WB$
11. $I_C = 150 mA, V_{CE} = 10V, I_{B1} = I_{B2} = 15 mA$
12. $I_C = 150 mA, I_{B1} = I_{B2} = +7.5 mA$
13. $I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA$
14. $I_C = 100 mA, I_{B1} = 40 mA, I_{B2} = 20 mA$
15. $V_{CE} = 10V, I_C = 100 mA, I_{B1} = I_{B2} = 30 mA, V_{CC} = 25V$
16. $I_C = 150 mA, V_{CE} = 6V, I_{B1} = I_{B2} = 5 mA$
17. $I_C = 10 mA, I_{B1} = 1 mA, I_{B2} = -1 mA$
18. $I_C = 300 mA, I_{B1} = I_{B2} = 30 mA, V_{CC} = 25V$
19. $V_{CC} = 20V, I_C = 100 mA, I_{B1} = I_{B2} = 5 mA$



Pro-Electron Series

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} (mA) @ V _{CB} (V) Max	f _{hfe} (kHz)* Min	f _{hfe} (kHz)* Max	I _C (mA) & V _{CE} (V)	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
BF167	TO-72(28)	40	30	4	4	27	4	10										45
BF173	TO-72(28)	40	25	4	38	38	7	10			0.9	7						47
BF194	TO92	30	20	5	66	210	1	10		0.65	0.74	1						46
BF195	TO-92	30	20	5	35	125	1	10		0.65	0.74	1						46
BF196	TO-092(71)	40	30	4	27	4	4	10			0.84	4						45
BF197	TO-92(71)	40	25	4	38	7	10	10			0.9	7						47
BF198	TO-92(71)	40	30	4	27	4	4	10			0.85	4						45
BF199	TO-92(71)	40	25	4	38	7	7	10			0.925	7						47
BF233	TO-92(71)	30	20	5	35	120	1	10										49
BF257	TO-39	160	160	5	50	25	30	10			30	5.5	5.5	90			20	15
BF258	TO-39	250	250	5	50	100	30	10			30	5.5	30	90			20	15
BF259	TO-39	300	300	5	50	100	30	10			30	5.5	30	90			20	15
BF-X29	TO-5	60	60		50	20	0.1	10	0.4		1.3	150	12	100	150		16	63
					50	40	1	10			0.9	30						
					50	50	10	10										
					50	50	50	10										
					50	100	10	10										
					50	400*	150	10										
BF-X65	TO-18	45	45	6	10	100	0.1	5	0.25		0.9	10	6.5			3	4	62
					I _{CEs}	100	1	5										
						100	10	5										
						120	1	5										
BF-X84	TO-39	100	60	5	500	20	10	10	0.15		1.2	10	12	50	360		11	14
					50	30	150	10	0.35		1.3	150						
					50	20	500	10	1.0		1.5	500						
					50	15	1A	10	1.6		2.0	1A						
BF-X85	TO-39	100	60	5	50	50	10	10	0.15		1.2	10	12	50	360		11	14
					500	70	150	10	0.35		1.3	150						
					50	30	500	10	1.0		1.5	500						
					50	15	1A	10	1.6		2.0	1A						
BF-X86	TO-39	40	35	5	50	50	10	10	0.15		1.2	10	12	50	360		16	14
					500	40	150	10	0.35		1.3	150						
					50	30	500	10	1.0		1.5	500						
					50	15	1A	10	1.6		2.0	1A						
BF-X87	TO-5	50	50	4	500	40	1	10	0.4		1.3	150	12	100	150		16	63
					50	40	10	10			0.9	30						
					40	40	150	10										
					40	25	500	10										
BF-X88	TO-5	40	40	4	50	40	1	10	0.4		1.3	150	12	100	150		16	63
					40	40	150	10			0.9	30						
					40	40	10	10										
					40	25	500	10										
BF-Y39	TO-18	45	25	5	50	30	400*	10	1.0		1.0	10	5	150			23	
BF-Y39-1	TO-18	45	25	5	50	30	110	10	1.0		1.0	10	5	150			23	
					50	120	1	5										
BF-Y39-2	TO-18	45	25	5	50	100	200	10	1.0		1.0	10	5	150			23	
BF-Y39-3	TO-18	45	25	5	50	30	400	10	1.0		1.0	10	5	150			23	
					50	180	400	10	1.0		1.0	10	5	150			23	
					50	120	1	5										

BFY50	TO-39	80	35	6	50 500	60 80	20 30 150 10	10 10	0.7 0.1 1.2 1.0	1.5 1.2 1.3 2.0	500 10 150 1A	12	60	50	360	11	14
BFY51	TO-39	60	30	6	50 500	40 60	30 40 150 10	10 10	1.0 0.15 1.2 1.0	1.5 1.2 1.0 1.0	500 10 150 1A	12	50	50	360	11	14
BFY52	TO-39	40	20	6	50 500	30 40	15 30 10 10	10 10	1.6 1.6 1.0 1.0	2.0 1A 1.5 500	1A 10 10 10	12	50	50	360	11	14
BFY56	TO-39	80	45	5	50	50	15 20 30 150 10	0.1 10 10	0.3 2.3 1.2 1.0	2.0 1A 1.6 1.0	150 10 100 10	25	40	50	625	12	14
BFY72	TO-5	50	28	5	0.02 ICES	40	15 20 30 40 150 10	1 10 10	0.25 0.7	1.2 1.6	150 500	8	50	50	170	18	20
BFY76	TO-18	45	6	6	20	30	80 30 200 0.01 5 80 0.5 5 140	5 5 5 5	0.35	0.5 0.75 0.1	0.1 1	6	2.4 2	0.05 0.5	4	10	07
BSX21	TO-18	120	80	5	500 0.04	50 120	20 4	3	0.9	4	4	60	60	4	650	12	14
BSX45-6	TO-39	BVCES 80	40	7	ICES	60	40 100	100	1.0	2.0 1000	500 20	20	60	50	650	12	14
BSX45-10	TO-39	BVCES 80	40	7	ICES	60	63 160	100	1.0	2.0 1A	500 20	20	60	50	650	12	14
BSX45-16	TO-39	BVCES 80	40	7	ICES	60	100 250	100	1.0	2.0 1A	500 20	20	60	50	650	12	14
BSX46-6	TO-39	BVCES 100	60	7	ICES	60	40 100	100	1.0	2.0 1A	500 25	20	60	50	650	12	14
BSX46-10	TO-39	BVCES 100	60	7	ICES	60	63 160	100	1.0	2.0 1A	500 25	20	60	50	650	12	14
BSX46-16	TO-39	BVCES 100	60	7	ICES	60	100 250	100	1.0	2.0 1A	500 25	20	60	50	650	12	14
BSX88	TO-18	40	15	5	25	20	15 30 120	0.5 1	0.4	0.72 0.8	10 6	6	300	10	75	13	21
BSY38	TO-18	20	12	5	100	20	30 60 10	0.35 1	0.25 0.6	0.85 1.5	10 100	5	200	10	45	14	21
BSY39	TO-18	20	12	5	100	20	40 120 10	0.35 1	0.25 0.6	0.7 1.5	10 100	5	200	10	45	14	21
BSY51	TO-5	60	25	5	100	30	40 120 150	10	1.0	1.3 1.5	150 9	9	130	50	50	20	20
BSY52	TO-5	60	25	5	100	30	100 300	150	1.0	1.3 1.5	150 9	9	130	50	50	20	20

Test Conditions: 1. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$
2. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 20 Hz to 15 kHz, BW = 200 Hz$
3. $I_C = 30 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 200 Hz$
4. $I_C = 20 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, BW = 10 Hz to 15 kHz, BW = 200 Hz$
5. $I_C = 200 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 20 Hz to 15 kHz, BW = 200 Hz$
6. $I_C = 100 \mu A, V_{CE} = 5V, R_S = 2 k\Omega, f = 10 Hz to 10 kHz, BW = 200 Hz$
7. $I_C = 50 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, BW = 10 Hz to 15 kHz, BW = 200 Hz$
8. $I_C = 50 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, f = 1 kHz, BW = 200 Hz$
9. $I_C = 200 \mu A, V_{CE} = 2V, R_S = 2 k\Omega, f = 1 kHz, BW = 200 Hz$
10. $I_C = 10 \mu A, V_{CE} = 5V, R_S = 10 k\Omega, BW = 10 Hz to 15 kHz, BW = 200 Hz$
11. $I_C = 150 \mu A, V_{CE} = 10V, I_{B1} = 150 \mu A, I_{B2} = 15 mA, BW = 200 Hz$
12. $I_C = 150 \mu A, I_{B1} = 150 \mu A, I_{B2} = 15 mA, BW = 200 Hz$
13. $I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA$
14. $I_C = 100 mA, I_{B1} = 40 mA, I_{B2} = 20 mA$
15. $V_{CC} = 10V, I_C = 100 mA, I_{B1} = 10 mA, I_{B2} = 10 mA$
16. $I_C = 150 mA, V_{CE} = 6V, I_{B1} = 15 mA, I_{B2} = 5 mA$
17. $I_C = 10 mA, I_{B1} = 1 mA, I_{B2} = -1 mA$
18. $I_C = 300 mA, I_{B1} = 150 mA, I_{B2} = 30 mA, V_{CC} = 25V$
19. $V_{CC} = 20V, I_C = 100 mA, I_{B1} = 15 mA, I_{B2} = 5 mA$



Pro-Electron Series

Type No.	Case Style	V _{CEO} (V) Min	V _{CEO} (V) Min	V _{BE0} (V) Min	I _{CBO} (mA) Max	I _{CB0} @ V _{CB} (V)	^h f _T (1kHz)* Min Max	I _C @ (mA)	V _{CE} & (V)	V _{CE(sat)} (V) & Max	V _{BE(sat)} V _{BE(on)*} @ (V) Min Max	I _C (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
BSY53	TO-5	75	30	7	10	60	20 35 40	0.1 10 150 500	10 10 10	0.6 2.0	1.3	150 500	9	150	50				20
BSY54	TO-5	75	30	7	10	60	35 75 100 40	0.1 10 150 500	10 10 10	0.6 2.0	1.3	150 500	9	150	50				20
BSY95A	TO-18	20	15	5	50	16	30 50	1 200	0.35 0.35	0.35	0.87	10	6	200	10				21

Test Conditions:

- I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, BW = 200 Hz
- I_C = 30 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 20 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 150 Hz
- I_C = 200 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 20 Hz to 15 kHz
- I_C = 100 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 10 Hz to 10 kHz
- I_C = 50 μA, V_{CE} = 5V, R_S = 10 kΩ, BW = 15 kHz
- I_C = 50 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 150 μA, V_{CE} = 10V, I_{B1} = I_{B2} = 15 mA
- I_C = 10 μA, V_{CE} = 5V, R_S = 10 Ω, WB
- I_C = 150 μA, V_{CE} = 10V, I_{B1} = I_{B2} = 20 mA
- I_C = 10 mA, I_{B1} = 3 mA, I_{B2} = 1 mA
- I_C = 100 μA, I_{B1} = 40 mA, I_{B2} = 20 mA
- I_C = 10 mA, I_{B1} = 1 mA, I_{B2} = -1 mA
- I_C = 100 μA, V_{CE} = 5V, I_{B1} = 1 mA, I_{B2} = -1 mA
- I_C = 300 μA, I_{B1} = I_{B2} = 30 mA, V_{CE} = 25V
- I_C = 100 μA, V_{CE} = 5V, R_S = 2 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 200 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 200 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 200 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 1 kHz, BW = 200 Hz
- I_C = 100 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 10 Hz to 10 kHz
- I_C = 100 μA, V_{CE} = 5V, R_S = 10 kΩ, f = 10 Hz to 10 kHz
- I_C = 150 μA, V_{CE} = 5V, I_{B1} = I_{B2} = 15 mA
- I_C = 20V, I_C = 100 mA, I_{B1} = I_{B2} = 5 mA



HIGH VOLTAGE

NPN Transistors

Type No.	Case Style	V _{CBO} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V)	h _{FE} Min	I _C (mA) Max	V _{CE} (V) &	V _{CE(sat)} (V) Max	V _{BE(sat)} (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3498	TO-30	100	100	6	50	50	20	0.1	10	0.2	0.8	10	10	150	20				08
2N3499	TO-39	100	100	6	50	50	25	1	10	0.25	0.9	50							08
							35	10	10	0.6	1.4	300							
2N3500	TO-39	150	150	6	50	75	35	0.1	10	0.2	0.8	10	10	150	20				08
							75	10	10	0.25	0.9	50							
2N3501	TO-39	150	150	6	50	75	40	10	10	0.25	0.9	50	8	150	20				08
							40	120	150	0.4	1.2	150							
2N5550	TO-92	160	140	6	100	100	60	1	5	0.15	1	10	6	100	300	10	10	1	16
							60	250	10	0.25	1.2	50							
2N5551	TO-92	180	160	6	50	120	80	1	5	0.15	1	10	6	100	300	10	8	1	16
							80	250	10	0.2	1	50							
MPSA42	TO-92	300	300	8	100	200	25	1	10	0.5	0.9	20	3	50	10				48
							40	10	10										
MPSA43	TO-92	200	200	6	100	160	25	1	10	0.4	0.9	20	4	50	10				48
							40	10	10										
MPSL01	TO-92	140	120	5	100	75	50	300	5	0.2	1.2	10	8	60	10				15
							40	30	20	0.3	1.4	50							
SE7056	TO-39	300	300	7	100	200	20	1	20	1	0.85	20	3	50	15				48
							40	10	20										
SP7056	X51D(36)	300	300	7	100	200	20	1	20	1	0.85	20	3	50	15				48

1. V_{CE} = 5V, I_C = 250 mA
R_S = 1 kΩ, WB



HIGH VOLTAGE

PNP Transistors

Type No.	Case Style	V _{CEO} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CBO} (nA) Max	V _{CB} (V) Min	h _{FE} Min	h _{FE} Max	I _C @ (mA) Max	V _{CE} (V) & V _{CE} (V)	V _{CE(sat)} (V) & V _{BE(sat)} (V) Max Min	I _C @ (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Condition	Process No.
2N3634	TO-39	140	140	5	100	100	40	45	0.1	10	0.3	0.8	10	10	30	600		1	73
							50	10	1	10	0.5	0.65	0.9	50					
							50	150	10	10									
							25	150	10	10									
2N3635	TO-39	140	140	5	100	100	80	80	0.1	10	0.3	0.8	10	10	30	600		1	73
							90	1	10	10	0.5	0.65	0.9	50					
							100	300	10	10									
							100	300	10	10									
							50	150	10	10									
2N3636	TO-39	175	175	5	100	100	40	40	0.1	10	0.3	0.8	10	10	30	600		1	73
							45	1	10	10	0.5	0.65	50						
							50	10	10	10									
							50	150	10	10									
							25	150	10	10									
2N3637	TO-39	175	175	5	100	100	80	80	0.1	10	0.3	0.8	10	10	30	600		1	73
							90	1	10	10	0.5	0.65	0.9	50					
							100	300	10	10									
							100	300	10	10									
							50	150	10	10									
2N5400	TO-92	130	120	5	100	100	30	30	1	5	0.2	1	10	6	100	400	8	2	74
							40	180	10	5	0.5	1	50						
							40	50	5	5									
							40	50	5	5									
2N5401	TO-92	160	150	5	50	120	50	50	1	5	0.2	1	10	6	100	300	8	2	74
							60	240	10	5	0.5	1	50						
							50	50	5	5									
							40	250	50	5	0.25	1.2	10	8	60				
MPSL5	TO-92	100	100	4	1μA	50	40	40	50	5	0.3	1.2	50						

1. V_{CC} = 100V
I_C = 50 mA
I_{B1} = I_{B2} = 5 mA

2. V_{CE} = 5V, I_C = 250 mA
R_S = 1 kΩ, R_B



DH3467C Quad PNP Core Driver

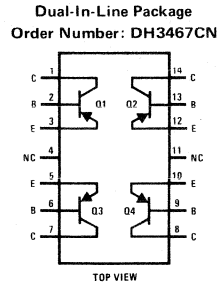
DESCRIPTION

The DH3467C consists of four 2N3467 type PNP transistors mounted in a 14-pin molded dual-in-line package. The device is primarily intended for core memory application requiring operating currents in the ampere range, high stand-off voltage, and fast turn-on and turn-off times.

TYPICAL CHARACTERISTICS

Turn-ON Time	18 ns
Turn-OFF Time	45 ns
Collector Current	1A
Collector-Base Breakdown Voltage	120V typ.
Collector Saturation Voltage at $I_C = 1A$	0.55V
Collector Saturation Voltage at $I_C = 0.5A$	0.31V

CONNECTION DIAGRAM



SWITCHING TIME TEST CIRCUITS

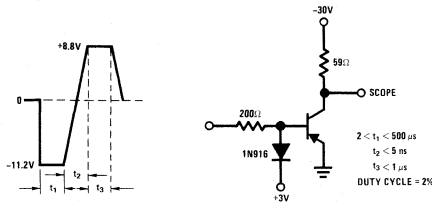


FIGURE 1. t_{on} Equivalent Test Circuit

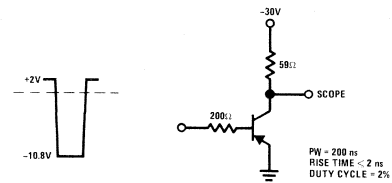


FIGURE 2. t_{off} Equivalent Test Circuit

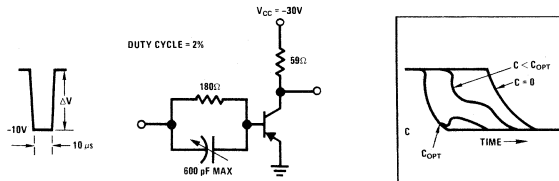


FIGURE 3. Q_T Test Circuit

ABSOLUTE MAXIMUM RATINGS

Collector to Base Voltage	40V
Collector to Emitter Voltage	40V
Collector to Emitter Voltage (Note)	40V
Emitter to Base Voltage	5V
Collector Current – Continuous	1.0A
Power Dissipation ($T_A = 25^\circ C$) (each device)	0.85W
Power Dissipation ($T_A = 25^\circ C$) (total package)	2.5W
Operating Junction Temperature	150°C Max
Operating Temperature Range	0°C to +85°C
Storage Temperature Range	-65°C to +150°C
Lead Temperature (Soldering, 10 sec.)	300°C

Note 1: Pulsed test, PW = 300μs, duty cycle = 1%

DH3467C

ELECTRICAL CHARACTERISTICS (T_A = 25°C, unless otherwise specified)

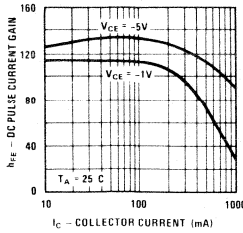
PARAMETER	CONDITIONS	LIMITS		UNITS
		MIN	MAX	
Collector to Base Breakdown Voltage (BV _{CBO})	I _C = 10 μA I _E = 0	-40		V
Emitter to Base Breakdown Voltage (BV _{EBO})	I _E = 10 μA I _C = 0	-5.0		V
Collector to Emitter Breakdown Voltage (Note 1) (BV _{CEO})	I _C = 10 mA I _B = 0	-40		V
DC Pulse Current Gain (Note 1) (h _{FE})	I _C = 150 mA V _{CE} = -1.0V	40		
DC Pulse Current Gain (Note 1) (h _{FE})	I _C = 500 mA V _{CE} = -1.0V	40	120	
DC Pulse Current Gain (Note 1) (h _{FE})	I _C = 1.0A V _{CE} = -5.0V	40		
Pulsed Collector Saturation Voltage (Note 1) (V _{CE(sat)})	I _C = 150 mA I _B = 15 mA		-0.30	V
Pulsed Collector Saturation Voltage (Note 1) (V _{CE(sat)})	I _C = 500 mA I _B = 50 mA		-0.50	V
Pulsed Collector Saturation Voltage (Note 1) (V _{CE(sat)})	I _C = 1.0A I _B = 100 mA		-1.0	V
Pulsed Base Saturation Voltage (Note 1) (V _{BE(sat)})	I _C = 150 mA I _B = 15 mA		-1.0	V
Pulsed Base Saturation Voltage (Note 1) (V _{BE(sat)})	I _C = 500 mA I _B = 50 mA	-0.8	-1.2	V
Pulsed Base Saturation Voltage (Note 1) (V _{BE(sat)})	I _C = 1.0A I _B = 100 mA		-1.6	V
Collector Cutoff Current (I _{CBO})	V _{CB} = -30V I _B = 0		100	nA
Collector Cutoff Current (I _{CBO(100°C)})	V _{CB} = -30V I _B = 0		15	μA
Collector Cutoff Current (I _{CEX})	V _{CB} = -30V V _{EB} = -3.0V		100	nA
Base Cutoff Current (I _{BL})	V _{CB} = -30V V _{EB} = -3.0V		120	nA
Total Control Charge (Figure 3) (Q _T)	i _C = 500 mA i _B = 50 mA		6.0	nC
Turn On Delay Time (Figure 1) (t _d)	I _C = 500 mA I _{B1} = 50 mA		10	ns
Rise Time (Figure 1) (t _r)	I _C = 500 mA I _{B1} = 50 mA		30	ns
Storage Time (Figure 2) (t _s)	I _C = 500 mA I _{B1} = I _{B2} = 50 mA		60	ns
Fall Time (Figure 2) (t _f)	I _C = 500 mA I _{B1} = I _{B2} = 50 mA		30	ns
Output Capacitance (f = 100 kHz) (C _{ob})	I _E = 0 V _{CB} = -10V		25	pF
Input Capacitance (f = 100 kHz) (C _{ib})	I _C = 0 V _{CB} = -0.5V		100	pF
High Frequency Current Gain (f = 100 MHz) (h _{fe})	I _C = 50 mA V _{CE} = 10V	1.75		

Note 1: Pulsed test, PW = 300μs, duty cycle = 1%

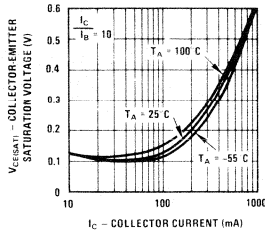
TYPICAL PERFORMANCE CHARACTERISTICS

DH3467C

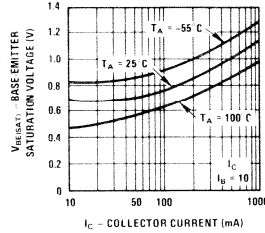
DC Pulse Current Gain vs Collector Current



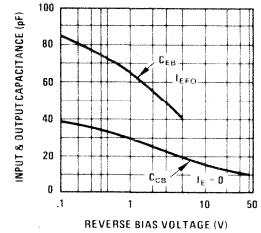
Collector-Emitter Saturation Voltage vs Collector Current



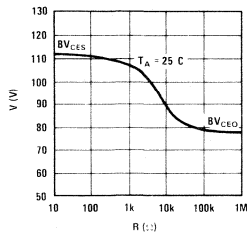
Base-Emitter Saturation Voltage vs Collector Current



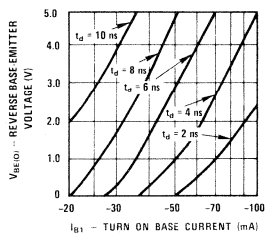
Input & Output Capacitance vs Reverse Bias Voltage



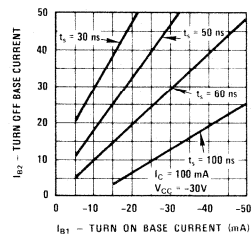
**BVCES vs RBE
IC = 10 mA**



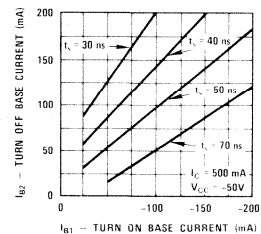
Delay Time vs Turn On Base Current and Reverse Base Emitter Voltage



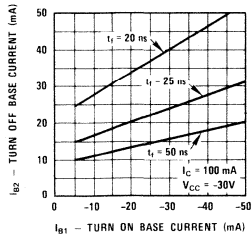
Storage Time vs Turn On and Turn Off Base Currents



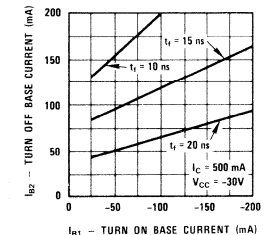
Storage Time vs Turn On and Turn Off Base Currents



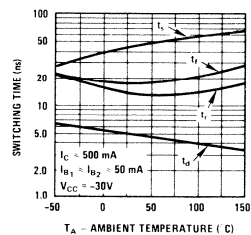
Fall Time vs Turn On and Turn Off Base Currents



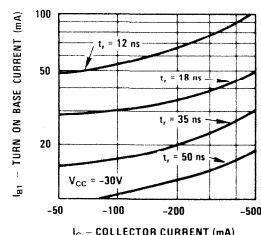
Fall Time vs Turn On and Turn Off Base Currents



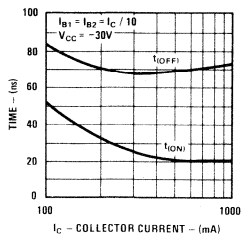
Switching Times vs Ambient Temperature



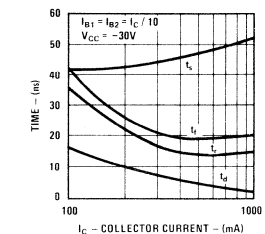
Rise Time vs Collector Current and Turn On Base Current



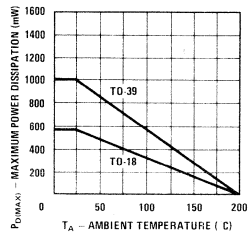
Turn On and Turn Off Times vs Collector Current



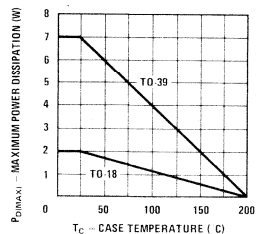
Switching Times vs Collector Current



Maximum Power Dissipation vs Ambient Temperature



Maximum Power Dissipation vs Case Temperature



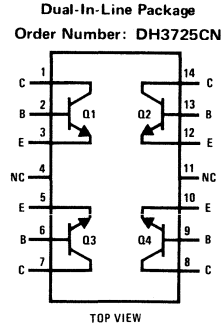


DH3725C Quad NPN Core Driver

DESCRIPTION

The DH3725C consists of four 2N3725 type NPN transistors mounted in a 14-pin molded dual-in-line package. The device is primarily intended for core memory application requiring operating currents in the ampere range, high stand-off voltage, and fast turn-on and turn-off times.

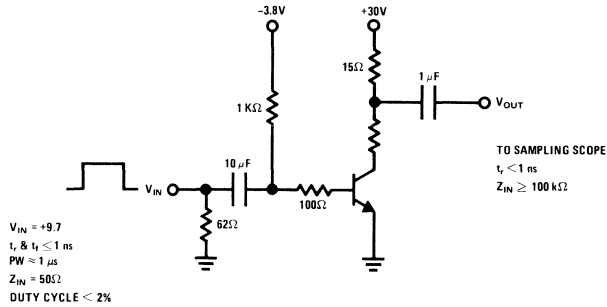
CONNECTION DIAGRAM



TYPICAL CHARACTERISTICS

Turn-ON Time	18 ns
Turn-OFF Time	45 ns
Collector Current	1A
Collector-Base Breakdown Voltage	120V typ.
Collector Saturation Voltage at $I_C = 1A$	0.55V
Collector Saturation Voltage at $I_C = 0.5A$	0.31V

SWITCHING TIME TEST CIRCUIT



$$I_C \approx 500 \text{ mA}, I_{B1} \approx 50 \text{ mA}, I_{B2} \approx -50 \text{ mA}$$

ABSOLUTE MAXIMUM RATINGS

Collector to Base Voltage	80V
Collector to Emitter Voltage	80V
Collector to Emitter Voltage (Note)	50V
Emitter to Base Voltage	6V
Collector Current — Continuous	1.0A
Power Dissipation ($T_A = 25^\circ\text{C}$)	0.6W
Power Dissipation ($T_C = 25^\circ\text{C}$)	1.5W
Operating Junction Temperature	150°C Max
Operating Temperature Range	0°C to +85°C
Storage Temperature Range	-65°C to +150°C
Lead Temperature (Soldering, 10 sec.)	300°C

Note: Ratings refer to a high-current point where collector-to-emitter voltage is lowest.

ELECTRICAL CHARACTERISTICS

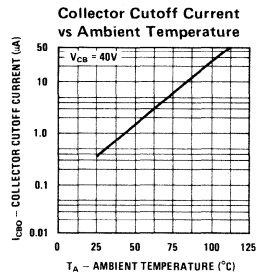
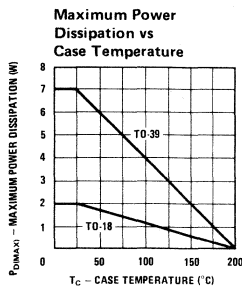
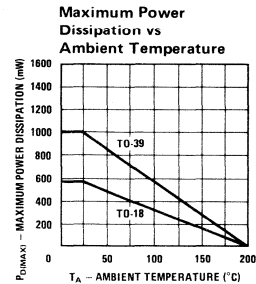
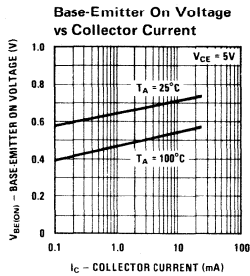
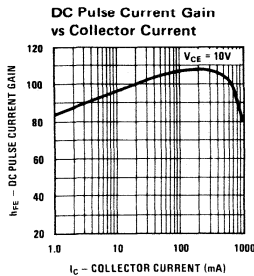
Each transistor ($T_A = 25^\circ\text{C}$, unless otherwise specified)

DH3725C

PARAMETER	CONDITIONS	LIMITS			UNITS
		MIN	TYP	MAX	
Collector to Emitter Sustaining Voltage (V_{CE0} (sust))	$I_C = 10\text{ mA}, I_B = 0$	50			V
Collector to Emitter Breakdown Voltage (BV_{CES})	$I_C = 10\ \mu\text{A}, V_{BE} = 0$	80			V
Collector to Base Breakdown Voltage (BV_{CBO})	$I_C = 10\ \mu\text{A}, I_E = 0$	80			V
Emitter to Base Breakdown Voltage (BV_{EBO})	$I_C = 0, I_E = 10\ \mu\text{A}$	6.0			V
Collector Saturation Voltage ($V_{CE(Sat)}$) (Note 1)	$I_C = 1\text{ A}, I_B = 100\text{ mA}$		0.55	0.95	V
	$I_C = 0.5\text{ A}, I_B = 50\text{ mA}$		0.31	0.52	V
	$I_C = 0.1\text{ A}, I_B = 10\text{ mA}$		0.19	0.26	V
DC Pulse Current Gain (h_{FE}) (Note 1)	$I_C = 1\text{ A}, V_{CE} = 5\text{ V}$	25	65		
	$I_C = 0.5\text{ A}, V_{CE} = 1\text{ V}$	35	45		
	$I_C = 0.1\text{ A}, V_{CE} = 1\text{ V}$	60	90	150	
Base Saturation Voltage ($V_{BE(Sat)}$) (Note 1)	$I_C = 1\text{ A}, I_B = 100\text{ mA}$		1.10	1.70	V
	$I_C = 0.5\text{ A}, I_B = 50\text{ mA}$		0.95	1.20	V
	$I_C = 0.1\text{ A}, I_B = 10\text{ mA}$		0.75	0.86	V
Collector Cutoff Current (I_{CBO})	$I_E = 0, V_{CB} = 60\text{ V}$		0.33	1.70	μA
Turn-ON Time	$I_C = 0.5\text{ A}, I_{B1} = 50\text{ mA}$ (See test circuit)		18	30	ns
Turn-OFF Time	$I_C = 0.5\text{ A}, I_{B1} = 50\text{ mA}$ $I_{B2} = 50\text{ mA}$ (See test circuit)		45	60	ns
High Frequency Current Gain	$f = 100\text{ MHz}, I_C = 50\text{ mA}, V_{CE} = 10\text{ V}$	2.5	4.5		
Common Base, Open Circuit, Output Capacitance	$I_E = 0, V_{CB} = 10\text{ V}$		4.8	10	pF
Common Base, Open Circuit, Input Capacitance	$I_C = 0, V_{BE} = 0.5\text{ V}$		40	55	pF

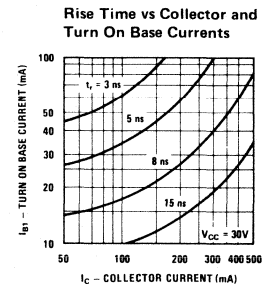
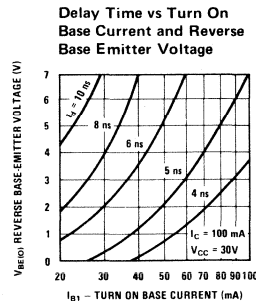
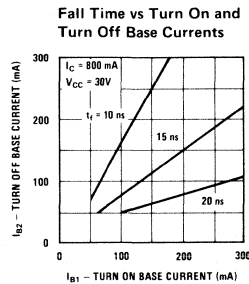
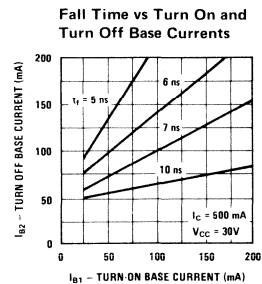
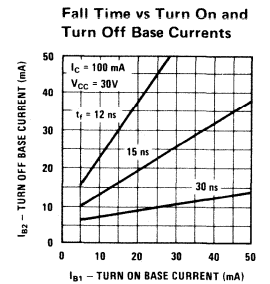
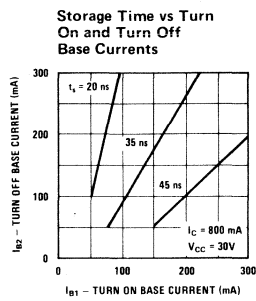
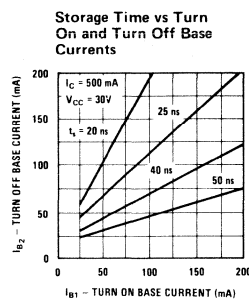
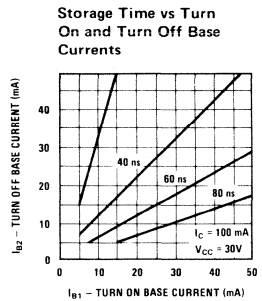
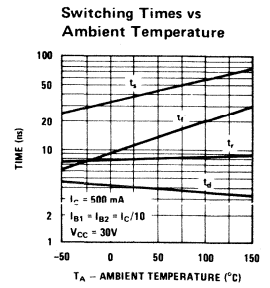
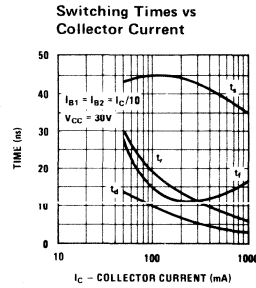
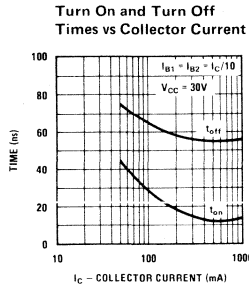
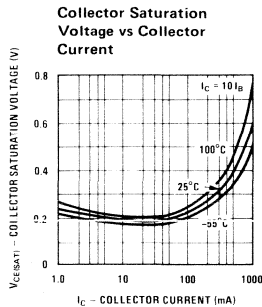
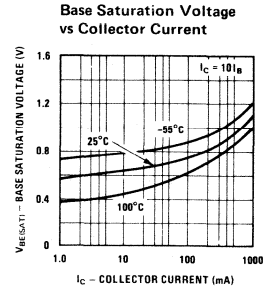
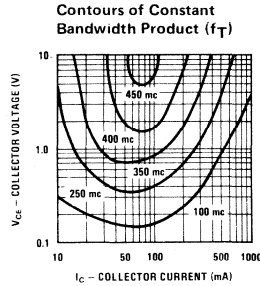
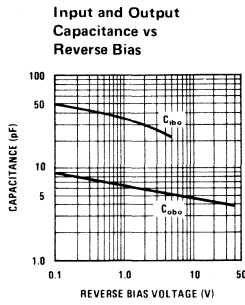
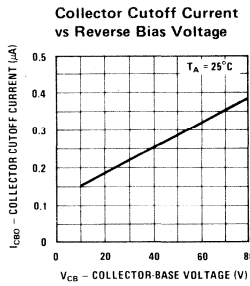
Note 1: Pulse conditions: Length = 300 μs , duty cycle = 1%.

TYPICAL PERFORMANCE CURVES (each transistor)



TYPICAL PERFORMANCE CURVES (each transistor)

DH3725C





Process 1A NPN Power

DESCRIPTION

This device is a single diffused, mesa transistor.

APPLICATION

This device is designed for use in regulator, power switching, solenoid driver, and general purpose amplifier circuits.

PRIME JEDEC TYPES:

2N3054

PARAMETER	TEST CONDITIONS ($T_C = 25^\circ\text{C}$)	MIN	TYP	MAX	UNITS
h_{FE}	$I_C = 0.5 \text{ A}, V_{CE} = 4.0\text{V}$	25	50		
h_{FE}	$I_C = 3.0 \text{ A}, V_{CE} = 4.0\text{V}$	5	12		
$V_{BE(ON)}$	$I_C = 1.5 \text{ A}, V_{CE} = 4.0\text{V}$		1.5	2.2	V
$V_{CE(SAT)}$	$I_C = 0.5 \text{ A}, I_B = .05 \text{ A}$.5	1.0	V
$V_{CE(SAT)}$	$I_C = 1.5 \text{ A}, I_B = .15 \text{ A}$		1.0	1.5	V
I_{CEO}	$V_{CE} = 30\text{V}$.1	1.0	mA
I_{CEX}	$V_{CE} = 90\text{V}, V_{EB} = 1.5\text{V}$.1	1.0	mA
I_{EBO}	$V_{EB} = 7.0\text{V}$.02	1.0	mA
$V_{CEO(SUS)}$	$I_C = 100 \text{ mA}$	40	60		V
$V_{CEX(SUS)}$	$I_C = 100 \text{ mA}, V_{EB} = 1.5\text{V}$	50	95		V
V_{EBO}	$I_B = -1.0 \text{ mA}$	7			V
POWER TEST	$t = 1 \text{ sec}$	25			W
f_T	$I_C = 200 \text{ mA}, V_{CE} = 4.0\text{V}$.8		MHz



Process 1B NPN Power

DESCRIPTION

This device is a single diffused, mesa transistor.

APPLICATION

This device is designed for use in regulator, power switching, solenoid driver, and general purpose amplifier circuits.

PRIME JEDEC TYPES:

2N3055, 2N6253

PARAMETER	TEST CONDITIONS ($T_C = 25^\circ\text{C}$)	MIN	TYP	MAX	UNIT
h_{FE}	$I_C = 4.0 \text{ A}, V_{CE} = 4.0\text{V}$	15	33		
h_{FE}	$I_C = 100 \text{ mA}, V_{CE} = 4.0\text{V}$		56		
$V_{BE(ON)}$	$I_C = 4.0 \text{ A}, V_{CE} = 4.0\text{V}$			1.8	V
$V_{CE(SAT)}$	$I_C = 4.0 \text{ A}, I_B = 0.4 \text{ A}$.5	1.1	V
$V_{CE(SAT)}$	$I_C = 15.0 \text{ A}, I_B = 5.0 \text{ A}$			4	V
I_{CEO}	$V_{CE} = 30\text{V}$			1.8	mA
I_{CEX}	$V_{CE} = 55\text{V}, V_{EB} = 1.5\text{V}$.1	2.0	mA
I_{EBO}	$V_{EB} = 7.0\text{V}$.02	5.0	mA
$V_{CEO(SUS)}$	$I_C = 200 \text{ mA}$	45	80		V
$V_{CEX(SUS)}$	$I_C = 100 \text{ mA}, V_{EB} = 1.5\text{V}$	55	100		V
V_{EBO}	$I_B = -5.0 \text{ mA}$	7			V
POWER TEST	$t = 1 \text{ sec}, V_{CE} = 45\text{V}$	117			W
f_T	$I_C = 1.0 \text{ A}, V_{CE} = 4\text{V}$.8		MHz



Process 1C NPN Power

DESCRIPTION

This device is a single diffused, mesa transistor.

APPLICATION

This device is designed for use in regulator, power switching, solenoid driver, and general purpose amplifier circuits.

PRIME JEDEC TYPES:

2N3442, 2N4347

PARAMETER	TEST CONDITIONS ($T_C = 25^\circ\text{C}$)	MIN	TYP	MAX	UNIT
h_{FE}	$I_C = 3\text{ A}, V_{CE} = 4.0\text{V}$	13	25		
h_{FE}	$I_C = 100\text{ mA}, V_{CE} = 4.0\text{V}$		70		
$V_{BE(ON)}$	$I_C = 3.0\text{ A}, V_{CE} = 4.0\text{V}$		1	2	V
$V_{CE(SAT)}$	$I_C = 3.0\text{ A}, I_B = .3\text{ A}$.6	1	V
$V_{CE(SAT)}$					
I_{CEO}	$V_{CE} = 100\text{V}$			200	mA
I_{CEX}	$V_{CE} = 125\text{V}, V_{EB} = 1.5\text{V}$.1	2.0	mA
I_{EBO}	$V_{EB} = 7.0\text{V}$.02	5.0	mA
$V_{CEO(SUS)}$	$I_C = 200\text{ mA}$	120	150		V
$V_{CEX(SUS)}$	$I_C = 100\text{ mA}, V_{EB} = 1.5\text{V}$	140	165		V
V_{EBO}	$I_B = -5.0\text{ mA}$	7			V
POWER TEST	$t = 1\text{ sec.}, I_C = 1.5\text{A}$	100	117		W



Process 1D NPN Power

DESCRIPTION

This device is a single diffused, mesa transistor.

APPLICATION

This device is designed for use in regulator, power switching, solenoid driver, and general purpose amplifier circuits.

PRIME JEDEC TYPES:

2N3771, 2N3772

PARAMETER	TEST CONDITIONS ($T_C = 25^\circ\text{C}$)	MIN	TYP	MAX	UNIT
h_{FE}	$I_C = 20\text{ A}, V_{CE} = 4\text{V}$	5	10		
h_{FE}	$I_C = 10\text{ A}, V_{CE} = 4\text{V}$	15	25		
$V_{BE(ON)}$	$I_C = 10\text{ A}, V_{CE} = 4\text{V}$		1.5	2.2	V
$V_{CE(SAT)}$	$I_C = 10\text{ A}, I_B = 1.0\text{ A}$.7	1.4	V
$V_{CE(SAT)}$	$I_C = 20\text{ A}, I_B = 4.0\text{ A}$		1.5	4.0	V
I_{CEO}	$V_{CE} = 30\text{V}$			10	mA
I_{CEX}	$V_{CE} = 50\text{V}, V_{EB} = 1.5\text{V}$.1	2.0	mA
I_{EBO}	$V_{EB} = 7\text{V}$.02	5.0	mA
$V_{CEO(SUS)}$	$I_C = 200\text{ mA}$	40	70		V
$V_{CEX(SUS)}$	$I_C = 200\text{ mA}, V_{EB} = 1.5\text{V}$	50	90		V
V_{EBO}	$I_B = -5.0\text{ mA}$	7.0			V
POWER TEST	$t = 1\text{ sec.}, V_{CE} = 40\text{V}$	150			W
f_T	$I_C = 1.0\text{ A}, V_{CE} = 4.0\text{V}$.8		MHz



Process 1E NPN Power

DESCRIPTION

This device is a single diffused, mesa transistor.

APPLICATION

This device is designed for use in regulator, power switching, solenoid driver, and general purpose amplifier circuits.

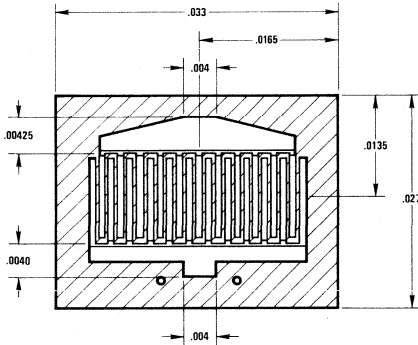
PRIME JEDEC TYPES:

2N3773, 2N4348

PARAMETER	TEST CONDITIONS ($T_C = 25^\circ\text{C}$)	MIN	TYP	MAX	UNIT
h_{FE}	$I_C = 10\text{ A}, V_{CE} = 4.0\text{V}$	10	15		
h_{FE}	$I_C = 5\text{ A}, V_{CE} = 4.0\text{V}$	15	30		
$V_{BE(ON)}$	$I_C = 5\text{ A}, V_{CE} = 4.0\text{V}$		1.0	2.0	V
$V_{CE(SAT)}$	$I_C = 10\text{ A}, I_B = 1.25\text{ A}$.7	2.0	V
$V_{CE(SAT)}$	$I_C = 5\text{ A}, I_B = 0.5\text{ A}$.35	1.0	V
I_{CEO}	$V_{CE} = 100\text{V}$			200	mA
I_{CEX}	$V_{CE} = 120\text{V}, V_{EB} = 1.5\text{V}$.2	2.0	mA
I_{EBO}	$V_{EB} = 7\text{V}$.1	5.0	mA
$V_{CEO(SUS)}$	$I_C = 200\text{ mA}$	120	150		V
$V_{CEX(SUS)}$	$I_C = 100\text{ mA}, V_{EB} = 1.5\text{V}$	140	165		V
V_{EBO}	$I_B = 5.0\text{ mA}$	7			V
POWER TEST	$t = 1\text{ sec.}, I = 1.5\text{ A}$	120	150		W



Process 01 NPN High Speed Switch



DESCRIPTION

Process 01 is an overlay double diffused, gold doped epitaxial device.

APPLICATION

This device was designed for ultra high speed core driver applications where predictable switching speed is a prime consideration.

PRINCIPAL DEVICE TYPES

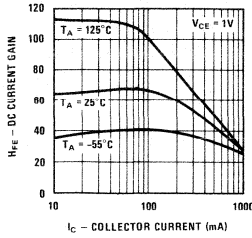
TO-18 2N6375

TO-39 (PKG 17) 2N6376

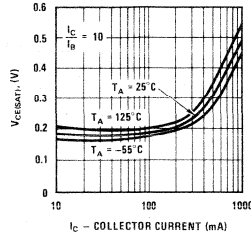
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$V_{CE} = 30V, I_C = 300 \text{ mA}, I_{B1} = 30 \text{ mA}$	10	14	20	ns	
t_{off}	$V_{CE} = 30V, I_C = 300 \text{ mA}, I_{B1} = -I_{B2} = 30 \text{ mA}$	20	27	40	ns	
t_{on}	$V_{CE} = 30V, I_C = 500 \text{ mA}, I_{B1} = 50 \text{ mA}$	8	10	16	ns	
t_{off}	$V_{CE} = 30V, I_C = 500 \text{ mA}, I_{B1} = -I_{B2} = 50 \text{ mA}$	20	28	40	ns	
t_{on}	$V_{CE} = 30V, I_C = 1 \text{ Amp}, I_{B1} = 100 \text{ mA}$	10	14	25	ns	
t_{off}	$V_{CE} = 30V, I_C = 1 \text{ Amp}, I_{B1} = -I_{B2} = 100 \text{ mA}$	15	25	35	ns	
h_{FE}	$V_{CE} = 10V, I_C = 50 \text{ mA}, f = 100 \text{ MHz}$	3.0	4.2			
C_{CB}	$V_{CB} = 10V$		6.5	10	pF	
C_{EB}	$V_{EB} = 0.5V$		55	65	pF	
H_{FE}	$V_{CE} = 1V, I_C = 10 \text{ mA}$	60				
H_{FE}	$V_{CE} = 1V, I_C = 100 \text{ mA}$	60				
H_{FE}	$V_{CE} = 1V, I_C = 300 \text{ mA}$	50				
H_{FE}	$V_{CE} = 1V, I_C = 500 \text{ mA}$	30		90		
H_{FE}	$V_{CE} = 1V, I_C = 1 \text{ Amp}$	20				
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.17	.25	V	
$V_{CE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$		0.22	.35	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.30	.40	V	
$V_{CE(SAT)}$	$I_C = 1 \text{ Amp}, I_B = 100 \text{ mA}$		0.49	.55	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.77	0.8	V	
$V_{BE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$	0.8	0.86	0.9	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$	0.85	0.94	1.0	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ Amp}, I_B = 100 \text{ mA}$	0.95	1.08	1.2	V	
I_{CBO}	$V_{CB} = 40V$			0.2	μA	
I_{EBO}	$V_{EB} = 4V$			0.2	μA	
BV_{CBO}	$I_C = 10 \mu A$	75	116		V	
BV_{EBO}	$I_E = 10 \mu A$	6.0	7.6		V	
BV_{CEO}	$I_C = 10 \text{ mA}$	30	40		V	

Process 01

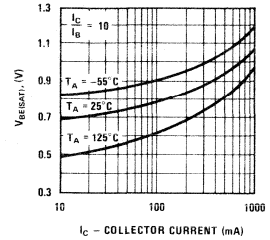
DC Current Gain vs Collector Current



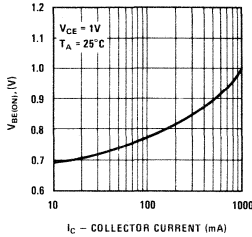
VCE(SAT), Collector Saturation Voltage



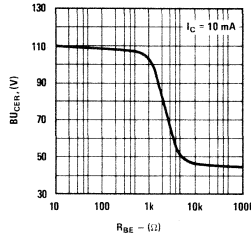
VBE(SAT), Base Saturation Voltage



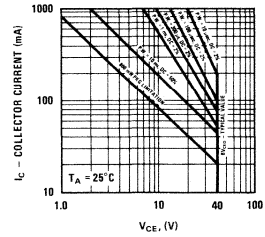
VBE(ON), Base Emitter On Voltage



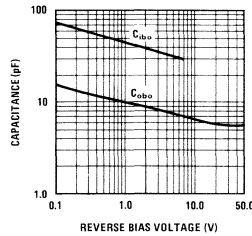
BVCER vs RBE



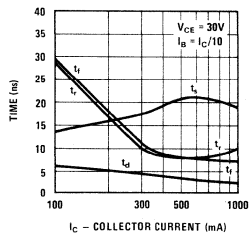
Safe Operating Area



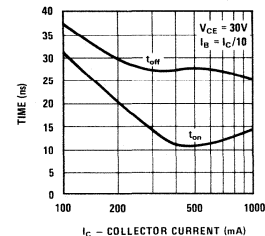
Capacitance vs Reverse Bias Voltage



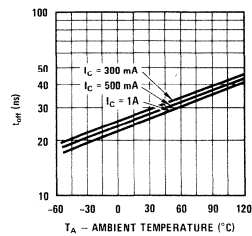
Switching Times vs Collector Current



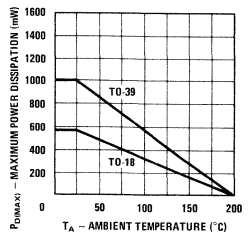
Turn On and Turn Off Times vs Collector Current



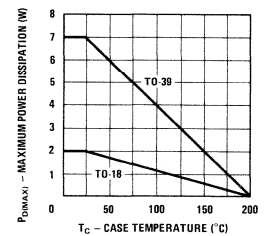
tOff vs Ambient Temperature



Maximum Power Dissipation vs Ambient Temperature

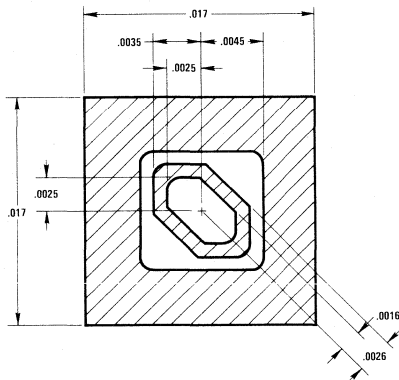


Maximum Power Dissipation vs Case Temperature





Process 04 NPN Small Signal



DESCRIPTION

Process 04 is a non-overlay double diffused silicon epitaxial device. Complement to Process 71.

APPLICATION

This device was designed for low noise, high gain, general purpose amplifier application. From $1 \mu\text{A}$ to 100 mA collector current.

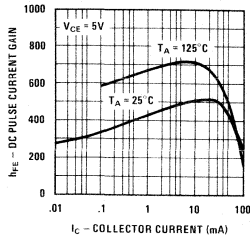
PRINCIPAL DEVICE TYPES:

TO-18 BC107 Series

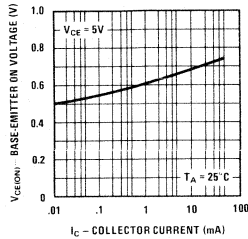
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF (spot)	$I_C = 200 \mu\text{A}$, $V_{CE} = 5\text{V}$ $f = 1 \text{ kHz}$, $R_S = 2\text{k}$		1.0	3.0	dB	TO-18
C_{ob}	$V_{CB} = 10\text{V}$, $f = 1 \text{ MHz}$		2.5	3.0	pF	TO-18
C_{ib}	$V_{EB} = 0.5\text{V}$, $f = 1 \text{ MHz}$		7.0	8.0	pF	TO-18
f_t	$V_{CE} = 5\text{V}$, $I_C = 10 \text{ mA}$	150	250		MHz	
h_{FE}	$V_{CE} = 5\text{V}$, $I_C = 100 \mu\text{A}$	50	250	500		
h_{FE}	$V_{CE} = 5\text{V}$, $I_C = 2 \text{ mA}$	100	400	750		
h_{FE}	$V_{CE} = 5\text{V}$, $I_C = 100 \text{ mA}$	75	250	300		
h_{FE}	$V_{CE} = 1\text{V}$, $I_C = 100 \text{ mA}$	30	100	150		
$V_{CE(sat)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$.040	.080	V	
$V_{CE(sat)}$	$I_C = 100 \text{ mA}$, $I_B = 5 \text{ mA}$.150	.200	V	
$V_{BE(sat)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$.75	.85	V	
BV_{CBO}	$I_C = 10 \mu\text{A}$	115	125		V	
BV_{CEO}	$I_C = 10 \text{ mA}$	45	50		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	8.0	9.0		V	
I_{CBO}	$V_{CB} = 40\text{V}$			10	NA	
I_{EBO}	$V_{EB} = 4\text{V}$			10	NA	

Process 04

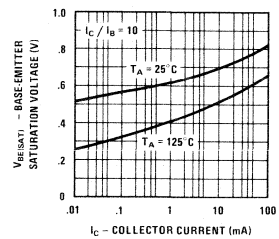
Pulsed DC Current Gain vs Collector Current



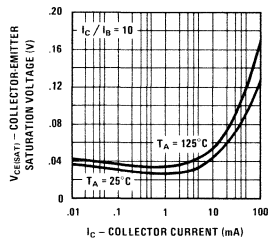
Base-Emitter On Voltage vs Collector Current



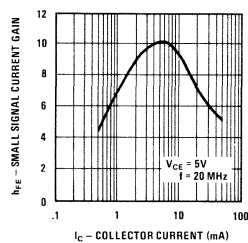
Base-Emitter Saturation Voltage vs Collector Current



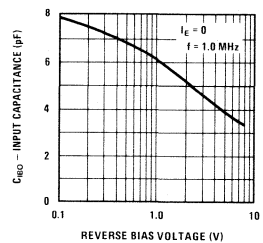
Collector-Emitter Saturation Voltage vs Collector Current



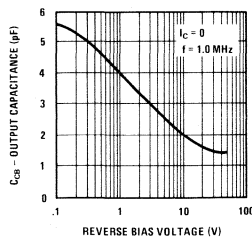
Small Signal Current Gain @ 20 MHz vs Collector Current



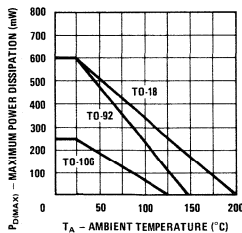
Input Capacitance vs Reverse Bias Voltage



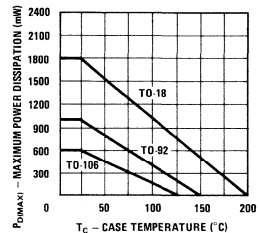
Output Capacitance vs Reverse Bias Voltage



Maximum Power Dissipation vs Ambient Temperature

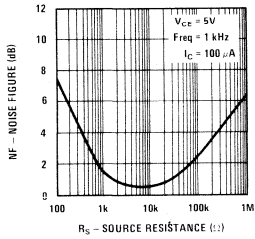


Maximum Power Dissipation vs Case Temperature

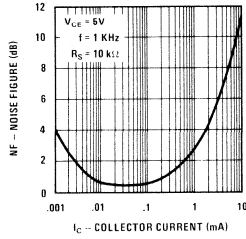


Process 04

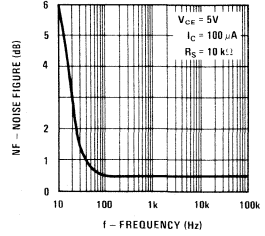
Noise Figure vs Source Resistance



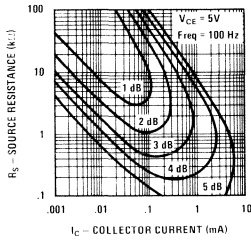
Noise Figure vs Collector Current



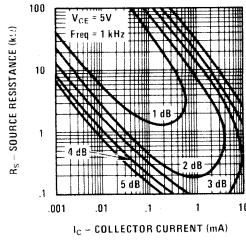
Noise Figure vs Frequency



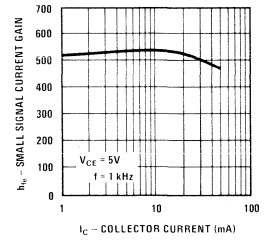
Contours of Constant Narrow Band Noise Figure



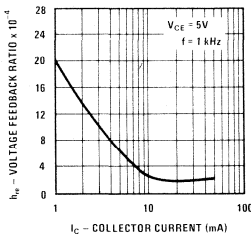
Contours of Constant Narrow Band Noise Figure



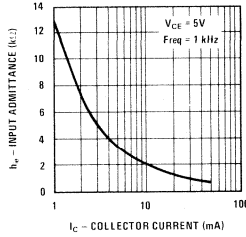
Small Signal Current Gain



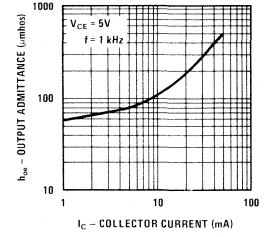
Voltage Feedback Ratio



Input Admittance

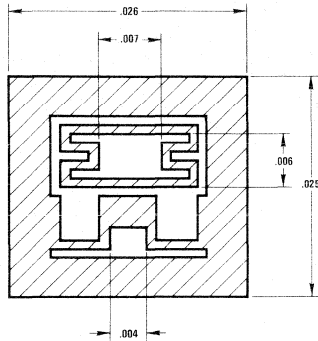


Output Admittance





Process 05 NPN Darlington



DESCRIPTION

Process 05 is a monolithic double diffused, silicon epitaxial Darlington.

APPLICATION

This device is designed for applications requiring extremely high current gain at collector currents to 1 Amp.

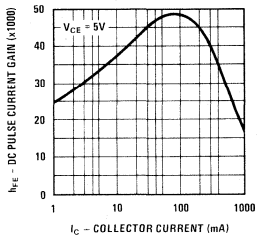
PRINCIPAL DEVICE TYPES:

TO-92, MPS-A12 (EBC), 2N5306 (ECB)

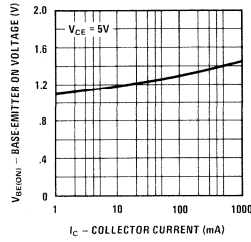
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF	$I_C = 1 \text{ mA}$, $V_{CE} = 5\text{V}$, $R_S = 100 \text{ k}$, $f = 1 \text{ kHz}$		2		dB	
C_{cb}	$V_{CB} = 10\text{V}$, $I_E = 0$, $f = 1 \text{ MHz}$		4	8	pF	
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 5\text{V}$ $I_C = 100 \text{ mA}$, $V_{CE} = 5\text{V}$	20,000 5,000	80,000 100,000	200,000 250,000		
$V_{CE(SAT)}$	10 mA, .01 mA 100 mA, .1 mA			1.0 1.5	V	
$V_{BE(ON)}$	10 mA, 5V 100 mA, 5V		1.2 1.25	1.4 2.0	V	
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 5.0\text{V}$, $f = 1 \text{ kHz}$		80,000			
BV_{CES}	$I_C = 100 \mu\text{A}$	20	45		V	
I_{CES}	$V_{CE} = 15\text{V}$, $V_{BE} = 0$			100	nA	
I_{CBO}	$V_{CB} = 15\text{V}$, $I_E = 0$			100	nA	
I_{EBO}	$V_{EB} = 10\text{V}$, $I_C = 0$			100	nA	

Process 05

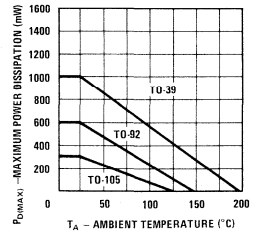
DC Pulse Current Gain vs Collector Current



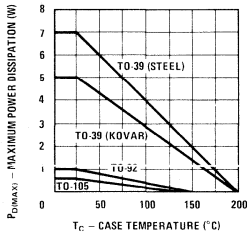
Base-Emitter On Voltage vs Collector Current



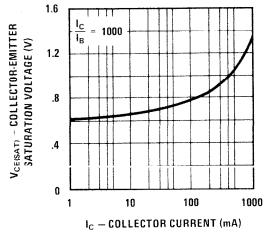
Maximum Power Dissipation vs Ambient Temperature



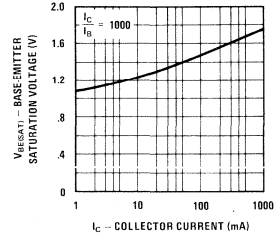
Maximum Power Dissipation vs Case Temperature



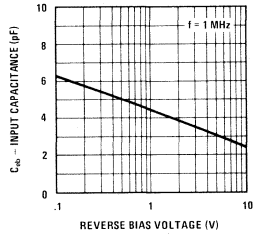
Collector-Emitter Saturation Voltage vs Collector Current



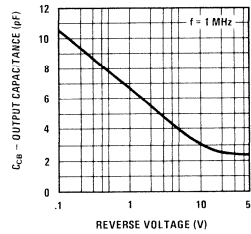
Base-Emitter Saturation Voltage vs Collector Current



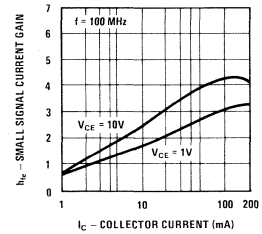
Input Capacitance vs Reverse Bias Voltage



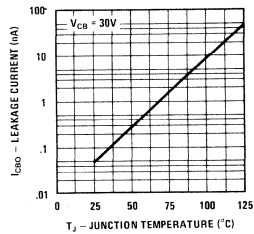
Output Capacitance vs Reverse Bias Voltage



Small Signal Current Gain vs Collector Current

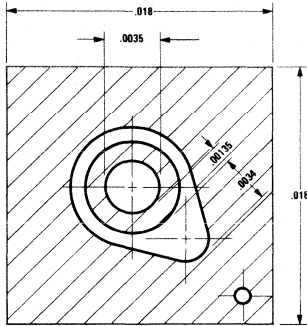


Collector-Base Diode Reverse Current vs Temperature





Process 07 NPN Small Signal



DESCRIPTION

Process 07 a nonoverlay, double diffused, silicon epitaxial device. Complement to Process 62.

APPLICATION

This device was designed for low noise, high gain general purpose amplifier applications. From 1 μ A to 25 mA collector current.

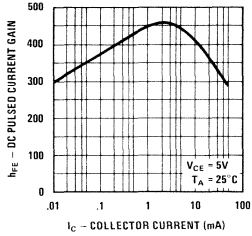
PRINCIPAL DEVICE TYPES:

TO-18	2N930
TO-71	2N2979
TO-78	2N2920
TO-92	2N5088 (EBC), 2N3392 (ECB)
TO-106	2N3565

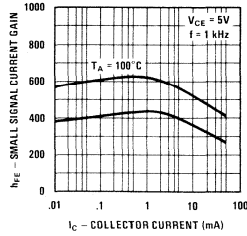
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF (spot)	$I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_S = 10\text{k}$, $f = 100 \text{ Hz}$, $P_{BW} = 20 \text{ Hz}$		3	10	dB	
NF (spot)	$I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_S = 10\text{k}$, $f = 1 \text{ kHz}$, $P_{BW} = 200 \text{ Hz}$		1	3	dB	
NF (spot)	$I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_S = 10\text{k}$, $f = 10 \text{ kHz}$, $P_{BW} = 2 \text{ kHz}$		1	3	dB	
NF (wide band)	$I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$, $R_S = 10\text{k}$, $P_{BW} = 15.7 \text{ kHz}$		1	3	dB	
h_{fe}	$I_C = 500 \mu\text{A}$, $V_{CE} = 5\text{V}$, $f = 20 \text{ MHz}$	5	7			
C_{cb}	$V_{CB} = 5\text{V}$		1.7	2.5	pF	TO-18
C_{eb}	$V_{EB} = 0.50\text{V}$		4.5	6.0	pF	TO-18
h_{FE}	$I_C = 1 \mu\text{A}$, $V_{CE} = 5\text{V}$	20	200	200		
h_{FE}	$I_C = 10 \mu\text{A}$, $V_{CE} = 5\text{V}$	20	300	600		
h_{FE}	$I_C = 100 \mu\text{A}$, $V_{CE} = 5\text{V}$	20	350	800		
h_{FE}	$I_C = 500 \mu\text{A}$, $V_{CE} = 5\text{V}$	20	425	1000		
h_{FE}	$I_C = 1 \text{ mA}$, $V_{CE} = 5\text{V}$	20	450	1000		
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 5\text{V}$	20	425	1000		
$V_{CE(SAT)}$	$I_C = 1 \text{ mA}$, $I_B = 0.10 \text{ mA}$		0.06	0.10	V	
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.08	0.15	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ mA}$, $I_B = 0.1 \text{ mA}$		0.65	0.75	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.70	0.85	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	60			V	
BV_{CBO}	$I_C = 1000 \mu\text{A}$	60			V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	6			V	
I_{CBO}	$V_{CB} = 45\text{V}$			10	nA	
I_{EBO}	$V_{EB} = 4\text{V}$			10	nA	

Process 07

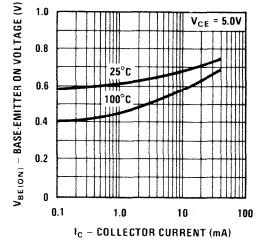
Pulsed DC Current Gain vs Collector Current



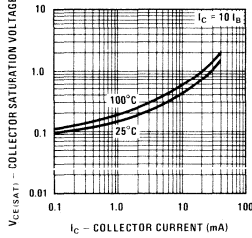
Small Signal Current Gain vs Collector Current



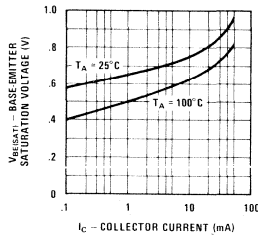
Base-Emitter On Voltage vs Collector Current



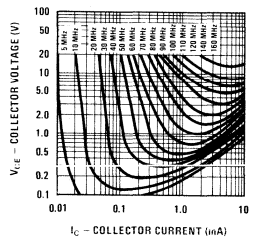
Collector Saturation Voltage vs Collector Current



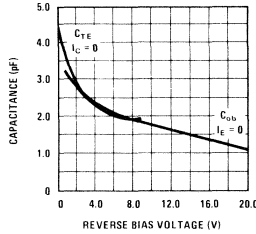
Base-Emitter Saturation Voltage vs Collector Current



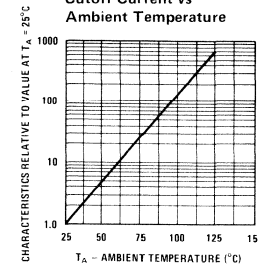
Contours of Constant Gain Bandwidth Product (f_T)



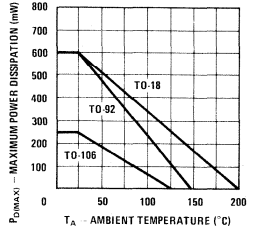
Input and Output Capacitance vs Reverse Bias Voltage



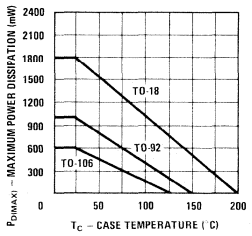
Normalized Collector Cutoff Current vs Ambient Temperature



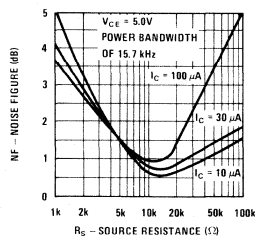
Maximum Power Dissipation vs Ambient Temperature



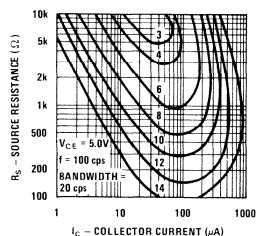
Maximum Power Dissipation vs Case Temperature



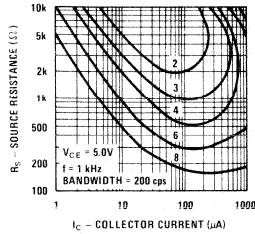
Wide Band Noise Figure vs Source Resistance



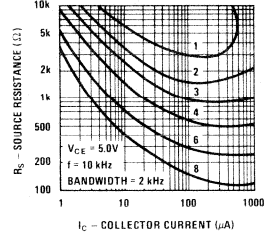
Contours of Constant Narrow Band Noise Figure



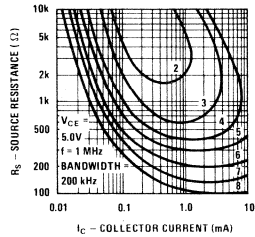
Contours of Constant Narrow Band Noise Figure



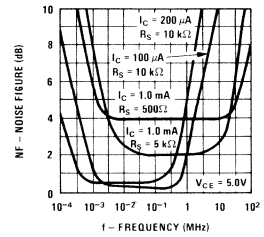
Contours of Constant Narrow Band Noise Figure



Contours of Constant Narrow Band Noise Figure



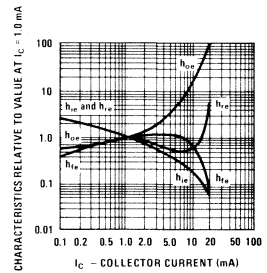
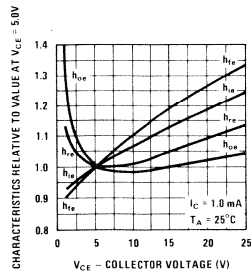
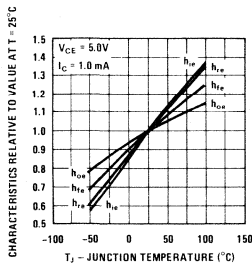
Noise Figure vs Frequency



SMALL SIGNAL CHARACTERISTICS (f = 1.0 kHz)

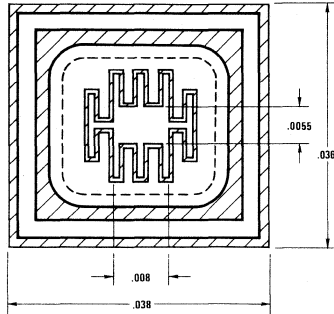
SYMBOL	CHARACTERISTIC	TYP.	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance	15	$k\Omega$	$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0V$
h_{oe}	Output Conductance	15	μmho	$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0V$
h_{re}	Voltage Feedback Ratio	425	$\times 10^{-6}$	$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0V$
h_{fe}	Small Signal Current Gain	400		$I_C = 1.0 \text{ mA}$ $V_{CE} = 5.0V$
h_{ib}	Input Resistance	27	ohms	$I_C = 1.0 \text{ mA}$ $V_{CB} = 5.0V$

TYPICAL COMMON EMITTER CHARACTERISTICS (f = 1.0 kHz)





Process 08 NPN High Voltage



DESCRIPTION

Complements Process 73.

APPLICATION

This device was designed as a general purpose amplifier and switch for applications requiring high line voltages.

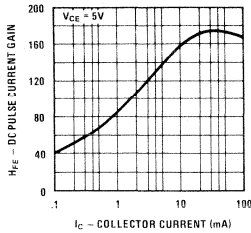
PRINCIPAL DEVICE TYPES:

TO-39 2N3501

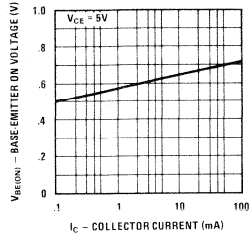
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
BV_{CEO}	I_C at 10 mA	100	160		V	
BV_{CRO}	I_C at 10 μ A	100	200		V	
BV_{EBO}	I_E at 10 μ A	6	7.5		V	
I_{CBO}	V_{CB} at 50V			50	nA	
I_{EBO}	V_{EB} at 4V			25	nA	
H_{FE}	I_C at 0.1 mA, V_{CE} at 10V	20	40			
H_{FE}	I_C at 1 mA, V_{CE} at 10V	25	70			
H_{FE}	I_C at 10 mA, V_{CE} at 10V	35	95			
H_{FE}	I_C at 150 mA, V_{CE} at 10V	40	100	300		
H_{FE}	I_C at 300 mA, V_{CE} at 10V	15	40			
$V_{CE(SAT)}$	I_C at 150 mA, I_B at 15 mA		0.25	0.4	V	
$V_{BE(SAT)}$	I_C at 150 mA, I_B at 15 mA		0.9	1.2	V	
C_{OB}	V_{CB} at 10V		7.5	10	pF	
C_{IB}	V_{EB} at 0.5V		65	80	pF	
FT	I_C at 20 mA, V_{CE} at 20V, f at 100 MHz	150	200		MHz	

Process 08

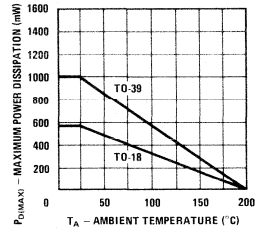
DC Pulse Current Gain vs Collector Current



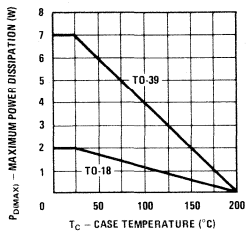
Base-Emitter On Voltage vs Collector Current



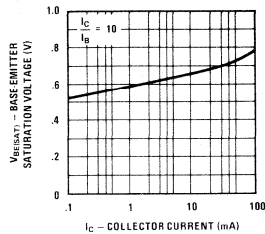
Maximum Power Dissipation vs Ambient Temperature



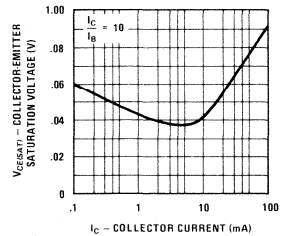
Maximum Power Dissipation vs Case Temperature



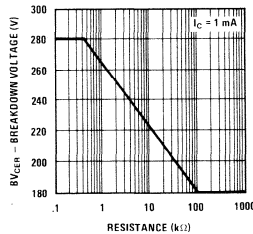
Base-Emitter Saturation Voltage vs Collector Current



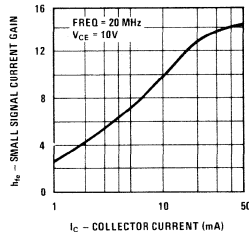
Collector-Emitter Saturation Voltage vs Collector Current



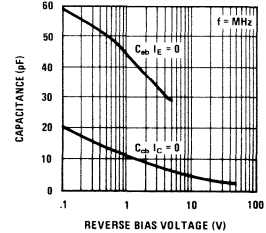
Collector-Emitter Break-down Voltage With Resistance Between Emitter and Base



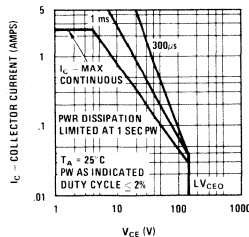
Small Signal Current Gain vs Collector Current



Input and Output Capacitance vs Reverse Bias Voltage

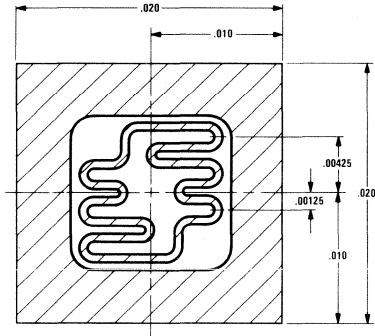


Safe Operating Area TO-39 With "Wake Field" Type 296-4 Heat Sink





Process 09 NPN Medium Power



DESCRIPTION

Process 09 is a nonoverlay double diffused silicon epitaxial device.

APPLICATION

This device was designed for general purpose audio amplifier applications at collector currents to one Amp.

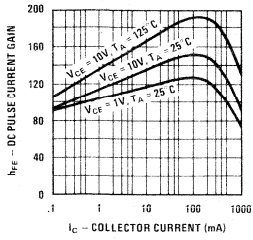
PRINCIPAL DEVICE TYPES:

TO-105 CS9013

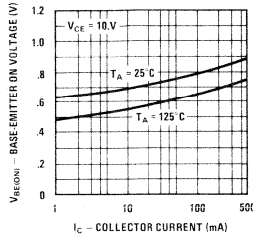
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
C_{OB}	$V_{CB} = 10V$		5	10	pF	
C_{iB}	$V_{EB} = .5V$		25	35	pF	
NF	$V_{CE} = 10V, I_C = 1 \text{ mA}$		1.0		dB	
f_T	$R_S = 1k, f = 1 \text{ kHz}$ $V_{CE} = 10V, I_C = 100 \text{ mA}$		400		MHz	
h_{FE}	$V_{CE} = 1.0V, I_C = 1 \text{ mA}$	25	120	250		
h_{FE}	$V_{CE} = 1.0V, I_C = 50 \text{ mA}$	40	130	350		
h_{FE}	$V_{CE} = 1.0V, I_C = 500 \text{ mA}$	25	100	150		
h_{FE}	$V_{CE} = 1.0V, I_C = 1A$	15	80	100		
$V_{CE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$.09		V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$.24		V	
$V_{BE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$.86		V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		1.0		V	
BV_{CBO}	$I_C = 1 \text{ mA}$		100			
BV_{CEO}	$I_C = 10 \text{ mA}$	25	30			
BV_{EBO}	$I_E = 1 \mu A$		7.5			
I_{CBO}	$V_{CB} = 40V$			50	nA	
I_{EBO}	$V_{EB} = 4.0V$			50	nA	

Process 09

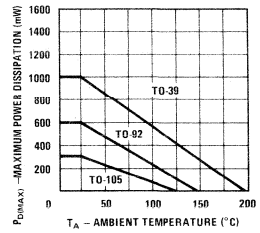
DC Pulse Current Gain vs Collector Current



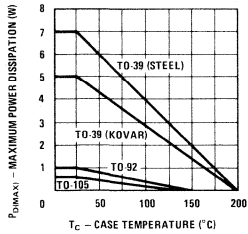
Base-Emitter On Voltage vs Collector Current



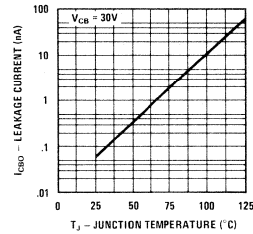
Maximum Power Dissipation vs Ambient Temperature



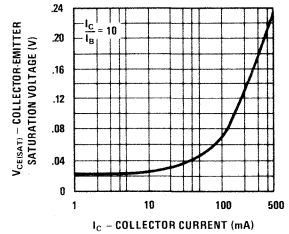
Maximum Power Dissipation vs Case Temperature



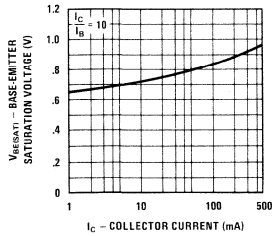
Collector-Base Diode Reverse Current vs Temperature



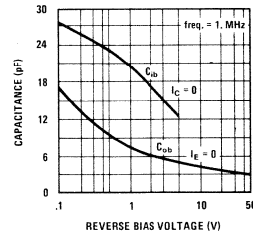
Collector-Emitter Saturation Voltage vs Collector Current



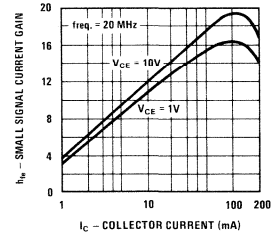
Base-Emitter Saturation Voltage vs Collector Current



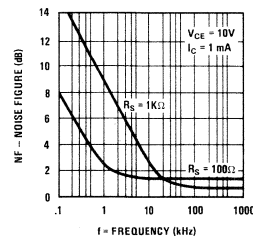
Capacitance vs Reverse Bias Voltage



Small Signal Current Gain vs Collector Current

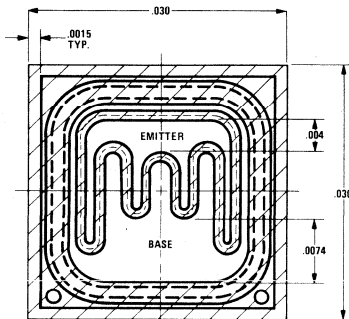


Noise Figure vs Frequency





Process 12 NPN Medium Power



DESCRIPTION

Process 12 is a nonoverlay, double diffused silicon epitaxial device. Complement to Process 67.

APPLICATION

This device was designed for general purpose medium power amplifiers and switches requiring collector currents up to 1 amp and collector voltages between 80 and 140 volts.

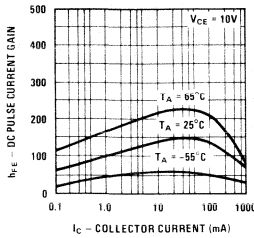
PRINCIPAL DEVICE TYPES:

TO-18	2N3700
TO-39	2N3019
TO-105	2N3568

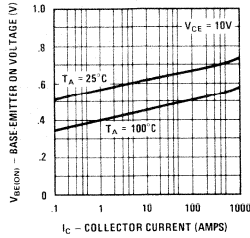
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 150 \text{ mA}$, $I_{B1} = 15 \text{ mA}$		50	60	ns	Fig. 1
t_{off}	$I_C = 150 \text{ mA}$, $I_{B2} = 15 \text{ mA}$		400	500	ns	
h_{fe}	$I_C = 50 \text{ mA}$, $V_{CE} = 10 \text{ V}$, $f = 20 \text{ MHz}$	4.0	6.5			
C_{cb}	$V_{CB} = 10 \text{ V}$		6.5	10	pF	TO-39
C_{eb}	$V_{EB} = 0.5$		50	60	pF	
NF	$I_C = 100 \mu\text{A}$, $V_{CE} = 10 \text{ V}$, $R_S = 1 \text{ k}$ $f = 1 \text{ kHz}$, PBW = 200 Hz		1.5	4	dB	
h_{FE}	$I_C = 100 \mu\text{A}$, $V_{CE} = 10 \text{ V}$	20	100			
h_{FE}	$I_C = 1 \text{ mA}$, $V_{CE} = 10 \text{ V}$	20	130			
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 10 \text{ V}$	20	140			
h_{FE}	$I_C = 100 \text{ mA}$, $V_{CE} = 10 \text{ V}$	20	160	400		
h_{FE}	$I_C = 500 \text{ mA}$, $V_{CE} = 10 \text{ V}$	20	130			
h_{FE}	$I_C = 1 \text{ A}$, $V_{CE} = 10 \text{ V}$	20	40			
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}$, $I_B = 10 \text{ mA}$		0.1	0.2	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}$, $I_B = 50 \text{ mA}$		0.35	0.5	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}$, $I_B = 10 \text{ mA}$		0.82	0.90	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}$, $I_B = 50 \text{ mA}$		1.0	1.20	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	80			V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	140			V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	7			V	
I_{CBO}	$V_{CB} = 90 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 5 \text{ V}$			50	nA	

Process 12

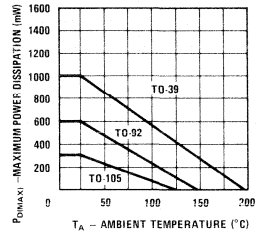
Pulsed DC Current Gain vs Collector Current



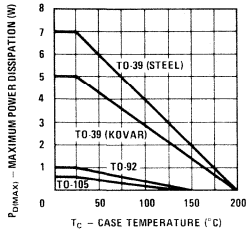
Base-Emitter On Voltage vs Collector Current



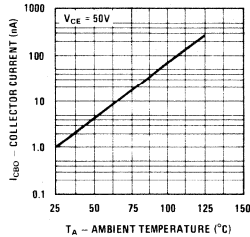
Maximum Power Dissipation vs Ambient Temperature



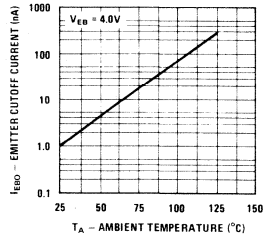
Maximum Power Dissipation vs Case Temperature



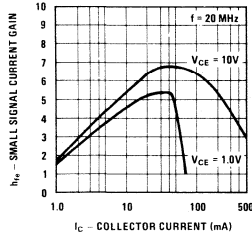
Collector Reverse Current vs Ambient Temperature



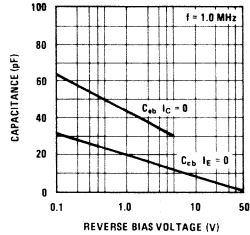
Emitter Cutoff Current vs Ambient Temperature



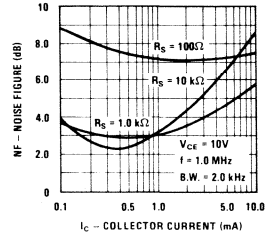
Small Signal Current Gain at 20 MHz



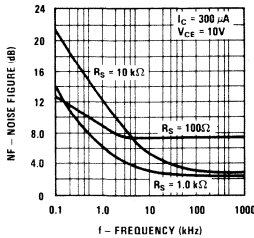
Collector-Base and Emitter Base Capacitance vs Reverse Bias Voltage



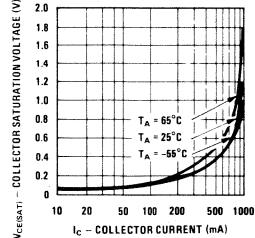
Noise Figure vs Collector Current



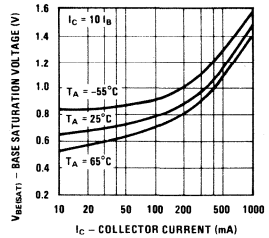
Noise Figure vs Frequency



Collector Saturation Voltage vs Collector Current

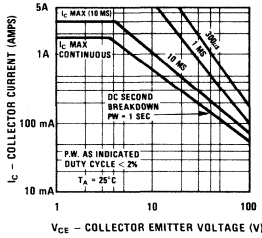


Base Saturation Voltage vs Collector Current

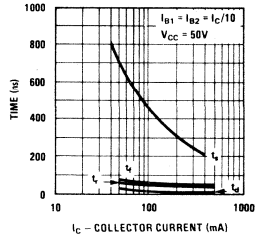


Process 12

Safe Operating Area TO-39 With "Wake Field" Type 296-4 Heat Sink



Switching Times vs Collector Current



Turn On and Turn Off Times vs Collector Current

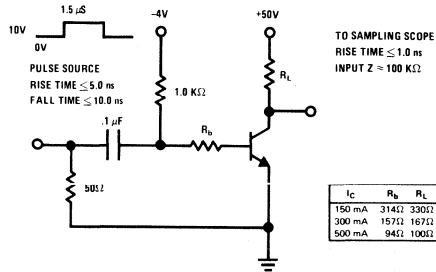
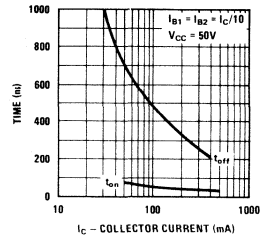
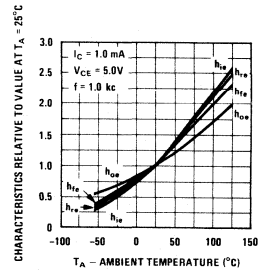
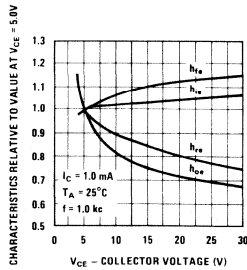
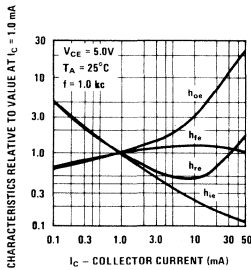


FIGURE 1. t_{on} , t_{off} Test Circuit

SMALL SIGNAL CHARACTERISTICS ($f = 1.0$ kHz)

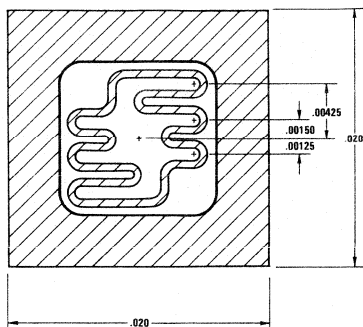
SYMBOL	CHARACTERISTIC	TYP.	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance	3000	ohms	$I_C = 1.0$ mA $V_{CE} = 5.0$ V
h_{oe}	Output Conductance	8.0	μ mhos	$I_C = 1.0$ mA $V_{CE} = 5.0$ V
h_{re}	Voltage Feedback Ratio	2.1	$\times 10^{-4}$	$I_C = 1.0$ mA $V_{CE} = 5.0$ V
h_{fe}	Small Signal Current Gain	100		$I_C = 1.0$ mA $V_{CE} = 5.0$ V

TYPICAL COMMON EMITTER CHARACTERISTICS ($f = 1.0$ kHz)





Process 13 NPN Medium Power



DESCRIPTION

Process 13 is a nonoverlay. Complement to Process 63.

APPLICATION

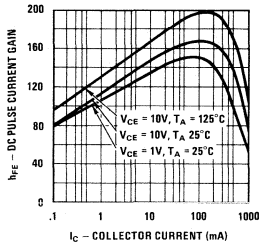
These devices were designed for use as medium power amplifiers and switches requiring collector currents of .1 mA to one Amp.

PRINCIPAL DEVICE TYPES:

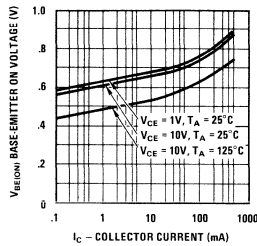
TO-92 2N4401 (EBC), 2N3704 (ECB)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 150 \text{ mA}, I_{B1} = 15 \text{ mA}$		25	35	ns	
t_{off}	$I_C = 150 \text{ mA}, I_{B2} = 15 \text{ mA}$		200	285	ns	
h_{fe}	$I_C = 20 \text{ mA}, V_{CE} = 20 \text{ V}, f = 100 \text{ MHz}$	2.5	3.5			
NF (spot)	$I_C = 100 \mu\text{A}, V_{CE} = 10 \text{ V}$ $R_S = 1 \text{ k}\Omega, f = 1 \text{ kHz}, \text{PBW} = 200 \text{ Hz}$		1.2	4.0	dB	
C_{ob}	$V_{CB} = 10 \text{ V}$		4.5		pF	
C_{ib}	$V_{EB} = .5 \text{ V}$		22		pF	
h_{FE}	$V_{CE} = 1.0 \text{ V}, I_C = 100 \mu\text{A}$	15	80	125		
h_{FE}	$V_{CE} = 1.0 \text{ V}, I_C = 1.0 \text{ mA}$	25	110	200		
h_{FE}	$V_{CE} = 1.0 \text{ V}, I_C = 10 \text{ mA}$	35	135	280		
h_{FE}	$V_{CE} = 1.0 \text{ V}, I_C = 150 \text{ mA}$	40	140	300		
h_{FE}	$V_{CE} = 1.0 \text{ V}, I_C = 500 \text{ mA}$	25	100	150		
h_{FE}	$V_{CE} = 5.0 \text{ V}, I_C = 1 \text{ A}$	15	45	60		
$V_{CE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.1	.2	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.26	.36	V	
$V_{BE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.87	.97	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		1.0	1.2	V	
BV_{CBO}	$I_C = 1.0 \mu\text{A}$		110		V	
BV_{CEO}	$I_C = 10 \text{ mA}$	35	45	50	V	
BV_{EBO}	$I_E = 1.0 \mu\text{A}$		7.5		V	
I_{CBO}	$V_{CB} = 40 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 4 \text{ V}$			50	nA	

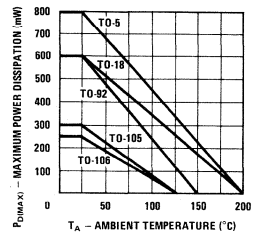
DC Pulse Current Gain vs Collector Current



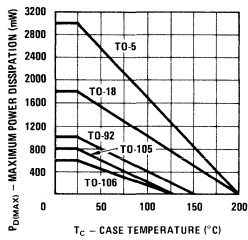
Base-Emitter On Voltage vs Collector Current



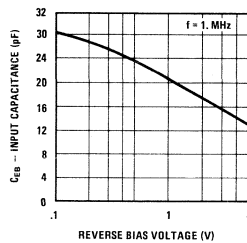
Maximum Power Dissipation vs Ambient Temperature



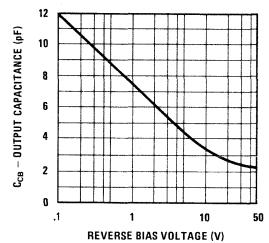
Maximum Power Dissipation vs Case Temperature



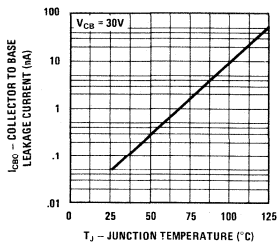
Input Capacitance vs Reverse Bias Voltage



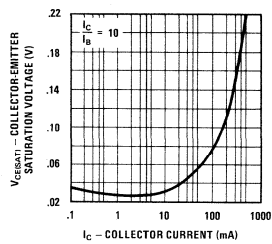
Output Capacitance vs Reverse Bias Voltage



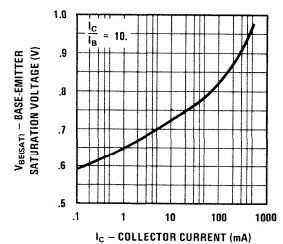
Collector to Base Diode Reverse Current vs Temperature



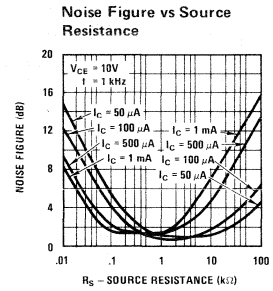
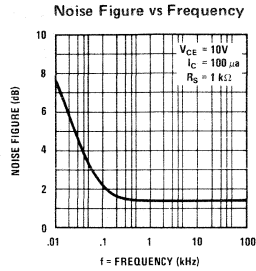
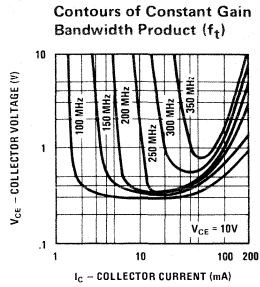
Collector-Emitter Saturation Voltage vs Collector Current



Base-Emitter Saturation Voltage vs Collector Current



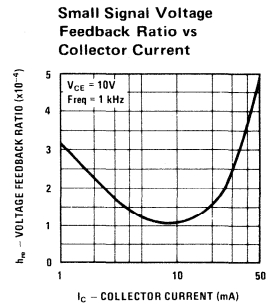
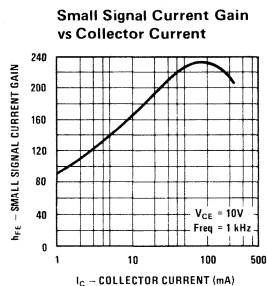
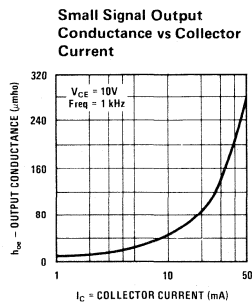
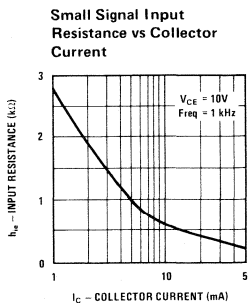
Process 13



SMALL SIGNAL CHARACTERISTICS ($f = 1.0 \text{ kHz}$)

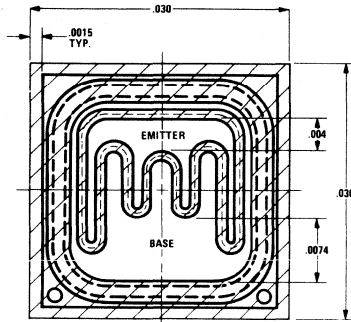
SYMBOL	CHARACTERISTIC	TYP	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance	600	ohms	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$
h_{oe}	Output Conductance	50	μmhos	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$
h_{fe}	Small Signal Current Gain	170		$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$
h_{re}	Voltage Feedback Ratio	120	$\times 10^{-6}$	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$

TYPICAL COMMON EMITTER CHARACTERISTICS ($f = 1.0 \text{ kHz}$)





Process 14 NPN Medium Power



DESCRIPTION

Process 14 is a nonoverlay double diffused silicon epitaxial device. Complement to Process 67.

APPLICATION

This device was designed for general purpose audio amplifier applications at collector currents to 500 mA.

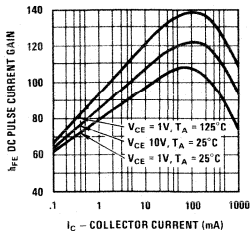
PRINCIPAL DEVICE TYPES:

TO-39	BFY50
TO-92	MPS6560
TO-105	2N3569

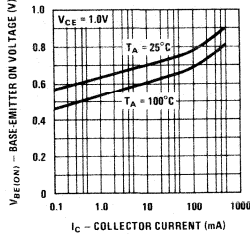
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
C_{ob}	$V_{CB} = 10V$		8	10	pF	
C_{ib}	$V_{EB} = 0.5V$		55	65	pF	
h_{fe}	$I_C = 50 \text{ mA}, V_{CE} = 10V, f = 20 \text{ MHz}$	5	10			
h_{FE}	$I_C = 0.1 \text{ mA}, V_{CE} = 1V$	20	60			
h_{FE}	$I_C = 1 \text{ mA}$	20	80			
h_{FE}	$I_C = 10 \text{ mA}$	20	100	400		
h_{FE}	$I_C = 100 \text{ mA}$	20	110			
h_{FE}	$I_C = 500 \text{ mA}$	20	70			
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.04	0.10	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.07	0.12	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.70	0.90	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.80	1.0	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	40			V	
BV_{CBO}	$I_C = 100 \mu A$	40			V	
BV_{EBO}	$I_E = 10 \mu A$	5			V	
I_{CBO}	$V_{CB} = 30$			50	nA	
I_{EBO}	$V_{EB} = 3$			50	nA	

Process 14

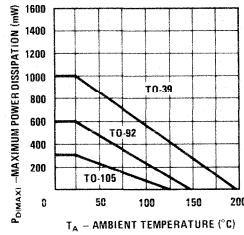
DC Pulse Current Gain vs Collector Current



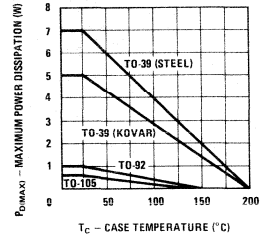
Base-Emitter On Voltage vs Collector Current



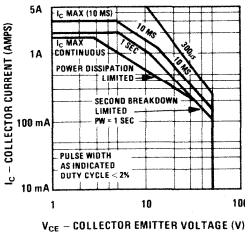
Maximum Power Dissipation vs Ambient Temperature



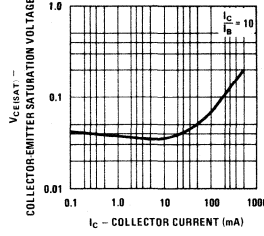
Maximum Power Dissipation vs Case Temperature



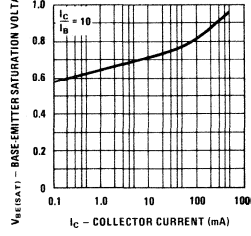
Safe Operating Area TO-39 With "Wake Field" Type 296-4 Heat Sink



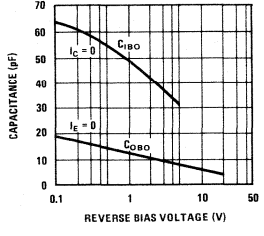
Collector-Emitter Saturation Voltage vs Collector Current



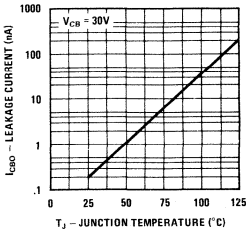
Base-Emitter Saturation Voltage vs Collector Current



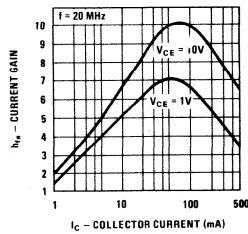
Capacitance vs Reverse Bias Voltage



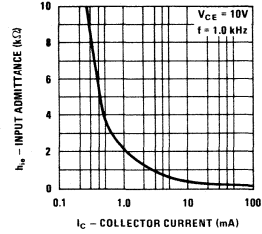
Collector-Base Diode Reverse Current vs Temperature



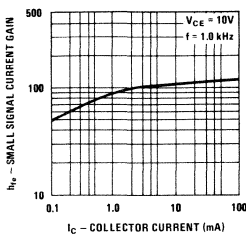
Small Signal Current Gain At 20 MHz vs Collector Current



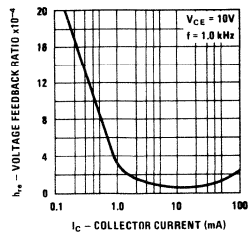
Input Admittance



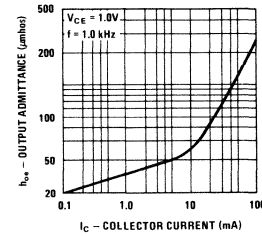
Small Signal Current Gain



Voltage Feedback Ratio

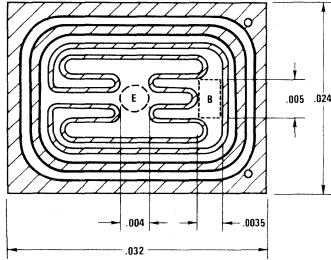


Output Admittance





Process 15 NPN High Voltage



DESCRIPTION

Process 15 is a nonoverlay, double diffused, epitaxial silicon device.

APPLICATION

This device was designed for general purpose high voltage amplifiers and switches.

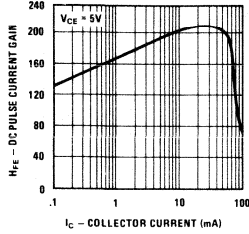
PRINCIPAL DEVICE TYPES:

TO-92 2N5832
 10-39 BF258

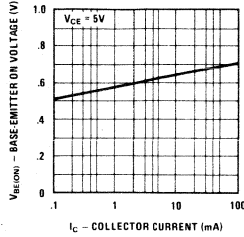
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
BV_{CEO}	$I_C = 1 \text{ mA}$	140	250		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	160	300		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	5	7.2		V	
I_{CBO}	$V_{CB} = 120\text{V}$		0.5	50	nA	
I_{EBO}	$V_{EB} = 4\text{V}$		0.3	50	nA	
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 5\text{V}$	50	161			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 5\text{V}$	50	200	500		
h_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 5\text{V}$	20	216			
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.068	0.15	V	
$V_{CE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$		0.107	0.25	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.698	1.0	V	
$V_{BE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 10 \text{ mA}$		0.778	1.2	V	
f_T	$I_C = 10 \text{ mA}, V_{CE} = 10\text{V}, f = 100 \text{ MHz}$	100	172	500	MHz	
C_{ob}	$V_{CB} = 10\text{V}$		4.97	6	pF	
C_{cb}	$V_{CB} = 10\text{V}$		2.43	4	pF	
C_{ib}	$V_{EB} = 0.5\text{V}$		51	60	pF	

Process 15

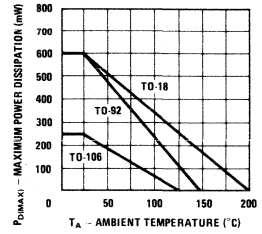
DC Pulse Current Gain vs Collector Current



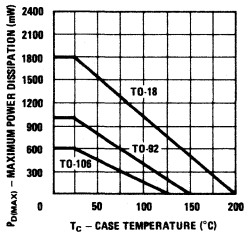
Base-Emitter on Voltage vs Collector Current



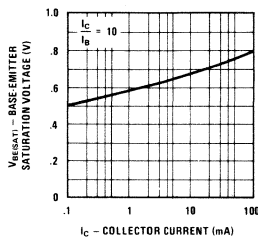
Maximum Power Dissipation vs Ambient Temperature



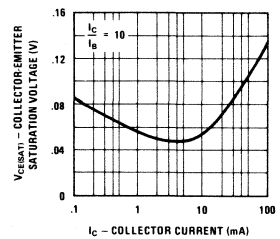
Maximum Power Dissipation vs Case Temperature



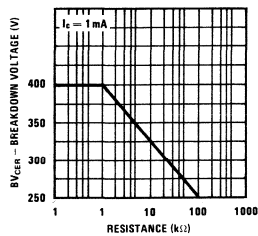
Base-Emitter Saturation Voltage vs Collector Current



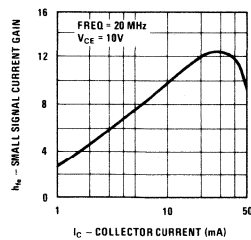
Collector-Emitter Saturation Voltage vs Collector Current



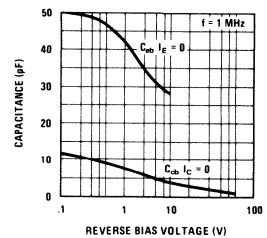
Collector-Emitter Breakdown Voltage With Resistance Between Emitter-Base



Small Signal Current Gain vs Collector Current

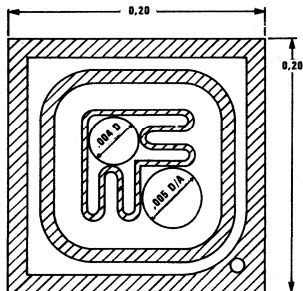


Input and Output Capacitance vs Reverse Bias Voltage





Process 16 NPN High Voltage



DESCRIPTION

Process 15 is a double diffused, epitaxial, planar, NPN Transistor.

APPLICATION

General purpose, high voltage amplifier applications.
Gas discharge display driver.

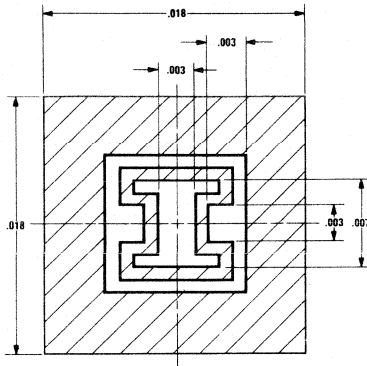
PRINCIPAL DEVICE TYPES:

TO-92 2N5551

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
BV_{CEO}	$I_C = 1 \text{ mA}$	100	170		V
BV_{CBO}	$I_C = 100 \mu\text{A}$	120	275		V
BV_{EBO}	$I_E = 10 \mu\text{A}$	5	7.2		V
I_{CBO}	$V_{CB} = 120\text{V}$		0.5	50	nA
I_{EBO}	$V_{EB} = 4\text{V}$		0.3	50	nA
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 5\text{V}$	50	110		
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 5\text{V}$	50	132	300	
h_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 5\text{V}$	20	60		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.064	0.15	V
$V_{CE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$		0.115	0.25	V
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.743	1.0	V
$V_{BE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 10 \text{ mA}$		0.825	1.2	V
f_T	$I_C = 10 \text{ mA}, V_{CE} = 10\text{V}, f = 100 \text{ MHz}$	100	220	300	MHz
C_{ob}	$V_{CB} = 10\text{V}$		2.67	6	pF
C_{cb}	$V_{CB} = 10\text{V}$		2.53	4	pF
C_{ib}	$V_{EB} = 0.5\text{V}$		1.5	30	pF



Process 20 NPN Medium Power



DESCRIPTION

Process 20 is nonoverlay double diffused, gold doped, silicon epitaxial device. Complement to Process 63.

APPLICATION

These devices were designed for use as medium power amplifiers and switches requiring collector currents of 0.1 to 500 mA.

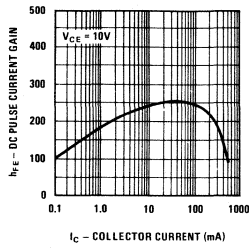
PRINCIPAL DEVICE TYPES:

TO-15	2N2219A
TO-18	2N2222A
TO-92	MPS3642
TO-105	2N3643
TO-106	2N4141

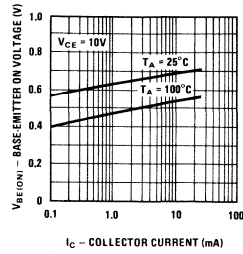
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 150 \text{ mA}, I_{B1} = 15 \text{ mA}$		25	35	ns	
t_{off}	$I_C = 150 \text{ mA}, I_{B2} = 15 \text{ mA}$		200	285	ns	
h_{fe}	$I_C = 20 \text{ mA}, V_{CE} = 20 \text{ V}, f = 100 \text{ MHz}$	2.5	3.5			
C_{cb}	$V_{CB} = 10 \text{ V}$		3.0	6.0	pF	
C_{cb}	$V_{EB} = 0.5 \text{ V}$		18	25	pF	
NF (spot)	$I_C = 100 \mu\text{A}, V_{CE} = 10 \text{ V}$ $R_S = 1 \text{ k}\Omega, f = 1 \text{ kHz}, \text{PBW} = 200 \text{ Hz}$		1.2	4.0	dB	
h_{FE}	$I_C = 100 \mu\text{A}, V_{CE} = 10 \text{ V}$	20	100			
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 10 \text{ V}$	20	195			
h_{FE}	$I_C = 10 \text{ mA}$	20	240	500		
h_{FE}	$I_C = 100 \text{ mA}$	20	250	500		
h_{FE}	$I_C = 500 \text{ mA}$	20	90			
h_{FE}	$I_C = 1 \text{ A}$	15	30			
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.12	0.50	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.35	1.0	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.90	1.2	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		1.00	1.5	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	40			V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	70			V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	6			V	
I_{CBO}	$V_{CB} = 60 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 3 \text{ V}$			50	nA	

Process 20

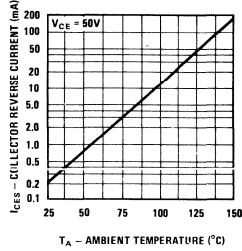
DC Pulse Current Gain vs Collector Current



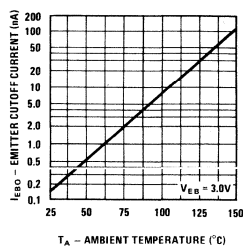
Base-Emitter On Voltage vs Collector Current



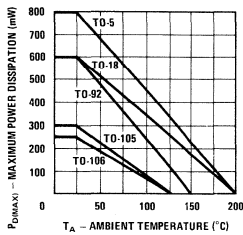
Collector Reverse Current vs Ambient Temperature



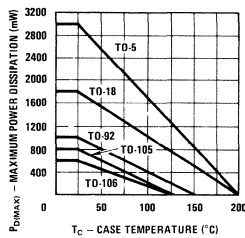
Emitter Cutoff Current vs Ambient Temperature



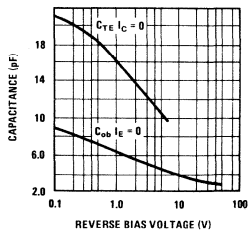
Maximum Power Dissipation vs Ambient Temperature



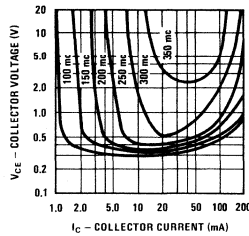
Maximum Power Dissipation vs Case Temperature



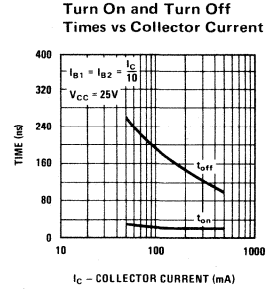
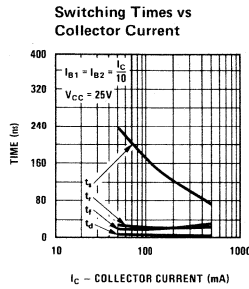
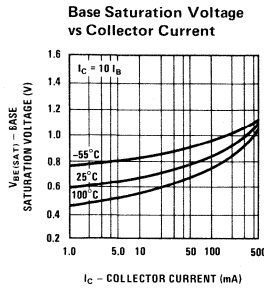
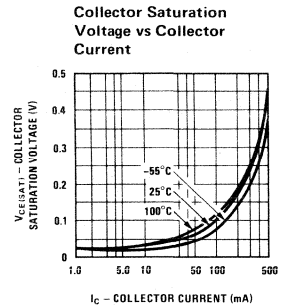
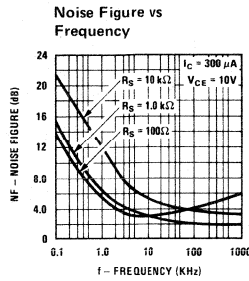
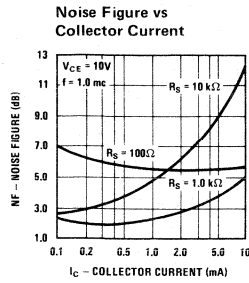
Emitter Transition and Output Capacitance vs Reverse Bias Voltage



Contours of Constant Gain Bandwidth Product (f_T)



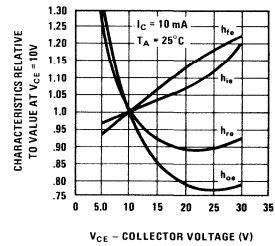
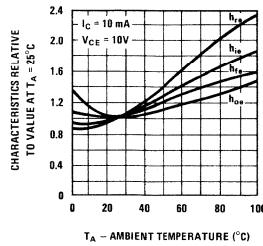
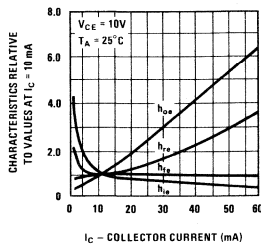
Process 20



SMALL SIGNAL CHARACTERISTICS (f = 1.0 kHz)

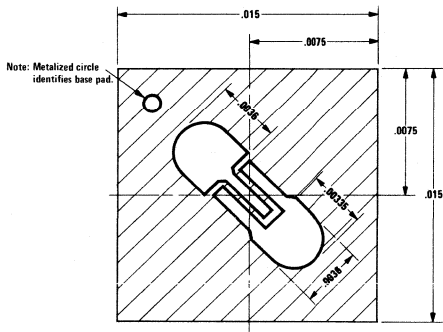
SYMBOL	CHARACTERISTIC	TYP.	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance	700	ohms	$I_C = 10 \text{ mA}$ $V_{CE} = 10\text{V}$
h_{oe}	Output Conductance	120	μmhos	$I_C = 10 \text{ mA}$ $V_{CE} = 10\text{V}$
h_{fe}	Small Signal Current Gain	240		$I_C = 10 \text{ mA}$ $V_{CE} = 10\text{V}$
h_{re}	Voltage Feedback Ratio	460	$\times 10^{-6}$	$I_C = 10 \text{ mA}$ $V_{CE} = 10\text{V}$

TYPICAL COMMON EMITTER CHARACTERISTICS (f = 1.0 kHz)





Process 21 NPN High Speed Switch



DESCRIPTION

Process 21 is an overlay, double diffused, gold doped silicon epitaxial device. Complement to Process 65.

APPLICATION

This device was designed for high speed saturated switching at collector currents of 10 to 100 mA.

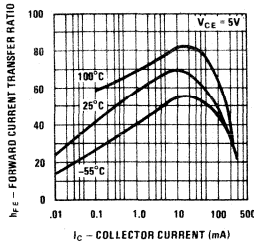
PRINCIPAL DEVICE TYPES:

TO-18 2N2369A
 TO-92 MPS2369 (EBC), 2N5030 (ECB)
 TO-106 2N4275

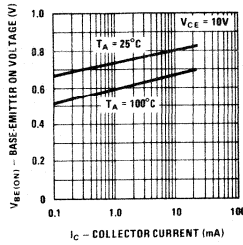
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_s	$I_{B1} = I_{B2} = I_C = 10 \text{ mA}$		7	13	ns	Fig. 1
t_{on}	$I_C = 10 \text{ mA}, I_{B1} = 3 \text{ mA}$		9	12	ns	Fig. 2
t_{off}	$I_C = 10 \text{ mA}, I_{B2} = 1.50 \text{ mA}$		10	18	ns	Fig. 2
h_{fe}	$I_C = 10 \text{ mA}, V_{CE} = 10V, f = 100 \text{ MHz}$	5.0	7.0			
C_{cb}	$V_{CB} = 5V$		2.0	4.0	pF	TO-18
C_{EB}	$V_{EB} = 0.5V$		4.0	5.0	pF	TO-18
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 1V$	40	70	200		
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 1V$	40	70	200		
h_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 1V$	40	60	200		
h_{FE}	$I_C = 100 \text{ mA}, V_{CE} = 1V$	40	50	200		
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 0.35V$	40	65	200		
h_{FE}	$I_C = 30 \text{ mA}, V_{CE} = 0.4V$	40	60	200		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.14	0.2	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.20	0.5	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.80	0.85	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		1.0	1.5	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	15	17		V	
BV_{CBO}	$I_C = 10 \mu A$	40	60		V	
BV_{EBO}	$I_E = 10 \mu A$	4.5	5.5		V	
I_{CBO}	$V_{CB} = 25V$			50	nA	
I_{EBO}	$V_{EB} = 3V$			50	nA	

Process 21

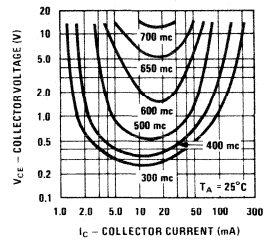
Pulse DC Current Gain vs Collector Current



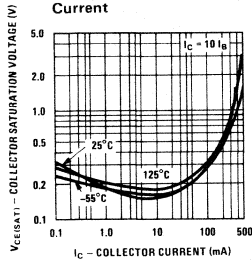
Base-Emitter On Voltage vs Collector Current



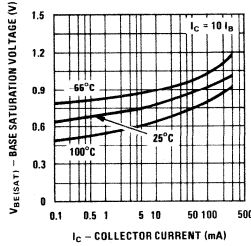
Contours of Constant Gain Bandwidth Product (fT)



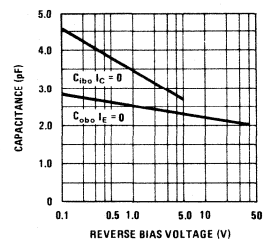
Collector Saturation Voltage vs Collector Current



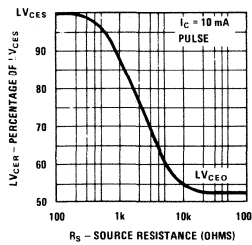
Base Saturation Voltage vs Collector Current



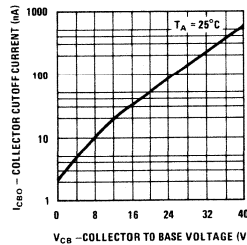
Emitter Transition and Output Capacitances vs Reverse Bias Voltage



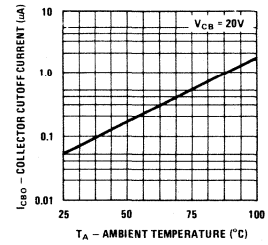
Lower Limiting Voltage vs Source Resistance



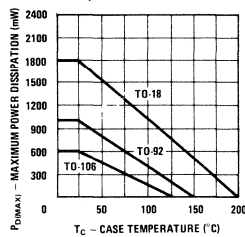
Collector Cutoff Current vs Reverse Bias Voltage



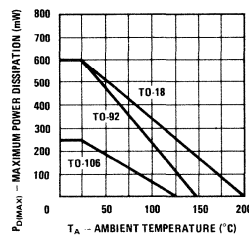
Collector Cutoff Current vs Ambient Temperature



Maximum Power Dissipation vs Case Temperature

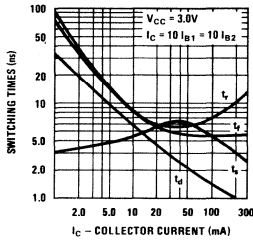


Maximum Power Dissipation vs Ambient Temperature

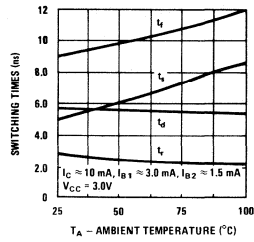


Process 21

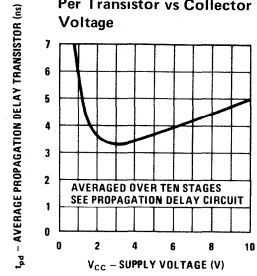
Switching Times vs Collector Current



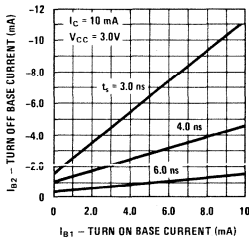
Switching Times vs Ambient Temperature



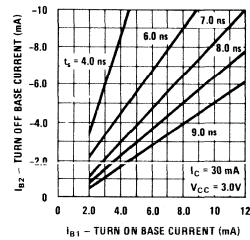
Average Propagation Delay Per Transistor vs Collector Voltage



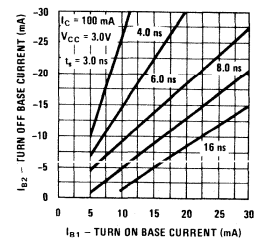
Storage Time vs Turn On and Turn Off Base Currents



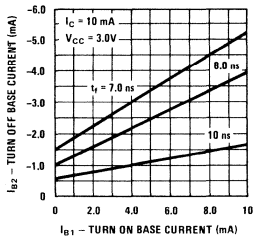
Storage Time vs Turn On and Turn Off Base Currents



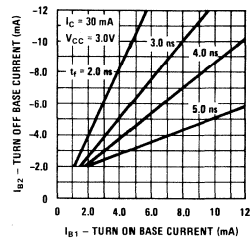
Storage Time vs Turn On and Turn Off Base Currents



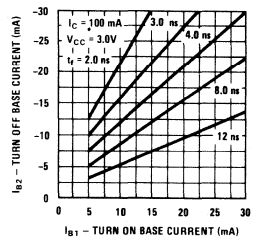
Fall Time vs Turn On and Turn Off Base Current



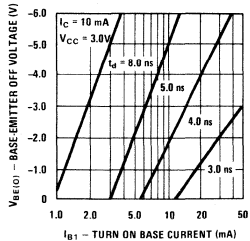
Fall Time vs Turn On and Turn Off Base Currents



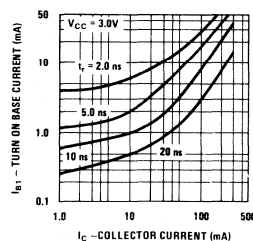
Fall Time vs Turn On and Turn Off Base Currents



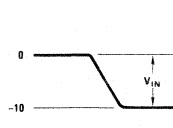
Delay Time vs Base Emitter Off Voltage and Turn On Base Current



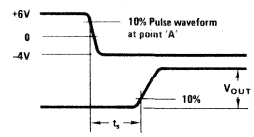
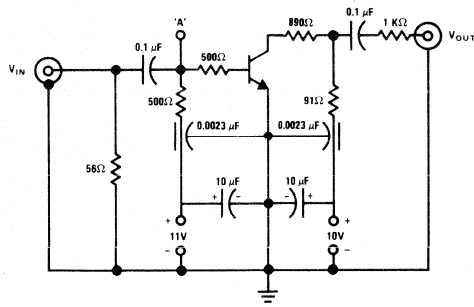
Rise Time vs Turn On Base Current and Collector Current



Process 21

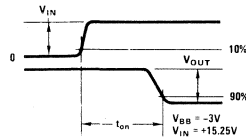


Pulse Generator
 V_{IN} Rise Time < 1 ns
 Source Impedance = 50Ω
 PW ≥ 300 ns
 Duty Cycle $< 2\%$

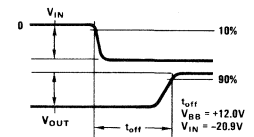
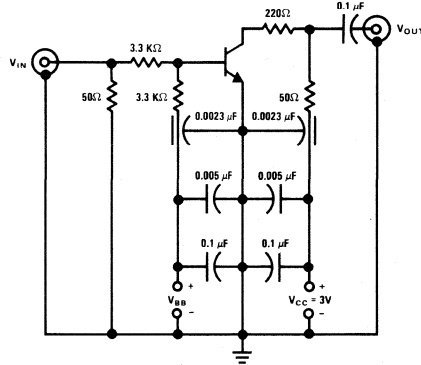


To Sampling Oscilloscope
 Input Impedance = 50Ω
 Rise Time ≤ 1 ns

FIGURE 1. Charge Storage Time Measurement Circuit

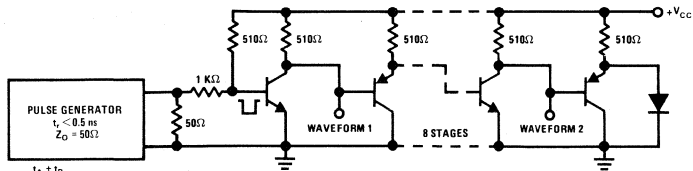


Pulse Generator
 V_{IN} Rise Time < 1 ns
 Source Impedance = 50Ω
 PW ≥ 300 ns
 Duty Cycle $< 2\%$



To Sampling Oscilloscope
 Input Impedance = 50Ω
 Rise Time ≤ 1 ns

FIGURE 2. t_{ON} , t_{OFF} Measurement Circuit



$t_{pd} = \frac{t_A + t_B}{20}$
 t_{pd} = Average Propagation per Transistor

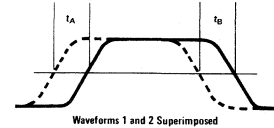
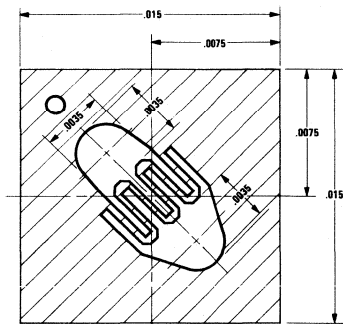


FIGURE 3. Circuit For Measurement of Propagation Delay



Process 22 NPN Small Signal



DESCRIPTION

Process 22 is an overlay, double diffused, gold doped silicon epitaxial device. Complement to Process 64.

APPLICATION

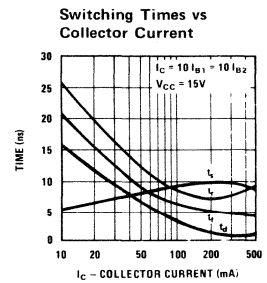
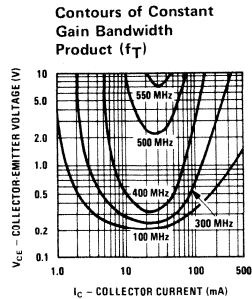
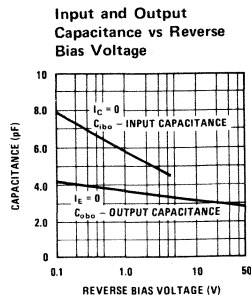
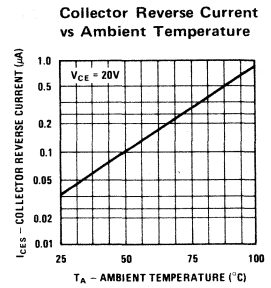
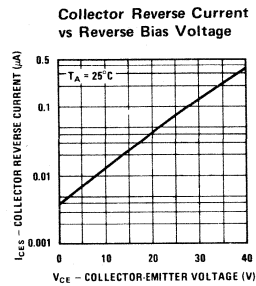
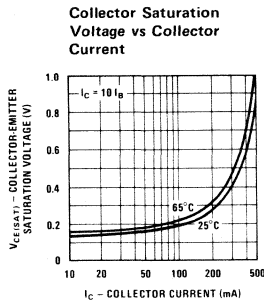
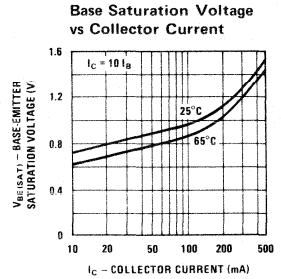
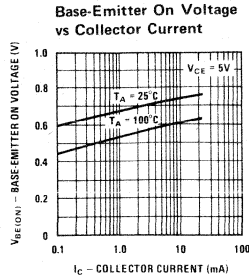
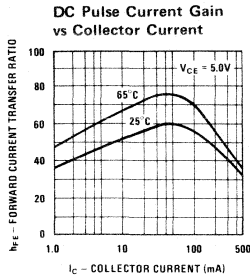
This device was designed for high speed logic and core driver applications to 300 mA.

PRINCIPAL DEVICE TYPES:

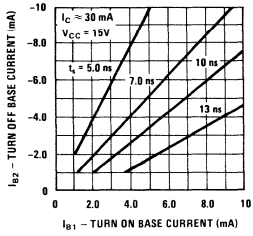
TO-52	2N3013
TO-92	MPS3646
TO-106	2N3646

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_s	$I_C = 10 \text{ mA}, I_{B1} = I_{B2} = 10 \text{ mA}$		12	18	ns	Fig. 1
t_{on}	$i_C = 300 \text{ mA}, i_{B1} = i_{B2} = 30 \text{ mA}$		10	18	ns	Fig. 2
t_{off}	$I_C = 300 \text{ mA}, I_{B1} = I_{B2} = 30 \text{ mA}$		18	30	ns	
C_{ob}	$V_{CB} = 5V$		3.2	5.0	pF	TO-18
C_{ob}	$V_{EB} = 0.5V$		6.2	8.0	pF	TO-18
h_{fe}	$I_C = 30 \text{ mA}, V_{CE} = 10V, f = 100 \text{ MHz}$	3.5	7.0	10		
h_{FE}	$V_{CE} = 1V, I_C = 10 \text{ mA}$	20	50	150		
h_{FE}	$V_{CE} = 1V, I_C = 30 \text{ mA}$	20	50	150		
h_{FE}	$V_{CE} = 1V, I_C = 100 \text{ mA}$	20	48	150		
h_{FE}	$V_{CE} = 1V, I_C = 300 \text{ mA}$	15	30	120		
h_{FE}	$V_{CE} = 0.4V, I_C = 30 \text{ mA}$	20	50	150		
h_{FE}	$V_{CE} = 0.5V, I_C = 100 \text{ mA}$	20	50	150		
$V_{CE(SAT)}$	$I_C = 30 \text{ mA}, I_B = 3 \text{ mA}$		0.14	0.20	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.20	0.28	V	
$V_{CE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$		0.40	0.50	V	
$V_{BE(SAT)}$	$I_C = 30 \text{ mA}, I_B = 3 \text{ mA}$		0.80	0.95	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.92	1.2	V	
$V_{BE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$		1.1	1.7	V	
BV_{CBO}	$I_C = 100 \mu A$	40	50		V	
BV_{CEO}	$I_C = 10 \text{ mA}$	15	18		V	
BV_{EBO}	$I_E = 100 \mu A$	5.0	5.7		V	
I_{CBO}	$V_{CB} = 20V$			50	nA	
I_{EBO}	$V_{EB} = 3V$			50	nA	

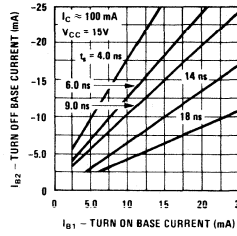
Process 22



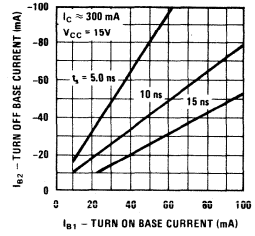
Storage Time vs Turn On and Turn Off Base Currents



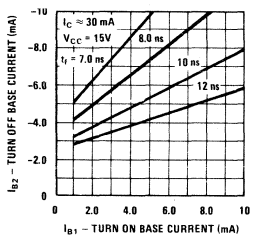
Storage Time vs Turn On and Turn Off Base Currents



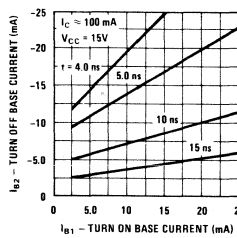
Storage Time vs Turn On and Turn Off Base Currents



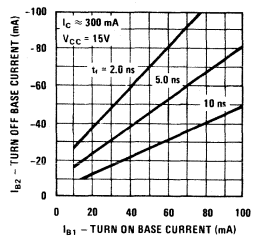
Fall Time vs Turn On and Turn Off Base Currents



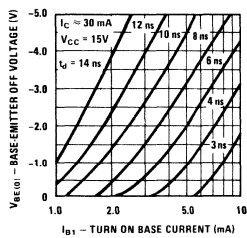
Fall Time vs Turn On and Turn Off Base Currents



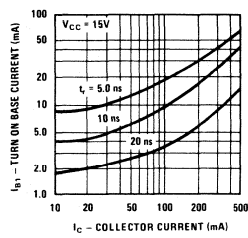
Fall Time vs Turn On and Turn Off Base Currents



Delay Time vs Base Emitter Off Voltage and Turn On Base Current



Rise Time vs Collector and Turn On Base Currents



Process 22

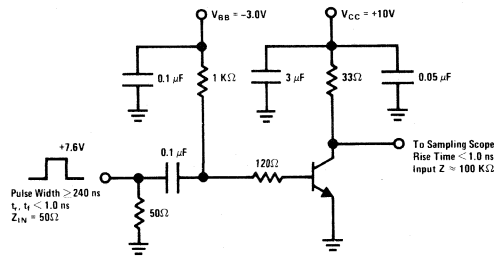
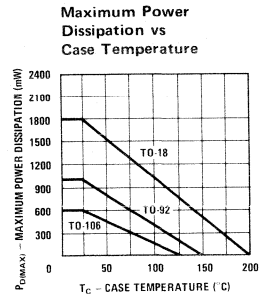
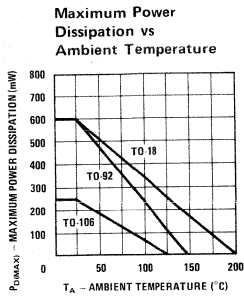
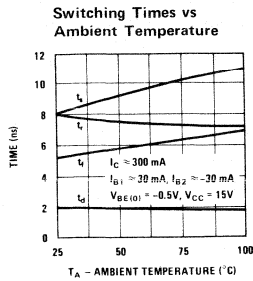


FIGURE 1. t_{on} , t_{off} Test Circuit

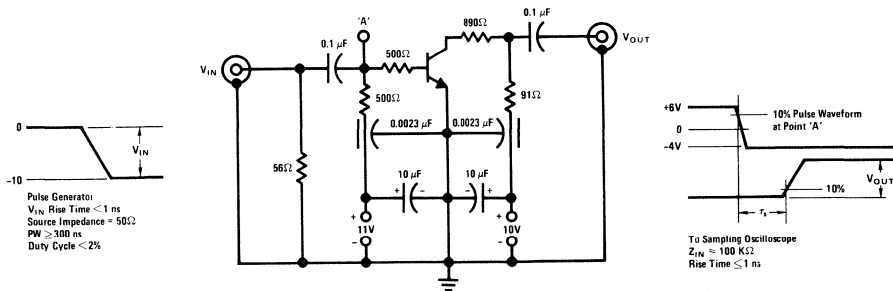
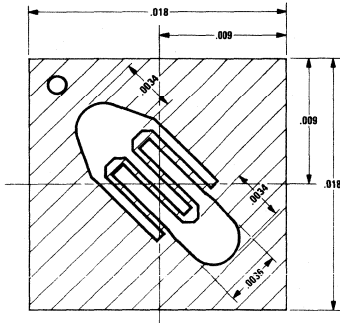


FIGURE 2. Charge Storage Time Measurement Circuit



Process 23 NPN Small Signal



DESCRIPTION

Process 23 is an overlay, double diffused gold doped silicon epitaxial device. Complement to Process 66.

APPLICATION

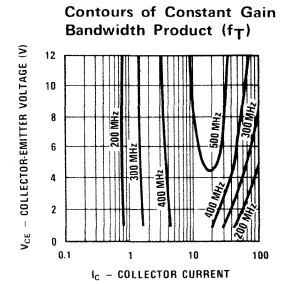
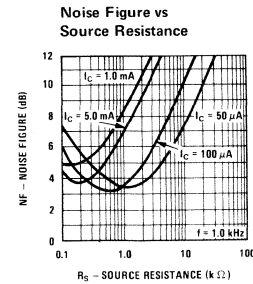
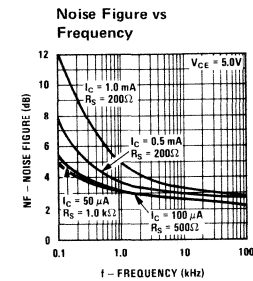
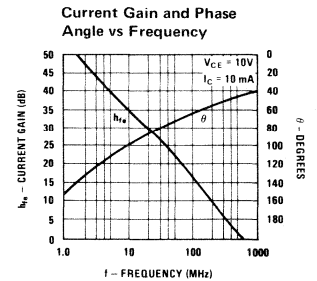
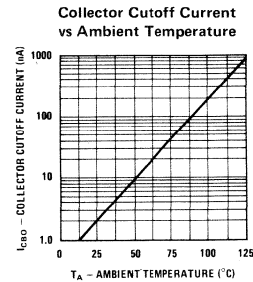
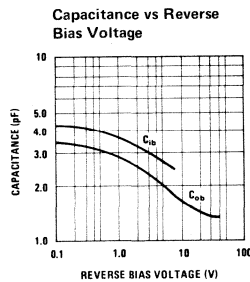
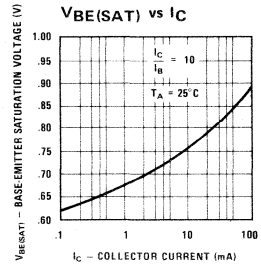
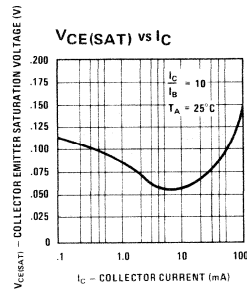
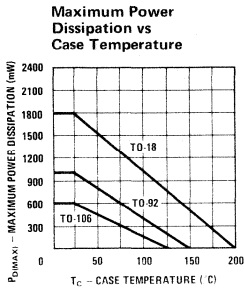
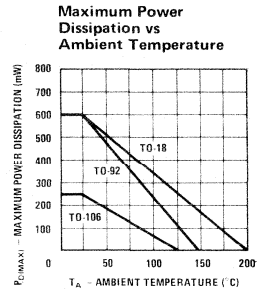
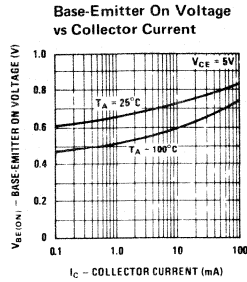
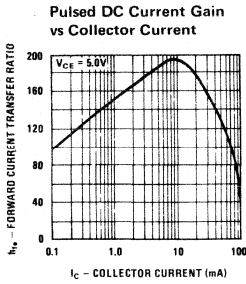
This device is designed as general purpose amplifier and switch. The useful dynamic range extends to 100 mA as a switch and to 100 MHz as an amplifier.

PRINCIPAL DEVICE TYPES:

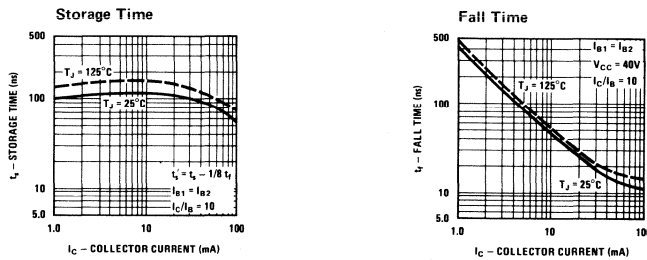
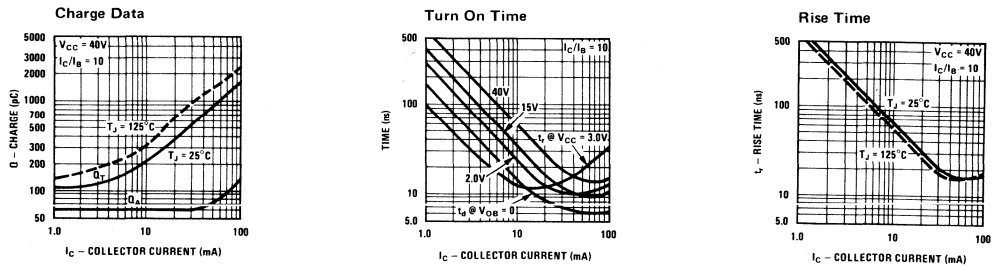
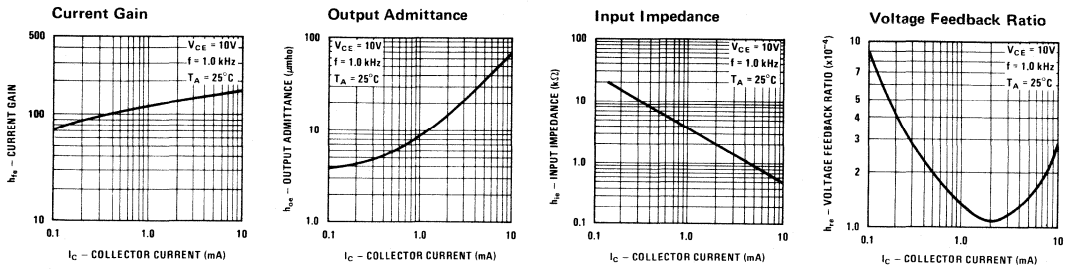
TO-18	NS3904
TO-92	2N3904
TO-106	SM3904

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 10 \text{ mA}, I_{B1} = 1 \text{ mA}$		30	70	ns	Fig. 1
t_{off}	$I_C = 10 \text{ mA}, I_{B2} = 1 \text{ mA}$		70	200	ns	Fig. 2
C_{ob}	$V_{CB} = 5 \text{ V}, f = 1 \text{ MHz}$		2.0	4.0	pF	TO-18
C_{ib}	$V_{EB} = 0.5 \text{ V}, f = 1 \text{ MHz}$		4.0	8.0	pF	TO-18
NF	$V_{CE} = 5 \text{ V}, I_C = 100 \mu\text{A}, R_S = 1 \text{ k}\Omega,$ $P_{BW} = 15.7 \text{ kHz}$		2.0	5.0	dB	
h_{fe}	$I_C = 10 \text{ mA}, V_{CE} = 20 \text{ V}, f = 100 \text{ MHz}$	2.0	5.0	7.0		
H_{FE}	$I_C = 100 \mu\text{A}, V_{CE} = 5 \text{ V}$	40	100	300		
H_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 5 \text{ V}$	70	150	300		
H_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 5 \text{ V}$	60	200	350		
H_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 5 \text{ V}$	30	120	200		
H_{FE}	$I_C = 100 \text{ mA}, V_{CE} = 5 \text{ V}$	20	50	100		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.1	0.15	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.70	0.80	V	
$V_{CE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$		0.12	0.2	V	
$V_{BE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$		0.75	0.85	V	
BV_{CBO}	$I_C = 10 \mu\text{A}$	60	90	120	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	40	60	80	V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	6.0		8.0	V	
I_{CBO}	$V_{CB} = 25 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 4 \text{ V}$			50	nA	

Process 23



h PARAMETERS ($V_{CE} = 10 V_{DC}, f = 1.0 \text{ kHz}, T_A = 25^\circ\text{C}$)



TRANSIENT CHARACTERISTICS ($-T_J = 25^\circ\text{C} \dots T_J = 125^\circ\text{C}$)

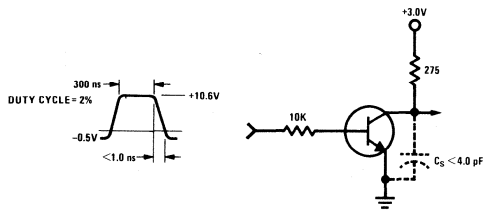


FIGURE 1. Delay and Rise Time Equivalent Test Circuit

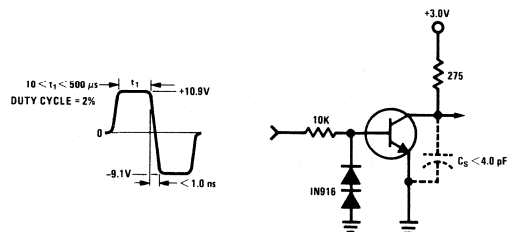
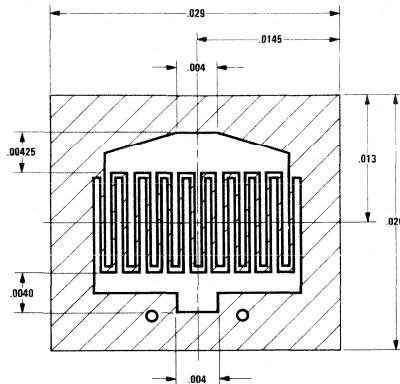


FIGURE 2. Storage and Fall Time Equivalent Test Circuit



Process 24 NPN High Speed High Voltage Switch



DESCRIPTION

Process 24 is an overlay double diffused gold doped epitaxial device.

APPLICATION

This device was designed for High Voltage, High Current core driver applications.

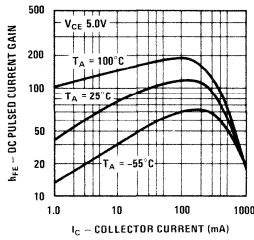
PRINCIPAL DEVICE TYPES:

TO-39 (pkg. 17) 2N3723

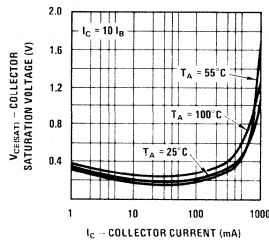
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$V_{CE} = 30V, I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		25	70	ns	Fig. 1
t_{off}	$V_{CE} = 30V, I_C = 500 \text{ mA}, I_{B1} = -I_{B2} = 50 \text{ mA}$		70	130	ns	Fig. 1
h_{fe}	$V_{CE} = 10V, I_C = 50 \text{ mA}, f = 100 \text{ MHz}$	3	4			
C_{ob}	$V_{CB} = 10V$		6	10	pF	
C_{ib}	$V_{EB} = 0.5V$		50	65	pF	
h_{fe}	$V_{CE} = 1V, I_C = 10 \text{ mA}$	25	45			
h_{fe}	$V_{CE} = 1V, I_C = 100 \text{ mA}$	40	70	150		
h_{fe}	$V_{CE} = 2V, I_C = 300 \text{ mA}$	15	35			
h_{fe}	$V_{CE} = 2V, I_C = 500 \text{ mA}$	15	30			
h_{fe}	$V_{CE} = 3V, I_C = 500 \text{ mA}$	15	25			
h_{fe}	$V_{CE} = 3V, I_C = 800 \text{ mA}$	12	30			
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.16	0.25	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.22	0.28	V	
$V_{CE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$		0.4	0.44	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.3	0.75	V	
$V_{CE(SAT)}$	$I_C = 800 \text{ mA}, I_B = 80 \text{ mA}$		0.6	2.0	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$			0.75	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$			0.85	V	
$V_{BE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$			1.1	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$.86		1.2	V	
$V_{BE(SAT)}$	$I_C = 800 \text{ mA}, I_B = 80 \text{ mA}$			1.5	V	
I_{CES}	$V_{CE} = 50V$			0.5	μA	
BV_{CBO}	$I_C = 100 \mu A$	80			V	
BV_{EBO}	$I_E = 100 \mu A$	6			V	
BV_{CEO}	$I_C = 10 \text{ mA}$	60	80		V	

Process 24

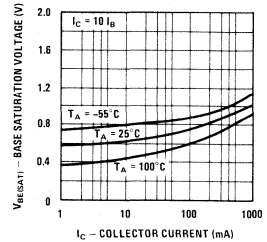
DC Pulsed Current Gain vs Collector Current



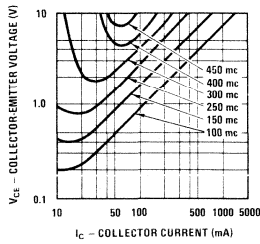
Collector Saturation Voltage vs Collector Current



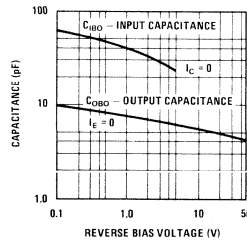
Base Saturation Voltage vs Collector Current



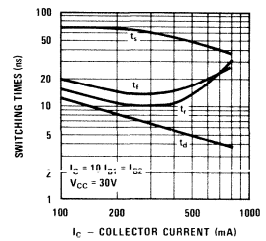
Contours of Constant Gain Bandwidth Product (fT)



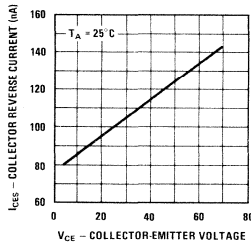
Input and Output Capacitance vs Reverse Bias Voltage



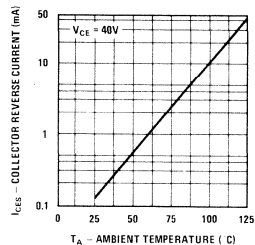
Switching Times vs Collector Current



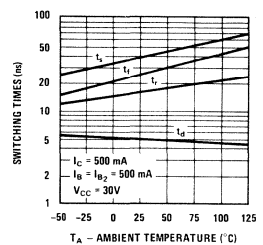
Collector Cutoff Current vs Reverse Bias Voltage



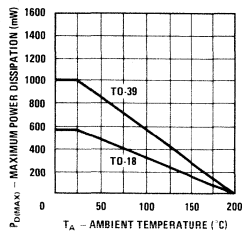
Collector Cutoff Current vs Ambient Temperature



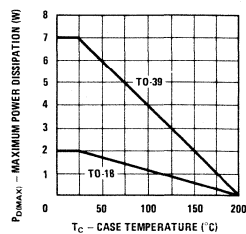
Switching Times vs Ambient Temperature



Maximum Power Dissipation vs Ambient Temperature

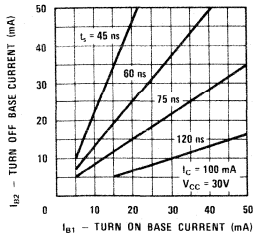


Maximum Power Dissipation vs Case Temperature

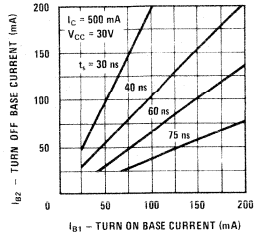


Process 24

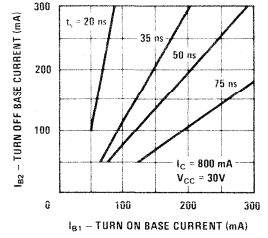
Storage Time vs Turn On and Turn Off Base Current



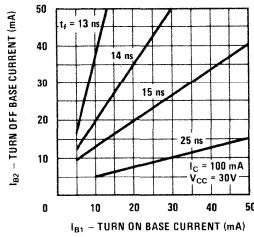
Storage Time vs Turn On and Turn Off Base Current



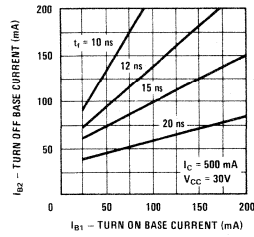
Storage Time vs Turn On and Turn Off Base Current



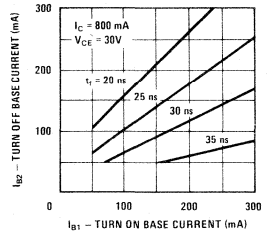
Fall Time vs Turn On and Turn Off Base Currents



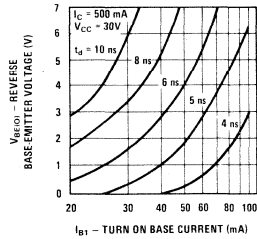
Fall Time vs Turn On and Turn Off Base Current



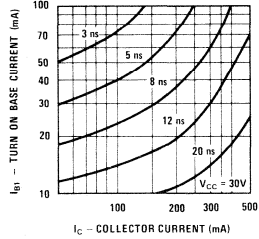
Fall Time vs Turn On and Turn Off Base Current



Delay Time vs Turn On Base Current and Reverse Base Emitter Voltage



Rise Time vs Collector and Turn On Base Current



SWITCHING TIME TEST CIRCUIT

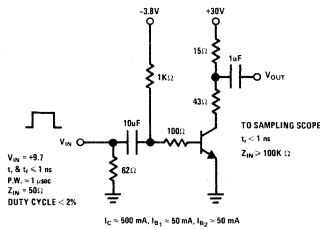
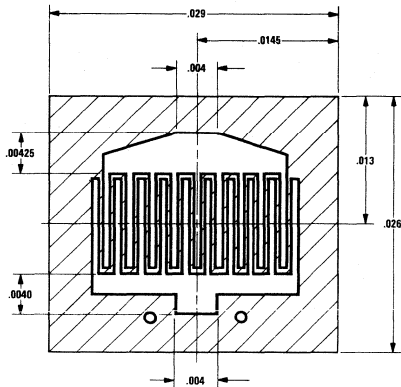


FIGURE 1.



Process 25 NPN Small Signal



DESCRIPTION

Process 25 is an overlay double diffused, gold doped silicon epitaxial device. Complement to Process 70.

APPLICATION

This device was designed for high speed core driver applications.

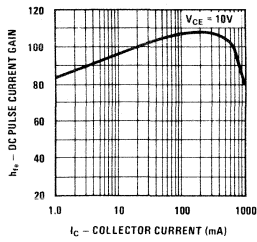
PRINCIPAL DEVICE TYPES:

TO-18 2N4014
TO-39 (pkg. 17) 2N3725

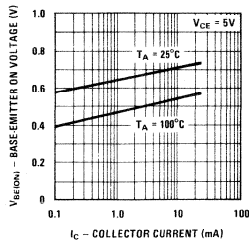
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 500 \text{ mA}, I_{B1} = 50 \text{ mA}$		12	35	ns	Fig. 1
t_{off}	$I_C = 500 \text{ mA}, I_{B2} = 50 \text{ mA}$		50	60	ns	Fig. 1
h_{fe}	$I_C = 50 \text{ mA}, V_{CE} = 10\text{V}, f = 100 \text{ MHz}$	2.5	4.25			
C_{cb}	$V_{CB} = 10\text{V}$		5	10	pF	
C_{eb}	$V_{EB} = 0.5\text{V}$		45	55	pF	
h_{fe}	$I_C = 10 \text{ mA}, V_{CE} = 1\text{V}$	40	60	120		
h_{fe}	$I_C = 100 \text{ mA}, V_{CE} = 1\text{V}$	60	90	150		
h_{fe}	$I_C = 300 \text{ mA}, V_{CE} = 1\text{V}$	35	65	120		
h_{fe}	$I_C = 500 \text{ mA}, V_{CE} = 1\text{V}$	25	50	100		
h_{fe}	$I_C = 800 \text{ mA}, V_{CE} = 1\text{V}$	20	28	40		
h_{fe}	$I_C = 1\text{A}, V_{CE} = 1\text{V}$	15	25	35		
h_{fe}	$I_C = 800 \text{ mA}, V_{CE} = 2\text{V}$	25	38	60		
h_{fe}	$I_C = 1\text{A}, V_{CE} = 5\text{V}$	25	40	60		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.155	0.20	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.155	0.20	V	
$V_{CE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$		0.240	0.40	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.350	0.50	V	
$V_{CE(SAT)}$	$I_C = 800 \text{ mA}, I_B = 80 \text{ mA}$		0.50	0.80	V	
$V_{CE(SAT)}$	$I_C = 1\text{A}, I_B = 100 \text{ mA}$		0.70	1.20	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.66	0.70	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$		0.77	0.85	V	
$V_{BE(SAT)}$	$I_C = 300 \text{ mA}, I_B = 30 \text{ mA}$		0.88	1.20	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.95	1.20	V	
$V_{BE(SAT)}$	$I_C = 800 \text{ mA}, I_B = 80 \text{ mA}$		1.10	1.50	V	
$V_{BE(SAT)}$	$I_C = 1\text{A}, I_B = 100 \text{ mA}$		1.18	1.70	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	30	50	60	V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	50	100	140	V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	5.5	6.5	7.0	V	
I_{CBO}	$V_{CB} = 40\text{V}$			1.0	μA	
I_{EBO}	$V_{EB} = 4\text{V}$			1.0	μA	

Process 25

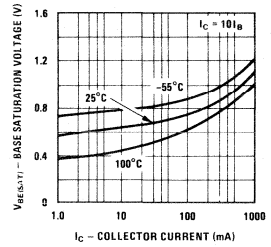
DC Pulse Current Gain vs Collector Current



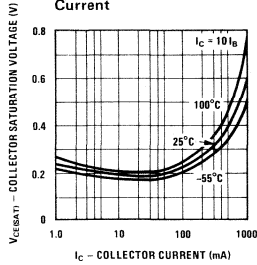
Base-Emitter On Voltage vs Collector Current



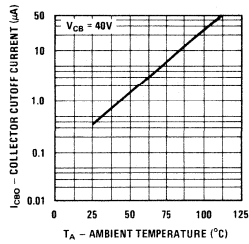
Base Saturation Voltage vs Collector Current



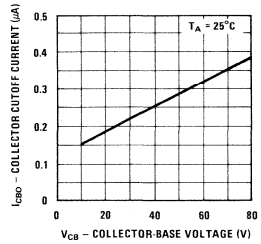
Collector Saturation Voltage vs Collector Current



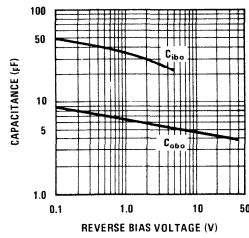
Collector Cutoff Current vs Ambient Temperature



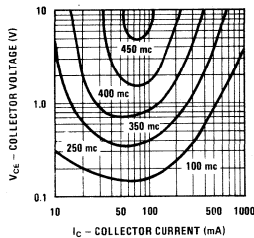
Collector Cutoff Current vs Reverse Bias Voltage



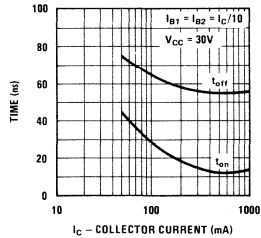
Input and Output Capacitance vs Reverse Bias



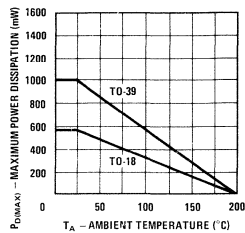
Contours of Constant Bandwidth Product (f_T)



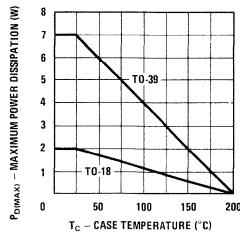
Turn On and Turn Off Times vs Collector Current



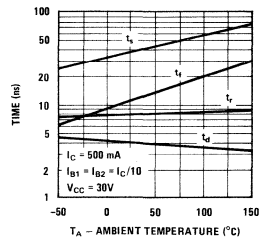
Maximum Power Dissipation vs Ambient Temperature



Maximum Power Dissipation vs Case Temperature

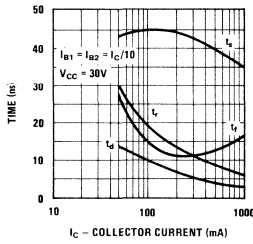


Switching Times vs Ambient Temperature

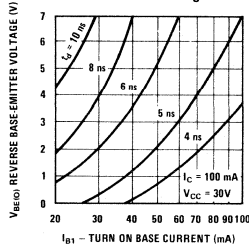


Process 25

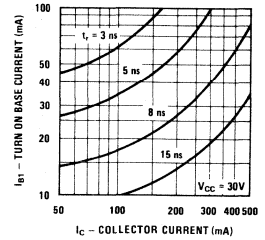
Switching Times vs Collector Current



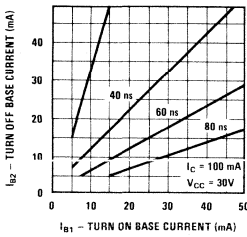
Delay Time vs Turn On Base Current and Reverse Base Emitter Voltage



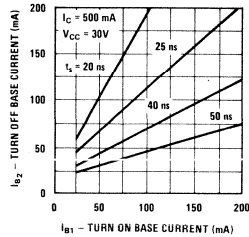
Rise Time vs Collector and Turn On Base Currents



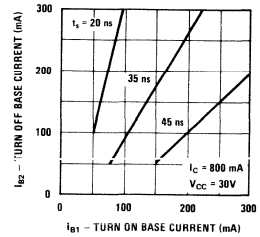
Storage Time vs Turn On and Turn Off Base Currents



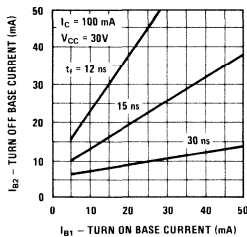
Storage Time vs Turn On and Turn Off Base Currents



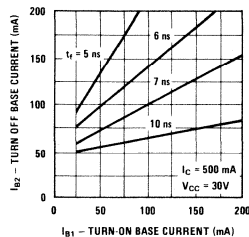
Storage Time vs Turn On and Turn Off Base Currents



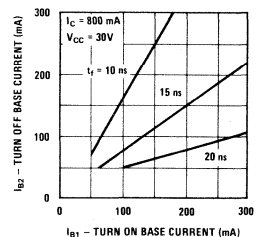
Fall Time vs Turn On and Turn Off Base Currents



Fall Time vs Turn On and Turn Off Base Currents



Fall Time vs Turn On and Turn Off Base Currents



SWITCHING TIME TEST CIRCUIT

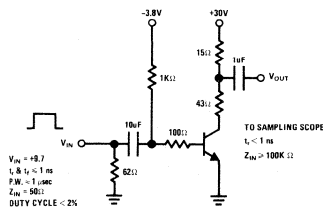
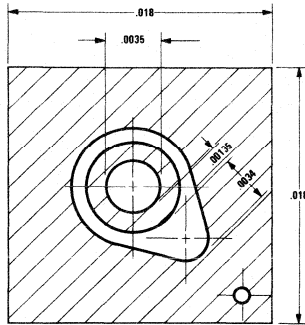


FIGURE 1. $I_C \approx 500$ mA, $I_{B1} \approx 50$ mA, $I_{B2} \approx -50$ mA



Process 26 NPN Small Signal



DESCRIPTION

Process 26 is a nonoverlay double diffused, silicon device.

APPLICATION

This device was designed for use as a general purpose amplifier useful to 100 MHz.

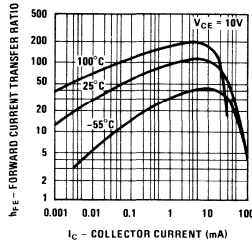
PRINCIPLE DEVICE TYPES:

TO-106 SE1001

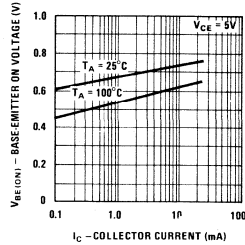
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF (spot)	$I_C = 200 \mu A, V_{CE} = 5V$ $R_S = 2k, f = 1 \text{ kHz}, \text{PBW} = 200 \text{ Hz}$		1.5	4	dB	
h_{fe}	$I_C = 10 \text{ mA}, V_{CE} = 10V$ $f = 100 \text{ MHz}$	2	4			
C_{cb}	$V_{CB} = 10V$		2.0	3.5	pF	TO-92
C_{eb}	$V_{EB} = .5V$		7.0	10	pF	
h_{FE}	$I_C = 10 \mu A, V_{CE} = 10V$	20	50			
h_{FE}	$I_C = 100 \mu A, V_{CE} = 10V$	20	80			
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 10V$	20	100			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 10V$	20	120	400		
h_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 10V$	10	130			
$V_{CE(SAT)}$	$I_C = 1 \text{ mA}, I_B = .1 \text{ mA}$		0.2	1	V	
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.45	2	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ mA}, I_B = .1 \text{ mA}$		0.65	0.80	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.8	1.0	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	40			V	
BV_{CBO}	$I_C = 100 \mu A$	40			V	
BV_{EBO}	$I_E = 10 \mu A$	5			V	
I_{CBO}	$V_{CB} = 20V$			50	nA	
I_{EBO}	$V_{EB} = 3V$			50	nA	

Process 26

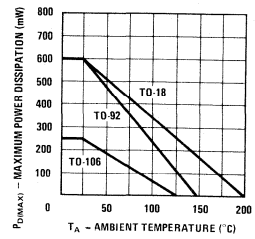
Pulsed DC Current Gain vs Collector Current



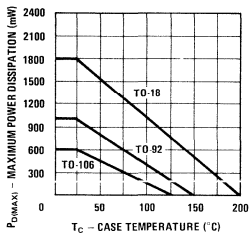
Base-Emitter On Voltage vs Collector Current



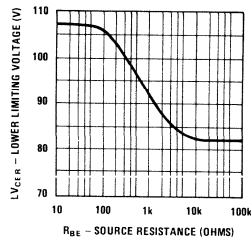
Maximum Power Dissipation vs Ambient Temperature



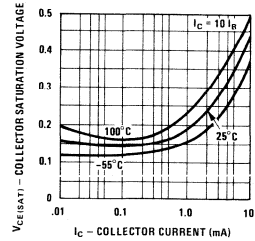
Maximum Power Dissipation vs Case Temperature



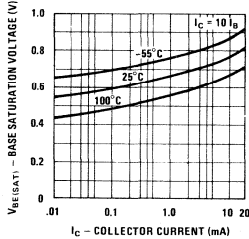
Lower Limiting Voltage vs Source Resistance



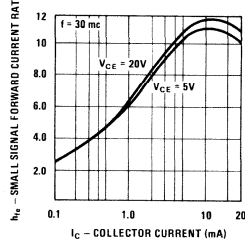
Collector Saturation Voltage vs Collector Current



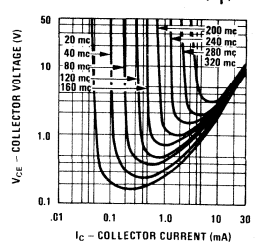
Base Saturation Voltage vs Collector Current



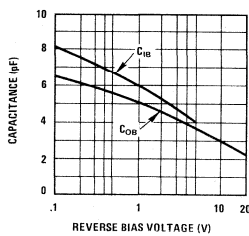
High Frequency Current Gain vs Collector Current



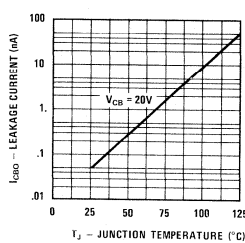
Contours of Constant Gain Bandwidth Product (fT)



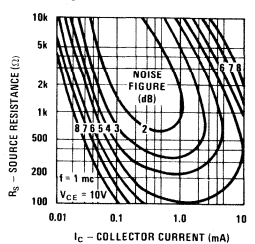
Capacitance vs Reverse Bias Voltage



Collector-Base Diode Reverse Current vs Temperature

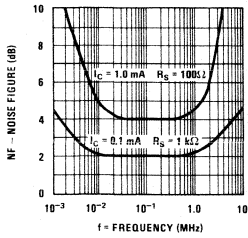


Contours of Spot Noise Figure

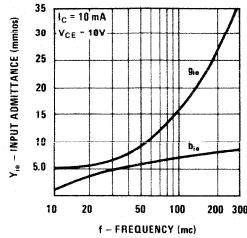


Process 26

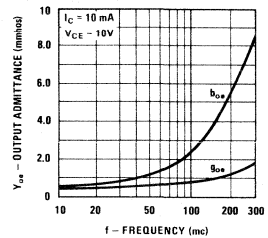
Noise Figure vs Frequency



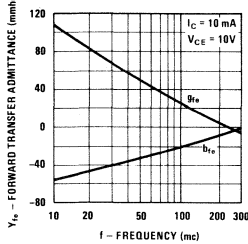
Input Admittance vs Frequency-Output Short Circuit



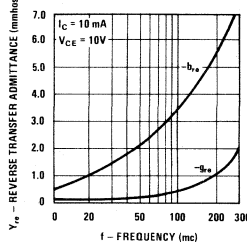
Output Admittance vs Frequency-Input Short Circuit



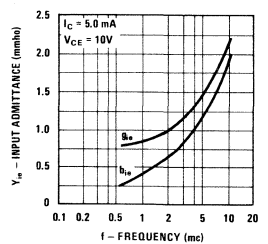
Forward Transfer Admittance vs Frequency-Output Short Circuit



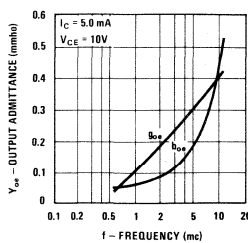
Reverse Transfer Admittance vs Frequency-Input Short Circuit



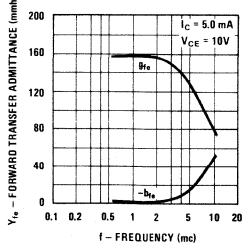
Input Admittance vs Frequency-Output Short Circuit



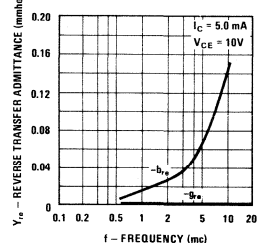
Output Admittance vs Frequency-Input Short Circuit



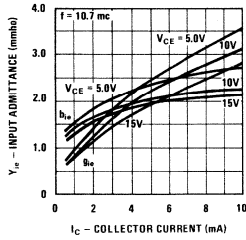
Forward Transfer Admittance vs Frequency-Output Short Circuit



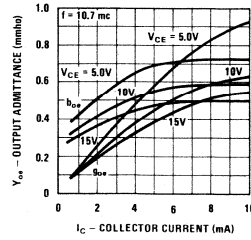
Reverse Transfer Admittance vs Frequency-Input Short Circuit



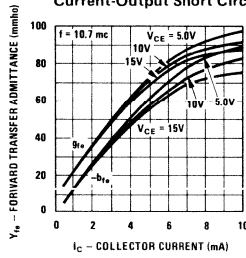
Input Admittance vs Collector Current-Output Short Circuit



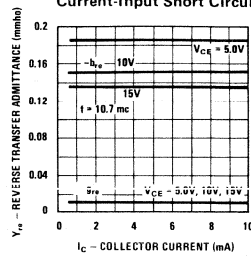
Output Admittance vs Collector Current-Input Short Circuit



Forward Transfer Admittance vs Collector Current-Output Short Circuit



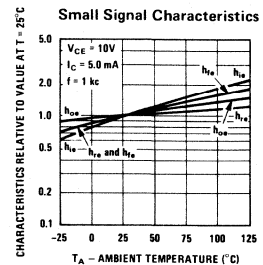
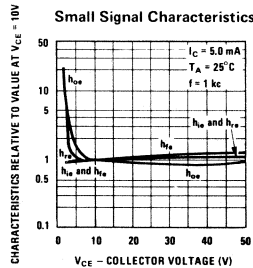
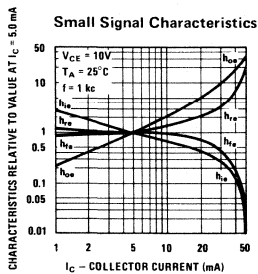
Reverse Transfer Admittance vs Collector Current-Input Short Circuit



SMALL SIGNAL CHARACTERISTICS (f = 1.0 kHz)

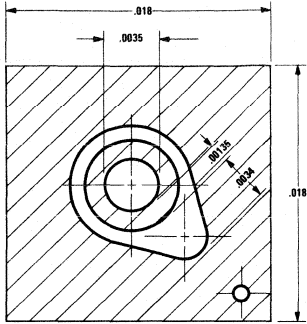
SYMBOL	CHARACTERISTIC	TYP.	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance	1130	Ohms	$I_C = 5.0 \text{ mA}$ $V_{CE} = 10V$
h_{oe}	Output Conductance	35	μmho	$I_C = 5.0 \text{ mA}$ $V_{CE} = 10V$
h_{re}	Voltage Feedback Ratio	1.25	$\times 10^{-4}$	$I_C = 5.0 \text{ mA}$ $V_{CE} = 10V$
h_{fe}	Small Signal Current Gain	145		$I_C = 5.0 \text{ mA}$ $V_{CE} = 10V$

TYPICAL COMMON EMITTER CHARACTERISTICS (f = 1.0 kHz)





Process 27 NPN Small Signal



DESCRIPTION

Process 27 is a nonoverlay, double diffused, silicon epitaxial device. Complement to Process 69.

APPLICATION

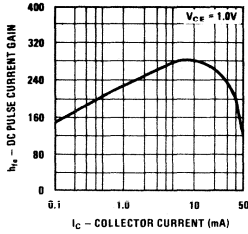
This device is designed for general purpose amplifier and switch useful from audio to RF frequencies.

PRINCIPAL DEVICE TYPES:

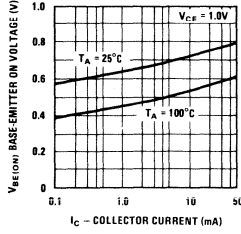
TO-18 2N915
 TO-92 MPSA20 (EBC), 2N2925 (ECB)
 TO-106 2N3694

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF (wide band)	$V_{CE} = 5V, I_C = 100 \mu A, f_{BW} = 15.7 \text{ kHz}$		1.5		dB	
NF (spot)	$V_{CE} = 5V, I_C = 100 \mu A, f = 1 \text{ kHz}$ $R_S = 1k$		1.5	3.0	dB	
C_{cb}	$V_{CB} = 10V, f = 1 \text{ MHz}$		2.0	2.5	pF	TO-18
C_{ob}	$V_{CB} = 10V, f = 1 \text{ MHz}$		2.5	3.0	pF	TO-18
C_{ib}	$V_{EB} = 0.50V, f = 1 \text{ MHz}$		5.5	7.0	pF	TO-18
f_T	$V_{CE} = 10V, I_C = 10 \text{ mA}$	100	500		MHz	
t_{on}	$V_{CE} = 10V, I_C = 10 \text{ mA}, I_{B1} = 1 \text{ mA}$	30	40	50	ns	
t_{off}	$V_{CE} = 10V, I_C = 10 \text{ mA}, I_{B2} = 1 \text{ mA}$	400	600	700	ns	
h_{FE}	$V_{CE} = 10V, I_C = 100 \mu A$	50	200	500		
h_{FE}	$V_{CE} = 10V, I_C = 1 \text{ mA}$	50	220	500		
h_{FE}	$V_{CE} = 10V, I_C = 10 \text{ mA}$	50	250	500		
h_{FE}	$V_{CE} = 10V, I_C = 50 \text{ mA}$	50	240	500		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.055	0.10	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.770	1.0	V	
BV_{CBO}	$I_C = 100 \mu A$	50	70		V	
BV_{CEO}	$I_C = 10 \text{ mA}$	30	50		V	
BV_{EBO}	$I_E = 10 \mu A$	5.0	6.5		V	
I_{CBO}	$V_{CB} = 40$			50	nA	
I_{EBO}	$V_{EB} = 4.0$			50	nA	

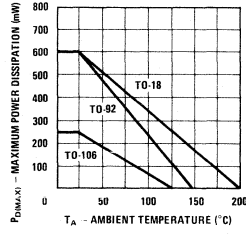
DC Pulse Current Gain vs Collector Current



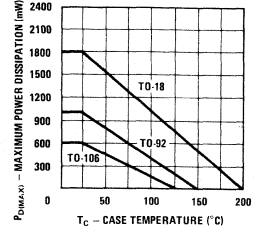
Base-Emitter On Voltage vs Collector Current



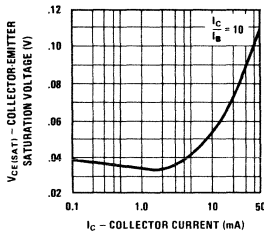
Maximum Power Dissipation vs Ambient Temperature



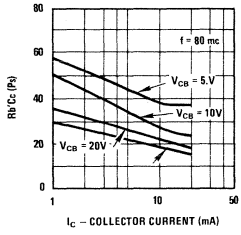
Maximum Power Dissipation vs Case Temperature



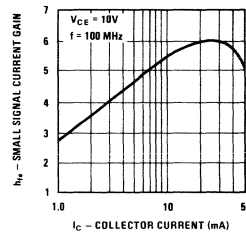
Collector-Emitter Saturation Voltage vs Collector Current



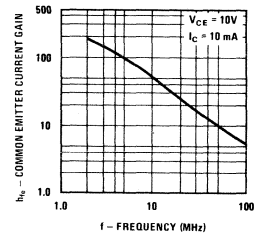
Rb'Cc vs Collector Current



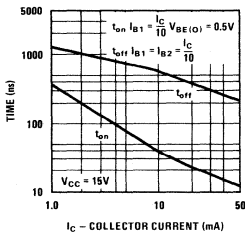
Small Signal Current Gain vs Collector Current



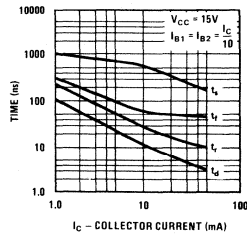
Small Signal Current Gain vs Frequency



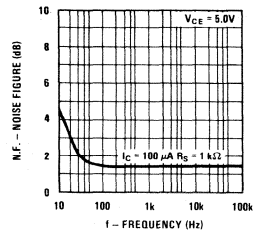
t_{on} And t_{off} vs Collector Current



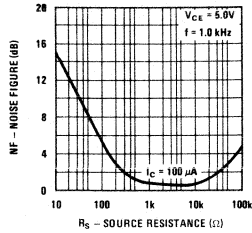
Switching Times vs Collector Current



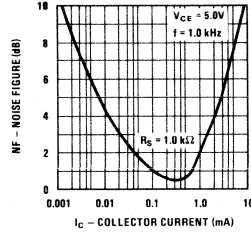
Noise Figure vs Frequency



Noise Figure vs Source Resistance

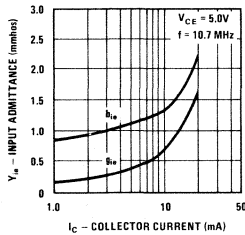


Noise Figure vs Collector Current

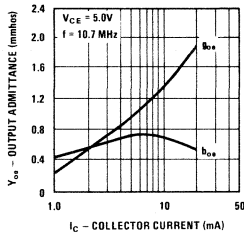


COMMON EMITTER Y PARAMETERS

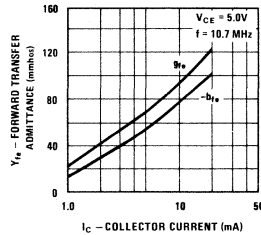
Input Admittance vs Collector Current



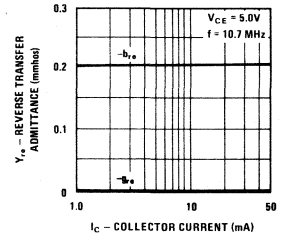
Output Admittance vs Collector Current



Forward Transfer Admittance vs Collector Current

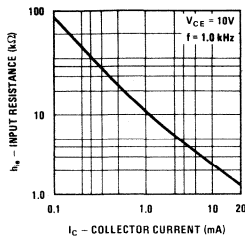


Reverse Transfer Admittance vs Collector Current

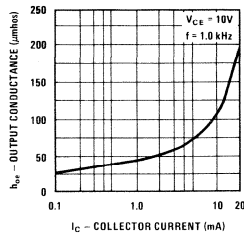


COMMON EMITTER H PARAMETERS

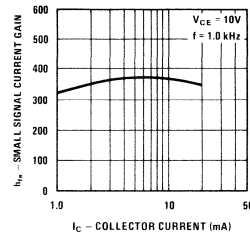
Small Signal Input Resistance vs Collector Current



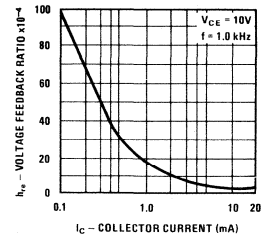
Small Signal Output Conductance vs Collector Current



Small Signal Current Gain vs Collector Current

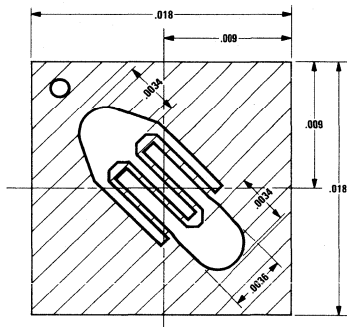


Small Signal Voltage Feedback Ratio vs Collector Current





Process 28 NPN High Speed Switch



DESCRIPTION

Process 28 is a double diffused, gold doped, silicon epitaxial device. Complement to Process 64.

APPLICATION

This device was designed for high speed medium voltage logic applications.

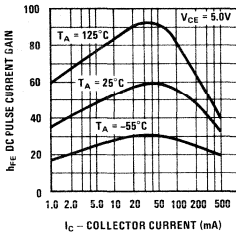
PRINCIPAL DEVICE TYPES:

TO-52 2N3014

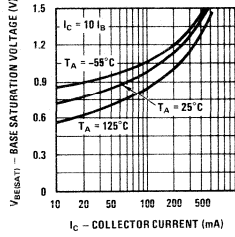
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 30 \text{ mA}, I_{B1} = 3 \text{ mA}, V_{CE} = 2\text{V}$		11	16	ns	Fig. 1
t_{off}	$I_C = 30 \text{ mA}, I_{B1} = -I_{B2} = 3 \text{ mA}, V_{CE} = 2\text{V}$		10	25	ns	Fig. 1
t_s	$I_C = I_{B1} = -I_{B2} = 10 \text{ mA}, V_{CE} = 10\text{V}$		8	18	ns	Fig. 2
h_{FE}	$I_C = 30 \text{ mA}, V_{CE} = 10\text{V}, f = 100 \text{ MHz}$	3.5	5.5			
C_{ob}	$V_{CB} = 5\text{V}$			5	pF	
C_{ib}	$V_{EB} = 0.5\text{V}$			8	pF	
H_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 0.4\text{V}$	25				
H_{FE}	$I_C = 30 \text{ mA}, V_{CE} = 0.4\text{V}$	30		120		
H_{FE}	$I_C = 100 \text{ mA}, V_{CE} = 1\text{V}$	25				
H_{FE}	$I_C = 30 \text{ mA}, V_{CE} = 0.4\text{V}, T_A = -55^\circ\text{C}$	12				
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$			0.18	V	
$V_{CE(SAT)}$	$I_C = 30 \text{ mA}, I_B = 3 \text{ mA}$			0.18	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$			0.35	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$			0.8	V	
$V_{BE(SAT)}$	$I_C = 30 \text{ mA}, I_B = 3 \text{ mA}$			0.95	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}, I_B = 10 \text{ mA}$			1.2	V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	40			V	
BV_{CEO}	$I_C = 10 \text{ mA}$	20			V	
BV_{CES}	$I_C = 100 \mu\text{A}$	40			V	
BV_{EBO}	$I_E = 100 \mu\text{A}$	5.0			V	
I_{CES}	$V_{CE} = 20\text{V}$			0.3	μA	
I_{CES}	$V_{CE} = 20\text{V}, T_A = 125^\circ\text{C}$			40	μA	

Process 28

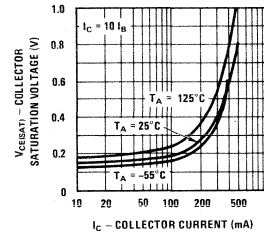
DC Pulse Current Gain vs Collector Current



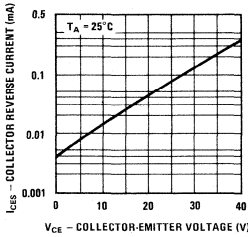
Base Saturation Voltage vs Collector Current



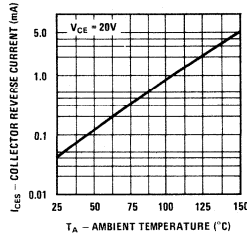
Collector Saturation Voltage vs Collector Current



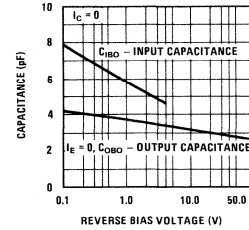
Collector Reverse Current vs Reverse Bias Voltage



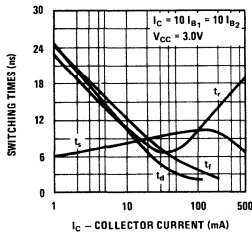
Collector Reverse Current vs Ambient Temperature



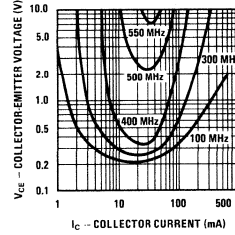
Input and Output Capacitance vs Reverse Bias Voltage



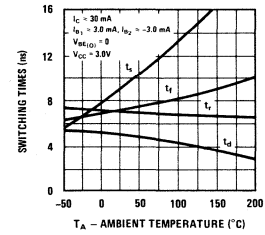
Switching Times vs Collector Current



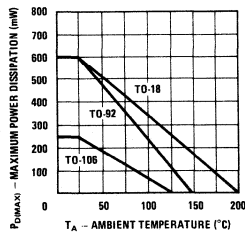
Contours of Constant Gain Bandwidth Product (fT)



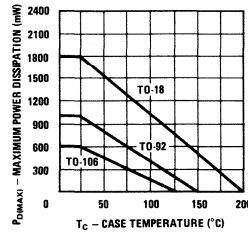
Switching Times vs Ambient Temperature



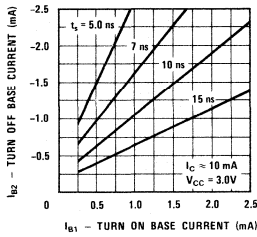
Maximum Power Dissipation vs Case Temperature



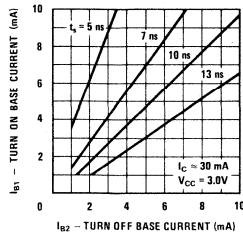
Maximum Power Dissipation vs Ambient Temperature



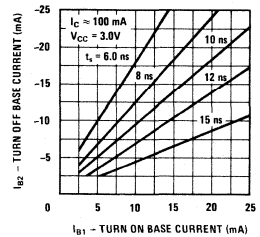
Storage Time vs Turn On and Turn Off Base Currents



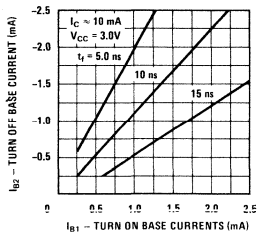
Storage Time vs Turn On and Turn Off Base Currents



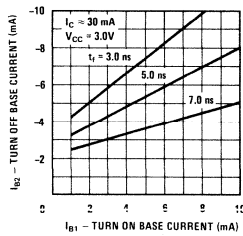
Storage Time vs Turn On and Turn Off Base Currents



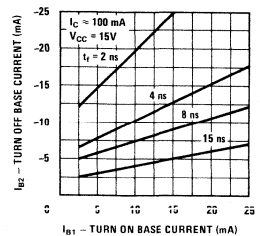
Fall Time vs Turn On and Turn Off Base Currents



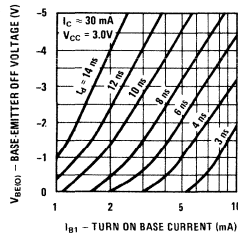
Fall Time vs Turn On and Turn Off Base Currents



Fall Time vs Turn On and Turn Off Base Currents



Delay Time vs Base-Emitter Off Voltage and Turn On Base Current



Rise Time vs Collector and Turn On Base Current

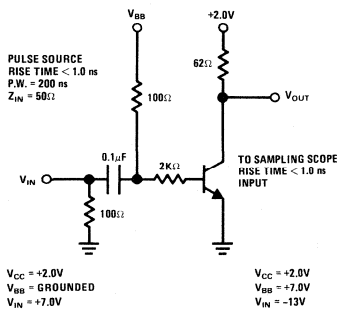
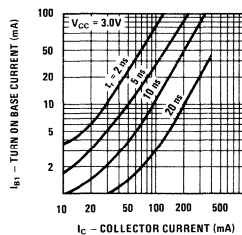


FIGURE 1. t_{on} and t_{off} Test Circuit

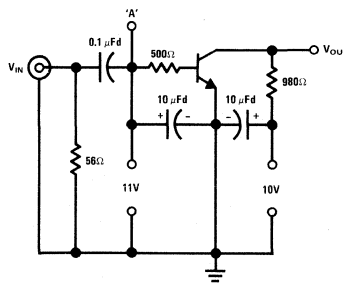
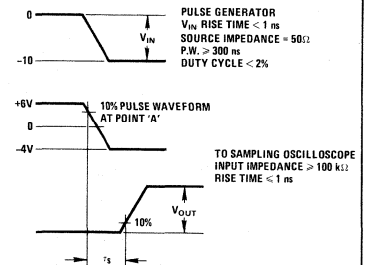
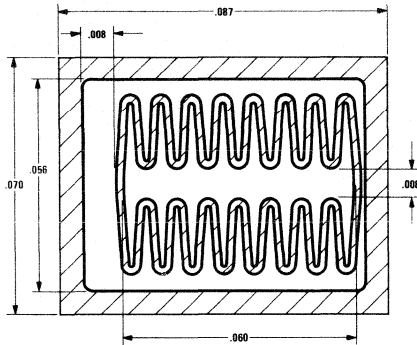


FIGURE 2. Charge Storage Time Measurement Circuit





Process 34 NPN Power Signal



DESCRIPTION

This device is nonoverlay double diffused, silicon epitaxial transistor.

APPLICATION

This device was designed for general purpose amplifier application utilizing collector currents to 5 amps.

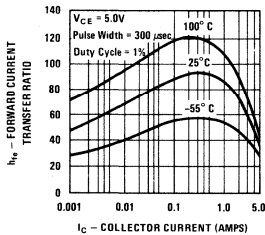
PRINCIPAL DEVICE TYPES:

TO-39 2N2891

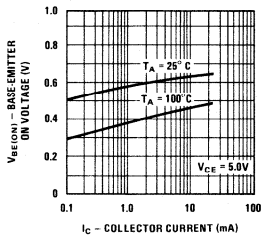
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 1A, I_{B1} = 0.1A$		90	120	ns	
t_{off}	$I_C = 1A, I_{B2} = 0.1A$		200	260	ns	
C_{ob}	$V_{CB} = 10V$		60	70	pF	
C_{ib}	$V_{EB} = 0.5V$		425	500	pF	
h_{fe}	$I_C = 200 mA, V_{CE} = 10V, f = 20 MHz$	4.0	5.0			
h_{FE}	$I_C = 1 mA, V_{CE} = 5V$	40	50	100		
h_{FE}	$I_C = 10 mA, V_{CE} = 5V$	40	70	100		
h_{FE}	$I_C = 100 mA, V_{CE} = 5V$	40	90	120		
h_{FE}	$I_C = 500 mA, V_{CE} = 5V$	40	95	150		
h_{FE}	$I_C = 1A, V_{CE} = 5V$	20	30	100		
h_{FE}	$I_C = 5A, V_{CE} = 5V$	15	20			
$V_{CE(SAT)}$	$I_C = 100 mA, I_B = 10 mA$		0.05	0.10	V	
$V_{CE(SAT)}$	$I_C = 1A, I_B = 100 mA$		0.20	0.25	V	
$V_{BE(SAT)}$	$I_C = 100 mA, I_B = 10 mA$		0.70	0.85	V	
$V_{BE(SAT)}$	$I_C = 1A, I_B = 100 mA$		0.90	1.10	V	
BV_{CEO}	$I_C = 10 mA$	80	100			
BV_{CBO}	$I_C = 100 \mu A$	100	150			
BV_{EBO}	$I_E = 10 \mu A$	8	10			
I_{CBO}	$V_{CB} = 60V$			100	nA	
I_{EBO}	$V_{EB} = 6V$			100	nA	

Process 34

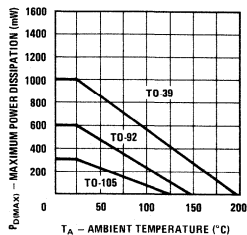
Pulsed DC Current Gain vs Collector Current



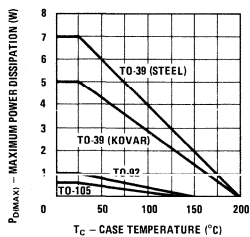
Base-Emitter On Voltage vs Collector Current



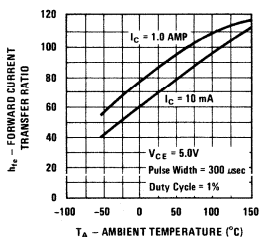
Maximum Power Dissipation vs Ambient Temperature



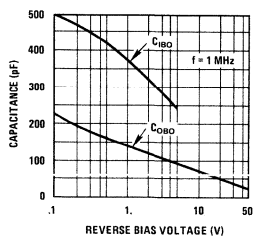
Maximum Power Dissipation vs Case Temperature



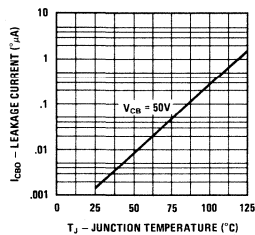
Pulsed DC Current Gain vs Ambient Temperature



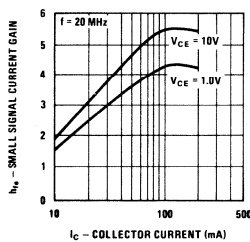
Capacitance vs Reverse Bias Voltage



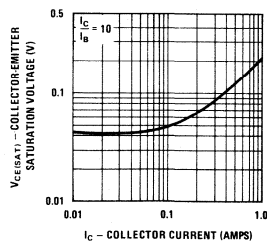
Collector-Base Diode Reverse Current vs Temperature



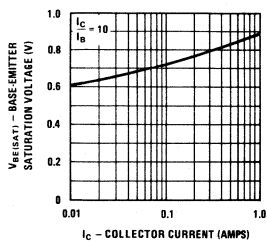
Small Signal Current Gain vs Collector Current



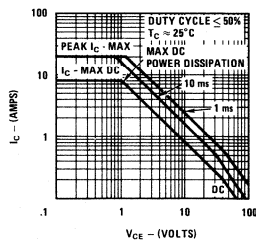
Collector-Emitter Saturation Voltage vs Collector Current



Base-Emitter Saturation Voltage vs Collector Current

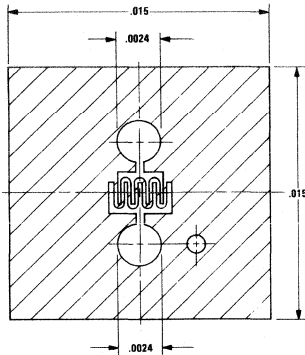


Safe Region of Operation





Process 42 NPN RF Amplifier



DESCRIPTION

Process 42 is an overlay double diffused silicon epitaxial device.

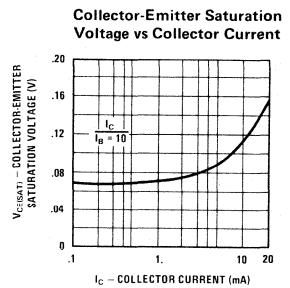
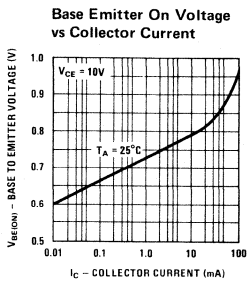
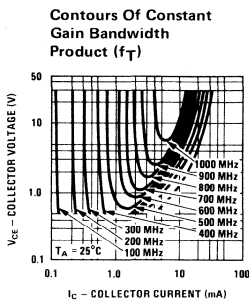
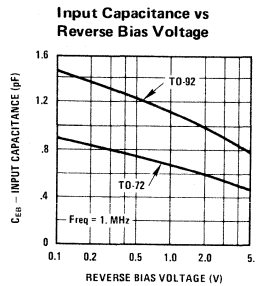
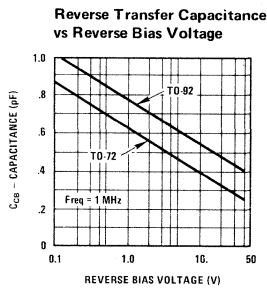
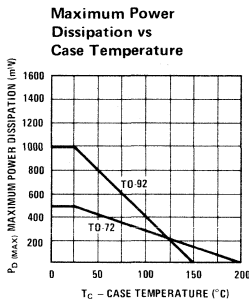
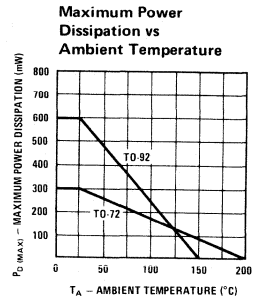
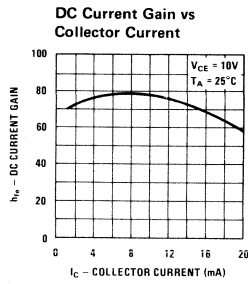
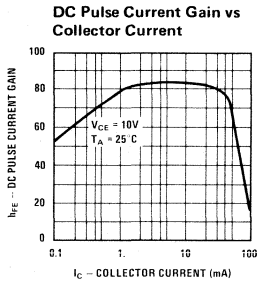
APPLICATION

This device was designed for use in low noise UHF/VHF amplifiers with collector current in the $100 \mu\text{A}$ to 10 mA range in common emitter or common base mode of operation.

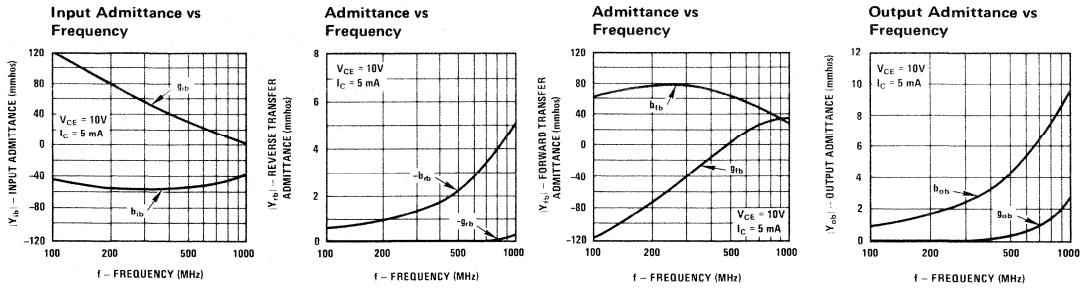
PRINCIPAL DEVICE TYPES:

TO-72 2N5179
TO-92 2SC535 (ECB), MPS-H10 (BEC)

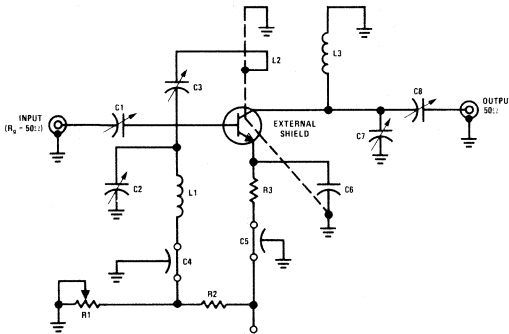
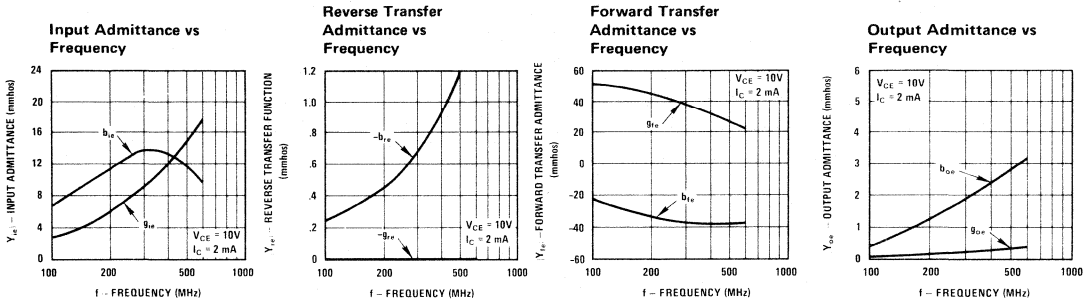
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
PG	$f = 450 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_C = 2 \text{ mA}$	10	14		dB	Fig. 1
NF	$f = 450 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_C = 2 \text{ mA}$ $R_g = 50\Omega$			5.0	dB	Fig. 1
PG	$f = 200 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_C = 2 \text{ mA}$	22	27		dB	Fig. 2
NF	$f = 200 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_C = 2 \text{ mA}$ $R_S = 120\Omega$		2.0	3.5	dB	Fig. 2
h_{fe}	$f = 100 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_C = 5 \text{ mA}$	7.0	10	15		
$rb'Cc$	$f = 79.8 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_C = 5 \text{ mA}$		3.5	10	ps	TO-72
C_{cb}	$f = 1.0 \text{ MHz}$, $V_{CB} = 10\text{V}$, $I_E = 0$		0.4	0.5	pF	TO-72
C_{ce}	$f = 1.0 \text{ MHz}$, $V_{CE} = 10\text{V}$, $I_B = 0$		0.2	0.3	pF	TO-72
C_{eb}	$f = 1.0 \text{ MHz}$, $V_{EB} = 0.5\text{V}$, $I_C = 0$		0.8	1.5	pF	TO-72
h_{FE}	$V_{CE} = 10\text{V}$, $I_C = 5 \text{ mA}$	30	80	250		
h_{FE}	$V_{CE} = 6\text{V}$, $I_C = 1 \text{ mA}$	20	65			
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 5 \text{ mA}$		0.07	0.3	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	30	45		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	35	50		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	3.0	5.5		V	
I_{CBO}	$V_{CB} = 30\text{V}$			100	nA	
I_{EBO}	$V_{EB} = 2.0$			50	nA	



COMMON BASE Y PARAMETERS VS FREQUENCY

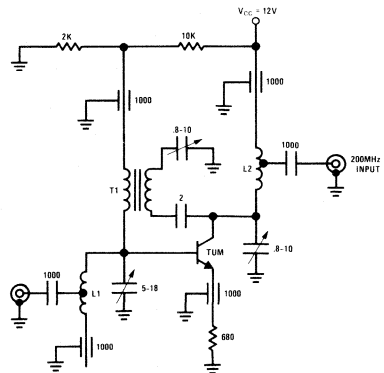


COMMON EMITTER Y PARAMETERS VS FREQUENCY



- C1, C2, C3, C7, C8 - 0.8-10 pF VARIABLE CAPACITOR
- C3 - PLASTIC TUBULAR TRIMMER CAPACITOR (ADJUSTED AND FIXED FOR A TRANSISTOR HAVING A TYPICAL VALUE OF C_{cb} OF 0.34 pF)
- C4 - 200 pF BUTTON TYPE FEEDTHROUGH CAPACITOR
- C5 - 1000 pF FEEDTHROUGH CAPACITOR
- C6 - 470 pF LEADLESS CERAMIC DISC CAPACITOR
- L1, L3 - 1" LENGTH OF 1/4" DIAMETER COPPER BAR STOCK
- L2 - 1/2 LOOP No. 14 AWG ENAMELED WIRE PARALLEL TO AND APPROXIMATELY 1/4" FROM L3
- R1 - 5k POTENTIOMETER
- R2 - 1.2k
- R3 - 2k

FIGURE 1. Neutralized 450-MHz Gain and Noise Figure Circuit



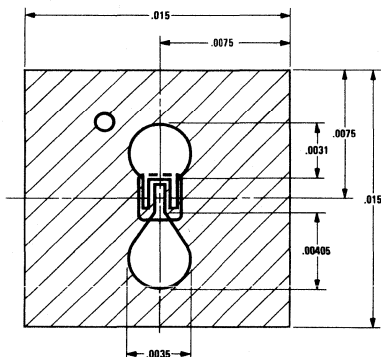
- L1 - 3T #16 WIRE, 1/2" L x 1/4" TAPPED 1/2T FROM COLD SIDE
- L2 - 6T #14 WIRE, 1" L x 1/4" TAPPED 1/2T FROM COLD SIDE
- T1 - #00 TT #16 WIRE CORE IS INDIANA GENERAL P/N F-684-03 SEC. 1T - 18 WIRE

ALL CAPACITANCE IN pF. ALL RESISTANCE IN OHMS.

FIGURE 2. Neutralized 200-MHz PF & NF Circuit



Process 43 NPN UHF Oscillator



DESCRIPTION

Process 43 is an overlay double diffused, silicon epitaxial device.

APPLICATION

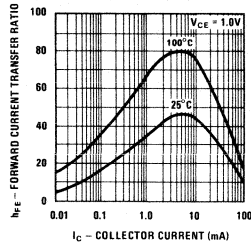
This device was designed for use as RF amplifiers and UHF oscillators with collector current in the 1 mA to 20 mA range.

PRINCIPAL DEVICE TYPES:

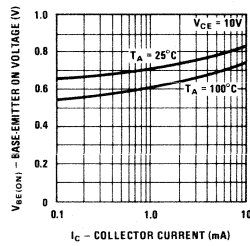
- TO-72 2N918
- TO-92 MPS3563 (EBC), 2N3663 (ECB)
- TO-106 2N3563, SE3002

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
G_{PE}	$f = 200 \text{ MHz}, I_C = 5 \text{ mA}, V_{CE} = 10 \text{ V}$	15	18		dB	Neutralized
NF	$f = 60 \text{ MHz}, I_C = 1 \text{ mA}, V_{CE} = 10 \text{ V}$ $R_S = 200 \Omega$		3	5	dB	
PO	$f = 500 \text{ MHz}, I_C = 8 \text{ mA}, V_{CE} = 15 \text{ V}$	30	35		mW	
PO	$f = 900 \text{ MHz}, I_C = 8 \text{ mA}, V_{CE} = 15 \text{ V}$	3	7		mW	
h_{fe}	$I_C = 5 \text{ mA}, V_{CE} = 10 \text{ V}, f = 100 \text{ MHz}$	6	9			
C_{cb}	$V_{CB} = 10 \text{ V}$		1.5	2.5	pF	
C_{eb}	$V_{EB} = .5 \text{ V}$		1.4	2.0	pF	
h_{FE}	$I_C = 100 \mu\text{A}, V_{CE} = 1 \text{ V}$	10	20			
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 1 \text{ V}$	20	35			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 1 \text{ V}$	20	45	150		
h_{FE}	$I_C = 5 \text{ mA}, V_{CE} = 10 \text{ V}$	20	100	200		
$V_{CE(SAT)}$	$I_C = 1 \text{ mA}, I_B = .1 \text{ mA}$		0.20	0.30	V	
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.25	0.40	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ mA}, I_B = .1 \text{ mA}$		0.75	0.85	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.85	0.95	V	
BV_{CEO}	$I_C = 3 \text{ mA}$	15	22		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	30	45		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	3	5.2		V	
I_{CBO}	$V_{CB} = 15 \text{ V}$			50	nA	
I_{EBO}	$V_{CB} = 3 \text{ V}$			50	nA	

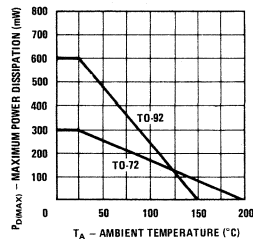
Pulsed DC Current Gain vs Collector Current



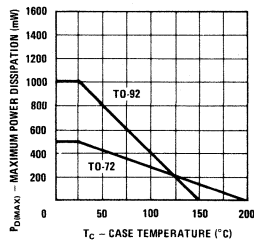
Base-Emitter On Voltage vs Collector Current



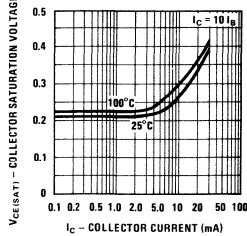
Maximum Power Dissipation vs Ambient Temperature



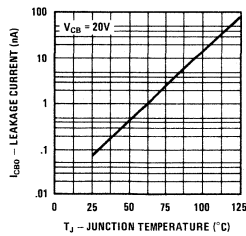
Maximum Power Dissipation vs Case Temperature



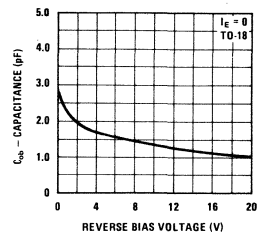
Collector Saturation Voltage vs Collector Current



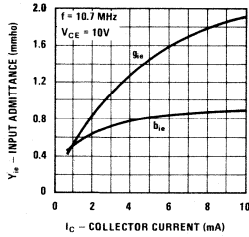
Collector-Base Diode Reverse Current vs Temperature



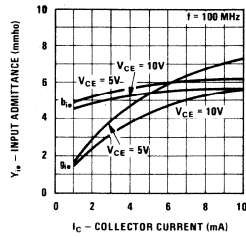
Output Capacitance vs Reverse Bias Voltage



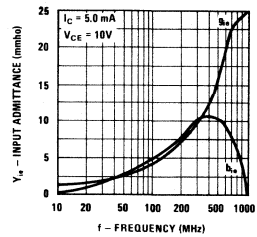
Input Admittance vs Collector Current-Output Short Circuit



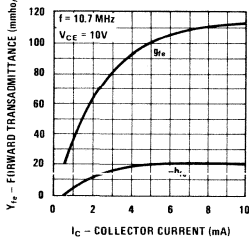
Input Admittance vs Collector Current-Output Short Circuit



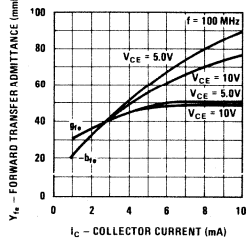
Input Admittance vs Frequency-Output Short Circuit



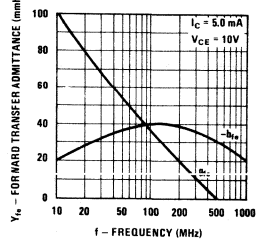
Forward Transfer Admittance vs Collector Current-Output Short Circuit



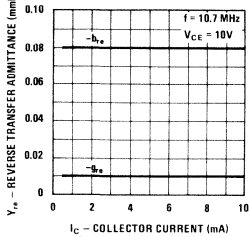
Forward Transfer Admittance vs Collector Current-Output Short Circuit



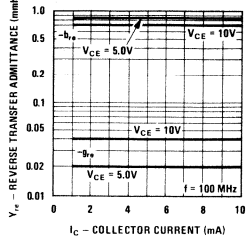
Forward Transfer Admittance vs Frequency-Output Open Circuit



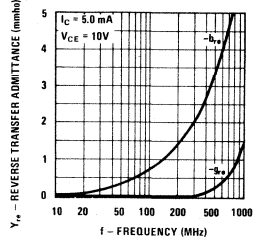
Reverse Transfer Admittance vs Collector Current-Input Short Circuit



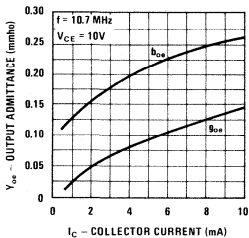
Reverse Transfer Admittance vs Collector Current-Input Short Circuit



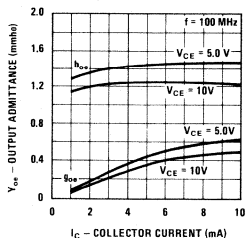
Reverse Transfer Admittance vs Frequency-Input Short Circuit



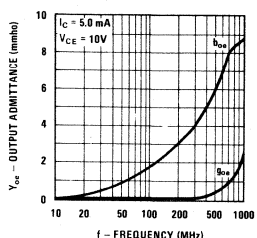
Output Admittance vs Collector Current-Input Short Circuit



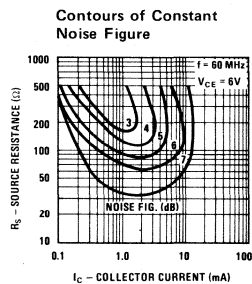
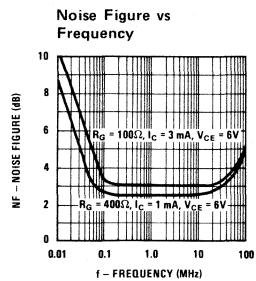
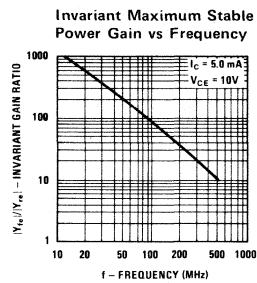
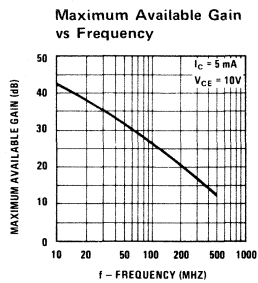
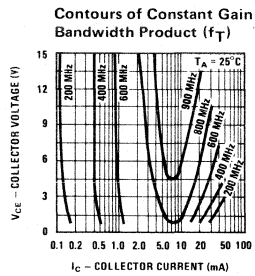
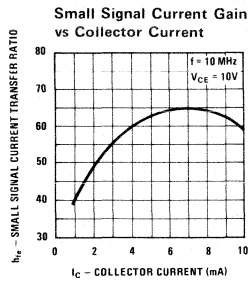
Output Admittance vs Collector Current-Input Short Circuit



Output Admittance vs Frequency-Input Short Circuit

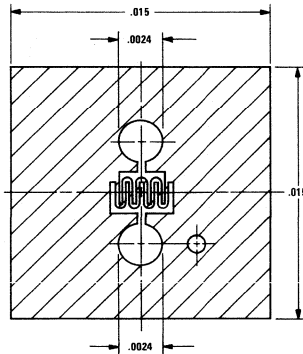


Process 43





Process 44 NPN AGC-RF Amplifier



DESCRIPTION

Process 44 is an overlay double diffused, silicon device.

APPLICATION

This device was designed for use as a low noise VHF amplifier with forward AGC capability.

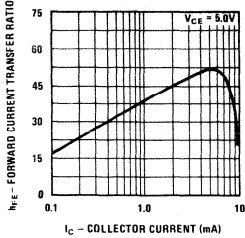
PRINCIPLE DEVICE TYPES:

TO-72 SE5020
TO-92 MPS-H30 (BEC)

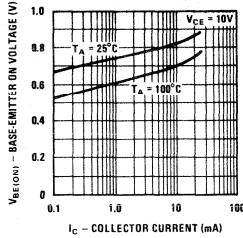
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF	$f = 200 \text{ MHz}$, $I_C = 2 \text{ mA}$, $V_{CE} = 10 \text{ V}$, $R_S = 50\Omega$		2.5	3.3	dB	Fig. 1
P_G	$f = 200 \text{ MHz}$, $I_C = 2 \text{ mA}$, $V_{CE} = 10 \text{ V}$, $R_S = 50\Omega$	20	24	27	dB	Fig. 1
NF	$f = 45 \text{ MHz}$, $I_C = 4 \text{ mA}$, $V_{CE} = 10 \text{ V}$, $R_S = 50\Omega$		3.0	5.0	dB	Fig. 2
P_G	$f = 45 \text{ MHz}$, $I_C = 4 \text{ mA}$, $V_{CE} = 10 \text{ V}$, $R_S = 50\Omega$	23	26	30	dB	Fig. 2
AGC	$f = 200 \text{ MHz}$, V_{AGC} at 30 dB Down	4.0	4.5	5.0	V	Fig. 1
AGC	$f = 45 \text{ MHz}$, V_{AGC} at 30 dB Down	4.5	5.0	5.5	V	Fig. 2
C_{cb}	$V_{CB} = 10 \text{ V}$		0.35	0.50	pF	TO-72
h_{fe}	$V_{CE} = 10 \text{ V}$, $I_C = 4 \text{ mA}$, $I_C = 100 \text{ MHz}$	3.75	5.0	8.0		
h_{FE}	$I_C = 4 \text{ mA}$, $V_{CE} = 10 \text{ V}$	20	60	200		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 5 \text{ mA}$		2.0	3.0	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 5 \text{ mA}$		0.85	0.92	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	20			V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	20			V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	3			V	
I_{CBO}	$V_{CB} = 15 \text{ V}$			10	nA	
I_{EBO}	$V_{EB} = 2 \text{ V}$			10	nA	

Process 44

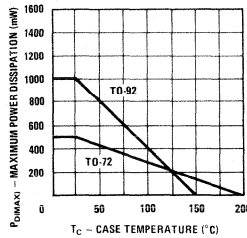
Pulsed DC Current Gain vs Collector Current



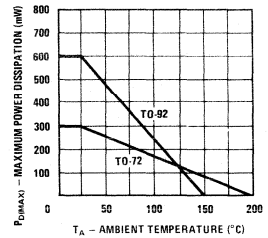
Base-Emitter On Voltage vs Collector Current



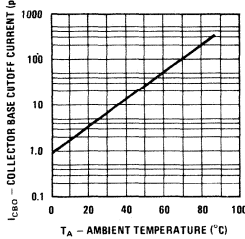
Maximum Power Dissipation vs Case Temperature



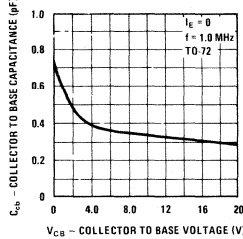
Maximum Power Dissipation vs Ambient Temperature



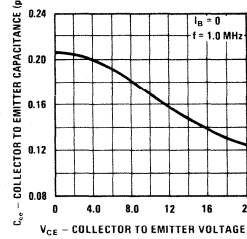
Collector Cutoff Current vs Ambient Temperature



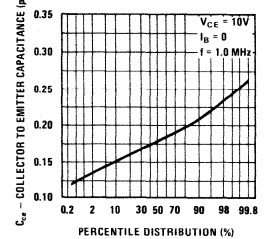
Collector to Base Capacitance vs Collector to Base Voltage



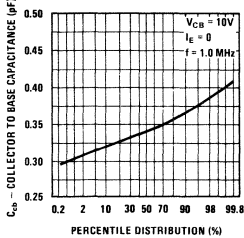
Collector to Emitter Capacitance vs Collector to Emitter Voltage



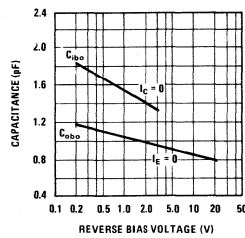
Distribution of Collector to Emitter Capacitance



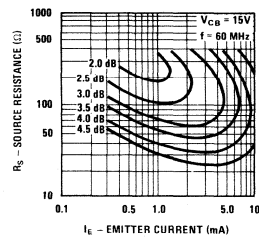
Distribution of Collector to Base Capacitance



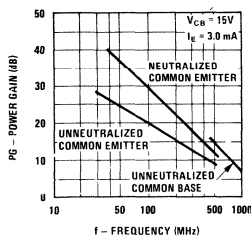
Input and Output Capacitance vs Reverse Bias Voltage



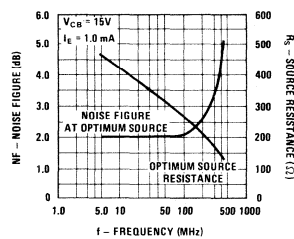
Noise Figure vs Source Resistance and Collector Current



Power Gain vs Frequency

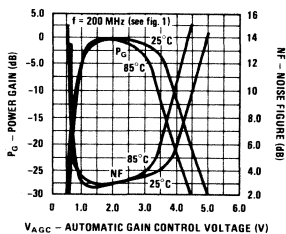


Noise Figure and Source Resistance vs Frequency

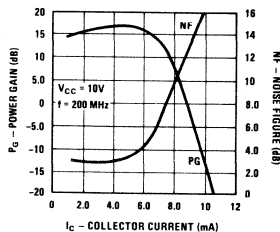


COMMON EMITTER PERFORMANCE

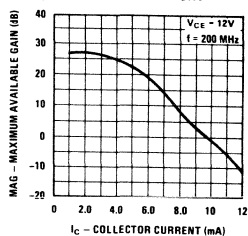
Power Gain and Noise Figure vs Automatic Gain Control Voltage



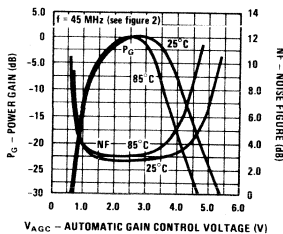
Power Gain and Noise Figure vs Collector Current



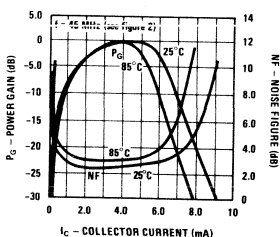
Maximum Available Gain vs Collector Current



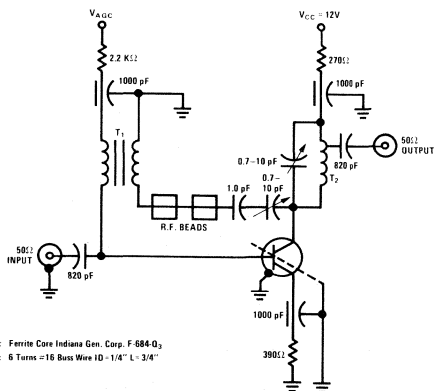
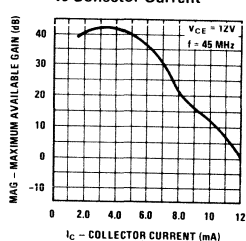
Power Gain and Noise Figure vs Automatic Gain Control Voltage



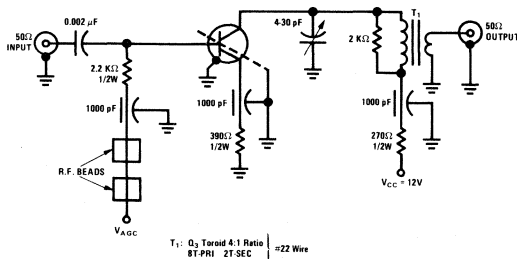
Power Gain and Noise Figure vs Collector Current



Maximum Available Gain vs Collector Current



T₁: Ferrite Core Indiana Gen. Corp. F 684-0₃
T₂: 6 Turns -16 Buss Wire 10 - 1/4" L - 3/4"



T₁: Q₁ Toroid 4:1 Ratio
8T-PRI 2T-SEC ≈22 Wire

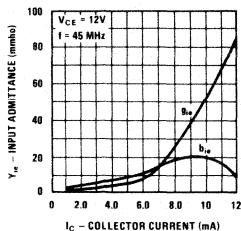
FIGURE 1. 200 MHz, AGC, Power Gain and Noise Figure Test Jig

FIGURE 2. 45 MHz, AGC, Power Gain and Noise Figure Test Jig

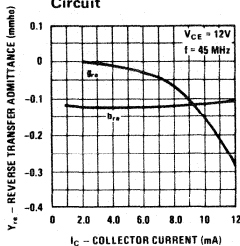
COMMON EMITTER Y PARAMETERS VS FREQUENCY

Process 44

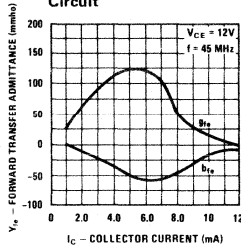
Input Admittance vs Collector Current - Output Short Circuit



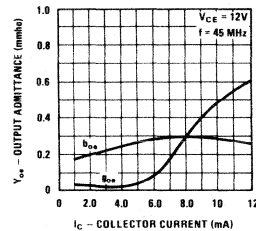
Reverse Transfer Admittance vs Collector Current - Input Short Circuit



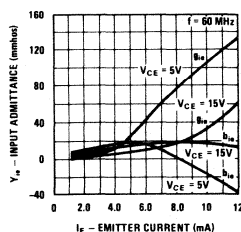
Forward Transfer Admittance vs Collector Current - Output Short Circuit



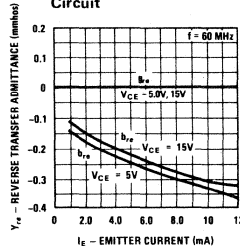
Output Admittance vs Collector Current - Input Short Circuit



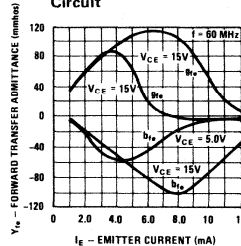
Input Admittance vs Emitter Current - Output Short Circuit



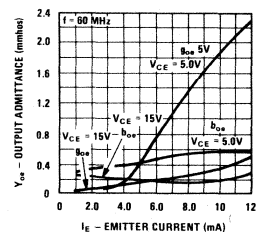
Reverse Transfer Admittance vs Emitter Current - Input Short Circuit



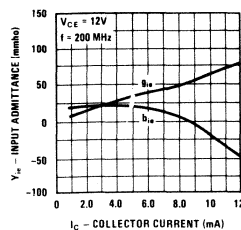
Forward Transfer Admittance vs Emitter Current - Output Short Circuit



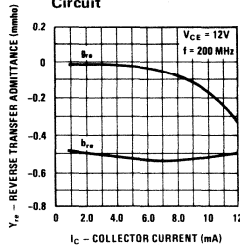
Output Admittance vs Emitter Current - Input Short Circuit



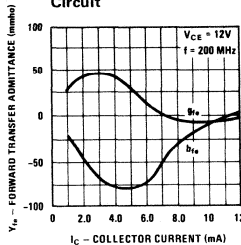
Input Admittance vs Collector Current - Output Short Circuit



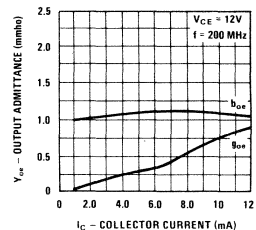
Reverse Transfer Admittance vs Collector Current - Input Short Circuit



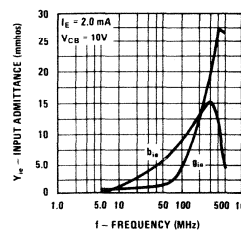
Forward Transfer Admittance vs Collector Current - Output Short Circuit



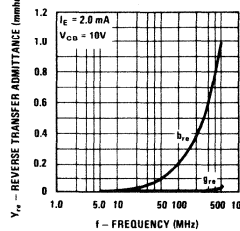
Output Admittance vs Collector Current - Input Short Circuit



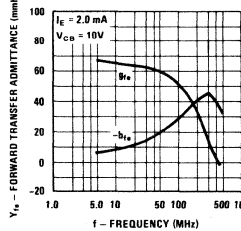
Input Admittance vs Frequency - Output Short Circuit



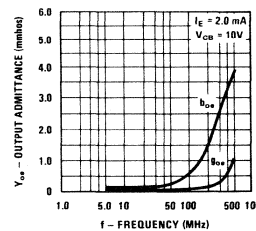
Reverse Transfer Admittance vs Frequency - Output Short Circuit



Forward Transfer Admittance vs Frequency - Input Short Circuit

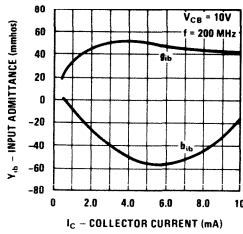


Output Admittance vs Frequency - Input Short Circuit

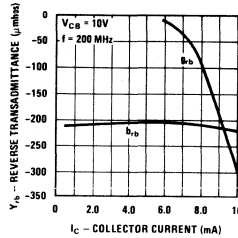


COMMON BASE Y PARAMETERS VS FREQUENCY

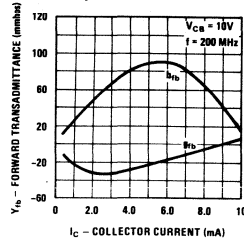
Input Admittance vs Collector Current-Output Short Circuit



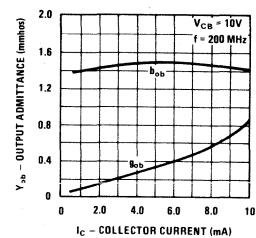
Reverse Transadmittance vs Collector Current-Input Short Circuit



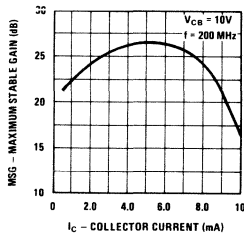
Forward Transadmittance vs Collector Current-Output Short Circuit



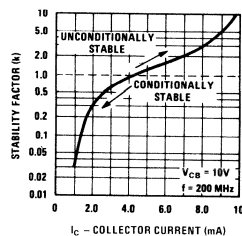
Output Admittance vs Collector Current-Input Short Circuit



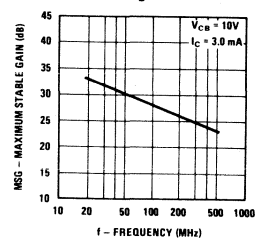
Maximum Stable Gain vs Collector Current Common Base Configuration



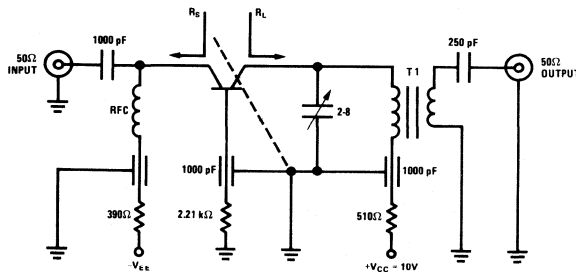
Common Base Configuration Stability Factor-k vs Collector Current



Maximum Stable Gain vs Frequency Common Base Configuration



Rollt stability factor "k" is defined as: $k = \frac{2g_{isc} - R_o (V_o, V_i)}{|Y_i Y_o|}$

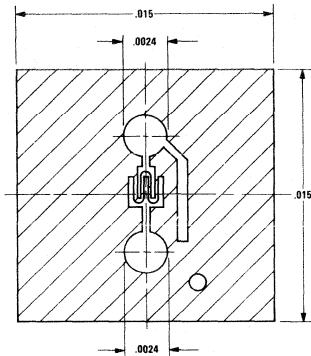


T₁ - 3:1 Ratio No. 22 Bifilar on Micrometals Toroid, P/N T30-12
 R_S = 50Ω, R_L = 2.5 kΩ
 f_{sw} = 8.0 MHz

FIGURE 3. 200 MHz Common Base Power Gain, Noise Figure, Automatic Gain Control Test Circuit.



Process 45 NPN AGC-IF Amplifier



DESCRIPTION

Process 45 is an overlay double diffused silicon device.

APPLICATION

This device was designed for use as a forward AGC amplifier in IF amplifiers without neutralization.

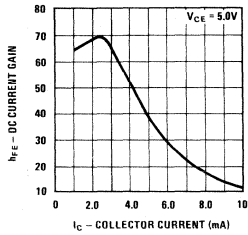
PRINCIPAL DEVICE TYPES:

TO-72 (pkg 28) SE5055
TO-92 MPS-H32 (BEC)

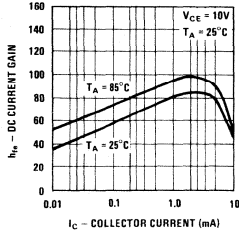
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
P_G	$f = 45 \text{ MHz}$, $V_{CE} = 10 \text{ V}$, $I_C = 3 \text{ mA}$, $R_G = 50\Omega$	27	29		dB	Fig. 1
NF	$f = 45 \text{ MHz}$, $V_{CE} = 10 \text{ V}$, $I_C = 3 \text{ mA}$, $R_G = 50\Omega$		2.8	5.0	dB	Fig. 1
C_{re}	$V_{CB} = 10 \text{ V}$		0.13	0.22	pF	TO-72
V_{AGC}	$f = 45 \text{ MHz}$, $V_{CC} = 12 \text{ V}$ 30 dB Gain Reduction	3.5	0.22 4.3	0.30 5.0	pF V	Fig. 1
V_{AGC}	$f = 45 \text{ MHz}$, $V_{CC} = 12 \text{ V}$ 50 dB Gain Reduction		6.50	8.0	V	Fig. 1
h_{fe}	$V_{CE} = 10 \text{ V}$, $I_C = 2 \text{ mA}$, $f = 100 \text{ MHz}$	3	5			
h_{FE}	$V_{CE} = 10 \text{ V}$, $I_C = 2 \text{ mA}$	20	80	250		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 5 \text{ mA}$		1.0	2.75	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 5 \text{ mA}$		0.92	1.0	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	30			V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	30			V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	3			V	
I_{CBO}	$V_{CB} = 20 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 2 \text{ V}$			50	nA	

Process 45

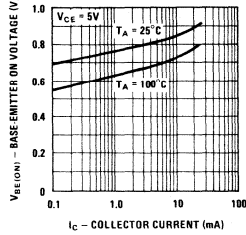
DC Current Gain vs Collector Current



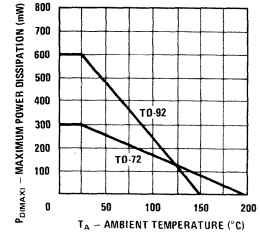
DC Pulse Current Gain vs Collector Current



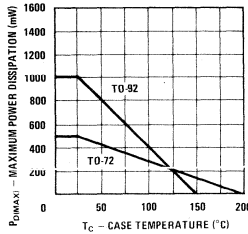
Base-Emitter On Voltage vs Collector Current



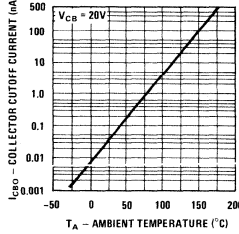
Maximum Power Dissipation vs Ambient Temperature



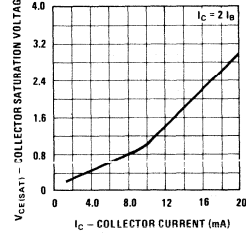
Maximum Power Dissipation vs Case Temperature



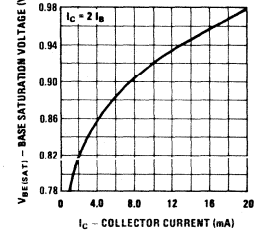
Collector Cutoff Current vs Ambient Temperature



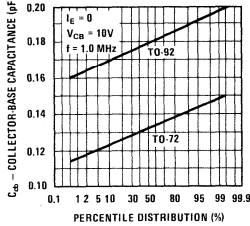
Collector Saturation Voltage vs Collector Current



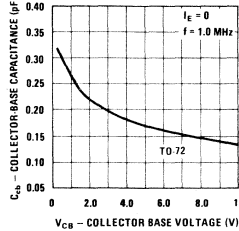
Base Saturation Voltage vs Collector Current



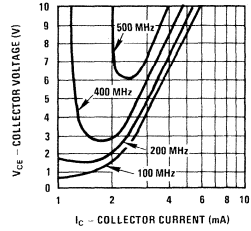
Distribution of Collector-Base Capacitance



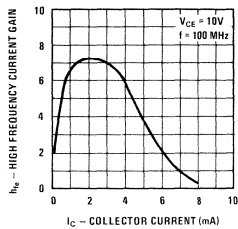
Collector-Base Capacitance vs Collector-Base Voltage



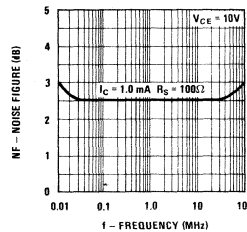
Contours of Constant Gain Bandwidth Product (fT)



High Frequency Current Gain vs Collector Current



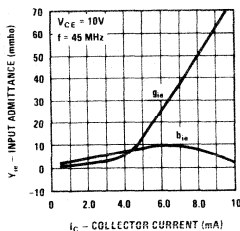
Noise Figure vs Frequency



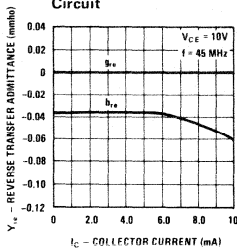
COMMON EMITTER Y PARAMETERS VS FREQUENCY

Process 45

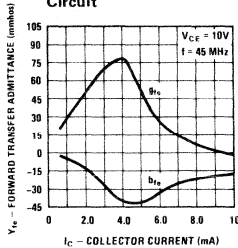
Input Admittance vs Collector Current- Output Short Circuit



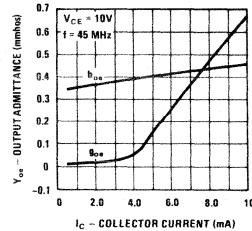
Reverse Transfer Admittance vs Collector Current- Input Short Circuit



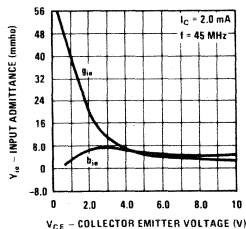
Forward Transfer Admittance vs Collector Current- Output Short Circuit



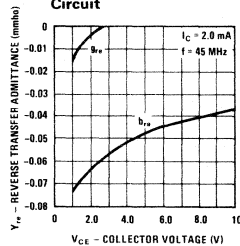
Output Admittance vs Collector Current- Input Short Circuit



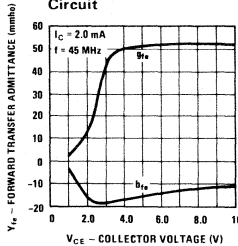
Input Admittance vs Collector Voltage- Output Short Circuit



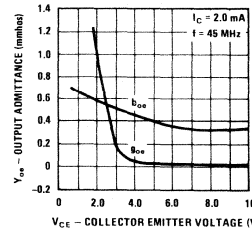
Reverse Transfer Admittance vs Collector Voltage- Input Short Circuit



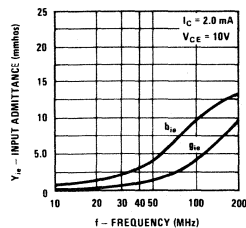
Forward Transfer Admittance vs Collector Voltage- Output Short Circuit



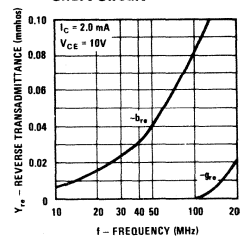
Output Admittance vs Collector Voltage- Input Short Circuit



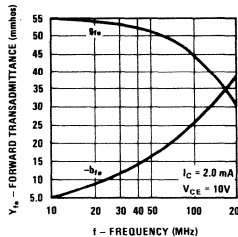
Input Admittance vs Frequency - Output Short Circuit



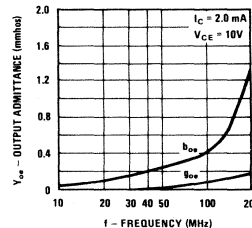
Reverse Transadmittance vs Frequency - Input Short Circuit



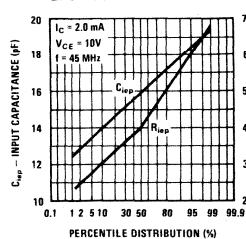
Forward Transadmittance vs Frequency - Output Short Circuit



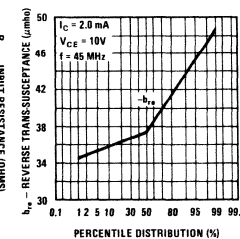
Output Admittance vs Frequency - Input Short Circuit



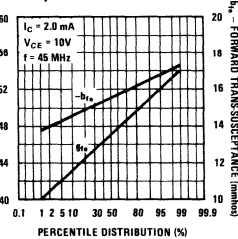
Distribution of Input Capacitance and Input Resistance- Output Short Circuit



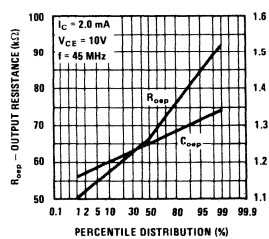
Distribution of Reverse Transadmittance- Input Short Circuit



Distribution of Forward Transfer Admittance- Output Short Circuit



Distribution of Output Capacitance and Output Resistance- Input Short Circuit



COMMON EMITTER PERFORMANCE

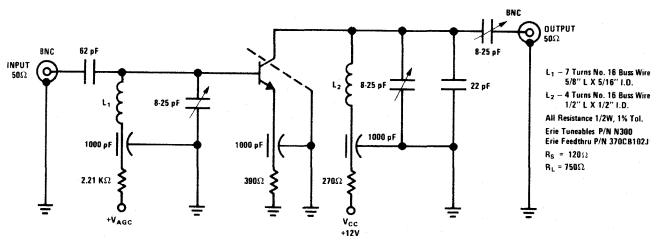
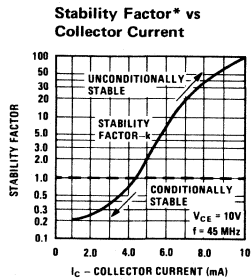
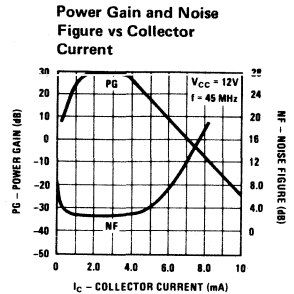
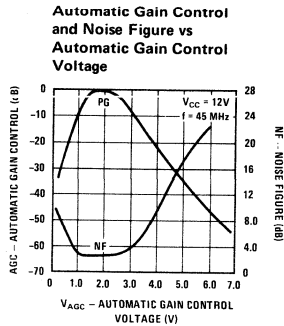
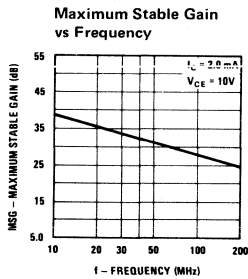
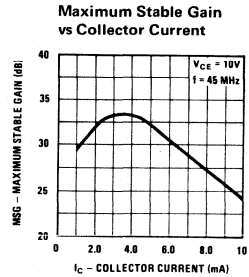
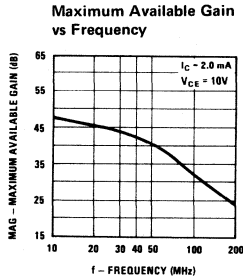
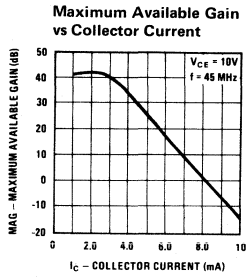
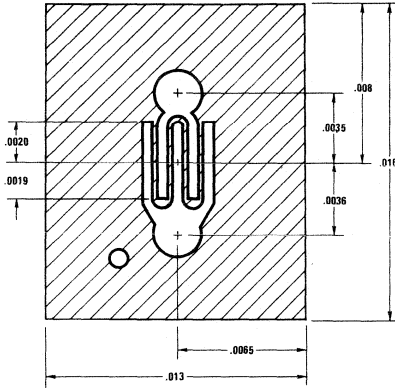


FIGURE 1. SE5055 45 MHz Gain, Noise Figure, AGC Circuit

* Rollett stability factor "k" is defined as: $k = \frac{2 - R_{11} - R_{22}}{|Y_1 Y_2|}$



Process 46 NPN RF-IF Amplifier



DESCRIPTION

Process 46 is an overlay double diffused, silicon epitaxial device.

APPLICATION

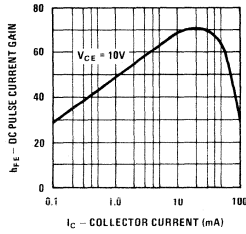
This device was designed for linear amplifier applications at audio through RF frequencies.

PRINCIPAL DEVICE TYPES:

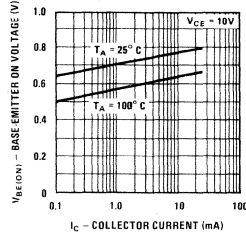
TO-92 ST5025

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
G_{pe}	$f = 45 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 10 \text{ mA}$	25	28		dB	
C_{cb}	$V_{CB} = 10\text{V}$		0.9	1.1	pF	TO-92
g_{oe}	$f = 45 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 10 \text{ mA}$			200	μmho	
h_{fe}	$I_C = 10 \text{ mA}, V_{CE} = 10\text{V}, f = 100 \text{ MHz}$	3.0	4.50			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 10\text{V}$	20	50	200		
$V_{CE(SAT)}$	$I_C = 20 \text{ mA}, I_B = 1 \text{ mA}$		0.2	0.6	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	30	60		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	30			V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	3.0			V	
I_{CBO}	$V_{CB} = 30\text{V}$			50	nA	
I_{EBO}	$V_{EB} = 2\text{V}$			50	nA	

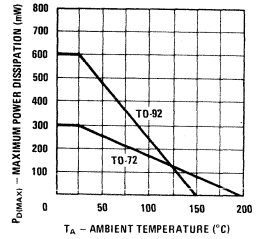
DC Pulse Current Gain vs Collector Current



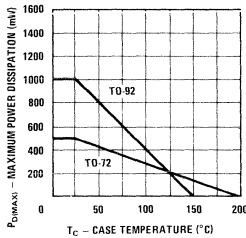
Base-Emitter On Voltage vs Collector Current



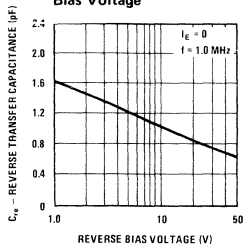
Maximum Power Dissipation vs Ambient Temperature



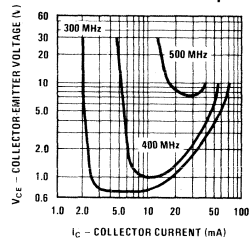
Maximum Power Dissipation vs Case Temperature



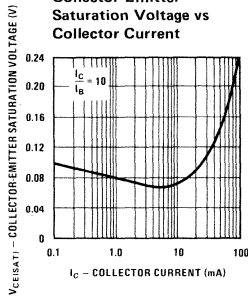
Reverse Transfer Capacitance vs Reverse Bias Voltage



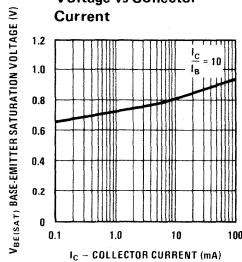
Contours of Constant Gain Bandwidth Product (fT)



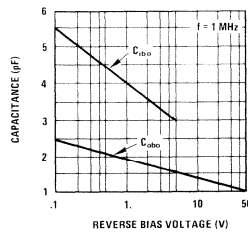
Collector-Emitter Saturation Voltage vs Collector Current



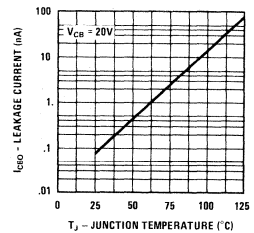
Base-Emitter Saturation Voltage vs Collector Current



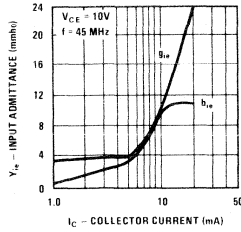
Capacitance vs Reverse Bias Voltage



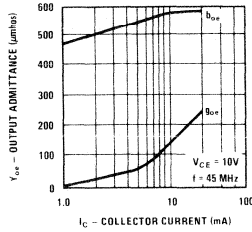
Collector-Base Diode Reverse Current vs Temperature



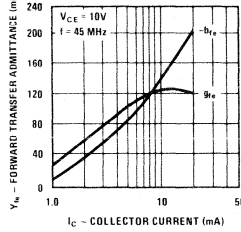
Input Admittance vs Collector Current



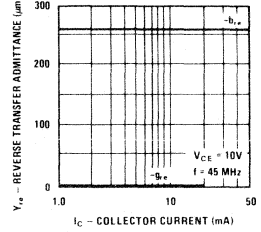
Output Admittance vs Collector Current



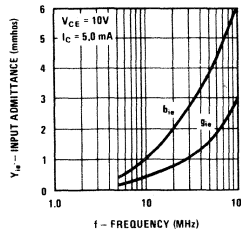
Forward Transfer Admittance vs Collector Current



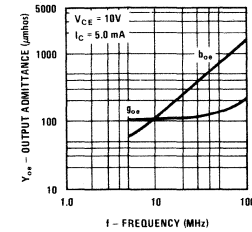
Reverse Transfer Admittance vs Collector Current



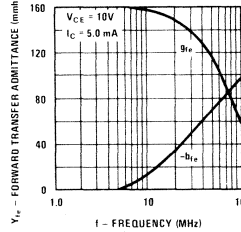
Input Admittance vs Frequency



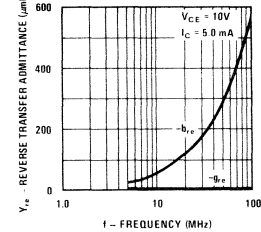
Output Admittance vs Frequency



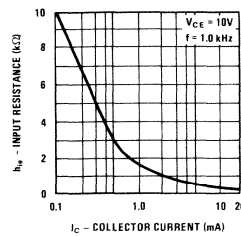
Forward Transfer Admittance vs Frequency



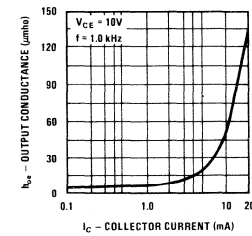
Reverse Transfer Admittance vs Frequency



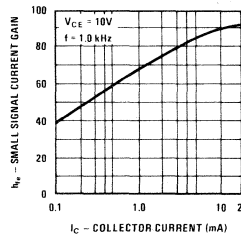
Small Signal Input Resistance vs Collector Current



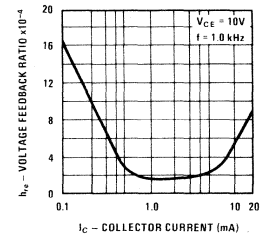
Small Signal Output Conductance vs Collector Current



Small Signal Current Gain vs Collector Current

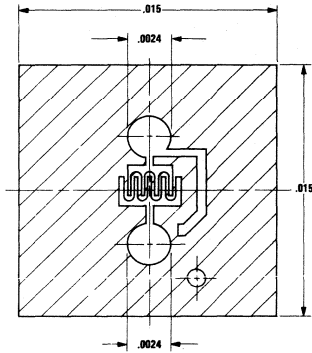


Small Signal Voltage Feedback Ratio vs Collector Current





Process 47 NPN RF-IF Amplifier



DESCRIPTION

Process 47 is an overlay double diffused, silicon epitaxial device, with a Faraday shield diffusion.

APPLICATION

This device was designed for application as an RF-IF amplifier for use to 300 MHz. Its primary application is as a third video IF in T.V.

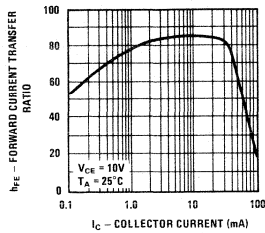
PRINCIPAL DEVICE TYPES:

TO-72 SE5035
TO-92 ST5030B

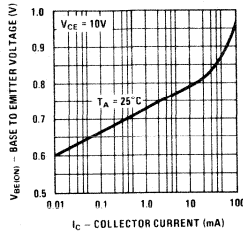
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
PG	$f = 200 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 4 \text{ mA}$	22	25		dB	Fig. 2
NF	$f = 200 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 2 \text{ mA}, R_S = 50\Omega$		2.0	4.0	dB	Fig. 3
G_{ve}	$f = 45 \text{ MHz}, V_{CE} = 15\text{V}, I_C = 7 \text{ mA}$	38	42	46	dB	Fig. 4
G_{pe}	$f = 200 \text{ MHz}, V_{CC} = 12\text{V}, I_C = 2 \text{ mA}$	17	20		dB	Fig. 3
C_{ib}	$V_{EB} = 0.5\text{V}$		2.0	3.0	pF	TO-92
C_{cb}	$V_{CB} = 15\text{V}$	0.25	0.33	0.40	pF	TO-92
g_{oe}	$f = 45 \text{ MHz}, V_{CE} = 15\text{V}, I_C = 7 \text{ mA}$			125	μmho	
h_{fe}	$f = 100 \text{ MHz}, V_{CE} = 15\text{V}, I_C = 7 \text{ mA}$	6	10			
h_{FE}	$V_{CE} = 15\text{V}, I_C = 7 \text{ mA}$	40	80	200		
$V_{CE(SAT)}$	$I_C = 20 \text{ mA}, I_B = 1 \text{ mA}$		0.3	1.0	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 5 \text{ mA}$		0.85	0.92	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	30	45		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	40	60		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	4.0	5.5			
I_{CBO}	$V_{CB} = 30\text{V}$			50	nA	
I_{EBO}	$V_{EB} = 3\text{V}$			50	nA	

Process 47

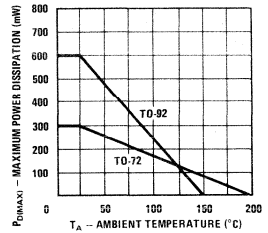
DC Pulse Current Gain vs Collector Current



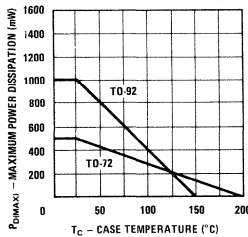
Base-Emitter On Voltage vs Collector Current



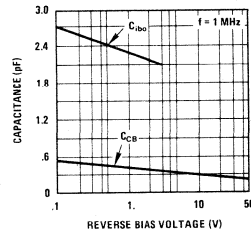
Maximum Power Dissipation vs Ambient Temperature



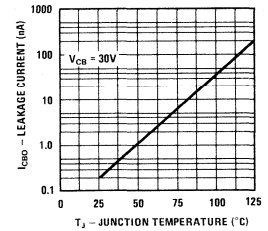
Maximum Power Dissipation vs Case Temperature



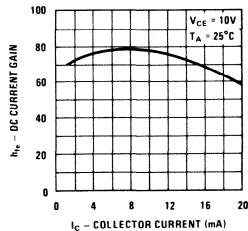
Capacitance vs Reverse Bias Voltage



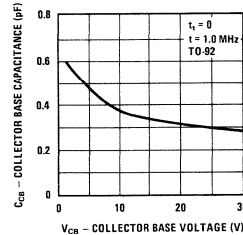
Collector-Base Diode Reverse Current vs Temperature



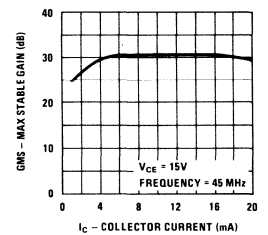
DC Current Gain vs Collector Current



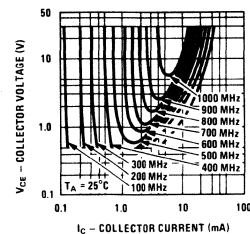
Collector-Base Capacitance vs Collector-Base Voltage

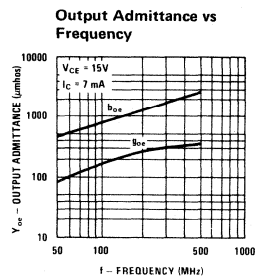
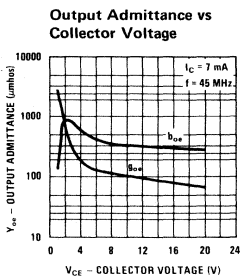
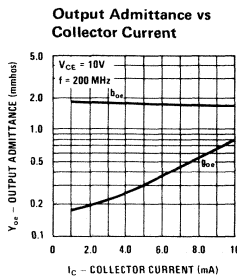
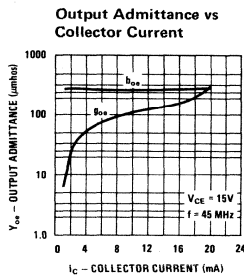
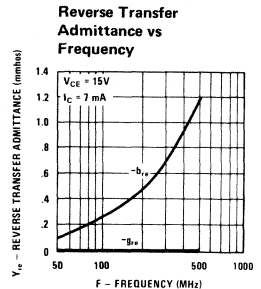
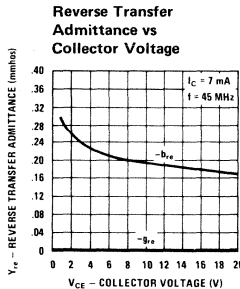
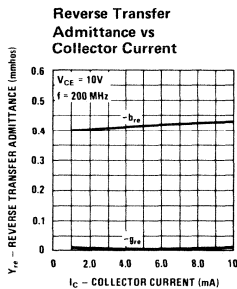
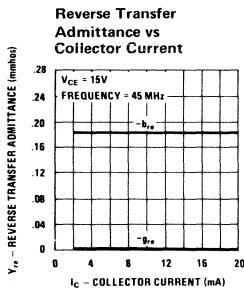
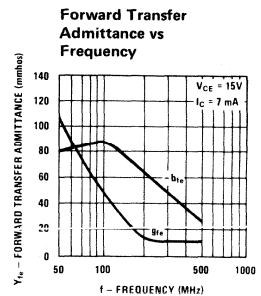
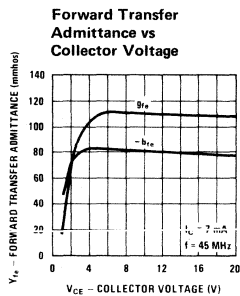
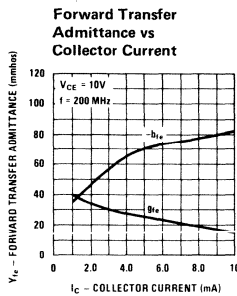
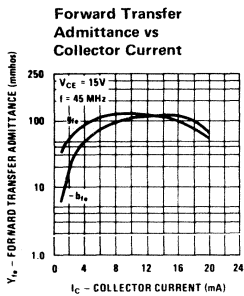
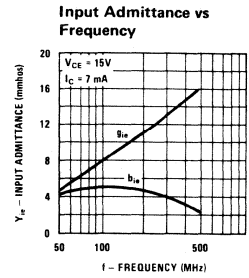
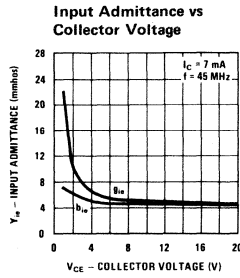
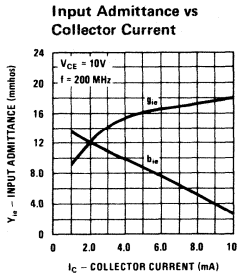
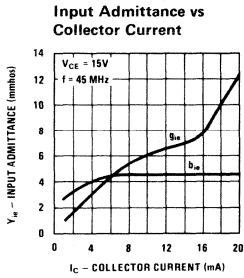


Max Stable Gain vs Collector Current

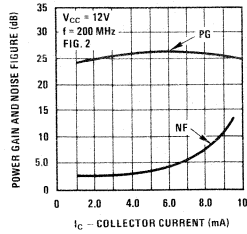


Contours of Constant Gain Bandwidth Product (fT)

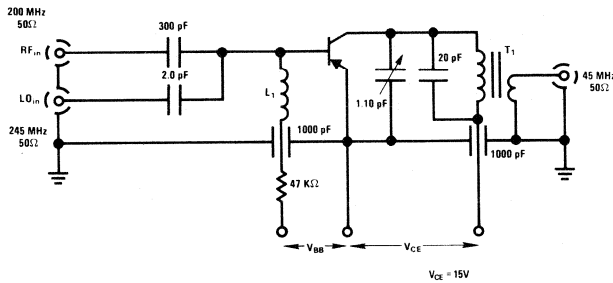
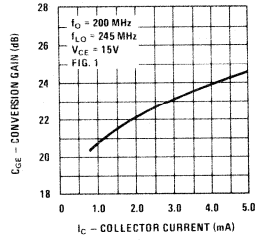




Power Gain and Noise Figure vs Collector Current

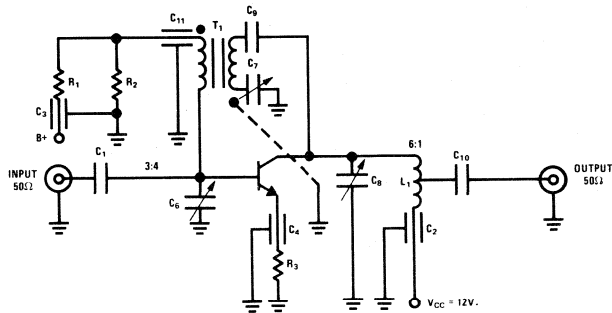


Conversion Gain vs Collector Current



L1 - Ohmite RFC Z235
 T1 - Primary 5 turns #34 wire
 1/4" dia.
 Secondary 2 turns #34 wire
 close wound over a Q100
 core (10.7 MHz)
 When terminated on
 primary side with 50Ω,
 primary measures
 1.5k, -25 pF.

FIGURE 1. 200 MHz Conversion Gain Test Circuit



C1, C10 = 1000 pF Duramica
 C2, C3, C4, C5, C11 = 1000 pF
 feed thru
 C6 = 8 - 25 pF
 C7, C8 = 0.7 - 10 pF
 C9 = 2 pF Duramica

R1 = 10 k Ω
 R2 = 2 k Ω
 R3 = 270 Ω
 L1 = 5 turns #14 wire,
 5/16" I.D. x 1" long

T1 = 1 turn #14 wire -
 primary
 1 turn #16 wire
 enamel, secondary.
 Wound on Balun
 form Ferrite core
 Indiana Gen. Corp.
 F-684 Q3

FIGURE 2. 200 MHz Power Gain Test Circuit

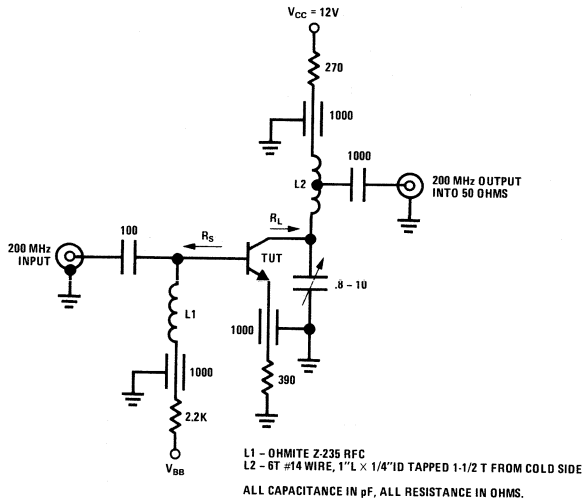


FIGURE 3. Unneutralized 200 MHz PG NF Test Circuit

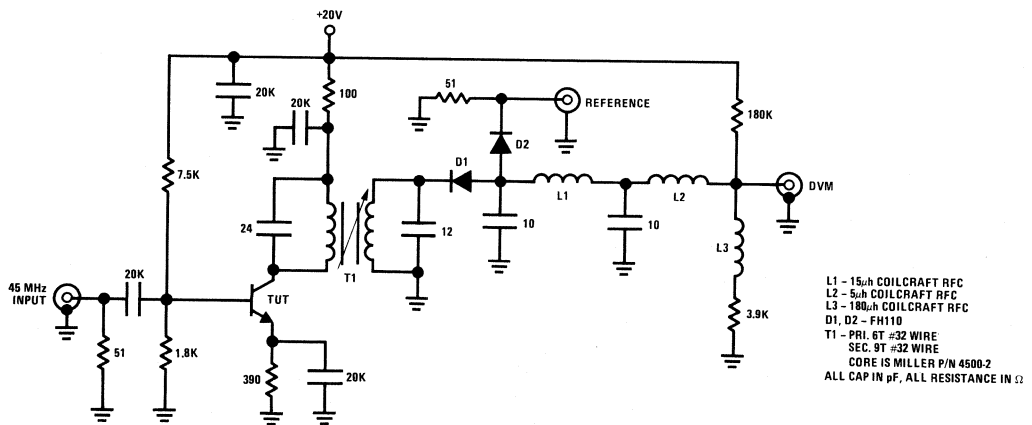


FIGURE 4. 45 MHz Voltage Gain (Gve) Circuit



Process 48 NPN High Voltage Video Output

DESCRIPTION

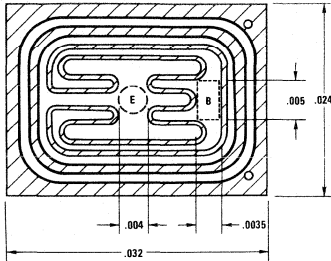
Process 48 is a nonoverlay triple diffused, silicon device with a field plate.

APPLICATION

This device was designed for application as a video output to drive color CRT.

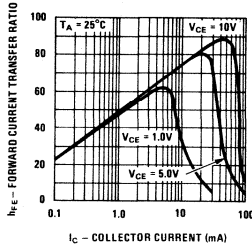
PRINCIPAL DEVICE TYPES:

TO-39 SE7056
X51 SP7056

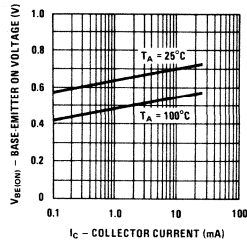


PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
C_{cb}	$V_{CB} = 20V$		2.5	3.5	pF	TO-39
h_{fe}	$f = 20 \text{ MHz}, V_{CE} = 100V$ $I_C = 15 \text{ mA}$	2.5	4.0			
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 20V$	15	50			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 20V$	30	100			
h_{FE}	$I_C = 30 \text{ mA}, V_{CE} = 20V$	30	100			
$V_{CE(SAT)}$	$I_C = 20 \text{ mA}, I_B = 2 \text{ mA}$		0.35	1.0	V	
$V_{BE(SAT)}$	$I_C = 20 \text{ mA}, I_B = 2 \text{ mA}$		0.74	0.85	V	
C_{eb}	$V_{EB} = 0.5V$		45	70	pF	
BV_{CEO}	$I_C = 5 \text{ mA}$	220	320	500	V	
BV_{CBO}	$I_C = 100 \mu A$	220	320	500	V	
BV_{EBO}	$I_E = 100 \mu A$	7.0			V	
I_{CBO}	$V_{CB} = 150V$			100	nA	
I_{EBO}	$V_{EB} = 6V$			100	nA	

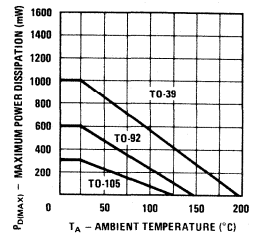
DC Pulse Current Gain vs Collector Current



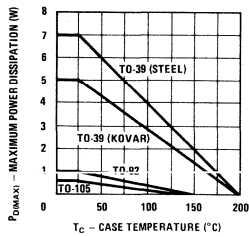
Base-Emitter On Voltage vs Collector Current



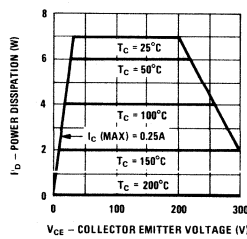
Maximum Power Dissipation vs Ambient Temperature



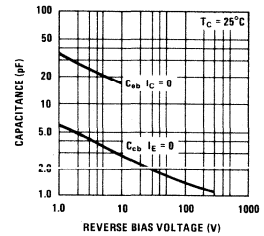
Maximum Power Dissipation vs Case Temperature



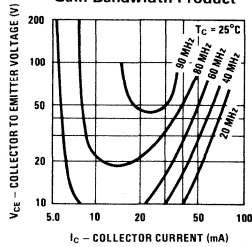
Guaranteed Maximum DC Power Dissipation vs Collector-Emitter Voltage



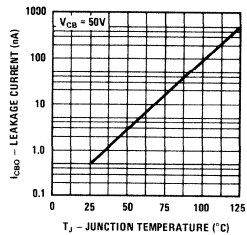
Collector to Base and Emitter to Base Capacitance vs Reverse Bias Voltage



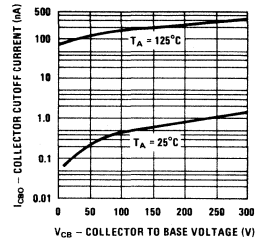
Contours of Constant Gain Bandwidth Product



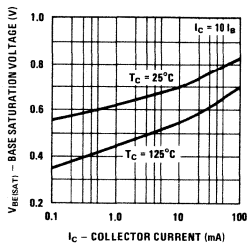
Collector-Base Diode Reverse Current vs Temperature



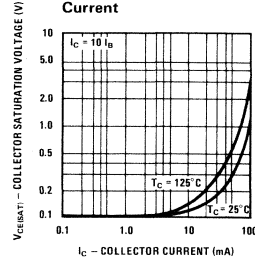
Collector Cutoff Current vs Collector Voltage



Base Saturation Voltage vs Collector Current

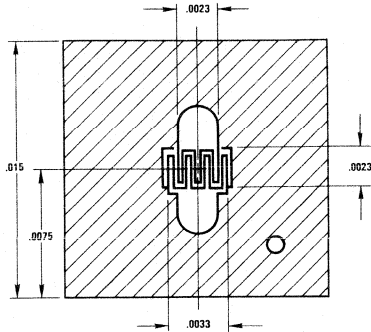


Collector Saturation Voltage vs Collector Current





Process 49 NPN RF Amplifier



DESCRIPTION

Process 49 is an overlay double diffused silicon epitaxial device.

APPLICATION

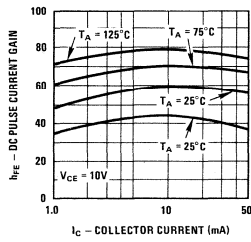
This device was designed for general RF amplifier applications to 250 MHz.

PRINCIPAL DEVICE TYPES:

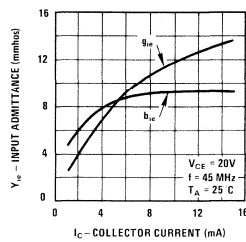
TO-92 (BEC) MPS6544, MPSH20

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
PG	$f = 45 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 10 \text{ mA}$	25	30		dB	
f_t	$V_{CE} = 10\text{V}, I_C = 10 \text{ mA}$	400	700		MHz	
$r_b' C_c$	$f = 31.9 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 8 \text{ mA}$		6.5	20.0	ps	TO-92
Ccb	$f = 1.0 \text{ MHz}, V_{CB} = 10\text{V}, I_E = 0$		0.55	0.65	pF	TO-92
h_{FE}	$V_{CE} = 10\text{V}, I_C = 30 \text{ mA}$	25	75			
h_{FE}	$V_{CE} = 10\text{V}, I_C = 4 \text{ mA}$	25				
$V_{BE(ON)}$	$V_{CE} = 10\text{V}, I_C = 10 \text{ mA}$		0.80	0.95	V	
$V_{CE(SAT)}$	$I_C = 30 \text{ mA}, I_C = 3 \text{ mA}$		0.15	0.50	V	
g_{oe}	$f = 45 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 10 \text{ mA}$			100	μmhos	
roep	$f = 4.5 \text{ MHz}, V_{CE} = 10\text{V}, I_C = 2 \text{ mA}$	80k			Ω	
BV_{CEO}	$I_C = 1 \text{ mA}$	40	55		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	45	75		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	4.0	5.5		V	
I_{CBO}	$V_{CB} = 30\text{V}$			50	nA	
I_{EBO}	$V_{EB} = 3.0\text{V}$			50	nA	

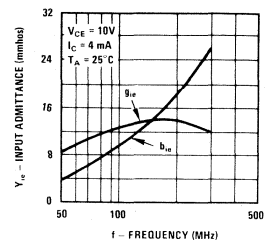
DC Pulse Current Gain vs Collector Current



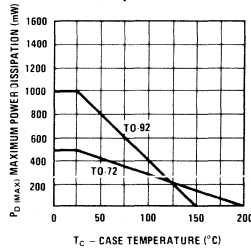
Input Admittance vs Collector Current



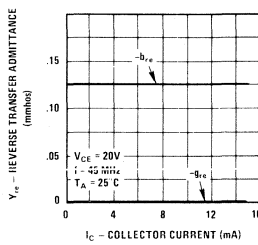
Input Admittance vs Frequency



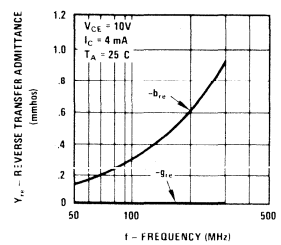
Maximum Power Dissipation vs Case Temperature



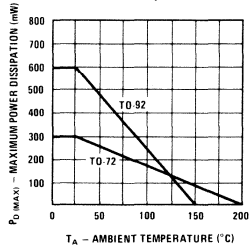
Reverse Transfer Admittance vs Collector Current



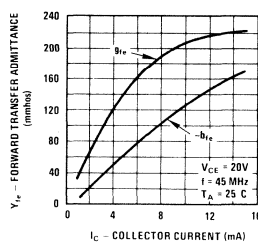
Reverse Transfer Admittance vs Frequency



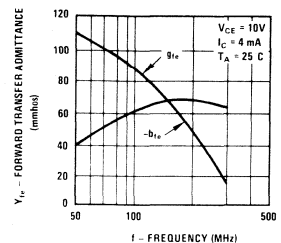
Maximum Power Dissipation vs Ambient Temperature



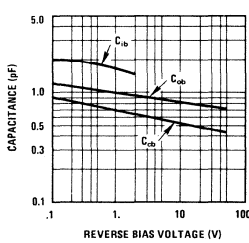
Forward Transfer Admittance vs Collector Current



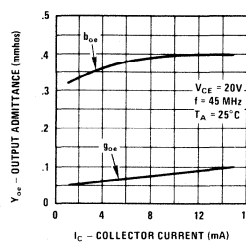
Forward Transfer Admittance vs Frequency



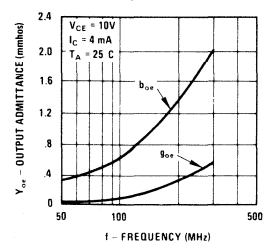
Capacitance vs Reverse Bias Voltage



Output Admittance vs Collector Current



Output Admittance vs Frequency



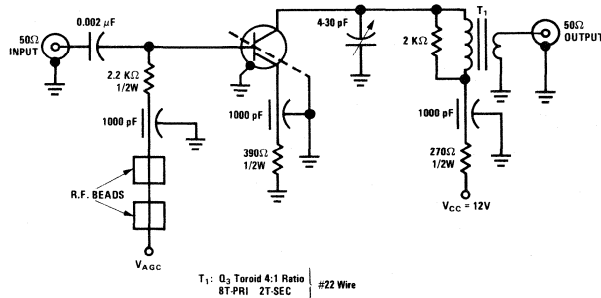
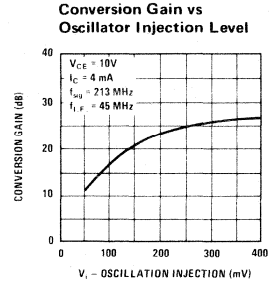
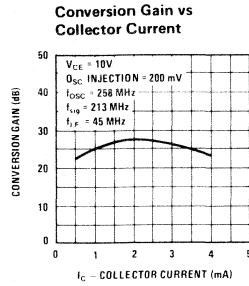
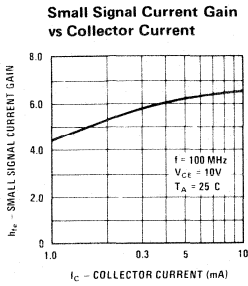


FIGURE 1. 45 MHz Power Gain Circuit

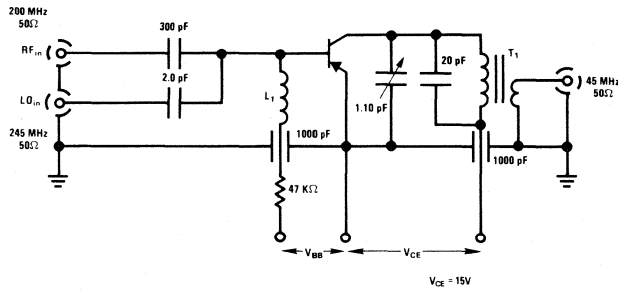
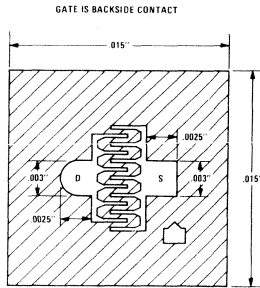


FIGURE 2. 200 MHz Conversion Gain Test Circuit



Process 50 N-Channel Junction FET



PACKAGES:

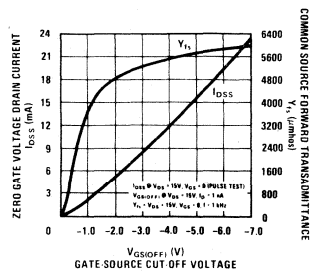
TO-72, TO-92, TO-106

PRINCIPAL DEVICE TYPES:

2N4416
2N5485
KE4416

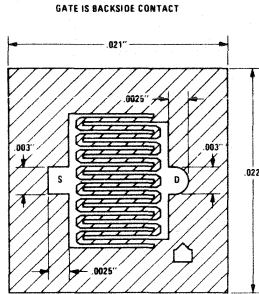
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0, I_G = 1 \mu A$	20	40	50	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0V$	1	10	25	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	3	5.0	7	mmho
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.02	10	nA
On Resistance	$R_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	100	175	500	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15, I_D = 1 nA$	0.7	3.5	9	V
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0$	0.6	0.7	1.0	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0$	3	3.5	5.0	pF

Process 50 is designed primarily for RF amplifier and mixer applications. It will operate up to 450 MHz with low noise figure and good power gain. These devices offer outstanding performance at VHF aircraft and communications frequencies. Their major advantage is low crossmodulation and intermodulation, low noise figure and good power gain. The device is also a good choice for analog switching where low capacitance is very important.





Process 51 N-Channel Junction FET



PACKAGES:

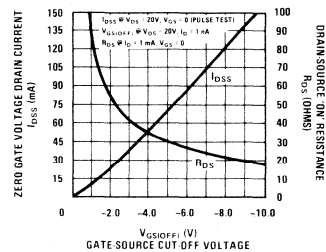
TO-18, TO-92, TO-106

PRINCIPAL DEVICE TYPES:

2N4091-93
 2N4391-93
 2N4856-61
 2N5638, 39, 40
 KE 4391, 92, 93

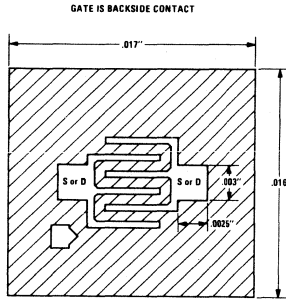
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	30	60	80	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20V, V_{GS} = 0$ Pulse Test	5	65	170	mA
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.05	10	nA
"ON" Resistance	$R_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	20	35	100	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 20, I_D = 1 nA$	0.5	4.5	10.0	V
Drain "OFF" Current	$I_{D(OFF)}$	$V_{DS} = 20, V_{GS} = -10V$		0.05	100	nA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$	3.0	3.5	4.0	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 mA, f = 1 MHz$	12	14	18	pF

Process 51 is designed primarily for electronic switching applications such as low ON resistance analog switching. It features excellent C_{iss} $R_{DS(ON)}$ time constant. The inherent zero offset voltage and low leakage current make these devices excellent for chopper stabilized amplifiers, sample and hold circuits, and reset switches. Low feed-through capacitance also allows them to handle video signals to 100 MHz.





Process 52 N-Channel Junction FET



PACKAGES:

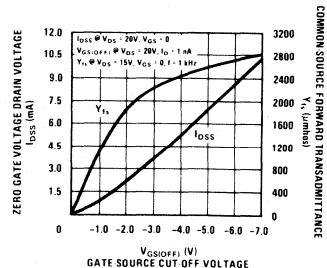
TO-18, TO-72, TO-92, TO-106

PRINCIPAL DEVICE TYPES:

2N4338, 39, 40, 41
 2N3684, 85, 86, 87
 2N4302-04
 2N5716-18

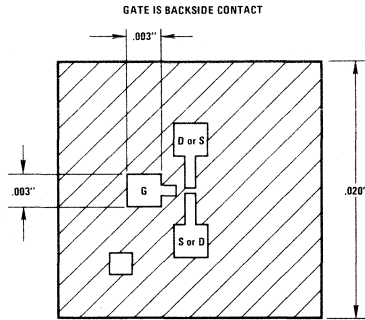
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	40	100	150	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20V, V_{GS} = 0$	0.1	3.0	10.0	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 20V, V_{GS} = 0$	0.5	1.8	3.0	mmho
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 30V, V_{DS} = 0$		0.01	2	nA
"ON" Resistance	$R_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	300	500	2000	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 20V, I_D = 1 nA$	0.5	3.0	8.0	V
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$	0.8	1.2	1.5	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0, f = 1 MHz$	3.0	4.0	5.0	pF

Process 52 is designed primarily for low level audio and general purpose applications. These devices provide excellent performance as input stages for piezo electric transducers or other high impedance signal sources. Their high output impedance and high voltage breakdown lend them to high gain audio and video amplifier applications. Source and drain are interchangeable.





Process 53 N-Channel Junction FET



PACKAGES:

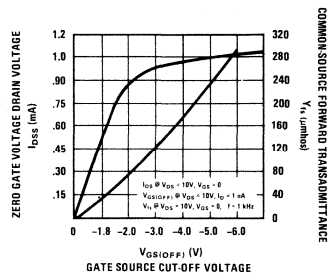
TO-18, TO-72

PRINCIPAL DEVICE TYPES:

2N3089
2N3452-54
2N4117-19
2N4117A-19A

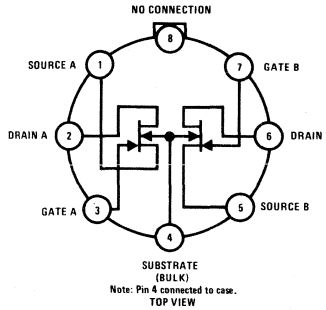
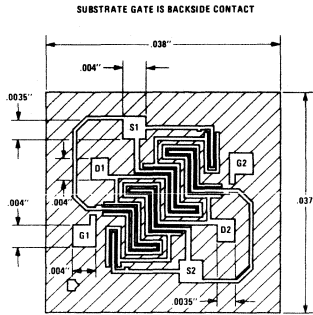
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	40	60	80	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 10V, V_{GS} = 0$	0.02	0.25	1	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 10V, V_{GS} = 0$	80	250	350	μmho
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.1	10	pA
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 10V, I_D = 1 nA$	0.5	2.2	6	V
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$	0.7	0.85	1.0	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0, f = 1 MHz$	1.7	2	2.5	pF

Process 53 is designed primarily for low current DC and audio applications. These devices provide excellent performance as input stages for sub pico-amp instrumentation or any high impedance signal sources.





Process 54 N-Channel Junction FET



PACKAGES:

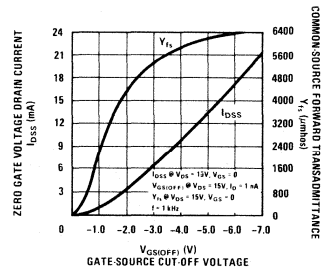
TO-99

PRINCIPAL DEVICE TYPES:

FM1200 SERIES

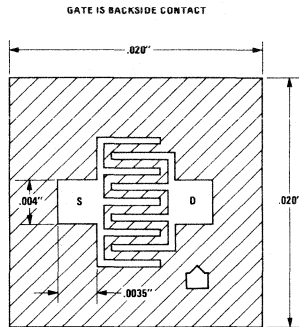
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	20	35		V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0$	0.2	5.0	20	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	0.8	3.5	10	mmho
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.10	10	nA
"ON" Resistance	$r_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	125	300	1200	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15V, I_D = 1 nA$	0.5	3.0	7.0	V
Gate Current	I_G	$V_{DG} = 15V, I_D = 0.20 mA$		40	100	pA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$		0.7	1.0	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0, f = 1 MHz$		5.0	8.0	pF

Process 54 is a monolithic matched JFET dual. It features high Y_{fs} and low offset voltage and temperature drift. This device can be used for low radio frequency balanced mixer applications, low level differential analog switching and as an input buffer for operational amplifiers. Typical offset voltage $|V_{GS1} - V_{GS2}|$ is about 5 mV with a temperature coefficient of $10 \mu V/^\circ C$.





Process 55 N-Channel Junction FET



PACKAGES:

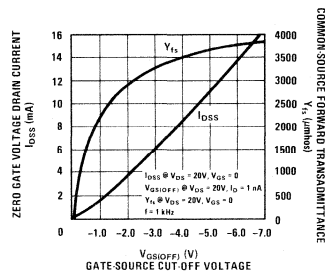
TO-18, TO-72, TO-92

PRINCIPAL DEVICE TYPES:

2N4221-22
2N5457, 58, 59
2N5361-64

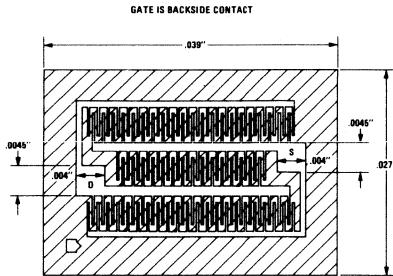
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	50	100	150	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20V, V_{GS} = 0$	0.5	5.0	17	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 20V, V_{GS} = 0$	0.8	3.5	5.0	mmho
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 30V, V_{DS} = 0$		0.02	3	nA
"ON" Resistance	$r_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	150	350	800	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 20V, I_D = 1 nA$	0.5	3.0	8.0	V
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$	1.0	1.5	2.0	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 mA, f = 1 MHz$	4.0	5.5	7.0	pF

Process 55 is a general purpose low level audio amplifier and switching transistor. Wafer processing is similar to process 52 but process 55 uses a larger geometry. This results in higher Y_{fs} , I_{DSS} , and capacitance and lower $R_{DS(ON)}$. It is useful for audio and video frequency amplifiers and RF amplifiers under 50 MHz. It may also be used for analog switching applications.





Process 58 N-Channel Junction FET



PACKAGES:

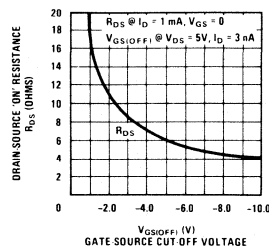
TO-52

PRINCIPAL DEVICE TYPES:

2N5432, 33, 34
NF 580 SERIES

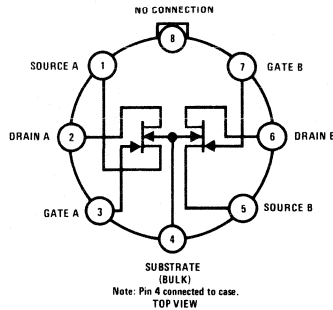
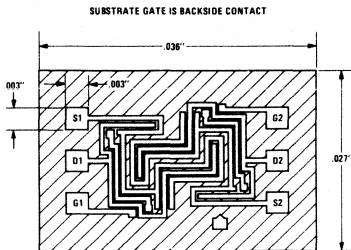
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	15	30	45	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 5V, V_{GS} = 0$ Pulse Test	100	400	1000	mA
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 15V, V_{DS} = 0$		0.10	20	nA
"ON" Resistance	$R_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	5.0	7.0	20	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 5V, I_D = 3 nA$	0.5	5.0	12	V
Drain "OFF" Current	$I_{D(OFF)}$	$V_{DS} = 5V, V_{GS} = -10V$		0.10	20	nA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$		12	25	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 mA, f = 1 MHz$		25	50	pF

Process 58 was developed for analog or digital switching applications where very low $R_{DS(ON)}$ is mandatory. Switching times are very fast and $R_{DS(ON)}$ C_{iss} time constant is low. The 7Ω typical on resistance is very useful in precision multiplex systems where switch resistance must be held to an absolute minimum.





Process 59 N-Channel Junction FET



PACKAGES:

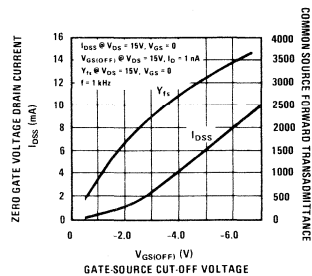
TO-99

PRINCIPAL DEVICE TYPES:

FM3954 SERIES
FM1100 SERIES

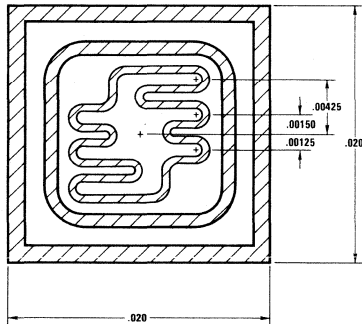
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	30	60	80	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0$	0.1	2.0	10.0	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	0.5	2.5	6.0	mmho
Reverse Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.05	2.0	nA
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15V, I_D = 1 nA$	0.5	3.0	6.0	V
Gate Current	I_G	$V_{DG} = 15V, I_D = 0.10 mA$		20	50	pA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$		0.3	0.6	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 mA, f = 1 MHz$		3.5	5.0	pF

Process 59 is a monolithic dual JFET. It is intended primarily for use as a buffer for Operational Amplifier applications. Process 59 used as a buffer for an LM101 or LM741 results in an excellent Op Amp for sample and hold circuits, integrators, charge amplifiers or other applications which cannot stand the excessive bias and offset current of bipolar Op Amps. Typical offset voltage $|V_{GS1} - V_{GS2}|$ is about 6 mV and temperature drift is $12 \mu V/^\circ C$.





Process 60 PNP Medium Power



DESCRIPTION

Complements Process 13.

APPLICATION

These devices are designed for general purpose amplifier applications at collector currents to 500 mA.

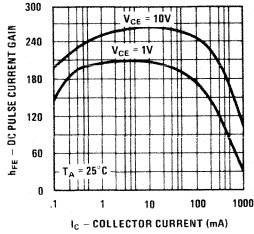
PRINCIPAL DEVICE TYPES:

TO-105 CS9012

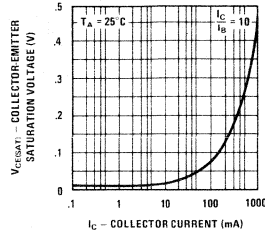
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
C_{OB}	$V_{CB} = 10V$		8	12	pF	
C_{IB}	$V_{EB} = 1V$		22	26	pF	
NF	$V_{CE} = 10V, I_C = 1 mA$ $R_S = 1k, f = 1 kHz$.5		dB	
f_T	$V_{CE} = 10V, I_C = 100 mA$		400		MHz	
h_{FE}	$V_{CE} = 1V, I_C = 1 mA$	50	200	300		
h_{FE}	$V_{CE} = 1V, I_C = 50 mA$	50	190	300		
h_{FE}	$V_{CE} = 1V, I_C = 150 mA$	50	165	300		
h_{FE}	$V_{CE} = 1V, I_C = 500 mA$	30	80	200		
$V_{CE(SAT)}$	$I_C = 150 mA, I_B = 15 mA$.1	.2	V	
$V_{CE(SAT)}$	$I_C = 500 mA, I_B = 50 mA$.3	.5	V	
$V_{BE(SAT)}$	$I_C = 150 mA, I_B = 15 mA$.8	.96	V	
$V_{BE(SAT)}$	$I_C = 500 mA, I_B = 50 mA$.98	1.2	V	
I_{CES}	$V_{CE} = 20V$			100	nA	
I_{CEO}	$V_{CE} = 20V$			100	nA	
BV_{CBO}	$I_C = 10 mA$	40	68		V	
BV_{EBO}	$I_E = 10 mA$	7	8		V	
BV_{CEO}	$I_C = 10 mA$	25	40		V	

Process 60

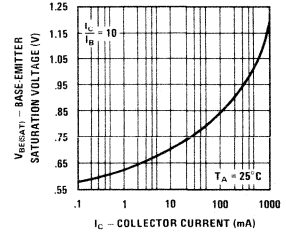
DC Pulse Current Gain vs Collector Current



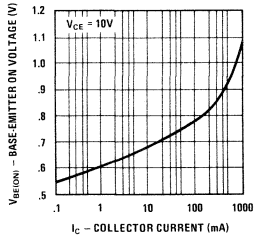
Collector-Emitter Saturation Voltage vs Collector Current



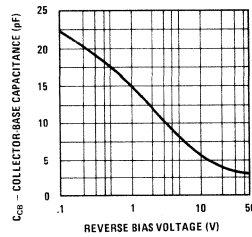
Base-Emitter Saturation Voltage vs Collector Current



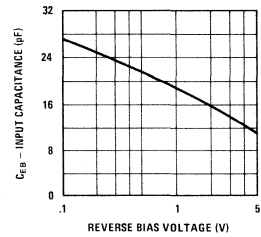
Base-Emitter On Voltage vs Collector Current



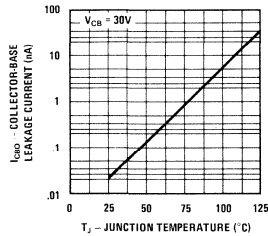
Collector-Base Capacitance vs Reverse Bias Voltage



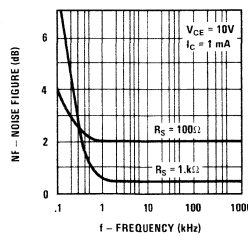
Input Capacitance vs Reverse Bias Voltage



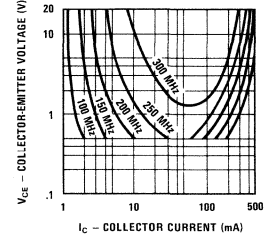
Collector-Base Diode Reverse Current vs Temperature



Noise Figure vs Frequency

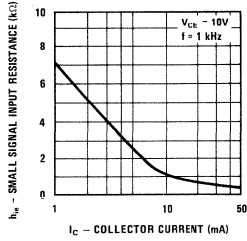


Contours of Constant Gain Bandwidth Product (f_T)

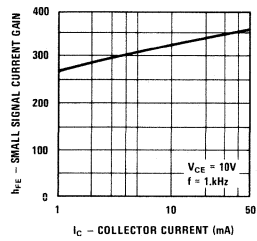


Process 60

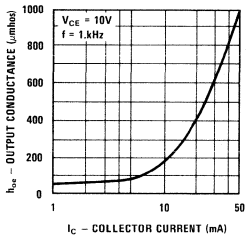
Small Signal Input Resistance vs Collector Current



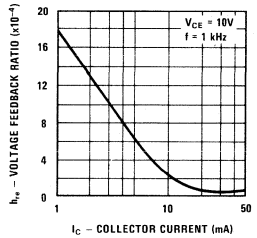
Small Signal Current Gain vs Collector Current



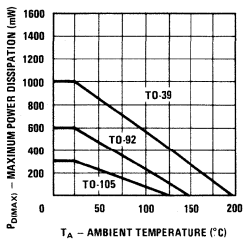
Small Signal Output Conductance vs Collector Current



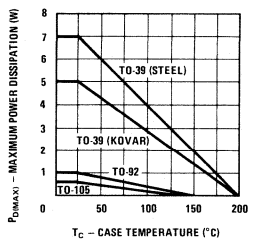
Small Signal Voltage Feedback Ratio vs Collector Current



Maximum Power Dissipation vs Ambient Temperature



Maximum Power Dissipation vs Case Temperature





Process 62 PNP Small Signal

DESCRIPTION

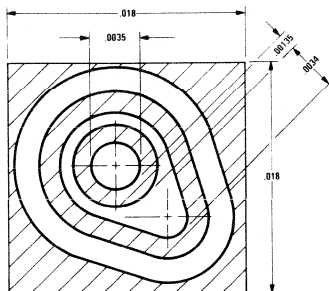
Process 62 is a nonoverlay double diffused, silicon epitaxial device. Complement to Process 07.

APPLICATION

These devices are designed for low level, high gain, low noise general purpose amplifier applications.

PRINCIPAL DEVICE TYPES:

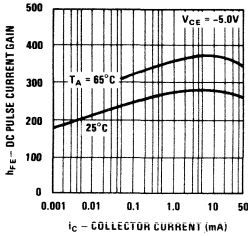
TO-18	2N3962
TO-46	2N2605
TO-92	2N5086 (EBC), 2N4058 (ECB)
TO-106	2N4250



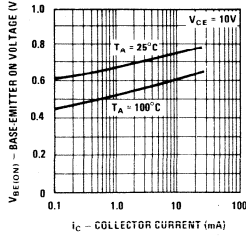
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF	$V_{CE} = 5V$, $I_C = 10 \mu A$, $R_S = 10 k\Omega$, $P_{BW} = 15.70 \text{ kHz}$		1.20	3	dB	
h_{fe}	$V_{CE} = 5V$, $I_C = 500 \mu A$, $f = 20 \text{ MHz}$	5	6			
C_{eb}	$V_{EB} = 0.5V$		6	7	pF	
C_{cb}	$V_{CB} = 5V$		3	5	pF	
h_{FE}	$I_C = 10 \mu A$, $V_{CE} = 5V$	50	200	400		
h_{FE}	$I_C = 100 \mu A$, $V_{CE} = 5V$	50	250	500		
h_{FE}	$I_C = 500 \mu A$, $V_{CE} = 5V$	50	260	500		
h_{FE}	$I_C = 1 \text{ mA}$, $V_{CE} = 5V$	50	270	500		
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 5V$	50	270	500		
$V_{CE(SAT)}$	$I_C = 1 \text{ mA}$, $I_B = 0.1 \text{ mA}$		0.05	0.10	V	
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.08	0.11	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ mA}$, $I_B = 0.1 \text{ mA}$		0.60	0.70	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.70	0.90	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	60	80		V	
BV_{CBO}	$I_C = 100 \mu A$	80	90		V	
BV_{EBO}	$I_E = 10 \mu A$	6	7.50		V	
I_{CBO}	$V_{CB} = 45V$			50	nA	
I_{EBO}	$V_{EB} = 5V$			50	nA	

Process 62

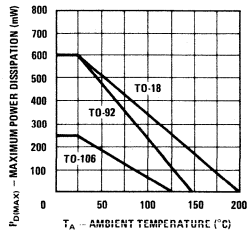
DC Pulse Current Gain vs Collector Current



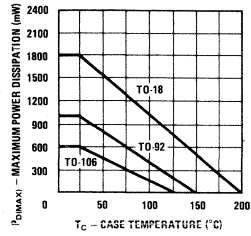
Base-Emitter On Voltage vs Collector Current



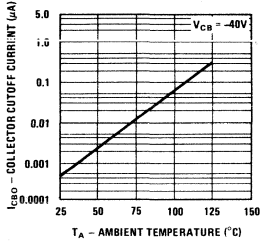
Maximum Power Dissipation vs Ambient Temperature



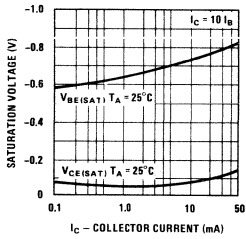
Maximum Power Dissipation vs Case Temperature



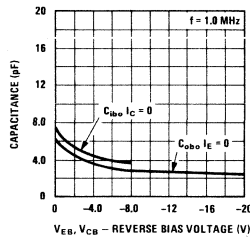
Collector Cutoff Current vs Ambient Temperature



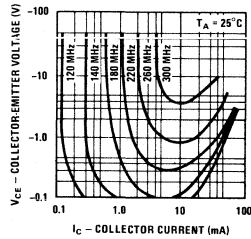
Collector and Base Saturation Voltage vs Collector Current



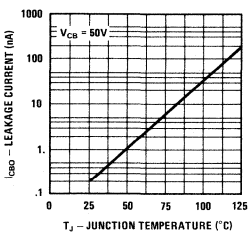
Input and Output Capacitances vs Reverse Bias Voltage



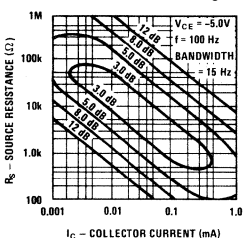
Contours of Constant Gain Bandwidth Product (fT)



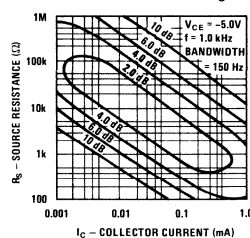
Collector-Base Diode Leakage Current vs Temperature



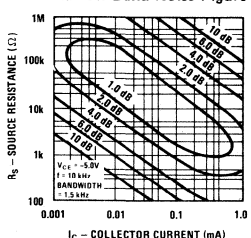
Contours of Constant Narrow Band Noise Figure



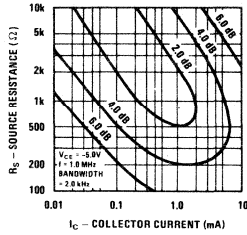
Contours of Constant Narrow Band Noise Figure



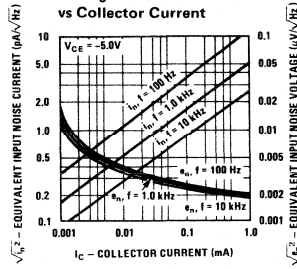
Contours of Constant Narrow Band Noise Figure



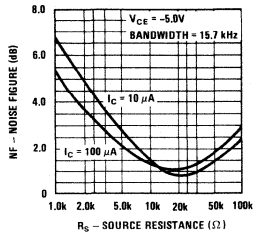
Contours of Constant Narrow Band Noise Figure



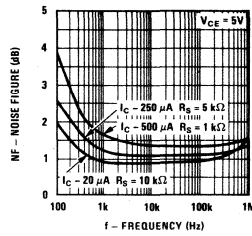
Equivalent Input Noise Voltage and Noise Current vs Collector Current



Wide Band Noise Figure vs Source Resistance



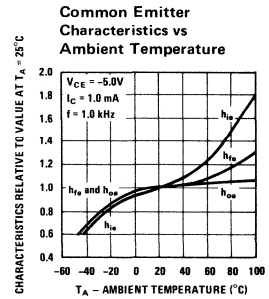
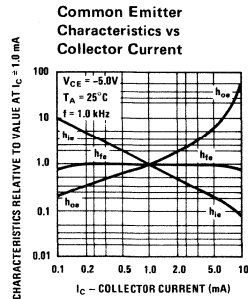
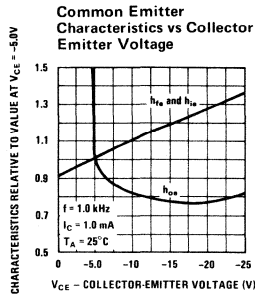
Noise Figure vs Frequency



SMALL SIGNAL CHARACTERISTICS (f = 1.0 kHz)

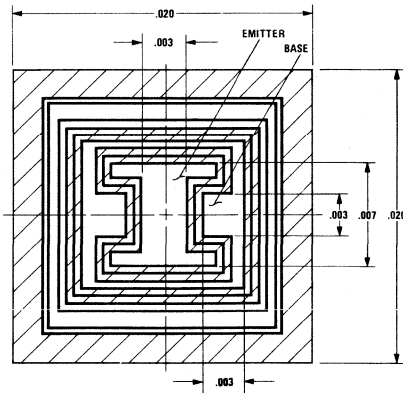
SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance	2.5	8.0	20	$k\Omega$	$I_C = 1.0 \text{ mA}$ $V_{CE} = -5.0V$
h_{oe}	Output Conductance	5.0	19	50	μmho	$I_C = 1.0 \text{ mA}$ $V_{CE} = -5.0V$
h_{re}	Voltage Feedback Ratio			10	$\times 10^{-4}$	$I_C = 1.0 \text{ mA}$ $V_{CE} = -5.0V$
h_{fe}	Small Signal Current Gain	100	250	800		$I_C = 1.0 \text{ mA}$ $V_{CE} = -5.0V$

TYPICAL COMMON EMITTER CHARACTERISTICS (f = 1.0 kHz)





Process 63 PNP Medium Power



DESCRIPTION

Process 63 is a nonoverlay double diffused, silicon epitaxial device. Complement to Process 20.

APPLICATION

This device was designed for use as general purpose amplifiers and switches requiring collector currents to 500 mA.

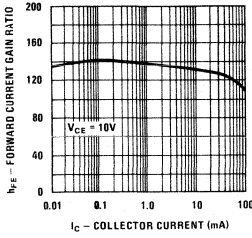
PRINCIPAL DEVICE TYPES:

TO-5	2N2905A
TO-18	2N2907A
TO-92	2N4403 (EBC), 2N3702 (ECB)
TO-105	2N3645
TO-106	2N4143

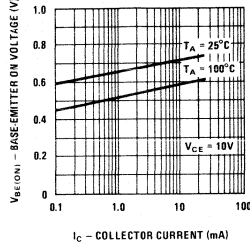
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 150 \text{ mA}, I_{B1} = 15 \text{ mA}$		30	45	ns	Fig. 1
t_{off}	$I_C = 150 \text{ mA}, I_{B2} = 15 \text{ mA}$		220	290	ns	Fig. 2
C_{cb}	$V_{CB} = 10 \text{ V}$		6	8	pF	TO-18
C_{eb}	$V_{EB} = 0.50 \text{ V}$		15	18	pF	TO-18
h_{fe}	$I_C = 20 \text{ mA}, V_{CE} = 20 \text{ V}, f = 100 \text{ MHz}$	2	3.00			
NF (spot)	$I_C = 100 \mu\text{A}, V_{CE} = 10 \text{ V}, R_S = 1 \text{ k}\Omega$ $f = 1 \text{ kHz}$		1.5	3	dB	
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 10 \text{ V}$	50	140	400		
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$	50	140	400		
h_{FE}	$I_C = 100 \text{ mA}, V_{CE} = 10 \text{ V}$	50	95	400		
h_{FE}	$I_C = 150 \text{ mA}, V_{CE} = 10 \text{ V}$	50	80	400		
h_{FE}	$I_C = 500 \text{ mA}, V_{CE} = 10 \text{ V}$	40	50	200		
$V_{CE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.25	0.40	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.40	1.00	V	
$V_{BE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		1.00	1.3	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		1.2	2.0	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	40	70		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	60	70		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	5	7		V	
I_{CBO}	$V_{CB} = 40 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 3 \text{ V}$			50	nA	

Process 63

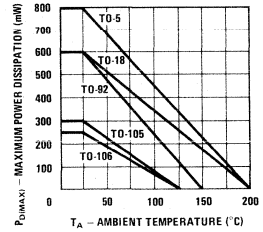
DC Pulse Current Gain vs Collector Current



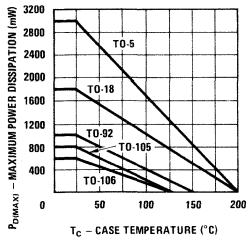
Base-Emitter On Voltage vs Collector Current



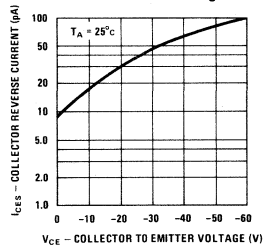
Maximum Power Dissipation vs Ambient Temperature



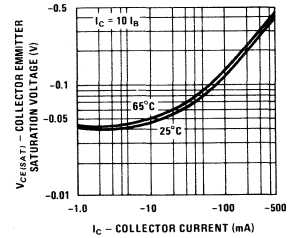
Maximum Power Dissipation vs Case Temperature



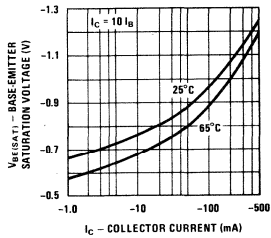
Collector Reverse Current vs Reverse Bias Voltage



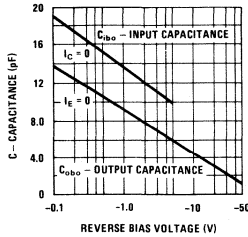
Pulsed Collector Saturation Voltage vs Collector Current



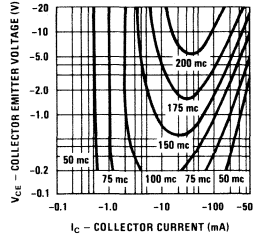
Pulsed Base Saturation Voltage vs Collector Current



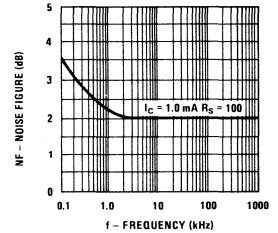
Input and Output Capacitances vs Reverse Bias Voltage



Contours of Constant Gain Bandwidth Product (fT)



Noise Figure vs Frequency



Process 63

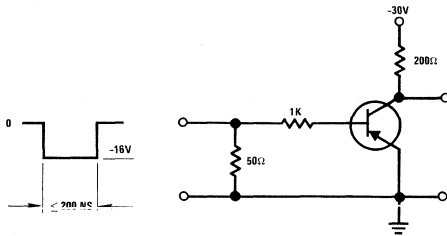
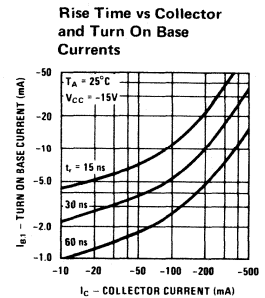
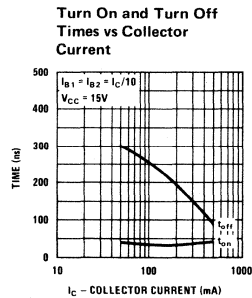
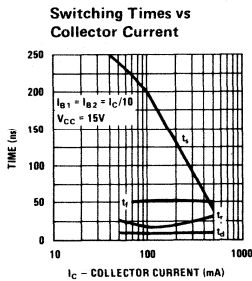


FIGURE 1. Saturated Turn-On Switching Time Test Circuit

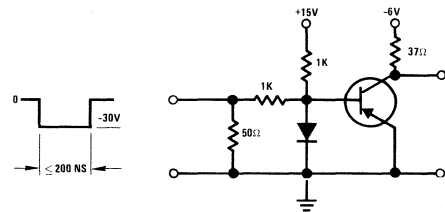
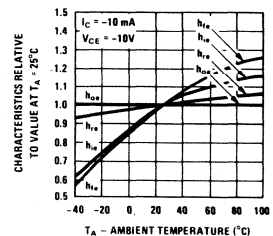
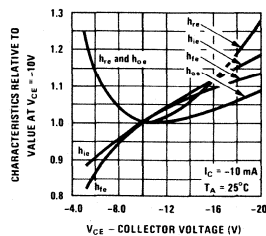
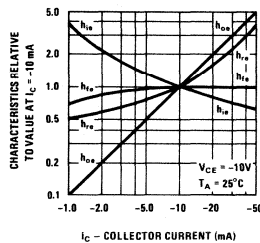


FIGURE 2. Saturated Turn-Off Switching Time Test Circuit

SMALL SIGNAL CHARACTERISTICS (f = 1.0 kHz)

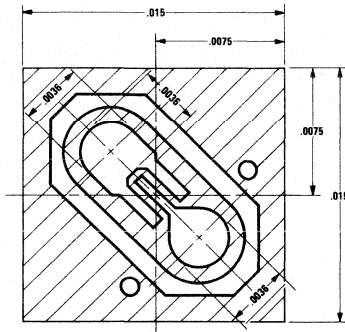
SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
h_{ie}	Input Resistance		480	2000	ohms	$I_C = 10 \text{ mA}$ $V_{CE} = -10V$
h_{oe}	Output Conductance		80	1200	μmhos	$I_C = 10 \text{ mA}$ $V_{CE} = -10V$
h_{re}	Voltage Feedback Ratio		162	1500	$\times 10^{-6}$	$I_C = 10 \text{ mA}$ $V_{CE} = -10V$
h_{fe}	Small Signal Current Gain	100				$I_C = 10 \text{ mA}$ $V_{CE} = -10V$

TYPICAL COMMON EMITTER CHARACTERISTICS (f = 1.0 kHz)





Process 64 PNP High Speed Switch



DESCRIPTION

Process 64 is an overlay double diffused, gold doped silicon epitaxial device. Complement to Process 22.

APPLICATION

This device was designed for high speed saturated switching applications at collector currents to 200 mA.

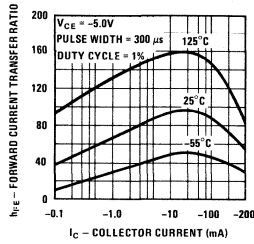
PRINCIPAL DEVICE TYPES:

TO-52 2N2894A
 TO-106 2N4313

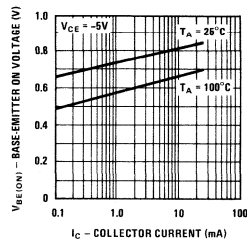
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 30 \text{ mA}$, $I_{B1} = 3 \text{ mA}$		10	20	ns	Fig. 1
t_{off}	$I_C = 30 \text{ mA}$, $I_{B2} = 3 \text{ mA}$		15	25	ns	Fig. 1
t_s	$I_C = I_{B1} = I_{B2} = 10 \text{ mA}$		15	20	ns	
C_{ob}	$V_{CE} = 5 \text{ V}$		3.0	4.5	pF	TO-18
C_{ib}	$V_{EB} = 0.5 \text{ V}$		5.0	6.0	pF	TO-18
h_{fe}	$f = 100 \text{ MHz}$, $I_C = 30 \text{ mA}$, $V_{CE} = 10 \text{ V}$	8	12			
h_{FE}	$I_C = 1 \text{ mA}$	20	65			
h_{FE}	$I_C = 10 \text{ mA}$	30	95			
h_{FE}	$I_C = 30 \text{ mA}$	40	95			
h_{FE}	$I_C = 100 \text{ mA}$	30	85			
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$		0.07	0.13	V	
$V_{CE(SAT)}$	$I_C = 30 \text{ mA}$		0.11	0.19	V	
$V_{CE(SAT)}$	$I_C = 100 \text{ mA}$		0.28	0.45	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$		0.80	0.92	V	
$V_{BE(SAT)}$	$I_C = 30 \text{ mA}$		0.90	1.15	V	
$V_{BE(SAT)}$	$I_C = 100 \text{ mA}$		1.10	1.50	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	12			V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	12			V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	4.50			V	
I_{CES}	$V_{CE} = 10 \text{ V}$			50	nA	

Process 64

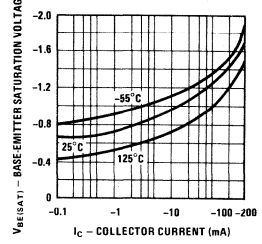
Pulsed DC Current Gain vs Collector Current



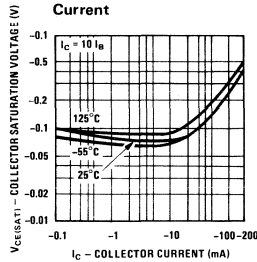
Base-Emitter On Voltage vs Collector Current



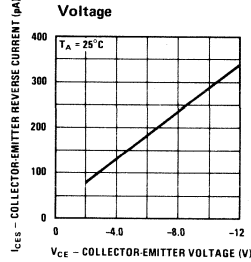
Base Saturation Voltage vs Collector Current



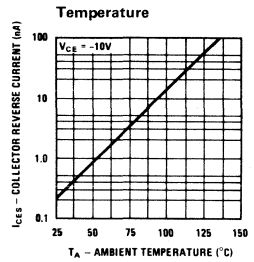
Collector Saturation Voltage vs Collector Current



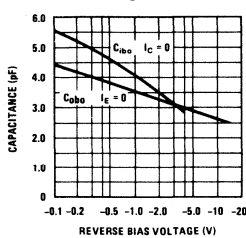
Collector-Base Reverse Current vs Reverse Bias Voltage



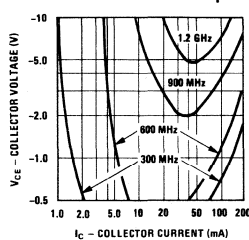
Collector-Base Diode Reverse Current vs Temperature



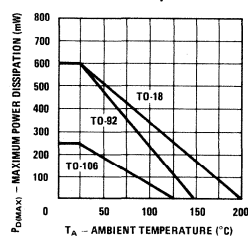
Input and Output Capacitance vs Reverse Bias Voltage



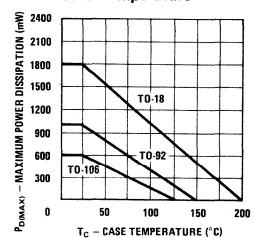
Contours of Constant Gain Bandwidth Product (f_T)



Maximum Power Dissipation vs Ambient Temperature



Maximum Power Dissipation vs Case Temperature



Process 64

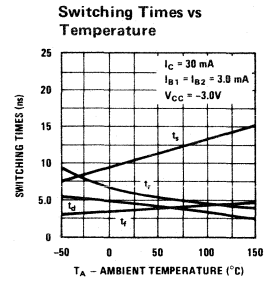
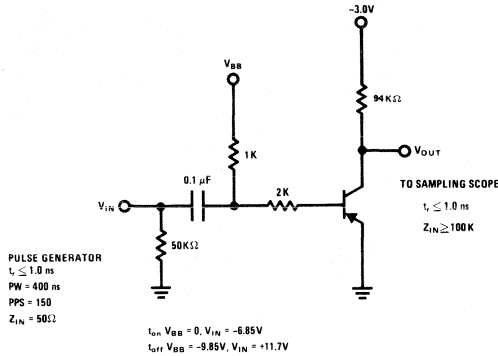
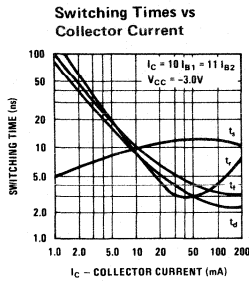
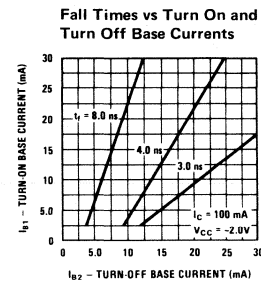
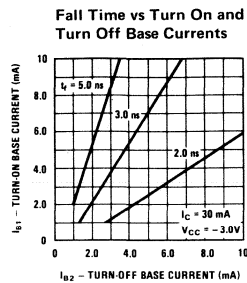
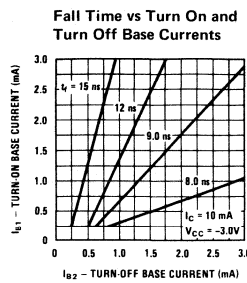
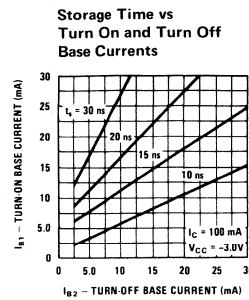
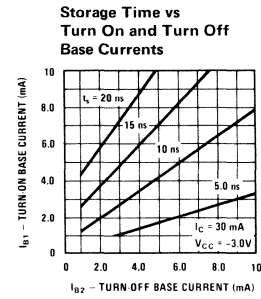
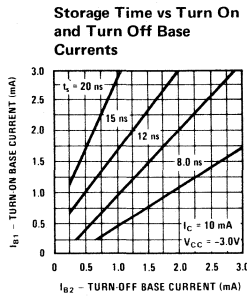
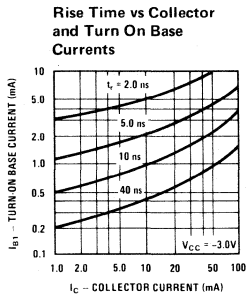
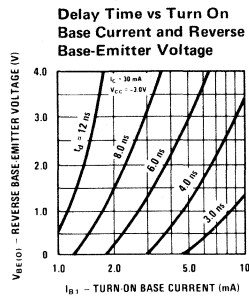
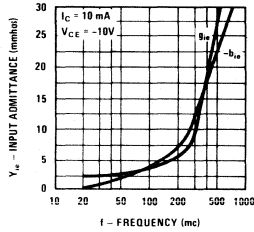


FIGURE 1. Switching Time Test Circuit

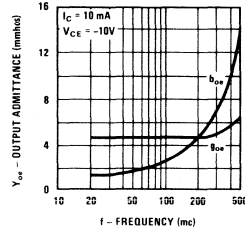


COMMON EMITTER VS FREQUENCY Y PARAMETERS

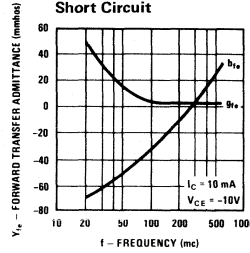
Input Admittance vs Frequency-Output Short Circuit



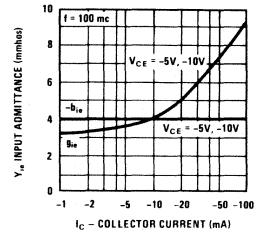
Output Admittance vs Frequency-Input Short Circuit



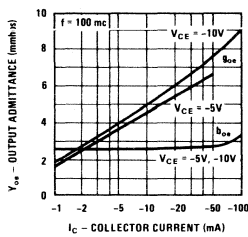
Forward Transfer Admittance vs Frequency-Output Short Circuit



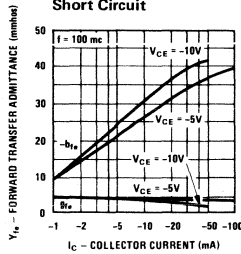
Input Admittance vs Collector Current and Voltage-Output Short Circuit



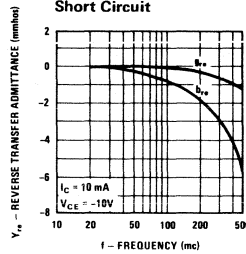
Output Admittance vs Collector Current and Voltage-Input Short Circuit



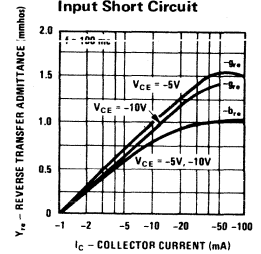
Forward Transfer Admittance vs Collector Current and Voltage-Output Short Circuit



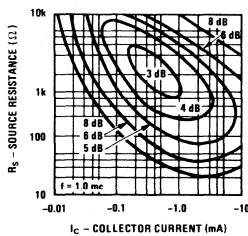
Reverse Transfer Admittance vs Frequency-Input Short Circuit



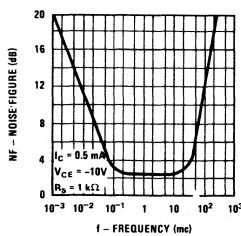
Reverse Transfer Admittance vs Collector Current and Voltage-Input Short Circuit



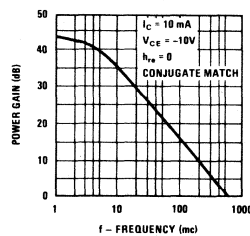
Noise Figure vs Source Resistance and Collector Current



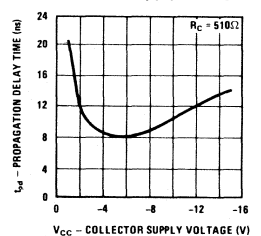
Noise Figure vs Frequency



M.A.G. vs Frequency

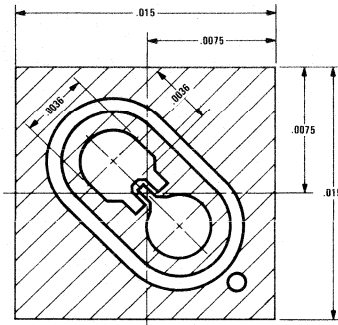


Propagation Delay Time vs Collector Supply Voltage





Process 65 PNP High Speed Switch



DESCRIPTION

Process 65 is an overlay double diffused, gold doped, silicon epitaxial device.

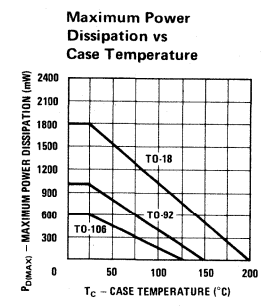
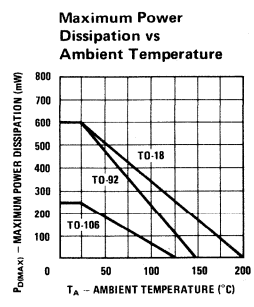
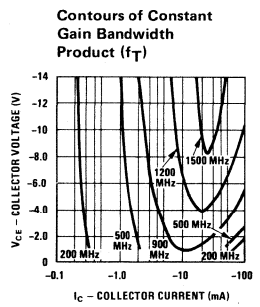
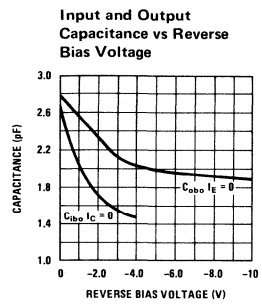
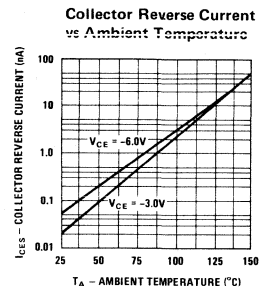
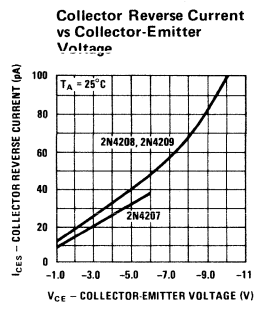
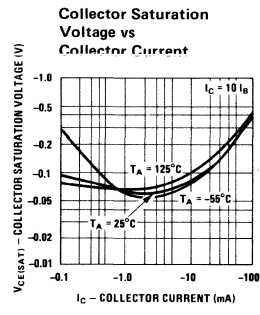
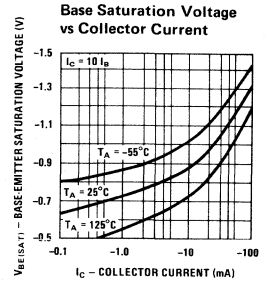
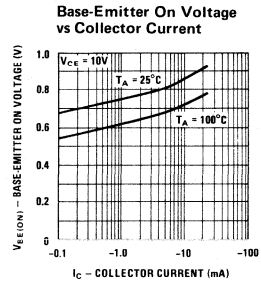
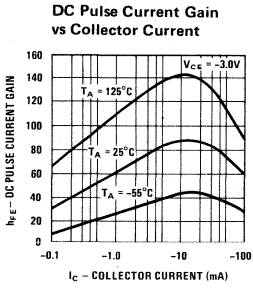
APPLICATION

This device was designed for very high speed saturate switching at collector currents to 50 mA.

PRINCIPAL DEVICE TYPES:

TO-18 2N4208
 TO-92 MPS3640
 TO-106 2N4258

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{off}	$I_C = 10 \text{ mA}, I_{B2} = 1 \text{ mA}$		15	20	ns	Fig. 1
t_{on}	$I_C = 10 \text{ mA}, I_{B1} = 1 \text{ mA}$		11	15	ns	Fig. 1
t_s	$I_C = I_{B1} = I_{B2} = 10 \text{ mA}$		15	20	ns	
C_{ob}	$V_{CB} = 5 \text{ V}$		2	3	pF	TO-18
C_{ib}	$V_{EB} = .5 \text{ V}$		2.5	3.5	pF	
h_{fe}	$V_{CE} = 10 \text{ V}, I_C = 10 \text{ mA}, f = 100 \text{ MHz}$	6.5	13			
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = 3 \text{ V}$	20	60			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = 3 \text{ V}$	20	85			
h_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 3 \text{ V}$	20	75			
h_{FE}	$I_C = 100 \text{ mA}, V_{CE} = 3 \text{ V}$	20	60			
h_{FE}	$I_C = 1 \text{ mA}, V_{CE} = .5 \text{ V}$	20	60			
h_{FE}	$I_C = 10 \text{ mA}, V_{CE} = .3 \text{ V}$	20	67	150		
h_{FE}	$I_C = 50 \text{ mA}, V_{CE} = 1.0 \text{ V}$	20	60			
$V_{CE(SAT)}$	$I_C = 1 \text{ mA}, I_B = .1 \text{ mA}$		0.07	0.13	V	
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.08	0.15	V	
$V_{CE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$		0.25	0.50	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ mA}, I_B = .1 \text{ mA}$		0.73	0.8	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		0.88	0.95	V	
$V_{BE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$		1.15	1.5	V	
BV_{CEO}	$I_C = 3 \text{ mA}$	6	13		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	6	13		V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	4.5			V	
I_{CBO}	$V_{CB} = 3 \text{ V}$			50	nA	



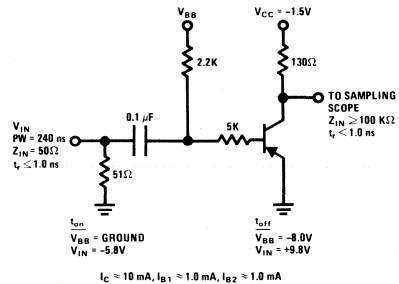
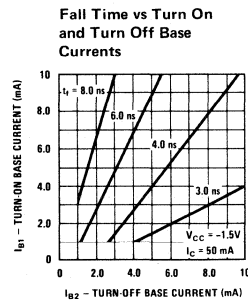
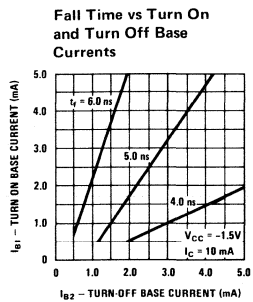
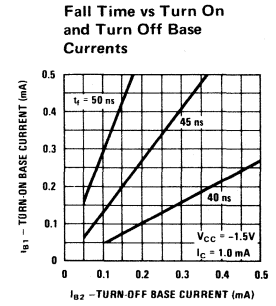
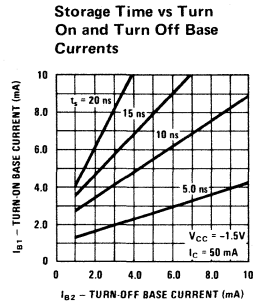
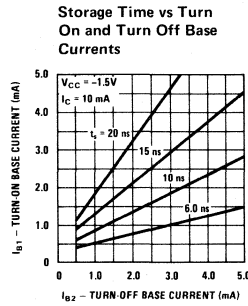
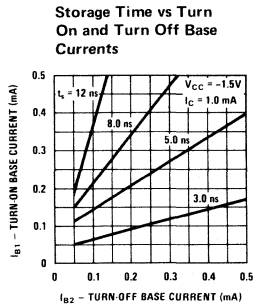
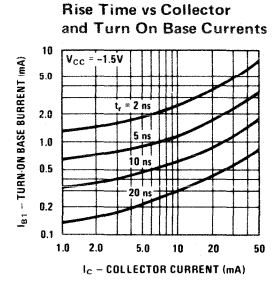
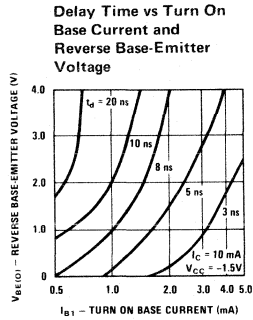
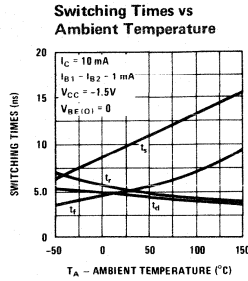
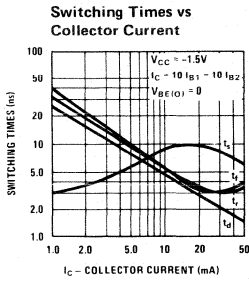


FIGURE 1. t_{on} and t_{off} Test Circuit



Process 66 PNP Small Signal

DESCRIPTION

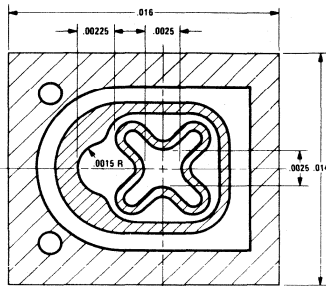
Process 66 is a nonoverlay double diffused, gold doped, silicon epitaxial device.

APPLICATION

This device was designed for general purpose amplifier and switching applications at collector currents of 10 μ A to 100 mA.

PRINCIPAL DEVICE TYPES:

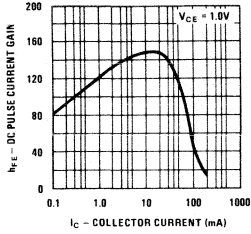
TO-18	NS3906
TO-92	2N3906
TO-106	SM3906



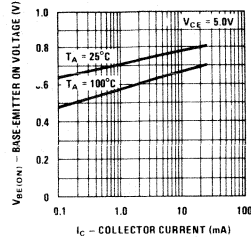
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{off}	$I_C = 10 \text{ mA}$, $I_{B2} = 1 \text{ mA}$		125	300	ns	
t_{on}	$I_C = 10 \text{ mA}$, $I_{R1} = 1 \text{ mA}$		30	70	ns	
C_{ob}	$V_{CB} = 5 \text{ V}$		3.0	4.5	pF	TO-92
C_{ib}	$V_{EB} = 0.5 \text{ V}$		6.0	10.0	pF	TO-92
h_{fe}	$f = 100 \text{ MHz}$, $V_{CE} = 20 \text{ V}$, $I_C = 10 \text{ mA}$	2.5	6.0			
NF (wide band)	$I_C = 100 \mu\text{A}$, $V_{CE} = 5 \text{ V}$, $R_S = 1 \text{ k}\Omega$		2.0	4.0	dB	
h_{FE}	$I_C = 0.1 \text{ mA}$, $V_{CE} = 1 \text{ V}$	40	80			
h_{FE}	$I_C = 1 \text{ mA}$, $V_{CE} = 1 \text{ V}$	40	120			
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 1 \text{ V}$	40	150	500		
h_{FE}	$I_C = 50 \text{ mA}$, $V_{CE} = 1 \text{ V}$	40	110			
h_{FE}	$I_C = 100 \text{ mA}$, $V_{CE} = 1 \text{ V}$	20	40			
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.05	0.25	V	
$V_{CE(SAT)}$	$I_C = 50 \text{ mA}$, $I_B = 5 \text{ mA}$		0.12	0.40	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.75	0.85	V	
$V_{BE(SAT)}$	$I_C = 50 \text{ mA}$, $I_B = 5 \text{ mA}$		0.85	0.95	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	40	50		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	40	60		V	
BV_{EBO}	$I_C = 10 \mu\text{A}$	5.0			V	
I_{CBO}	$V_{CB} = 25 \text{ V}$			50	nA	
I_{EBO}	$V_{EB} = 4 \text{ V}$			50	nA	

Process 66

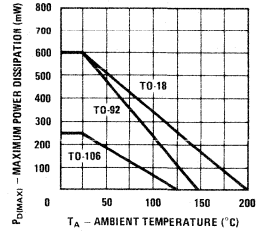
DC Pulse Current Gain vs Collector Current



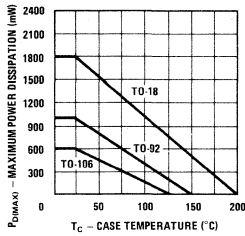
Base-Emitter On Voltage vs Collector Current



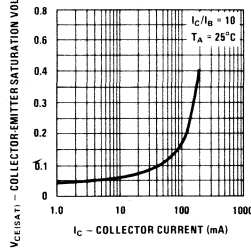
Maximum Power Dissipation vs Ambient Temperature



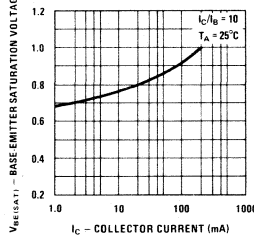
Maximum Power Dissipation vs Case Temperature



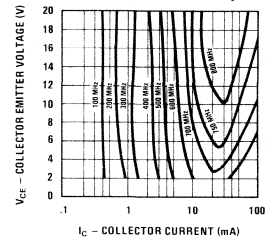
Collector-Emitter Saturation Voltage vs Collector Current



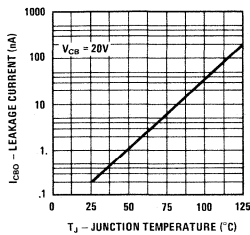
Base-Emitter Saturation Voltage vs Collector Current



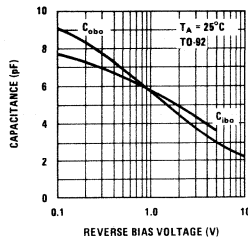
Contours of Constant Gain Bandwidth Product (fT)



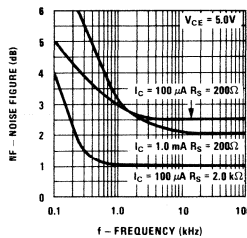
Collector-Base Diode Reverse Current vs Temperature



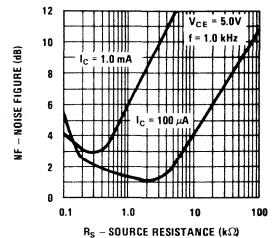
Common Base Open Circuit Input and Output Capacitance vs Reverse Bias Voltage



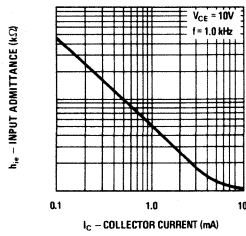
Noise Figure vs Frequency



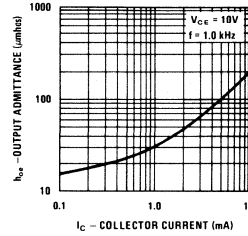
Noise Figure vs Source Resistance



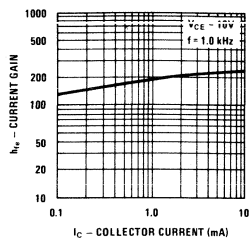
Input Admittance



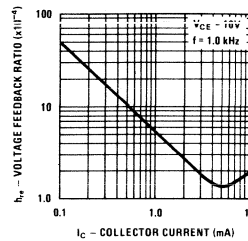
Output Admittance



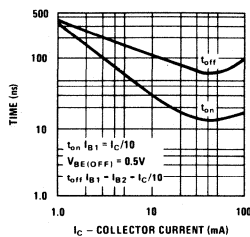
Current Gain



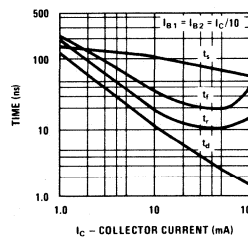
Voltage Feedback Ratio



Turn On and Turn Off Times vs Collector Current

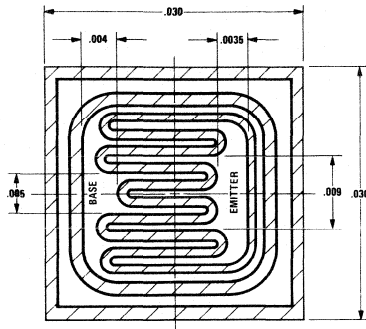


Switching Times vs Collector Current





Process 67 PNP Medium Power



DESCRIPTION

Process 67 is a nonoverlay double diffused silicon device. Complement to Process 12.

APPLICATION

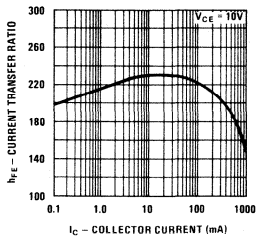
This device is designed for general purpose amplifier and switching applications at currents to one amp.

PRINCIPAL DEVICE TYPES:

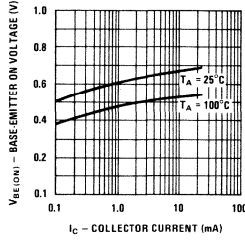
TO-39 2N4033
 TO-92 MPS4356
 TO-106 2N4356

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{on}	$I_C = 500 \text{ mA}, I_{B1} = 50 \text{ mA}$	20	25	60	ns	
t_{off}	$I_C = 500 \text{ mA}, I_{B2} = 50 \text{ mA}$	200	250	400	ns	
C_{ob}	$V_{CB} = 10\text{V}$		14	18	pF	TO-39
C_{ib}	$V_{EB} = 0.50\text{V}$		80	100	pF	TO-39
h_{fe}	$V_{CE} = 10\text{V}, I_C = 50 \text{ mA}, f = 100 \text{ MHz}$	1.5	2			
NF (spot)	$I_C = 100 \mu\text{A}, R_S = 1\text{k}, V_{CE} = 10\text{V}, f = 1 \text{ kHz}$		0.5	4	dB	
h_{FE}	$I_C = 0.10 \text{ mA}$	50	200			
h_{FE}	$I_C = 1.0 \text{ mA}$	50	220			
h_{FE}	$I_C = 10 \text{ mA}$	50	230	350		
h_{FE}	$I_C = 100 \text{ mA}$	50	220			
h_{FE}	$I_C = 500 \text{ mA}$	50	170			
h_{FE}	$I_C = 1\text{A}$	25	150			
$V_{CE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.1	0.2	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.25	0.4	V	
$V_{BE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.8	1.0	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.95	1.2	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	60	80		V	
BV_{CBO}	$I_C = 100 \mu\text{A}$	80	120		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	5.0	7.00		V	
I_{CBO}	$V_{CB} = 60\text{V}$			50	nA	
I_{EBO}	$V_{EB} = 4\text{V}$			50	nA	

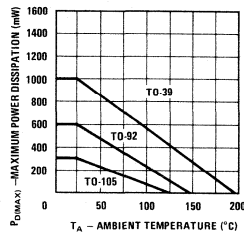
DC Pulse Current Gain vs Collector Current



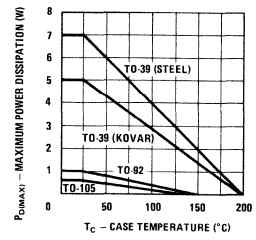
Base-Emitter On Voltage vs Collector Current



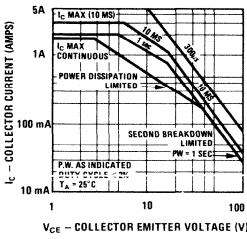
Maximum Power Dissipation vs Ambient Temperature



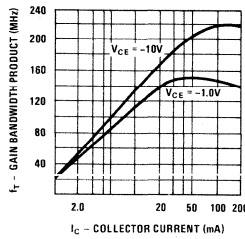
Maximum Power Dissipation vs Case Temperature



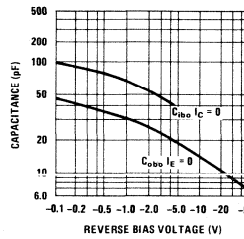
Safe Operating Area TO-39 With "Wake Field" Type 296-4 Heat Sink



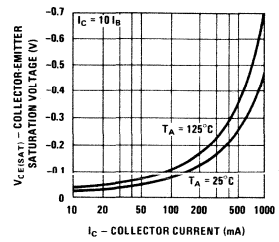
Gain Bandwidth Product vs Collector Current



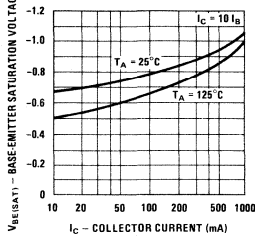
Common Base Open Circuit Input and Output Capacitance vs Reverse Bias Voltage



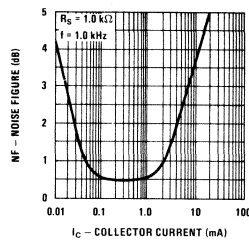
Collector-Emitter Saturation Voltage vs Collector Current



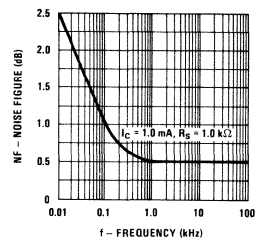
Base-Emitter Saturation Voltage vs Collector Current



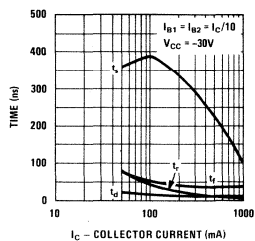
Noise Figure vs Collector Current



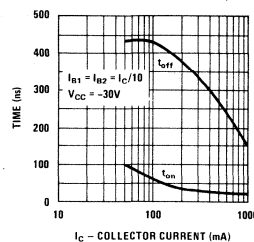
Noise Figure vs Frequency



Switching Times vs Collector Current

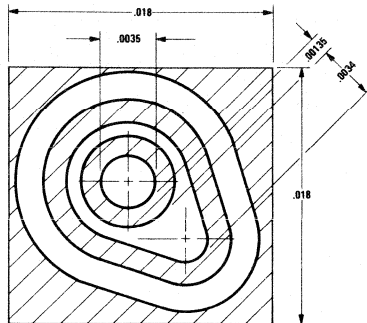


Turn On and Turn Off Times vs Collector Current





Process 69 PNP Small Signal



DESCRIPTION

Process 69 is a nonoverlay double diffused, silicon epitaxial device. Complements Process 27.

APPLICATION

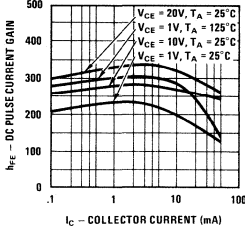
This device was designed for general purpose amplifier and switching applications to collector currents of 100 mA.

PRINCIPAL DEVICE TYPES:

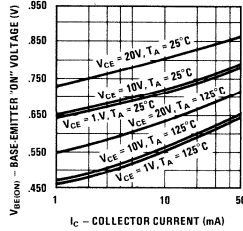
TO-18 2N3251A

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
T_{ON}	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		50	70	nS	
T_{OFF}	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$		125	225	nS	
NF	$V_{CE} = 5V, I_C = 100 \mu\text{A}, f = 1 \text{ kHz}$ $R_S = 1 \text{ k}\Omega$		1.7	4.5	dB	
C_{OB}	$V_{CE} = 5V$		4	5.0	pF	
C_{IB}	$V_{EB} = 1V$		6.5	8.0	pF	
f_T	$V_{CE} = 20V, I_C = 10 \text{ mA}$	250	450		MHz	
H_{FE}	1V, 100 μA	40	150	300		
H_{FE}	1V, 1 mA	45	160	325		
H_{FE}	$V_{CE} = 1V, I_C = 10 \text{ mA}$	50	150	350		
H_{FE}	$V_{CE} = 1V, I_C = 50 \text{ mA}$	15	65	110		
H_{FE}	$V_{CG} = 1V, I_C = 100 \text{ mA}$		18	35		
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$.15	.25	V	
$V_{CE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$.25	.50	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$.74	.90	V	
$V_{BE(SAT)}$	$I_C = 50 \text{ mA}, I_B = 5 \text{ mA}$.85	1.20	V	
I_{CBO}	$V_{CB} = 30V$		1.5	50	nA	
I_{EBO}	$V_{EB} = 4V$.05	50	nA	
BV_{CBO}	$I_C = 10 \mu\text{A}$	50	90			
BV_{EBO}	$I_C = 10 \mu\text{A}$	5.0	7.0			
BV_{CEO}	$I_C = 1 \text{ mA}$	40	70			
BV_{CES}	$I_C = 10 \mu\text{A}$		90			

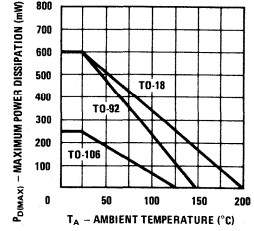
DC Pulse Current Gain vs Collector Current



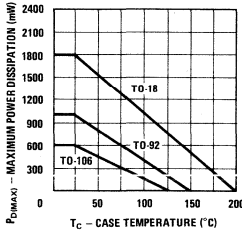
Base-Emitter On Voltage vs Collector Current



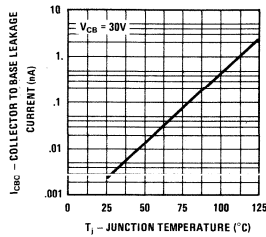
Maximum Power Dissipation vs Ambient Temperature



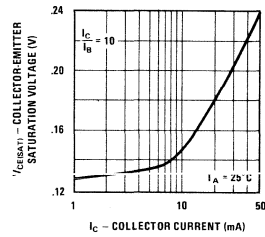
Maximum Power Dissipation vs Case Temperature



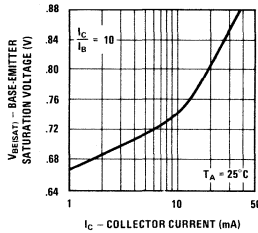
Collector-Base Diode Reverse Current vs Temperature



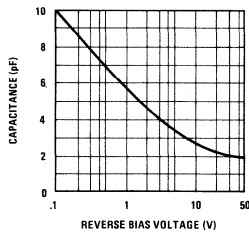
Collector-Emitter Saturation Voltage vs Collector Current



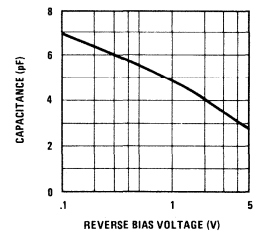
Base-Emitter On Voltage vs Collector Current



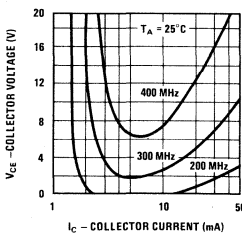
Output Capacitance vs Reverse Bias Voltage



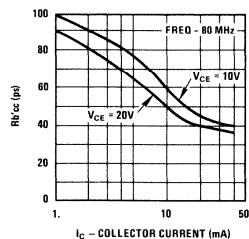
Input Capacitance vs Reverse Bias Voltage



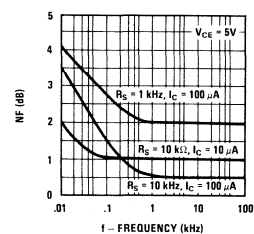
Contours of Constant Gain Bandwidth Product (f_T)



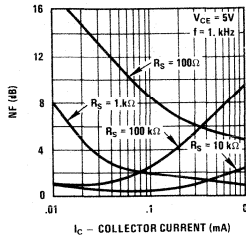
Rb'cc vs Collector Current



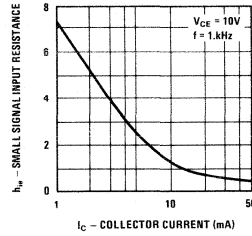
Noise Figure vs Frequency



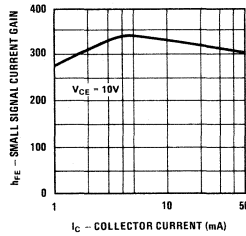
Noise Figure vs Collector Current



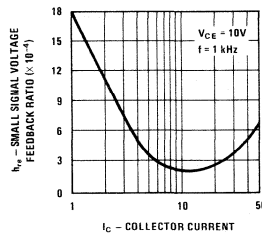
Small Signal Input Resistance vs Collector Current



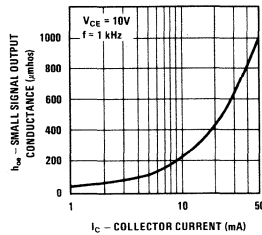
Small Signal Current Gain vs Collector Current



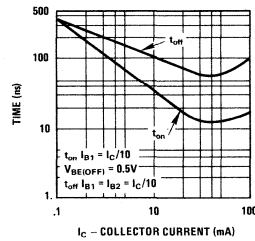
Small Signal Voltage Feedback Ratio vs Collector Current



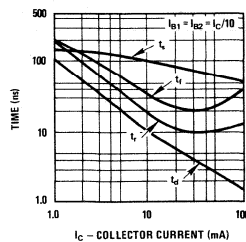
Small Signal Output Conductance vs Collector Current



Turn On and Turn Off Times vs Collector Current

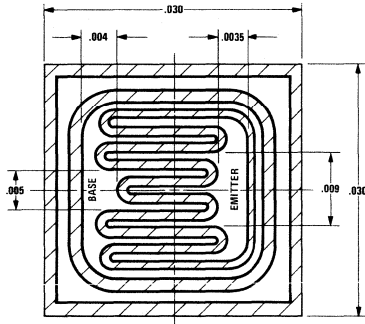


Switching Times vs Collector Current





Process 70 PNP Core Driver



DESCRIPTION

Process 70 is a nonoverlay double diffused, gold doped, silicon epitaxial device compliant to process 25.

APPLICATION

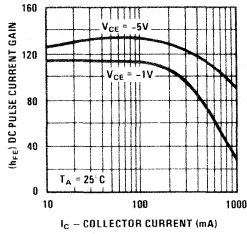
This device was designed primarily for high speed saturated switching applications.

PRINCIPAL DEVICE TYPES:

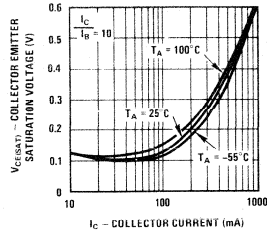
TO-39 (pkg. 17) 2N3467

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
t_{ON}	$I_C = 500 \text{ mA}, I_{B1} = 50 \text{ mA}$		20	40	ns	Fig. 1
t_{OFF}	$i_C = 500 \text{ mA}, I_{B2} = 50 \text{ mA}$		64	90	ns	Fig. 2
h_{fe}	$I_C = 50 \text{ mA}, V_{CE} = -10\text{V}, f = 100 \text{ MHz}$	1.75	2.9			
C_{ob}	$V_{CB} = -10\text{V}$		14	25	pF	
C_{ib}	$V_{eb} = -0.5\text{V}$		72	100	pF	
h_{FE}	$I_C = 150 \text{ mA}, V_{CE} = -1\text{V}$	40	120			
h_{FE}	$I_C = 500 \text{ mA}, V_{CE} = -1\text{V}$	40	75	120		
h_{FE}	$I_C = 1 \text{ Amp}, V_{CE} = -5\text{V}$	40	85			
$V_{CE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.165	0.3	V	
$V_{CE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$		0.30	0.5	V	
$V_{CE(SAT)}$	$I_C = 1 \text{ Amp}, I_B = 100 \text{ mA}$		0.50	1.0	V	
$V_{BE(SAT)}$	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$		0.80	1.0	V	
$V_{BE(SAT)}$	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$	0.8	0.90	1.2	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ Amp}, I_B = 100 \text{ mA}$		1.1	1.6	V	
BV_{CEO}	$I_C = 10 \text{ mA}$	40	66		V	
BV_{CBO}	$I_C = 10 \mu\text{A}$	40	98		V	
BV_{EBO}	$I_E = 10 \mu\text{A}$	5	8.0		V	
I_{CBO}	$V_{CB} = 30\text{V}$		10	100	nA	
I_{CEX}	$V_{CE} = -30\text{V}, V_{BE(OFF)} = -3\text{V}$		10	100	nA	
I_{bL}	$V_{CE} = -30\text{V}, V_{BE(OFF)} = -3\text{V}$		10	120	nA	

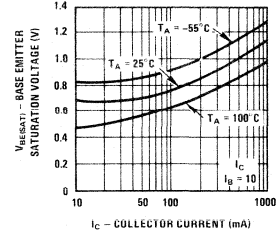
DC Pulse Current Gain vs Collector Current



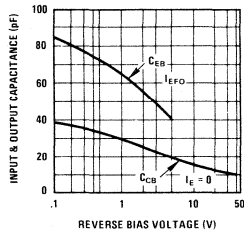
Collector-Emitter Saturation Voltage vs Collector Current



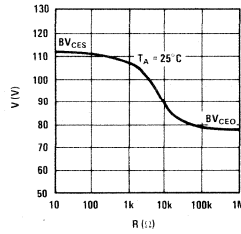
Base-Emitter Saturation Voltage vs Collector Current



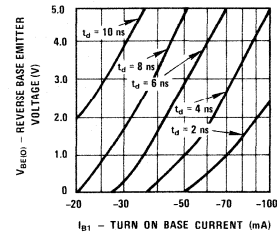
Input & Output Capacitance vs Reverse Bias Voltage



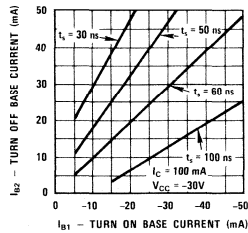
BVCES vs RBE IC = 10 mA



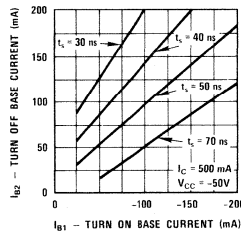
Delay Time vs Turn On Base Current and Reverse Base Emitter Voltage



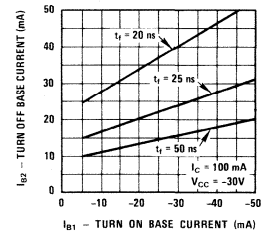
Storage Time vs Turn On and Turn Off Base Currents



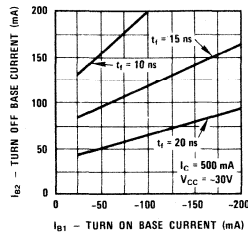
Storage Time vs Turn On and Turn Off Base Currents



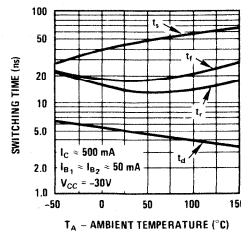
Fall Time vs Turn On and Turn Off Base Currents



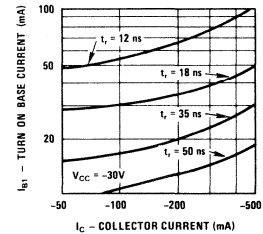
Fall Time vs Turn On and Turn Off Base Currents



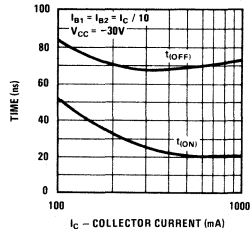
Switching Times vs Ambient Temperature



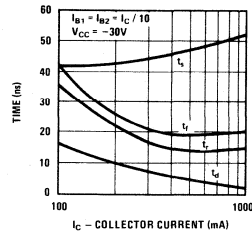
Rise Time vs Collector Current and Turn On Base Current



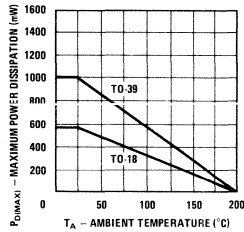
Turn On and Turn Off Times vs Collector Current



Switching Times vs Collector Current



Maximum Power Dissipation vs Ambient Temperature



Maximum Power Dissipation vs Case Temperature

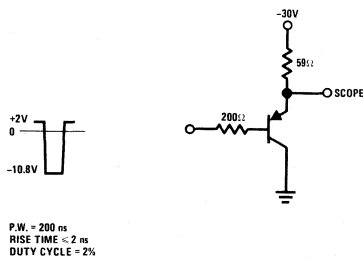
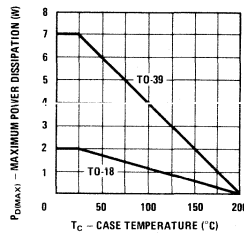


FIGURE 1. t_{ON} Equivalent Test Circuit

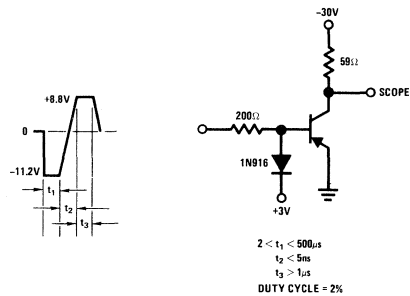


FIGURE 2. t_{OFF} Equivalent Test Circuit



Process 71 PNP Small Signal

DESCRIPTION

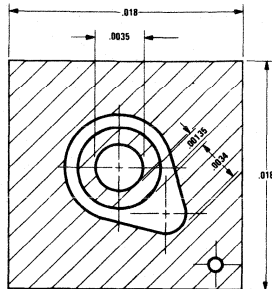
Process 71 is a nonoverlay, double diffused, silicon device. Complement to Process 04.

APPLICATION

This device was designed for general purpose amplifier applications at collector currents to 20 mA.

PRINCIPAL DEVICE TYPES:

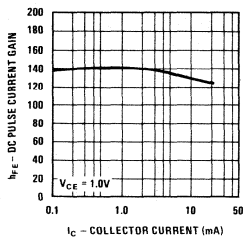
TO-18 BC177 Series
TO-106 BC251 Series



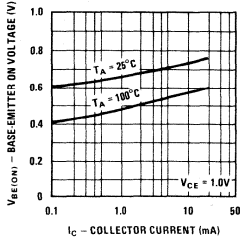
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
NF (spot)	$I_C = 200 \mu A$, $V_C = 5V$, $R_S = 2k$, $f = 1 \text{ kHz}$		0.5	2.50	dB	
h_{fe}	$I_C = 10 \text{ mA}$, $V_{CE} = 5V$, $f = 100 \text{ MHz}$	3	5			
C_{ob}	$V_{CB} = 10V$		4	6	pF	TO-18
C_{ib}	$V_{EB} = 0.50V$		8	12	pF	TO-18
h_{FE}	$I_C = 100 \mu A$, $V_{CE} = 1V$	40	140	400		
h_{FE}	$I_C = 1 \text{ mA}$, $V_{CE} = 1V$	40	140	400		
h_{FE}	$I_C = 10 \text{ mA}$, $V_{CE} = 1V$	40	130			
h_{FE}	$I_C = 20 \text{ mA}$, $V_{CE} = 1V$	40	125			
$V_{CE(SAT)}$	$I_C = 1 \text{ mA}$, $I_B = 0.10 \text{ mA}$		0.04	0.10	V	
$V_{CE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.055	0.11	V	
$V_{BE(SAT)}$	$I_C = 1 \text{ mA}$, $I_B = 0.10 \text{ mA}$		0.8	0.95	V	
$V_{BE(SAT)}$	$I_C = 10 \text{ mA}$, $I_B = 1 \text{ mA}$		0.9	1.0	V	
BV_{CEO}	$I_C = 1 \text{ mA}$	40	50		V	
BV_{CBO}	$I_C = 100 \mu A$	40			V	
BV_{EBO}	$I_E = 10 \mu A$	5	6		V	
I_{CBO}	$V_{CB} = 30V$			50	nA	
I_{EBO}	$V_{EB} = 3V$			50	nA	

Process 71

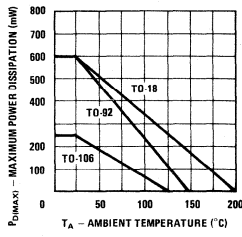
DC Pulse Current Gain vs Collector Current



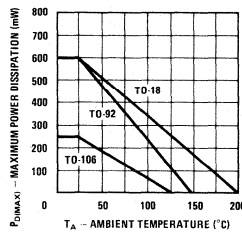
Base-Emitter On Voltage vs Collector Current



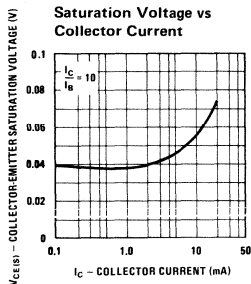
Maximum Power Dissipation vs Ambient Temperature



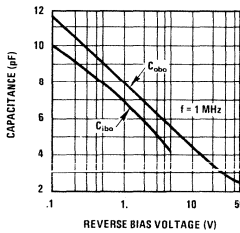
Maximum Power Dissipation vs Case Temperature



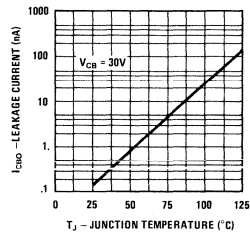
Collector-Emitter Saturation Voltage vs Collector Current



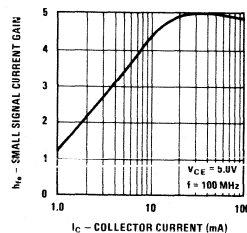
Capacitance vs Reverse Bias Voltage



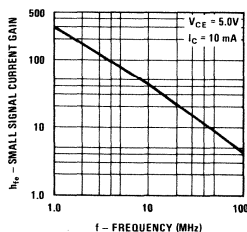
Collector-Base Diode Reverse Current vs Temperature



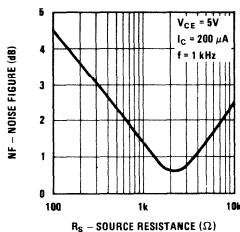
Small Signal Current Gain vs Collector Current



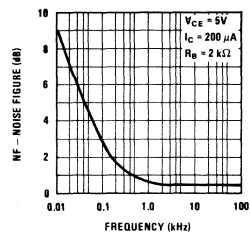
Capacitance vs Reverse Bias Voltage



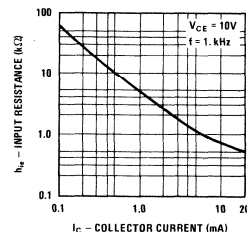
Noise Figure vs Source Resistance



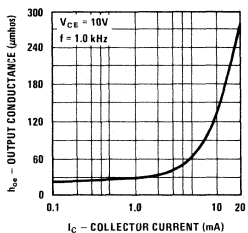
Noise Figure vs Frequency



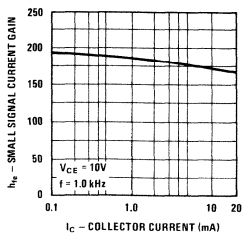
Small Signal Input Resistance vs Collector Current



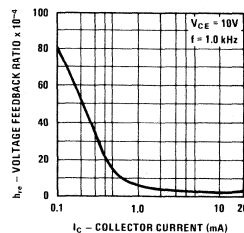
Small Signal Output Conductance vs Collector Current



Small Signal Current Gain vs Collector Current



Small Signal Voltage Feedback Ratio vs Collector Current





Process 73 PNP High Voltage

DESCRIPTION

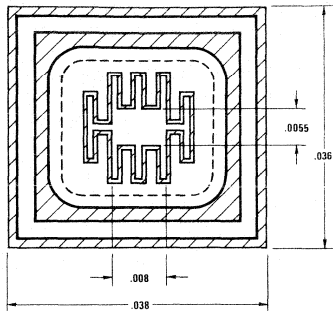
Process 73 is nonoverlay doubled diffused, silicon epitaxial device. Complement to Process 08.

APPLICATION

This device was designed as a general purpose amplifier and switch for applications requiring high line voltages.

PRINCIPAL DEVICE TYPES:

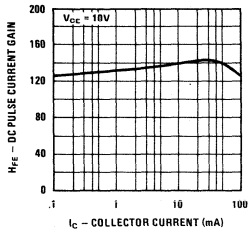
TO-39 2N3634



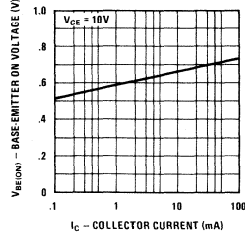
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
BV_{CEO}	I_C at 10 mA	140	180		V	
BV_{CBO}	I_C at 100 μ A	140	240		V	
BV_{EBO}	I_E at 10 μ A	5	7		V	
I_{CBO}	V_{CB} at 100V			100	nA	
I_{EBO}	V_{EB} at 3V			50	nA	
H_{FE}	I_C at 0.1 mA, V_{CE} at 10V	40	80			
H_{FE}	I_C at 1 mA, V_{CE} at 10V	45	90			
H_{FE}	I_C at 10 mA, V_{CE} at 10V	50	100			
H_{FE}	I_C at 50 mA, V_{CE} at 10V	25	50			
$V_{CE(SAT)}$	I_C at 50 mA, I_B at 5 mA		0.25	0.5	V	
$V_{BE(SAT)}$	I_C at 50 mA, I_B at 5 mA		0.65	0.9		
C_{OB}	V_{CB} at 20V		8	10	pF	
C_{iB}	V_{EB} at 1.0V		50	75	pF	
F_T	I_C at 30 mA, V_{CE} at 30V, F at 100 MHz	150	225		MHz	

Process 73

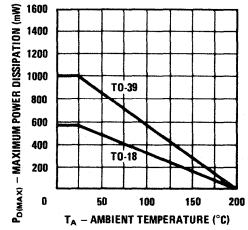
DC Pulse Current Gain vs Collector Current



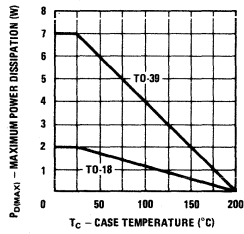
Base-Emitter On Voltage vs Collector Current



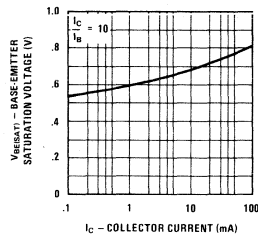
Maximum Power Dissipation vs Ambient Temperature



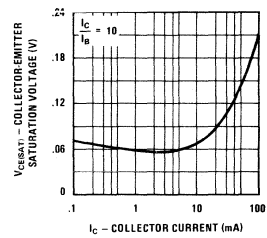
Maximum Power Dissipation vs Case Temperature



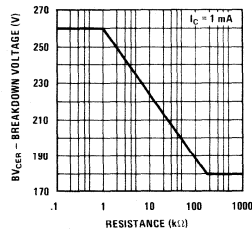
Base-Emitter Saturation Voltage vs Collector Current



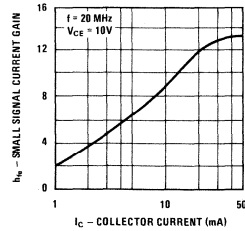
Collector-Emitter Saturation Voltage vs Collector Current



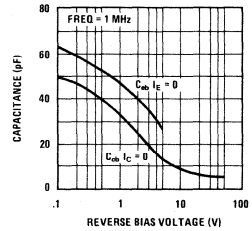
Collector-Emitter Breakdown Voltage With Resistance Between Emitter-Base



Small Signal Current Gain vs Collector Current



Input and Output Capacitance vs Reverse Bias Voltage





Process 74 PNP High Voltage

DESCRIPTION

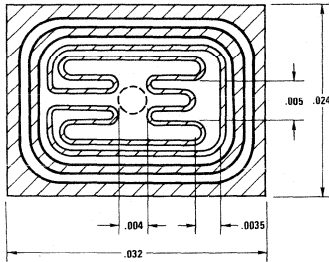
Process 74 is nonoverlap doubled diffused, silicon epitaxial device. Complement to Process 15.

APPLICATION

This device was designed as a general purpose amplifier and switch for applications requiring high line voltages

PRINCIPAL DEVICE TYPES:

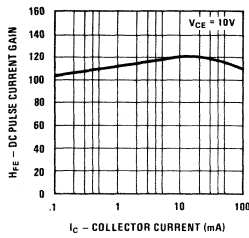
TO-92 2N5401



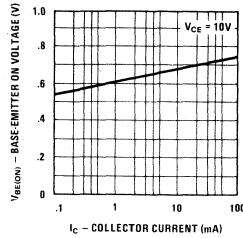
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
BV_{CEO}	I_C at 1 mA	120	170		V	
BV_{CBO}	I_C at 100 μA	130	220		V	
BV_{EBO}	I_E at 10 μA	5	6.5			
I_{CBO}	V_{CB} at 100V			100	nA	
I_{EBO}	V_{EB} at 3V			50	nA	
H_{FE}	I_C at 1 mA, V_{CE} at 5V	30	60			
H_{FE}	I_C at 10 mA, V_{CE} at 5V	40	100	240		
H_{FE}	I_C at 50 mA, V_{CE} at 5V	40	60			
$V_{CE(SAT)}$	I_C at 50 mA, I_B at 5 mA		0.18	0.25		
$V_{BE(SAT)}$	I_C at 50 mA, I_B at 5 mA		0.75	1.0		
COB	V_{CB} at 10V		5	6.0	pF	
F_T	I_C at 10 mA, V_{CE} at 10V, F at 100 MHz	100	200	400	MHz	

Process 74

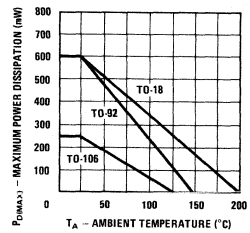
DC Pulse Current Gain vs Collector Current



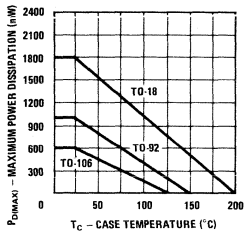
Base-Emitter On Voltage vs Collector Current



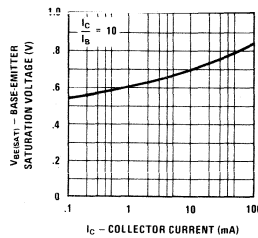
Maximum Power Dissipation vs Ambient Temperature



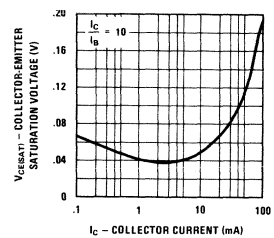
Maximum Power Dissipation vs Case Temperature



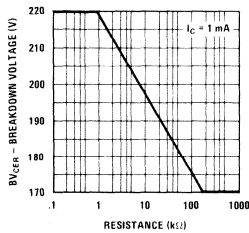
Base-Emitter Saturation Voltage vs Collector Current



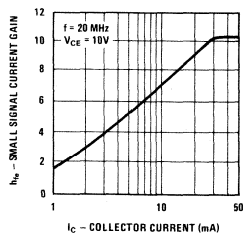
Collector-Emitter Saturation Voltage vs Collector Current



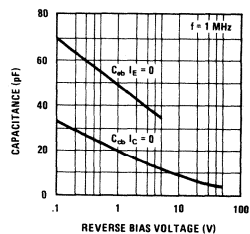
Collector-Emitter Breakdown Voltage With Resistance Between Base-Emitter



Small Signal Current Gain vs Collector Current

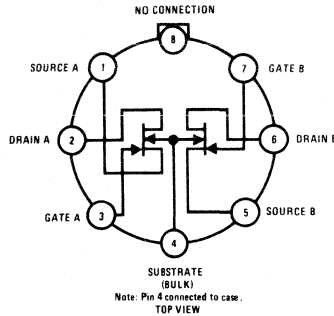
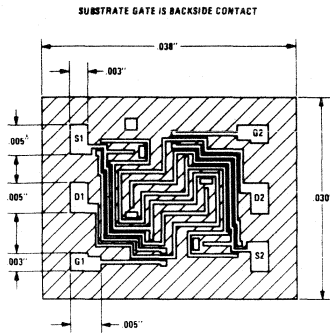


Input and Output Capacitance vs Reverse Bias Voltage





Process 82 N-Channel Junction FET



PACKAGES:

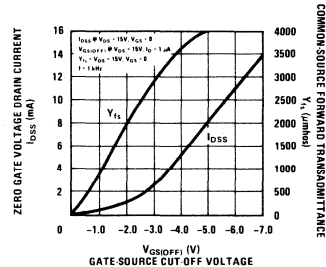
TO-99

PRINCIPAL DEVICE TYPES:

FM1100A SERIES

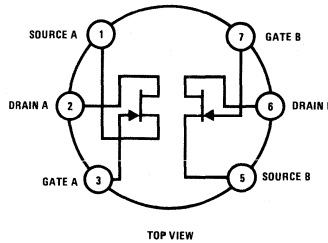
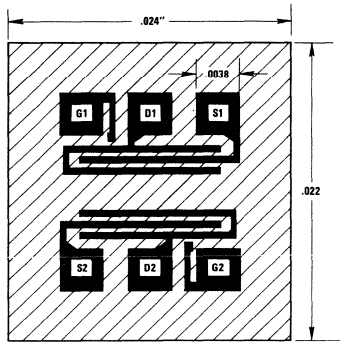
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	20	35		V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0$	0.1	3.0	10	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	0.5	3.0	6.0	mmho
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15V, I_D = 1 \mu A$	0.5	3.0	6.0	V
Gate Current	I_G	$V_{DG} = 35V, I_D = 0.10 \text{ mA}$	0.1	0.4	10	pA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 \text{ MHz}$		0.3	0.6	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 \text{ mA}, f = 1 \text{ MHz}$		3.5	5.0	pF

Process 82 is a monolithic dual JFET. It is strictly intended for operational amplifier input buffer applications. Special processing results in extremely low input bias current and virtually unmeasurable offset current. It is important to note that the sub-pico ampere bias current is measured at 35 volts. Typical CMRR is 115 dB. Performance superior to electrometer tubes can be readily achieved with low offset voltage and almost zero long term drift.





Process 83 N-Channel Junction FET



PACKAGES:

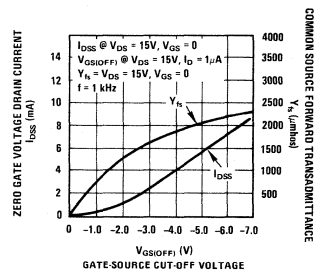
TO-71

PRINCIPAL DEVICE TYPES:

2N5196-99
 FM1300 Series
 2N3954-58
 2N5045-47
 2N5545-47
 U231-235
 2N3921-22
 2N4084-85

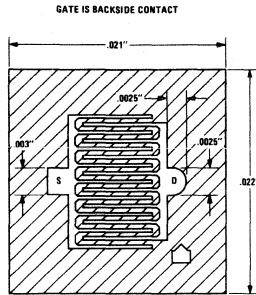
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	30	70	100	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0$	0.2	3.0	10	mA
Forward Transconductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	0.5	1.5	3	mmho
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15V, I_D = 1 \mu A$	0.5	3.0	8	V
Gate Current	I_G	$V_{DG} = 20V, I_D = 0.10 \text{ mA}$	1	10	100	pA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 \text{ MHz}$				pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 \text{ mA}, f = 1 \text{ MHz}$				pF

Process 83 is a monolithic dual JFET with a diode isolated substrate. It is intended for operational amplifier input buffer applications. Processing results in low input bias current and virtually unmeasurable offset current.





Process 88 P-Channel Junction FET



PACKAGES:

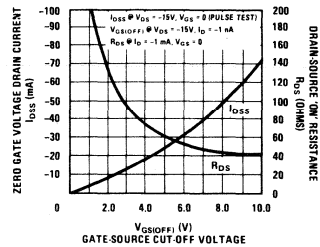
TO-18P, TO-72, TO-106

PRINCIPAL DEVICE TYPES:

2N3382-86
 3N5114-16
 P1086E
 2N3993-94
 2N5018-21

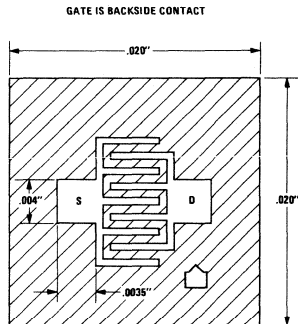
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	30	40	50	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0$	5.0	30	90	mA
Forward Trans-conductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	4.0	12.0	16.0	mmho
Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.05	10	nA
"ON" Resistance	$R_{DS(ON)}$	$V_{DS} = 0, V_{GS} = 0$	60	100	200	Ω
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15V, I_D = 1 nA$	0.5	5.0	10	V
Drain "OFF" Current	$I_{D(OFF)}$	$V_{DS} = 15V, V_{GS} = -10V$		0.05	10	nA
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1MHz$	3.0	4.0	5.0	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 mA, f = 1 MHz$	12	14	15	pF

Process 88 is designed primarily for electronic switching applications where a P channel device is desirable. Inherent zero offset voltage, low leakage and low $R_{DS(ON)}$ C_{iss} time constant make this device excellent for low level analog switching, sample and hold circuits and chopper stabilized amplifiers. This device is the compliment to process 51.





Process 89 P-Channel Junction FET



PACKAGES:

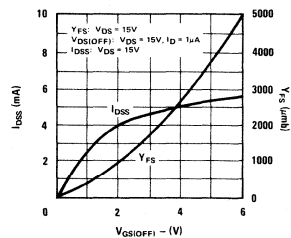
TO-18P, TO-72, TO-92, TO-106

PRINCIPAL DEVICE TYPES:

2N2608
 2N4381
 2N5460-62
 2N3329-32

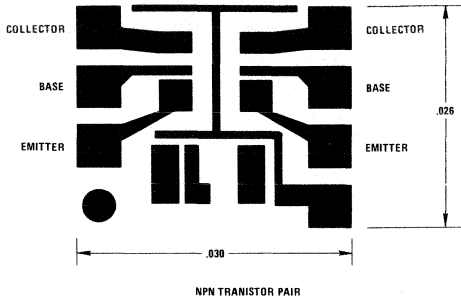
CHARACTERISTIC	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Gate-Source Breakdown Voltage	BV_{GSS}	$V_{DS} = 0V, I_G = 1 \mu A$	20	30		V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 15V, V_{GS} = 0$	0.3	3	20	mA
Forward Trans-conductance	Y_{fs}	$V_{DS} = 15V, V_{GS} = 0$	1	2.5	4	mmho
Gate Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0$		0.1	10	nA
Pinch Off Voltage	$V_{GS(OFF)}$	$V_{DS} = 15V, I_D = 1 nA$	0.5	3	9	V
Feedback Capacitance	C_{rss}	$V_{DG} = 15V, I_S = 0, f = 1 MHz$		2	2.5	pF
Input Capacitance	C_{iss}	$V_{DS} = 15V, I_D = 2 mA, f = 1 MHz$		7	8.5	pF

Process 89 is designed primarily for low level amplifier applications. This device is the complement to Process 55.





Process 570 NPN Monolithic Dual



DESCRIPTION

Monolithic junction isolated NPN Transistor Pair.

APPLICATION

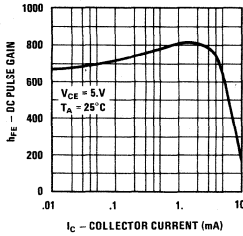
This device is designed for applications requiring extremely close matching.

PRINCIPAL DEVICE TYPES:

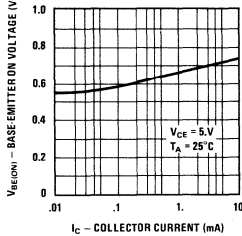
ND5700
ND5701
ND5702

PARAMETER	TEST CONDITIONS	ND5700		ND5701		ND5702		UNITS
		MIN	MAX	MIN	MAX	MIN	MAX	
h_{FE1}/h_{FE2}	$I_C = 10 \mu A, V_{CE} = 5.0V$		5.0		10		10	%
$ V_{BE1} - V_{BE2} $	$I_C = 10 \mu A \text{ to } 5.0 \text{ mA}, V_{CE} = 5.0V$		0.5		1.0		2.0	mV
$ \Delta(V_{BE1} - V_{BE2}) $	$I_C = 10 \mu A, V_{CE} = 5.0V,$ $T_A = -55^\circ C \text{ to } +125^\circ C$		2.0		5.0		10	$\mu V/^\circ C$
C_{ob}	$I_E = 0, V_{CB} = 5.0V$		3.0		3.0		3.0	pF
C_{ib}	$I_C = 0, V_{EB} = 0.5V$		3.0		3.0		3.0	pF
h_{fe}	$I_C = 1.0 \text{ mA}, V_{CE} = 5.0V, f = 1 \text{ kHz}$	220	2200	220	2200	220	2200	
h_{FE}	$I_C = 10 \mu A, V_{CE} = 5.0V$	200	1500	200	1500	200	1500	
h_{FE}	$I_C = 1.0 \text{ mA}, V_{CE} = 5.0V$	200	2000	200	2000	200	2000	
h_{FE}	$I_C = 5.0 \text{ mA}, V_{CE} = 5.0V$	200	2000	200	2000	200	2000	
$V_{CE(SAT)}$	$I_C = 1.0 \text{ mA}, I_B = 0.1 \text{ mA}$.3		.3		.3	V
$V_{CE(SAT)}$	$I_C = 5.0 \text{ mA}, I_B = 0.5 \text{ mA}$		1.1		1.1		1.1	V
$V_{BE(SAT)}$	$I_C = 1.0 \text{ mA}, I_B = 0.1 \text{ mA}$.8		.8		.8	V
$V_{BE(SAT)}$	$I_C = 5.0 \text{ mA}, I_B = 0.5 \text{ mA}$.9		.9		.9	V
$V_{BE(ON)}$	$I_C = 10 \mu A, V_{CE} = 5.0V$		0.7		0.7		0.7	V
BV_{CBO}	$I_C = 10 \mu A$	45		45		45		V
BV_{CEO}	$I_C = 5 \text{ mA}$	45		45		45		V
BV_{EBO}	$I_E = 10 \mu A$	6.0		6.0		6.0		V
I_{CBO}	$V_{CB} = 50V$		0.2		0.2		0.2	nA
I_{EBO}	$V_{EB} = 4.5V$		0.2		0.2		0.2	nA

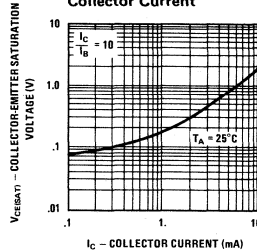
DC Pulse Current Gain vs Collector Current



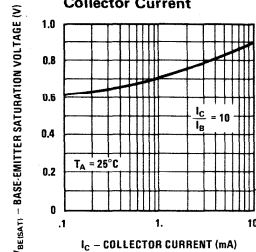
Base-Emitter On Voltage vs Collector Current



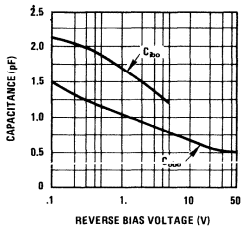
Collector-Emitter Saturation Voltage vs Collector Current



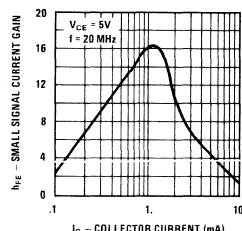
Base-Emitter Saturation Voltage vs Collector Current



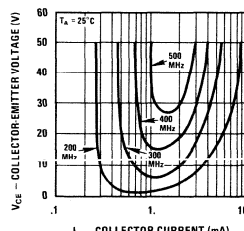
Input and Output Capacitance vs Reverse Bias Voltage



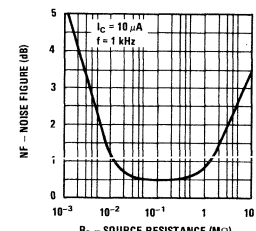
Small Signal Current Gain vs Collector Current



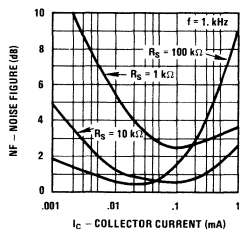
Contours of Constant Gain Bandwidth Product



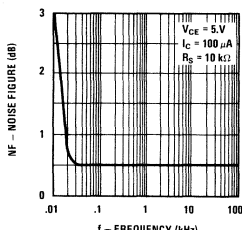
Noise Figure vs Source Resistance



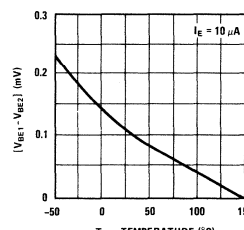
Noise Figure vs Collector Current



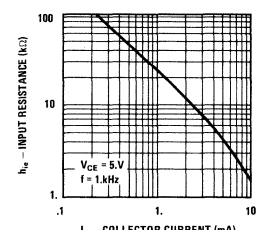
Noise Figure vs Frequency



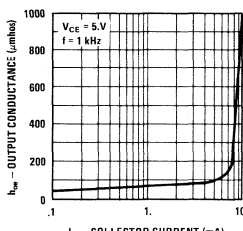
[VBE1 - VBE2] vs Temperature



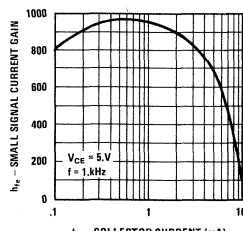
Small Signal Input Resistance vs Collector Current



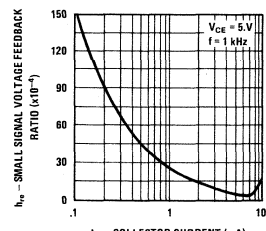
Small Signal Output Conductance vs Collector Current



Small Signal Current Gain vs Collector Current

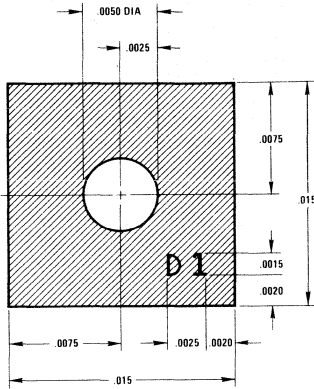


Small Signal Voltage Feedback Ratio vs Collector Current





Process D1 High Speed Diode



DESCRIPTION

Process D1 is a gold doped epitaxial silicon diode. (cathode back contact)

APPLICATION

This device was designed in die form for hybrid circuit applications requiring a high speed diode having controlled forward characteristics.

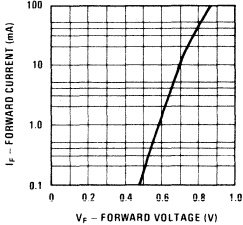
PRINCIPAL DEVICE TYPE:

1N914 (Available in dice or wafer form only)

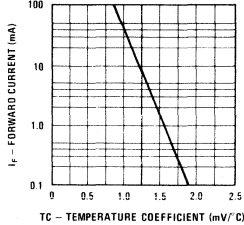
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS	NOTES
BV	10 μ A	60	80	100	V	
I_R	50V		30	100	nA	
V_F	100 μ A	0.46	0.48	0.49	V	
V_F	1.0 mA	0.56	0.58	0.62	V	
V_F	10 mA	0.66	0.70	0.74	V	
V_F	100 mA	0.82	0.90	0.93	V	
V_F	500 mA		1.2	1.4	V	
C_o	0V		1.1	1.8	pF	
t_{rr}	$I_F = I_R = 1.0$ mA to 10 mA		2.5	4.0	ns	
t_{rr}	$I_F = I_R = 10$ mA to 100 mA		3.0	4.0	ns	
t_{rr}	$I_F = I_R = 20$ mA to 200 mA		4.0	6.0	ns	

Process D1

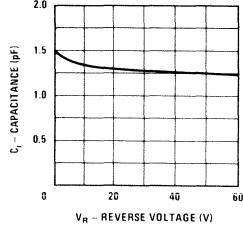
Forward Voltage vs Forward Current



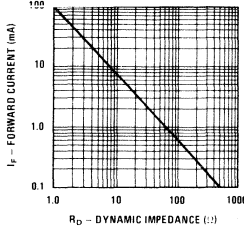
Forward Current vs Temperature Coefficient



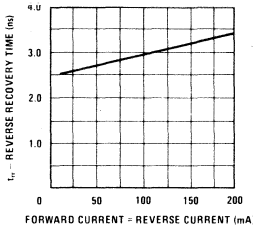
Capacitance vs Reverse Voltage



Dynamic Impedance vs Forward Current



Reverse Recovery Time vs Forward Current (I_F = I_R)

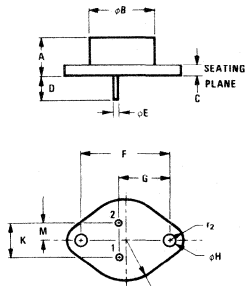




Package Outlines

NOTE: Numbers in parentheses are NS internal package codes.

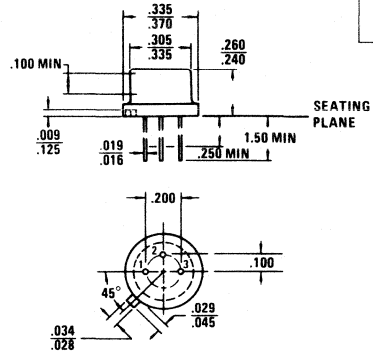
TO-3 (98)



Terminal Connections
 Pin 1 - Ground
 Pin 2 - Output
 Case - Input

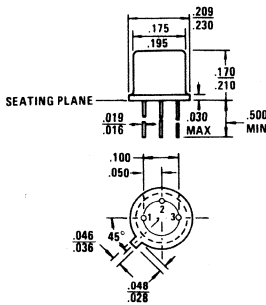
SYMBOL	INCHES	
	MIN	MAX
A	.250	.450
φE	.038	.043
φB	.420	.675
K	.420	.440
M	.205	.225
C		.135
D	.312	
φH	.151	.161
F	1.177	1.197
r ₁		.525
r ₂		.188
G	.655	.675

TO-5 (03)



PIN	T
1	E
2	B
3	C

TO-18 (02, 11, 19*)



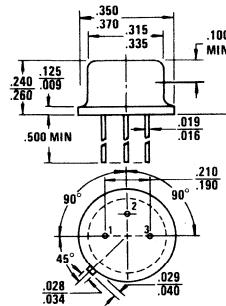
* (19 IS SOLID BASE)

PIN	T (02), (19)
1	E
2	B
3	C

PIN	FET N (02)
1	S
2	D
3	G

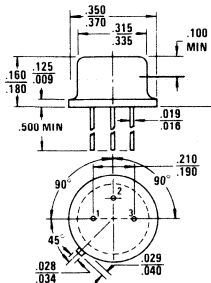
PIN	FET P (11)
1	S
2	G
3	D

TO-39 (10, 16)



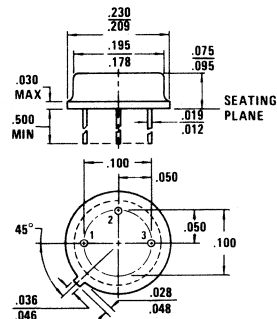
PIN	T
1	E
2	B
3	C

TO-39 (17) LO-PROFILE



PIN	T
1	E
2	B
3	C

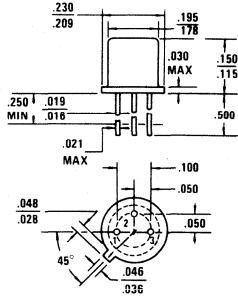
TO-46 (06)



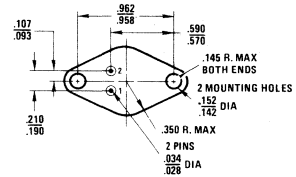
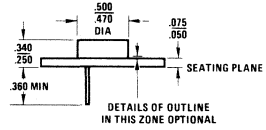
PIN	T
1	E
2	B
3	C

TO-52 (07, 18)

PIN	T (18)	FET (07)
1	E	S
2	B	D
3	C	G



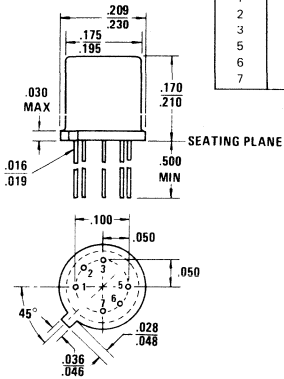
TO-66 (99)



PIN 1 - BASE
 PIN 2 - EMITTER
 CASE - COLLECTOR
 MOUNTING FLANGE - COLLECTOR

TO-71 (08, 12)

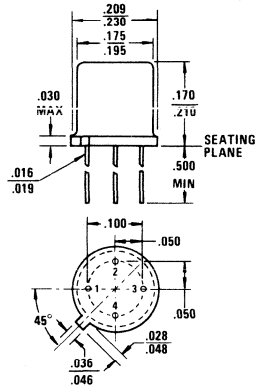
PIN	T (08)	FET (12)
1	E	S1
2	B	D1
3	C	G1
5	E	S2
6	B	D2
7	C	G2



TO-72 (23, 25, 28)

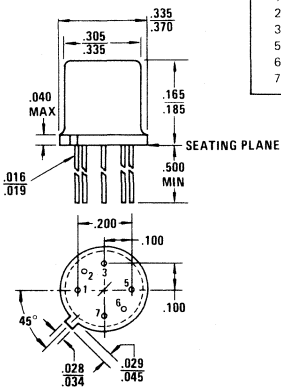
PIN	T (25)	FET N (25)
1	E	S
2	B	D
3	C	G
4	GND	CASE

PIN	T (28)	FET P (23)
1	B	S
2	E	G
3	C	D
4	GND	CASE



TO-78 (24, 27)

PIN	T (27)	FET (24)
1	C	S1
2	B	D1
3	E	G1
5	E	S2
6	B	D2
7	C	G2

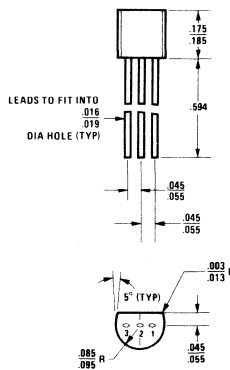


TO-92 (71, 72, 74)

PIN	71	
	T	FET
1	C	G
2	E	D
3	B	S

PIN	72	
	T	FET
1	C	G
2	B	S
3	E	D

PIN	74	
	T	FET
1	B	S
2	C	G
3	E	D



NOTES



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